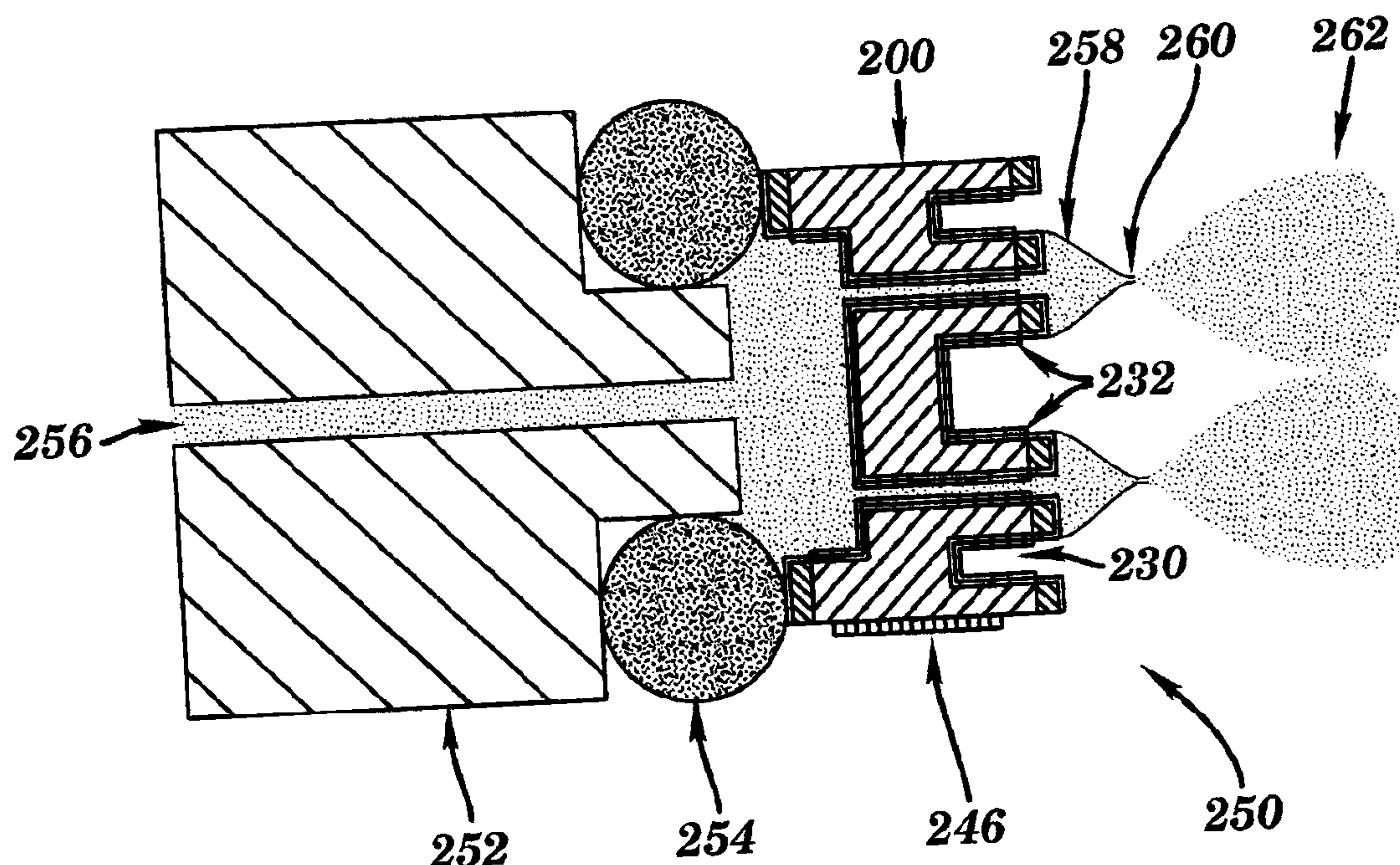




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(57) Abrégé/Abstract:

A microchip-based electrospray device, system, and method of fabrication thereof are disclosed. The electrospray device (250) includes a substrate (200) defining a channel (224) between an entrance orifice on an injection surface and an exit orifice on an ejection surface, a nozzle (232) defined by a portion recessed from the ejection surface surrounding the exit orifice, and an electric field generating source for application of an electric potential to the substrate to optimize and generate an electrospray (262). A method and system are disclosed to generate multiple electrospray plumes from a single fluid stream that provides an ion intensity as measured by a mass spectrometer that is approximately proportional to the number of electrospray plumes formed for analytes contained within the fluid. A plurality of electrospray nozzle devices (232) can be used in the form of an array of miniaturized nozzles for the purpose of generating multiple electrospray plumes (262) from multiple nozzles (232) for the same fluid stream. This invention dramatically increases the sensitivity of microchip electrospray devices (250) compared to prior disclosed systems and methods.

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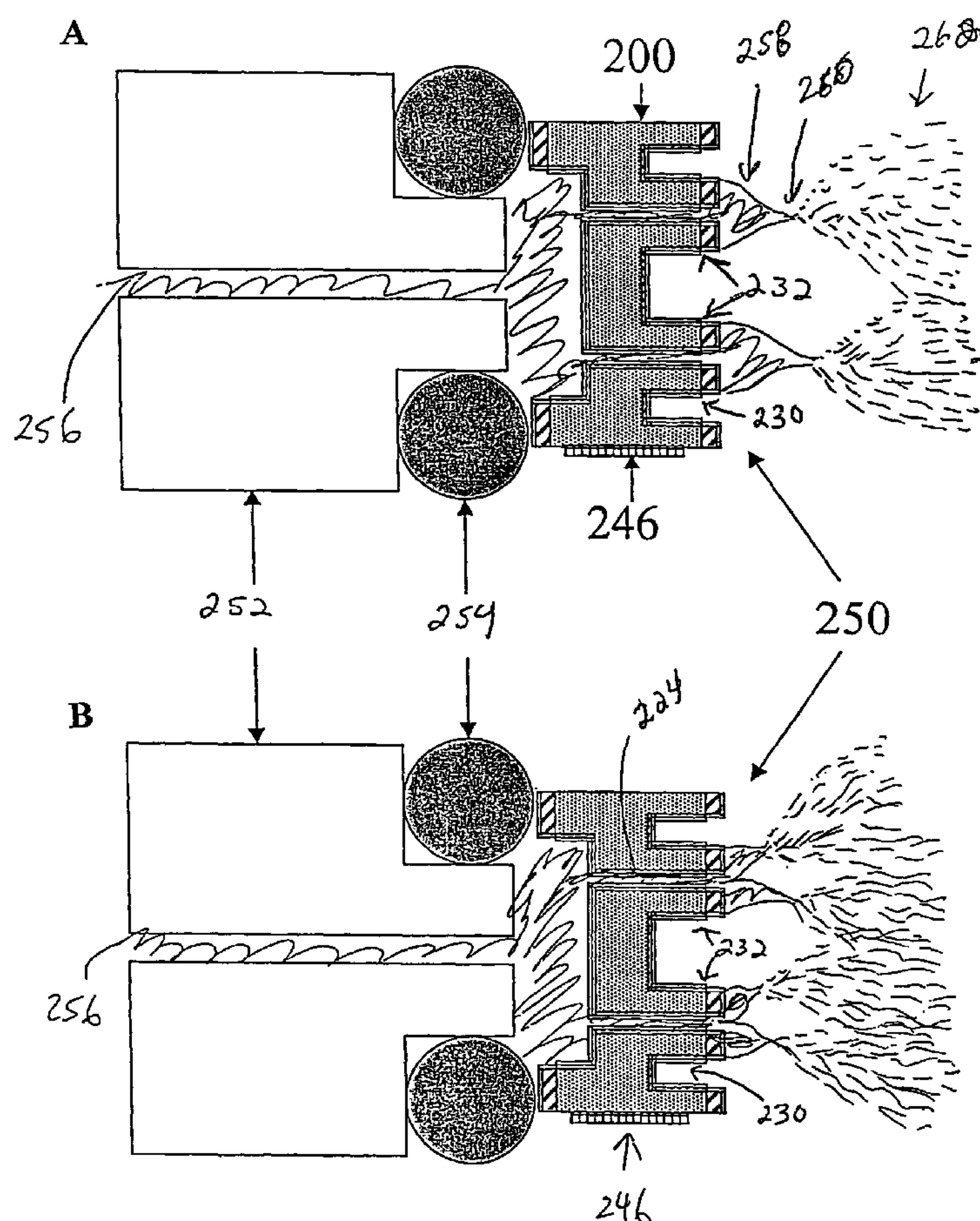
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(54) Title: MULTIPLE ELECTROSPRAY DEVICE, SYSTEMS AND METHODS



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MULTIPLE ELECTROSPRAY DEVICE, SYSTEMS AND METHODS

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FIELD OF THE INVENTION

The present invention relates generally to an integrated miniaturized fluidic system fabricated using Micro-ElectroMechanical System (MEMS) technology, particularly to an integrated monolithic microfabricated device capable of generating multiple sprays from a single fluid stream.

BACKGROUND OF THE INVENTION

New trends in drug discovery and development are creating new demands on analytical techniques. For example, combinatorial chemistry is often employed to discover new lead compounds, or to create variations of a lead compound. Combinatorial chemistry techniques can generate thousands of compounds (combinatorial libraries) in a relatively short time (on the order of days to weeks). Testing such a large number of compounds for biological activity in a timely and efficient manner requires high-throughput screening methods which allow rapid evaluation of the characteristics of each candidate compound.

The quality of the combinatorial library and the compounds contained therein is used to assess the validity of the biological screening data. Confirmation that the correct molecular weight is identified for each compound or a statistically relevant number of compounds along with a measure of compound purity are two important measures of the quality of a combinatorial library. Compounds can be analytically characterized by removing a portion of solution from each well and injecting the contents into a separation device such as liquid chromatography or capillary electrophoresis instrument coupled to a mass spectrometer.

Development of viable screening methods for these new targets will often depend on the availability of rapid separation and analysis techniques for analyzing the results of assays. For example, an assay for potential toxic metabolites of a candidate drug would need to identify both the candidate drug and the

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metabolites of that candidate. An understanding of how a new compound is absorbed in the body and how it is metabolized can enable prediction of the likelihood for an increased therapeutic effect or lack thereof.

Given the enormous number of new compounds that are being
5 generated daily, an improved system for identifying molecules of potential therapeutic value for drug discovery is also critically needed. Accordingly, there is a critical need for high-throughput screening and identification of compound-target reactions in order to identify potential drug candidates.

Liquid chromatography (LC) is a well-established analytical method
10 for separating components of a fluid for subsequent analysis and/or identification. Traditionally, liquid chromatography utilizes a separation column, such as a cylindrical tube with dimensions 4.6 mm inner diameter by 25 cm length, filled with tightly packed particles of 5 μm diameter. More recently, particles of 3 μm diameter are being used in shorter length columns. The small particle size provides a large
15 surface area that can be modified with various chemistries creating a stationary phase. A liquid eluent is pumped through the LC column at an optimized flow rate based on the column dimensions and particle size. This liquid eluent is referred to as the mobile phase. A volume of sample is injected into the mobile phase prior to the LC column. The analytes in the sample interact with the stationary phase based on the
20 partition coefficients for each of the analytes. The partition coefficient is defined as the ratio of the time an analyte spends interacting with the stationary phase to the time spent interacting with the mobile phase. The longer an analyte interacts with the stationary phase, the higher the partition coefficient and the longer the analyte is retained on the LC column. The diffusion rate for an analyte through a mobile phase
25 (mobile-phase mass transfer) also affects the partition coefficient. The mobile-phase mass transfer can be rate limiting in the performance of the separation column when it is greater than 2 μm (Knox, J.H.J. J. Chromatogr. Sci. 18:453-461 (1980)). Increases in chromatographic separation are achieved when using a smaller particle size as the stationary phase support.

30 The purpose of the LC column is to separate analytes such that a unique response for each analyte from a chosen detector can be acquired for a quantitative or qualitative measurement. The ability of a LC column to generate a separation is determined by the dimensions of the column and the particle size

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supporting the stationary phase. A measure of the ability of LC columns to separate a given analyte is referred to as the theoretical plate number N . The retention time of an analyte can be adjusted by varying the mobile phase composition and the partition coefficient for an analyte. Experimentation and a fundamental understanding of the partition coefficient for a given analyte determine which stationary phase is chosen.

To increase the throughput of LC analyses requires a reduction in the dimensions of the LC column and the stationary phase particle dimensions. Reducing the length of the LC column from 25 cm to 5 cm will result in a factor of 5 decrease in the retention time for an analyte. At the same time, the theoretical plates are reduced 5-fold. To maintain the theoretical plates of a 25 cm length column packed with 5 μm particles, a 5 cm column would need to be packed with 1 μm particles. However, the use of such small particles results in many technical challenges.

One of these technical challenges is the backpressure resulting from pushing the mobile phase through each of these columns. The backpressure is a measure of the pressure generated in a separation column due to pumping a mobile phase at a given flow rate through the LC column. For example, the typical backpressure of a 4.6 mm inner diameter by 25 cm length column packed with 5 μm particles generates a backpressure of 100 bar at a flow rate of 1.0 mL/min. A 5 cm column packed with 1 μm particles generates a back pressure 5 times greater than a 25 cm column packed with 5 μm particles. Most commercially available LC pumps are limited to operating pressures less than 400 bar and thus using an LC column with these small particles is not feasible.

Detection of analytes separated on an LC column has traditionally been accomplished by use of spectroscopic detectors. Spectroscopic detectors rely on a change in refractive index, ultraviolet and/or visible light absorption, or fluorescence after excitation with a suitable wavelength to detect the separated components. Additionally, the effluent from an LC column may be nebulized to generate an aerosol which is sprayed into a chamber to measure the light scattering properties of the analytes eluting from the column. Alternatively, the separated components may be passed from the liquid chromatography column into other types of analytical instruments for analysis. The volume from the LC column to the detector is minimized in order to maintain the separation efficiency and analysis sensitivity. All

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system volume not directly resulting from the separation column is referred to as the dead volume or extra-column volume.

The miniaturization of liquid separation techniques to the nano-scale involves small column internal diameters ($< 100\ \mu\text{m}$ i.d.) and low mobile phase flow rates ($< 300\ \text{nL/min}$). Currently, techniques such as capillary zone electrophoresis (CZE), nano-LC, open tubular liquid chromatography (OTLC), and capillary electrochromatography (CEC) offer numerous advantages over conventional scale high performance liquid chromatography (HPLC). These advantages include higher separation efficiencies, high-speed separations, analysis of low volume samples, and the coupling of 2-dimensional techniques. One challenge to using miniaturized separation techniques is detection of the small peak volumes and a limited number of detectors that can accommodate these small volumes. However, coupling of low flow rate liquid separation techniques to electrospray mass spectrometry results in a combination of techniques that are well suited as demonstrated in J.N. Alexander IV, et al., Rapid Commun. Mass Spectrom. 12:1187-91 (1998). The process of electrospray at flow rates on the order of nanoliters ("nL") per minute has been referred to as "nanoelectrospray".

Capillary electrophoresis is a technique that utilizes the electrophoretic nature of molecules and/or the electroosmotic flow of fluids in small capillary tubes to separate components of a fluid. Typically, a fused silica capillary of $100\ \mu\text{m}$ inner diameter or less is filled with a buffer solution containing an electrolyte. Each end of the capillary is placed in a separate fluidic reservoir containing a buffer electrolyte. A potential voltage is placed in one of the buffer reservoirs and a second potential voltage is placed in the other buffer reservoir. Positively and negatively charged species will migrate in opposite directions through the capillary under the influence of the electric field established by the two potential voltages applied to the buffer reservoirs. Electroosmotic flow is defined as the fluid flow along the walls of a capillary due to the migration of charged species from the buffer solution under the influence of the applied electric field. Some molecules exist as charged species when in solution and will migrate through the capillary based on the charge-to-mass ratio of the molecular species. This migration is defined as electrophoretic mobility. The electroosmotic flow and the electrophoretic mobility of each component of a fluid determine the overall migration for each fluidic component. The fluid flow profile

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resulting from electroosmotic flow is flat due to the reduction in frictional drag along the walls of the separation channel. This results in improved separation efficiency compared to liquid chromatography where the flow profile is parabolic resulting from pressure driven flow.

5 Capillary electrochromatography is a hybrid technique that utilizes the electrically driven flow characteristics of electrophoretic separation methods within capillary columns packed with a solid stationary phase typical of liquid chromatography. It couples the separation power of reversed-phase liquid chromatography with the high efficiencies of capillary electrophoresis. Higher
10 efficiencies are obtainable for capillary electrochromatography separations over liquid chromatography, because the flow profile resulting from electroosmotic flow is flat due to the reduction in frictional drag along the walls of the separation channel when compared to the parabolic flow profile resulting from pressure driven flows. Furthermore, smaller particle sizes can be used in capillary electrochromatography
15 than in liquid chromatography, because no backpressure is generated by electroosmotic flow. In contrast to electrophoresis, capillary electrochromatography is capable of separating neutral molecules due to analyte partitioning between the stationary and mobile phases of the column particles using a liquid chromatography separation mechanism.

20 Microchip-based separation devices have been developed for rapid analysis of large numbers of samples. Compared to other conventional separation devices, these microchip-based separation devices have higher sample throughput, reduced sample and reagent consumption, and reduced chemical waste. The liquid flow rates for microchip-based separation devices range from approximately 1-
25 300 nanoliters per minute for most applications. Examples of microchip-based separation devices include those for capillary electrophoresis ("CE"), capillary electrochromatography ("CEC") and high-performance liquid chromatography ("HPLC") include Harrison et al., Science 261:859-97 (1993); Jacobson et al., Anal. Chem. 66:1114-18 (1994), Jacobson et al., Anal. Chem. 66:2369-73 (1994), Kutter et al., Anal. Chem. 69:5165-71 (1997) and He et al., Anal. Chem. 70:3790-97 (1998).
30 Such separation devices are capable of fast analyses and provide improved precision and reliability compared to other conventional analytical instruments.

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The work of He et al., Anal. Chem. 70:3790-97 (1998) demonstrates some of the types of structures that can be fabricated in a glass substrate. This work shows that co-located monolithic support structures (or posts) can be etched reproducibly in a glass substrate using reactive ion etching (RIE) techniques.

5 Currently, anisotropic RIE techniques for glass substrates are limited to etching features that are 20 μm or less in depth. This work shows rectangular 5 μm by 5 μm width by 10 μm in depth posts and stated that deeper structures were difficult to achieve. The posts are also separated by 1.5 μm . The posts supports the stationary phase just as with the particles in LC and CEC columns. An advantage to the posts
10 over conventional LC and CEC is that the stationary phase support structures are monolithic with the substrate and therefore, immobile.

He et. al., also describes the importance of maintaining a constant cross-sectional area across the entire length of the separation channel. Large variations in the cross-sectional area can create pressure drops in pressure driven flow
15 systems. In electrokinetically driven flow systems, large variations in the cross-sectional area along the length of a separation channel can create flow restrictions that result in bubble formation in the separation channel. Since the fluid flowing through the separation channel functions as the source and carrier of the mobile solvated ions, formation of a bubble in a separation channel will result in the disruption of the
20 electroosmotic flow.

Electrospray ionization provides for the atmospheric pressure ionization of a liquid sample. The electrospray process creates highly-charged droplets that, under evaporation, create ions representative of the species contained in the solution. An ion-sampling orifice of a mass spectrometer may be used to sample
25 these gas phase ions for mass analysis. When a positive voltage is applied to the tip of the capillary relative to an extracting electrode, such as one provided at the ion-sampling orifice of a mass spectrometer, the electric field causes positively-charged ions in the fluid to migrate to the surface of the fluid at the tip of the capillary. When a negative voltage is applied to the tip of the capillary relative to an extracting
30 electrode, such as one provided at the ion-sampling orifice to the mass spectrometer, the electric field causes negatively-charged ions in the fluid to migrate to the surface of the fluid at the tip of the capillary.

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When the repulsion force of the solvated ions exceeds the surface tension of the fluid being electrosprayed, a volume of the fluid is pulled into the shape of a cone, known as a Taylor cone, which extends from the tip of the capillary. A liquid jet extends from the tip of the Taylor cone and becomes unstable and generates charged-droplets. These small charged droplets are drawn toward the extracting electrode. The small droplets are highly-charged and solvent evaporation from the droplets results in the excess charge in the droplet residing on the analyte molecules in the electrosprayed fluid. The charged molecules or ions are drawn through the ion-sampling orifice of the mass spectrometer for mass analysis. This phenomenon has been described, for example, by Dole et al., Chem. Phys. 49:2240 (1968) and Yamashita et al., J. Phys. Chem. 88:4451 (1984). The potential voltage ("V") required to initiate an electrospray is dependent on the surface tension of the solution as described by, for example, Smith, IEEE Trans. Ind. Appl. 1986, IA-22:527-35 (1986). Typically, the electric field is on the order of approximately 10^6 V/m. The physical size of the capillary and the fluid surface tension determines the density of electric field lines necessary to initiate electrospray.

When the repulsion force of the solvated ions is not sufficient to overcome the surface tension of the fluid exiting the tip of the capillary, large poorly charged droplets are formed. Fluid droplets are produced when the electrical potential difference applied between a conductive or partly conductive fluid exiting a capillary and an electrode is not sufficient to overcome the fluid surface tension to form a Taylor cone.

Electrospray Ionization Mass Spectrometry: Fundamentals, Instrumentation, and Applications, edited by R.B. Cole, ISBN 0-471-14564-5, John Wiley & Sons, Inc., New York summarizes much of the fundamental studies of electrospray. Several mathematical models have been generated to explain the principals governing electrospray. Equation 1 defines the electric field E_c at the tip of a capillary of radius r_c with an applied voltage V_c at a distance d from a counter electrode held at ground potential:

$$E_c = \frac{2V_c}{r_c \ln(4d/r_c)} \quad (1)$$

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The electric field E_{on} required for the formation of a Taylor cone and liquid jet of a fluid flowing to the tip of this capillary is approximated as:

$$E_{on} \approx \left(\frac{2\gamma \cos\theta}{\epsilon_0 r_c} \right)^{1/2} \quad (2)$$

5

where γ is the surface tension of the fluid, θ is the half-angle of the Taylor cone and ϵ_0 is the permittivity of vacuum. Equation 3 is derived by combining equations 1 and 2 and approximates the onset voltage V_{on} required to initiate an electrospray of a fluid from a capillary:

10

$$V_{on} \approx \left(\frac{r_c \gamma \cos\theta}{2\epsilon_0} \right)^{1/2} \ln(4d/r_c) \quad (3)$$

15

As can be seen by examination of equation 3, the required onset voltage is more dependent on the capillary radius than the distance from the counter-electrode.

20

It would be desirable to define an electrospray device that could form a stable electrospray of all fluids commonly used in CE, CEC, and LC. The surface tension of solvents commonly used as the mobile phase for these separations range from 100% aqueous ($\gamma = 0.073$ N/m) to 100% methanol ($\gamma = 0.0226$ N/m). As the surface tension of the electrospray fluid increases, a higher onset voltage is required to initiate an electrospray for a fixed capillary diameter. As an example, a capillary with a tip diameter of 14 μm is required to electrospray 100% aqueous solutions with an onset voltage of 1000 V. The work of M.S. Wilm et al., Int. J. Mass Spectrom. Ion Processes 136:167-80 (1994), first demonstrates nanoelectrospray from a fused-silica capillary pulled to an outer diameter of 5 μm at a flow rate of 25 nL/min.

25

Specifically, a nanoelectrospray at 25 nL/min was achieved from a 2 μm inner diameter and 5 μm outer diameter pulled fused-silica capillary with 600–700 V at a distance of 1-2 mm from the ion-sampling orifice of an electrospray equipped mass spectrometer.

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Electrospray in front of an ion-sampling orifice of an API mass spectrometer produces a quantitative response from the mass spectrometer detector due to the analyte molecules present in the liquid flowing from the capillary. One advantage of electrospray is that the response for an analyte measured by the mass spectrometer detector is dependent on the concentration of the analyte in the fluid and independent of the fluid flow rate. The response of an analyte in solution at a given concentration would be comparable using electrospray combined with mass spectrometry at a flow rate of 100 $\mu\text{L}/\text{min}$ compared to a flow rate of 100 nL/min . D.C. Gale et al., Rapid Commun. Mass Spectrom. 7:1017 (1993) demonstrate that higher electrospray sensitivity is achieved at lower flow rates due to increased analyte ionization efficiency. Thus by performing electrospray on a fluid at flow rates in the nanoliter per minute range provides the best sensitivity for an analyte contained within the fluid when combined with mass spectrometry.

Thus, it is desirable to provide an electrospray device for integration of microchip-based separation devices with API-MS instruments. This integration places a restriction on the capillary tip defining a nozzle on a microchip. This nozzle will, in all embodiments, exist in a planar or near planar geometry with respect to the substrate defining the separation device and/or the electrospray device. When this coplanar or near planar geometry exists, the electric field lines emanating from the tip of the nozzle will not be enhanced if the electric field around the nozzle is not defined and controlled and, therefore, an electrospray is only achievable with the application of relatively high voltages applied to the fluid.

Attempts have been made to manufacture an electrospray device for microchip-based separations. Ramsey et al., Anal. Chem. 69:1174-78 (1997) describes a microchip-based separations device coupled with an electrospray mass spectrometer. Previous work from this research group including Jacobson et al., Anal. Chem. 66:1114-18 (1994) and Jacobson et al., Anal. Chem. 66:2369-73 (1994) demonstrate impressive separations using on-chip fluorescence detection. This more recent work demonstrates nanoelectrospray at 90 nL/min from the edge of a planar glass microchip. The microchip-based separation channel has dimensions of 10 μm deep, 60 μm wide, and 33 mm in length. Electroosmotic flow is used to generate fluid flow at 90 nL/min . Application of 4,800 V to the fluid exiting the separation

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channel on the edge of the microchip at a distance of 3-5 mm from the ion-sampling orifice of an API mass spectrometer generates an electrospray. Approximately 12 nL of the sample fluid collects at the edge of the microchip before the formation of a Taylor cone and stable nanoelectrospray from the edge of the microchip. The volume of this microchip-based separation channel is 19.8 nL. Nanoelectrospray from the edge of this microchip device after capillary electrophoresis or capillary electrochromatography separation is rendered impractical since this system has a dead-volume approaching 60% of the column (channel) volume. Furthermore, because this device provides a flat surface, and, thus, a relatively small amount of physical asperity for the formation of the electrospray, the device requires an impractically high voltage to overcome the fluid surface tension to initiate an electrospray.

Xue, Q. et al., Anal. Chem. 69:426-30 (1997) also describes a stable nanoelectrospray from the edge of a planar glass microchip with a closed channel 25 μm deep, 60 μm wide, and 35-50 mm in length. An electrospray is formed by applying 4,200 V to the fluid exiting the separation channel on the edge of the microchip at a distance of 3-8 mm from the ion-sampling orifice of an API mass spectrometer. A syringe pump is utilized to deliver the sample fluid to the glass microchip at a flow rate of 100 to 200 nL/min. The edge of the glass microchip is treated with a hydrophobic coating to alleviate some of the difficulties associated with nanoelectrospray from a flat surface that slightly improves the stability of the nanoelectrospray. Nevertheless, the volume of the Taylor cone on the edge of the microchip is too large relative to the volume of the separation channel, making this method of electrospray directly from the edge of a microchip impracticable when combined with a chromatographic separation device.

T. D. Lee et. al., 1997 International Conference on Solid-State Sensors and Actuators Chicago, pp. 927-30 (June 16-19, 1997) describes a multi-step process to generate a nozzle on the edge of a silicon microchip 1-3 μm in diameter or width and 40 μm in length and applying 4,000 V to the entire microchip at a distance of 0.25-0.4 mm from the ion-sampling orifice of an API mass spectrometer. Because a relatively high voltage is required to form an electrospray with the nozzle positioned in very close proximity to the mass spectrometer ion-sampling orifice, this device

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produces an inefficient electrospray that does not allow for sufficient droplet evaporation before the ions enter the orifice. The extension of the nozzle from the edge of the microchip also exposes the nozzle to accidental breakage. More recently, T. D. Lee et.al., in 1999 Twelfth IEEE International Micro Electro Mechanical Systems Conference (January 17-21, 1999), presented this same concept where the electrospray component was fabricated to extend 2.5 mm beyond the edge of the microchip to overcome this phenomenon of poor electric field control within the proximity of a surface.

Thus, it is also desirable to provide an electrospray device with controllable spraying and a method for producing such a device that is easily reproducible and manufacturable in high volumes.

U.S. Patent 5,501,893 to Laermer et. al., reports a method of anisotropic plasma etching of silicon (Bosch process) that provides a method of producing deep vertical structures that is easily reproducible and controllable. This method of anisotropic plasma etching of silicon incorporates a two step process. Step one is an anisotropic etch step using a reactive ion etching (RIE) gas plasma of sulfur hexafluoride (SF_6). Step two is a passivation step that deposits a polymer on the vertical surfaces of the silicon substrate. This polymerizing step provides an etch stop on the vertical surface that was exposed in step one. This two step cycle of etch and passivation is repeated until the depth of the desired structure is achieved. This method of anisotropic plasma etching provides etch rates over 3 $\mu\text{m}/\text{min}$ of silicon depending on the size of the feature being etched. The process also provides selectivity to etching silicon versus silicon dioxide or resist of greater than 100:1 which is important when deep silicon structures are desired. Laermer et. al., in 1999 Twelfth IEEE International Micro Electro Mechanical Systems Conference (January 17-21, 1999), reported improvements to the Bosch process. These improvements include silicon etch rates approaching 10 $\mu\text{m}/\text{min}$, selectivity exceeding 300:1 to silicon dioxide masks, and more uniform etch rates for features that vary in size.

The present invention is directed toward a novel utilization of these features to improve the sensitivity of prior disclosed microchip-based electrospray systems.

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SUMMARY OF THE INVENTION

The present invention relates to an electrospray device for spraying a fluid which includes an insulating substrate having an injection surface and an ejection surface opposing the injection surface. The substrate is an integral monolith having either a single spray unit or a plurality of spray units for generating multiple sprays from a single fluid stream. Each spray unit includes an entrance orifice on the injection surface; an exit orifice on the ejection surface; a channel extending between the entrance orifice and the exit orifice; and a recess surrounding the exit orifice and positioned between the injection surface and the ejection surface. The entrance orifices for each of the plurality of spray units are in fluid communication with one another and each spray unit generates an electrospray plume of the fluid. The electrospray device also includes an electric field generating source positioned to define an electric field surrounding the exit orifice. In one embodiment, the electric field generating source includes a first electrode attached to the substrate to impart a first potential to the substrate and a second electrode to impart a second potential. The first and the second electrodes are positioned to define an electric field surrounding the exit orifice. This device can be operated to generate multiple electrospray plumes of fluid from each spray unit, to generate a single combined electrospray plume of fluid from a plurality of spray units, and to generate multiple electrospray plumes of fluid from a plurality of spray units. The device can also be used in conjunction with a system for processing an electrospray of fluid, a method of generating an electrospray of fluid, a method of mass spectrometric analysis, and a method of liquid chromatographic analysis.

Another aspect of the present invention is directed to an electrospray system for generating multiple sprays from a single fluid stream. The system includes an array of a plurality of the above electrospray devices. The electrospray devices can be provided in the array at a device density exceeding about 5 devices/cm², about 16 devices/cm², about 30 devices/cm², or about 81 devices/cm². The electrospray devices can also be provided in the array at a device density of from about 30 devices/cm² to about 100 devices/cm².

Another aspect of the present invention is directed to an array of a plurality of the above electrospray devices for generating multiple sprays from a single fluid stream. The electrospray devices can be provided in an array wherein the

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spacing on the ejection surface between adjacent devices is about 9 mm or less, about 4.5 mm or less, about 2.2 mm or less, about 1.1 mm or less, about 0.56 mm or less, or about 0.28 mm or less, respectively.

Another aspect of the present invention is directed to a method of
5 generating an electrospray wherein an electrospray device is provided for spraying a fluid. The electospray device includes a substrate having an injection surface and an ejection surface opposing the injection surface. The substrate is an integral monolith which includes an entrance orifice on the injection surface; an exit orifice on the ejection surface; a channel extending between the entrance orifice and the exit orifice;
10 and a recess surrounding the exit orifice and positioned between the injection surface and the ejection surface. The method can be performed to generate multiple electrospray plumes of fluid from each spray unit, to generate a single combined electrospray plume of fluid from a plurality of spray units, and to generate multiple electrospray plumes of fluid from a plurality of spray units. The electrospray device
15 also includes an electric field generating source positioned to define an electric field surrounding the exit orifice. In one embodiment, the electric field generating source includes a first electrode attached to the substrate to impart a first potential to the substrate and a second electrode to impart a second potential. The first and the second electrodes are positioned to define an electric field surrounding the exit orifice.
20 Analyte from a fluid sample is deposited on the injection surface and then eluted with an eluting fluid. The eluting fluid containing analyte is passed into the entrance orifice through the channel and through the exit orifice. A first potential is applied to the first electrode and a second potential is applied to the fluid through the second electrode. The first and second potentials are selected such that fluid discharged from
25 the exit orifice of each of the spray units forms an electrospray.

Another aspect of the present invention is directed to a method of producing an electrospray device which includes providing a substrate having opposed first and second surfaces, each coated with a photoresist over an etch-resistant material. The photoresist on the first surface is exposed to an image to form a
30 pattern in the form of at least one ring on the first surface. The photoresist on the first surface which is outside and inside the at least one ring is then removed to form an annular portion. The etch-resistant material is removed from the first surface of the substrate where the photoresist is removed to form holes in the etch-resistant material.

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Photoresist remaining on the first surface is then optionally removed. The first surface is then coated with a second coating of photoresist. The second coating of photoresist within the at least one ring is exposed to an image and removed to form at least one hole. The material from the substrate coincident with the at least one hole in the

5 second layer of photoresist on the first surface is removed to form at least one passage extending through the second layer of photoresist on the first surface and into the substrate. Photoresist from the first surface is then removed. An etch-resistant layer is applied to all exposed surfaces on the first surface side of the substrate. The etch-resistant layer from the first surface that is around the at least one ring and the

10 material from the substrate around the at least one ring are removed to define at least one nozzle on the first surface. The photoresist on the second surface is then exposed to an image to form a pattern circumscribing extensions of the at least one hole formed in the etch-resistant material of the first surface. The etch-resistant material on the second surface is then removed where the pattern is. Material is removed from

15 the substrate coincident with where the pattern in the photoresist on the second surface has been removed to form a reservoir extending into the substrate to the extent needed to join the reservoir and the at least one passage. An etch-resistant material is then applied to all exposed surfaces of the substrate to form the electrospray device. The method further includes the step of applying a silicon nitride layer over all

20 surfaces after the etch-resistant material is applied to all exposed surfaces of the substrate.

Another aspect of the present invention is directed another method of producing an electrospray device including providing a substrate having opposed first and second surfaces, the first side coated with a photoresist over an etch-resistant

25 material. The photoresist on the first surface is exposed to an image to form a pattern in the form of at least one ring on the first surface. The exposed photoresist is removed on the first surface which is outside and inside the at least one ring leaving the unexposed photoresist. The etch-resistant material is removed from the first surface of the substrate where the exposed photoresist was removed to form holes in

30 the etch-resistant material. Photoresist is removed from the first surface. Photoresist is provided over an etch-resistant material on the second surface and exposed to an image to form a pattern circumscribing extensions of the at least one ring formed in the etch-resistant material of the first surface. The exposed photoresist on the second

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surface is removed. The etch-resistant material on the second surface is removed coincident with where the photoresist was removed. Material is removed from the substrate coincident with where the etch-resistant material on the second surface was removed to form a reservoir extending into the substrate. The remaining photoresist
5 on the second surface is removed. The second surface is coated with an etch-resistant material. The first surface is coated with a second coating of photoresist. The second coating of photoresist within the at least one ring is exposed to an image. The exposed second coating of photoresist is removed from within the at least one ring to form at least one hole. Material is removed from the substrate coincident with the at
10 least one hole in the second layer of photoresist on the first surface to form at least one passage extending through the second layer of photoresist on the first surface and into substrate to the extent needed to reach the etch-resistant material coating the reservoir. Photoresist from the first surface is removed. Material is removed from the substrate exposed by the removed etch-resistant layer around the at least one ring to
15 define at least one nozzle on the first surface. The etch-resistant material coating the reservoir is removed from the substrate. An etch resistant material is applied to coat all exposed surfaces of the substrate to form the electrospray device.

The electrospray device of the present invention can generate multiple electrospray plumes from a single fluid stream and be simultaneously combined with
20 mass spectrometry. Each electrospray plume generates a signal for an analyte contained within a fluid that is proportional to that analytes concentration. When multiple electrospray plumes are generated from one nozzle, the ion intensity for a given analyte will increase with the number of electrospray plumes emanating from that nozzle as measured by the mass spectrometer. When multiple nozzle arrays
25 generate one or more electrospray plumes, the ion intensity will increase with the number of nozzles times the number of electrospray plumes emanating from the nozzle arrays.

The present invention achieves a significant advantage in terms of high-sensitivity analysis of analytes by electrospray mass spectrometry. A method of
30 control of the electric field around closely positioned electrospray nozzles provides a method of generating multiple electrospray plumes from closely positioned nozzles in a well-controlled process. An array of electrospray nozzles is disclosed for generation of multiple electrospray plumes of a solution for purpose of generating an ion

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response as measured by a mass spectrometer that increases with the total number of generated electrospray plumes. The present invention achieves a significant advantage in comparison to prior disclosed electrospray systems and methods for combination with microfluidic chip-based devices incorporating a single nozzle
5 forming a single electrospray.

The electrospray device of the present invention generally includes a silicon substrate material defining a channel between an entrance orifice on an injection surface and a nozzle on an ejection surface (the major surface) such that the electrospray generated by the device is generally perpendicular to the ejection surface.
10 The nozzle has an inner and an outer diameter and is defined by an annular portion recessed from the ejection surface. The recessed annular region extends radially from the outer diameter. The tip of the nozzle is co-planar or level with and does not extend beyond the ejection surface. Thus, the nozzle is protected against accidental breakage. The nozzle, the channel, and the recessed annular region are etched from
15 the silicon substrate by deep reactive-ion etching and other standard semiconductor processing techniques.

All surfaces of the silicon substrate preferably have insulating layers thereon to electrically isolate the liquid sample from the substrate and the ejection and injection surfaces from each other such that different potential voltages may be
20 individually applied to each surface, the silicon substrate and the liquid sample. The insulating layer generally constitutes a silicon dioxide layer combined with a silicon nitride layer. The silicon nitride layer provides a moisture barrier against water and ions from penetrating through to the substrate thus preventing electrical breakdown between a fluid moving in the channel and the substrate. The electrospray apparatus
25 preferably includes at least one controlling electrode electrically contacting the substrate for the application of an electric potential to the substrate.

Preferably, the nozzle, channel and recess are etched from the silicon substrate by reactive-ion etching and other standard semiconductor processing techniques. The injection-side features, through-substrate fluid channel, ejection-side
30 features, and controlling electrodes are formed monolithically from a monocrystalline silicon substrate -- i.e., they are formed during the course of and as a result of a fabrication sequence that requires no manipulation or assembly of separate components.

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Because the electrospray device is manufactured using reactive-ion etching and other standard semiconductor processing techniques, the dimensions of such a device nozzle can be very small, for example, as small as 2 μm inner diameter and 5 μm outer diameter. Thus, a through-substrate fluid channel having, for
5 example, 5 μm inner diameter and a substrate thickness of 250 μm only has a volume of 4.9 pL ("picoliters"). The micrometer-scale dimensions of the electrospray device minimize the dead volume and thereby increase efficiency and analysis sensitivity when combined with a separation device.

The electrospray device of the present invention provides for the
10 efficient and effective formation of an electrospray. By providing an electrospray surface (i.e., the tip of the nozzle) from which the fluid is ejected with dimensions on the order of micrometers, the device limits the voltage required to generate a Taylor cone and subsequent electrospray. The nozzle of the electrospray device provides the physical asperity on the order of micrometers on which a large electric field is
15 concentrated. Further, the nozzle of the electrospray device contains a thin region of conductive silicon insulated from a fluid moving through the nozzle by the insulating silicon dioxide and silicon nitride layers. The fluid and substrate voltages and the thickness of the insulating layers separating the silicon substrate from the fluid determine the electric field at the tip of the nozzle. Additional electrode(s) on the
20 ejection surface to which electric potential(s) may be applied and controlled independent of the electric potentials of the fluid and the substrate may be incorporated in order to advantageously modify and optimize the electric field in order to focus the gas phase ions produced by the electrospray.

The microchip-based electrospray device of the present invention
25 provides minimal extra-column dispersion as a result of a reduction in the extra-column volume and provides efficient, reproducible, reliable and rugged formation of an electrospray. This electrospray device is perfectly suited as a means of electrospray of fluids from microchip-based separation devices. The design of this electrospray device is also robust such that the device can be readily mass-produced
30 in a cost-effective, high-yielding process.

The electrospray device may be interfaced to or integrated downstream from a sampling device, depending on the particular application. For example, the

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analyte may be electrosprayed onto a surface to coat that surface or into another device for purposes of conveyance, analysis, and/or synthesis. As described previously, highly charged droplets are formed at atmospheric pressure by the electrospray device from nanoliter-scale volumes of an analyte. The highly charged
5 droplets produce gas-phase ions upon sufficient evaporation of solvent molecules which may be sampled, for example, through an ion-sampling orifice of an atmospheric pressure ionization mass spectrometer ("API-MS") for analysis of the electrosprayed fluid.

A multi-system chip thus provides a rapid sequential chemical analysis
10 system fabricated using Micro-ElectroMechanical System ("MEMS") technology. The multi-system chip enables automated, sequential separation and injection of a multiplicity of samples, resulting in significantly greater analysis throughput and utilization of the mass spectrometer instrument for high-throughput detection of compounds for drug discovery.

15 Another aspect of the present invention provides a silicon microchip-based electrospray device for producing electrospray of a liquid sample. The electrospray device may be interfaced downstream to an atmospheric pressure ionization mass spectrometer ("API-MS") for analysis of the electrosprayed fluid.

The use of multiple nozzles for electrospray of fluid from the same
20 fluid stream extends the useful flow rate range of microchip-based electrospray devices. Thus, fluids may be introduced to the multiple electrospray device at higher flow rates as the total fluid flow is split between all of the nozzles. For example, by using 10 nozzles per fluid channel, the total flow can be 10 times higher than when using only one nozzle per fluid channel. Likewise, by using 100 nozzles per fluid
25 channel, the total flow can be 100 times higher than when using only one nozzle per fluid channel. The fabrication methods used to form these electrospray nozzles allow for multiple nozzles to be easily combined with a single fluid stream channel greatly extending the useful fluid flow rate range and increasing the mass spectral sensitivity for microfluidic devices.

30

BRIEF DESCRIPTION OF THE DRAWINGS

Figure 1A shows a plan view of a one-nozzle electrospray device of the present invention.

5 Figure 1B shows a plan view of a two-nozzle electrospray device of the present invention.

Figure 1C shows a plan view of a three-nozzle electrospray device of the present invention.

10 Figure 1D shows a plan view of a fourteen-nozzle electrospray device of the present invention.

Figure 2A shows a perspective view of a one-nozzle electrospray device of the present invention.

Figure 2B shows a perspective view of a two-nozzle electrospray device of the present invention.

15 Figure 2C shows a perspective view of a three-nozzle electrospray device of the present invention.

Figure 2D shows a perspective view of a fourteen-nozzle electrospray device of the present invention.

20 Figure 3A shows a cross-sectional view of a one-nozzle electrospray device of the present invention.

Figure 3B shows a cross-sectional view of a two-nozzle electrospray device of the present invention.

Figure 3C shows a cross-sectional view of a three-nozzle electrospray device of the present invention.

25 Figure 3D shows a cross-sectional view of a fourteen-nozzle electrospray device of the present invention.

Figure 4 is a perspective view of the injection or reservoir side of an electrospray device of the present invention.

30 Figure 5A shows a cross-sectional view of a two-nozzle electrospray device of the present invention generating one electrospray plume from each nozzle.

Figure 5B shows a cross-sectional view of a two-nozzle electrospray device of the present invention generating two electrospray plumes from each nozzle.

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Figure 6A shows a perspective view of a one-nozzle electrospray device of the present invention generating one electrospray plume from one nozzle.

Figure 6B shows a perspective view of a one-nozzle electrospray device of the present invention generating two electrospray plumes from one nozzle.

5 Figure 6C shows a perspective view of a one-nozzle electrospray device of the present invention generating three electrospray plumes from one nozzle.

Figure 6D shows a perspective view of a one-nozzle electrospray device of the present invention generating four electrospray plumes from one nozzle.

10 Figure 7A shows a video capture picture of a microfabricated electrospray nozzle generating one electrospray plume from one nozzle.

Figure 7B shows a video capture picture of a microfabricated electrospray nozzle generating two electrospray plumes from one nozzle.

Figure 8A shows the total ion chromatogram ("TIC") of a solution undergoing electrospray.

15 Figure 8B shows the mass chromatogram for the protonated analyte at m/z 315. Region 1 is the resulting ion intensity from one electrospray plume from one nozzle. Region 2 is from two electrospray plumes from one nozzle. Region 3 is from three electrospray plumes from one nozzle. Region 4 is from four electrospray plumes from one nozzle. Region 5 is from two electrospray plumes from one nozzle.

20 Figure 9A shows the mass spectrum from Region 1 of Figure 8B.

Figure 9B shows the mass spectrum from Region 2 of Figure 8B.

Figure 9C shows the mass spectrum from Region 3 of Figure 8B.

Figure 9D shows the mass spectrum from Region 4 of Figure 8B.

25 Figure 10 is a chart of the ion intensity for m/z 315 versus the number of electrospray plumes emanating from one nozzle.

Figure 11A is a plan view of a two by two array of groups of four nozzles of an electrospray device.

Figure 11B is a perspective view of a two by two array of groups of four nozzles taken through a line through one row of nozzles.

30 Figure 11C is a cross-sectional view of a two by two array of groups of four nozzles of an electrospray device.

Figure 12A is a cross-sectional view of a 20 μm diameter nozzle with a nozzle height of 50 μm . The fluid has a voltage of 1000V, substrate has a voltage of

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zero V and a third electrode (not shown due to the scale of the figure) is located 5 mm from the substrate and has a voltage of zero V. The equipotential field lines are shown in increments of 50 V.

Figure 12B is an expanded region around the nozzle shown in Figure
5 12A.

Figure 12C is a cross-sectional view of a 20 μm diameter nozzle with a nozzle height of 50 μm . The fluid has a voltage of 1000V, substrate has a voltage of zero V and a third electrode (not shown due to the scale of the figure) is located 5 mm from the substrate and has a voltage of 800 V. The equipotential field lines are shown
10 in increments of 50 V.

Figure 12D is a cross-sectional view of a 20 μm diameter nozzle with a nozzle height of 50 μm . The fluid has a voltage of 1000V, substrate has a voltage of 800 V and a third electrode (not shown due to the scale of the figure) is located 5 mm from the substrate and has a voltage of zero V. The equipotential field lines are
15 shown in increments of 50 V.

Figures 13A –13C are cross-sectional views of an electrospray device of the present invention illustrating the transfer of a discrete sample quantity to a reservoir contained on the substrate surface.

Figure 13D is a cross-sectional view of an electrospray device of the
20 present invention illustrating the evaporation of the solution leaving an analyte contained within the fluid on the surface of the reservoir.

Figure 13E is a cross-sectional view of an electrospray device of the present invention illustrating a fluidic probe sealed against the injection surface delivering a reconstitution fluid to redissolve the analyte for electrospray mass
25 spectrometry analysis.

Figure 14A is a plan view of mask one of an electrospray device.

Figure 14B is a cross-sectional view of a silicon substrate 200 showing silicon dioxide layers 210 and 212 and photoresist layer 208.

Figure 14C is a cross-sectional view of a silicon substrate 200 showing
30 removal of photoresist layer 208 to form a pattern of 204 and 206 in the photoresist.

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Figure 14D is a cross-sectional view of a silicon substrate 200 showing removal of silicon dioxide 210 from the regions 212 and 214 to expose the silicon substrate in these regions to form a pattern of 204 and 206 in the silicon dioxide 210.

Figure 14E is a cross-sectional view of a silicon substrate 200 showing
5 removal of photoresist 208.

Figure 15A is a plan view of mask two of an electrospray device.

Figure 15B is a cross-sectional view of a silicon substrate 200 of
Figure 14E with a new layer of photoresist 208'.

Figure 15C is a cross-sectional view of a silicon substrate 200 showing
10 of removal of photoresist layer 208' to form a pattern of 204 in the photoresist and exposing the silicon substrate 218.

Figure 15D is a cross-sectional view of a silicon substrate 200 showing the removal of silicon substrate material from the region 218 to form a cylinder 224.

Figure 15E is a cross-sectional view of a silicon substrate 200 showing
15 removal of photoresist 208'.

Figure 15F is a cross-sectional view of a silicon substrate 200 showing thermal oxidation of the exposed silicon substrate 200 to form a layer of silicon dioxide 226 and 228 on exposed silicon horizontal and vertical surfaces, respectively.

Figure 15G is a cross-sectional view of a silicon substrate 200 showing
20 selective removal of silicon dioxide 226 from all horizontal surfaces.

Figure 15H is a cross-sectional view of a silicon substrate 200 showing removal of silicon substrate 220 to form an annular space 230 around the nozzles 232.

Figure 16A is a plan view of mask three of an electrospray device showing reservoir 234.

Figure 16B is a cross-sectional view of a silicon substrate 200 of
25 Figure 15I with a new layer of photoresist 232 on silicon dioxide 212.

Figure 16C is a cross-sectional view of a silicon substrate 200 showing removal of photoresist layer 232 to form a pattern 234 in the photoresist exposing silicon dioxide 236.

Figure 16D is a cross-sectional view of a silicon substrate 200 showing
30 removal of silicon dioxide 236 from region 234 to expose silicon 238 in the pattern of 234.

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Figure 16E is a cross-sectional view of a silicon substrate 200 showing removal of silicon 238 from region 234 to form reservoir 240 in the pattern of 234.

Figure 16F is a cross-sectional view of a silicon substrate 200 showing removal of photoresist 232.

5 Figure 16G is a cross-sectional view of a silicon substrate 200 showing thermal oxidation of the exposed silicon substrate 200 to form a layer of silicon dioxide 242 on all exposed silicon surfaces.

 Figure 16H is a cross-sectional view of a silicon substrate 200 showing low pressure vapor deposition of silicon nitride 244 conformally coating all surfaces
10 of the electrospray device 300.

 Figure 16I is a cross-sectional view of a silicon substrate 200 showing metal deposition of electrode 246 on silicon substrate 200.

 Figure 17A is a plan view of mask four of an electrospray device.

 Figure 17B is a cross-sectional view of a silicon substrate 300 showing
15 silicon dioxide layers 310 and 312 and photoresist layer 308.

 Figure 17C is a cross-sectional view of a silicon substrate 300 showing removal of photoresist layer 308 to form a pattern of 304 and 306 in the photoresist.

 Figure 17D is a cross-sectional view of a silicon substrate 300 showing removal of silicon dioxide 310 from the regions 318 and 320 to expose the silicon
20 substrate in these regions to form a pattern of 204 and 206 in the silicon dioxide 310.

 Figure 17E is a cross-sectional view of a silicon substrate 300 showing removal of photoresist 308.

 Figure 18A is a plan view of mask five of an electrospray device.

 Figure 18B is a cross-sectional view of a silicon substrate 300 showing
25 deposition of a film of positive-working photoresist 326 on the silicon dioxide layer 312.

 Figure 18C is a cross-sectional view of a silicon substrate 300 showing removal of exposed areas 324 of photoresist layer 326.

 Figure 18D is a cross-sectional view of a silicon substrate 300 showing
30 etching of the exposed area 328 of the silicon dioxide layer 312.

 Figure 18E is a cross-sectional view of a silicon substrate 300 showing the etching of reservoir 332.

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Figure 18F is a cross-sectional view of a silicon substrate 300 showing removal of the remaining photoresist 326.

Figure 18G is a cross-sectional view of a silicon substrate 300 showing deposition of the silicon dioxide layer 334.

5 Figure 19A is a plan view of mask six of an electrospray device showing through-wafer channels 304.

Figure 19B is a cross-sectional view of a silicon substrate 300 showing deposition of a layer of photoresist 308' on silicon dioxide layer 310.

10 Figure 19C is a cross-sectional view of a silicon substrate 300 showing removal of the exposed area 304 of the photoresist.

Figure 19D is a cross-sectional view of a silicon substrate 300 showing etching of the through-wafer channels 336.

Figure 19E is a cross-sectional view of a silicon substrate 300 showing removal of photoresist 308'.

15 Figure 19F is a cross-sectional view of a silicon substrate 300 showing removal of silicon substrate 320 to form an annular space 338 around the nozzles.

Figure 19G is a cross-sectional view of a silicon substrate 300 showing removal of silicon dioxide layers 310, 312 and 334.

20 Figure 20A is a cross-sectional view of a silicon substrate 300 showing deposition of silicon dioxide layer 342 coating all silicon surfaces of the electrospray device 300.

Figure 20B is a cross-sectional view of a silicon substrate 300 showing deposition of silicon nitride layer 344 coating all surfaces of the electrospray device 300.

25 Figure 20C is a cross-sectional view of a silicon substrate 300 showing metal deposition of electrodes 346 and 348.

Figures 21A and 21B show a perspective view of scanning electron micrograph images of a multi-nozzle device fabricated in accordance with the present invention.

DETAILED DESCRIPTION OF THE INVENTION

Control of the electric field at the tip of a nozzle is an important component for successful generation of an electrospray for microfluidic microchip-based systems. This invention provides sufficient control and definition of the electric field in and around a nozzle microfabricated from a monolithic silicon substrate for the formation of multiple electrospray plumes from closely positioned nozzles. The present nozzle system is fabricated using Micro-ElectroMechanical System ("MEMS") fabrication technologies designed to micromachine 3-dimensional features from a silicon substrate. MEMS technology, in particular, deep reactive ion etching ("DRIE"), enables etching of the small vertical features required for the formation of micrometer dimension surfaces in the form of a nozzle for successful nanoelectrospray of fluids. Insulating layers of silicon dioxide and silicon nitride are also used for independent application of an electric field surrounding the nozzle, preferably by application of a potential voltage to a fluid flowing through the silicon device and a potential voltage applied to the silicon substrate. This independent application of a potential voltage to a fluid exiting the nozzle tip and the silicon substrate creates a high electric field, on the order of 10^8 V/m, at the tip of the nozzle. This high electric field at the nozzle tip causes the formation of a Taylor cone, fluidic jet and highly-charged fluidic droplets characteristic of the electrospray of fluids. These two voltages, the fluid voltage and the substrate voltage, control the formation of a stable electrospray from this microchip-based electrospray device.

The electrical properties of silicon and silicon-based materials are well characterized. The use of silicon dioxide and silicon nitride layers grown or deposited on the surfaces of a silicon substrate are well known to provide electrical insulating properties. Incorporating silicon dioxide and silicon nitride layers in a monolithic silicon electrospray device with a defined nozzle provides for the enhancement of an electric field in and around features etched from a monolithic silicon substrate. This is accomplished by independent application of a voltage to the fluid exiting the nozzle and the region surrounding the nozzle. Silicon dioxide layers may be grown thermally in an oven to a desired thickness. Silicon nitride can be deposited using low pressure chemical vapor deposition ("LPCVD"). Metals may be further vapor deposited on these surfaces to provide for application of a potential voltage on the

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surface of the device. Both silicon dioxide and silicon nitride function as electrical insulators allowing the application of a potential voltage to the substrate that is different than that applied to the surface of the device. An important feature of a silicon nitride layer is that it provides a moisture barrier between the silicon substrate, silicon dioxide and any fluid sample that comes in contact with the device. Silicon nitride prevents water and ions from diffusing through the silicon dioxide layer to the silicon substrate which may cause an electrical breakdown between the fluid and the silicon substrate. Additional layers of silicon dioxide, metals and other materials may further be deposited on the silicon nitride layer to provide chemical functionality to silicon-based devices.

Figures 1A – 1D show plan views of 1, 2, 3 and 14 nozzle electrospray devices, respectively, of the present invention. Figures 2A – 2D show perspective views of the nozzle side of an electrospray device showing 1, 2, 3 and 14 nozzles, respectively, etched from the silicon substrate 200. Figures 3A – 3D show cross-sectional views of 1, 2, 3 and 14 nozzle electrospray devices, respectively. The nozzle or ejection side of the device and the reservoir or injection side of the device are connected by the through-wafer channels 224 thus creating a fluidic path through the silicon substrate 200.

Fluids may be introduced to this microfabricated electrospray device by a fluid delivery device such as a probe, conduit, capillary, micropipette, microchip, or the like. The perspective view of Figure 4 shows a probe 252 that moves into contact with the injection or reservoir side of the electrospray device of the present invention. The probe can have a disposable tip. This fluid probe has a seal, for example an o-ring 254, at the tip to form a seal between the probe tip and the injection surface of the substrate 200. Figure 4 shows an array of a plurality of electrospray devices fabricated on a monolithic substrate. One liquid sample handling device is shown for clarity, however, multiple liquid sampling devices can be utilized to provide one or more fluid samples to one or more electrospray devices in accordance with the present invention. The fluid probe and the substrate can be manipulated in 3-dimensions for staging of, for example, different devices in front of a mass spectrometer or other sample detection apparatus.

As shown in Figure 5, to generate an electrospray, fluid may be delivered to the through-substrate channel 224 of the electrospray device 250 by, for

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example, a capillary 256, micropipette or microchip. The fluid is subjected to a potential voltage, for example, in the capillary 256 or in the reservoir 242 or via an electrode provided on the reservoir surface and isolated from the surrounding surface region and the substrate 200. A potential voltage may also be applied to the silicon
5 substrate via the electrode 246 on the edge of the silicon substrate 200 the magnitude of which is preferably adjustable for optimization of the electrospray characteristics. The fluid flows through the channel 224 and exits from the nozzle 232 in the form of a Taylor cone 258, liquid jet 260, and very fine, highly charged fluidic droplets 262. Figure 5 shows a cross-sectional view of a two-nozzle array of the present invention.
10 Figure 5A shows a cross-sectional view of a 2 nozzle electrospray device generating one electrospray plume from each nozzle for a single fluid stream. Figure 5B shows a cross-sectional view of a 2 nozzle electrospray device generating 2 electrospray plumes from each nozzle for a single fluid stream.

The nozzle 232 provides the physical asperity to promote the formation
15 of a Taylor cone 258 and efficient electrospray 262 of a fluid 256. The nozzle 232 also forms a continuation of and serves as an exit orifice of the through-wafer channel 224. The recessed annular region 230 serves to physically isolate the nozzle 232 from the surface. The present invention allows the optimization of the electric field lines emanating from the fluid 256 exiting the nozzle 232, for example, through
20 independent control of the potential voltage of the fluid 256 and the potential voltage of the substrate 200.

Figures 6A – 6D illustrate 1, 2, 3 and 4 electrospray plumes,
respectively, generated from one nozzle 232. Figures 7A – 7B show video capture
pictures of a microfabricated electrospray device of the present invention generating
25 one electrospray plume from one nozzle and two electrospray plumes from one nozzle, respectively. Figure 8 shows mass spectral results acquired from a microfabricated electrospray device of the present invention generating from 1 to 4 electrospray plumes from a single nozzle. The applied fluid potential voltage relative to the applied substrate potential voltage controls the number of electrospray plumes
30 generated. Figure 8A shows the total ion chromatogram (“TIC”) of a solution containing an analyte at a concentration of 5 μ M resulting from electrospray of the fluid from a microfabricated electrospray device of the present invention. The substrate voltage for this example is held at zero V while the fluid voltage is varied to

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control the number of electrospray plumes exiting the nozzle. Figure 8B shows the selected mass chromatogram for the analyte at m/z 315. In this example, Region I has one electrospray plume exiting the nozzle tip with a fluid voltage of 950V. Region II has two electrospray plumes exiting the nozzle tip with a fluid voltage of 1050V.

5 Region III has three electrospray plumes exiting the nozzle tip with a fluid voltage of 1150 V. Region IV has four electrospray plumes exiting the nozzle tip with a fluid voltage of 1250V. Region V has two electrospray plumes exiting the nozzle tip.

Figure 9A shows the mass spectrum resulting from Region I with one electrospray plume. Figure 9B shows the mass spectrum resulting from Region II
10 with two electrospray plumes. Figure 9C shows the mass spectrum resulting from Region III with three electrospray plumes. Figure 9D shows the mass spectrum resulting from Region IV with four electrospray plumes exiting the nozzle tip. It is clear from the results that this invention can provide an increase in the analyte response measured by a mass spectrometer proportional to the number of electrospray
15 plumes exiting the nozzle tip. Figure 10 charts the ion intensity for m/z 315 for 1, 2, 3 and 4 electrospray plumes exiting the nozzle tip.

Figures 11A – 11C illustrate a system having a two by two array of electrospray devices. Each device has a group of four electrospray nozzles in fluid communication with one common reservoir containing a single fluid sample source.
20 Thus, this system can generate multiple sprays for each fluid stream up to four different fluid streams.

The electric field at the nozzle tip can be simulated using SIMION™ ion optics software. SIMION™ allows for the simulation of electric field lines for a defined array of electrodes. Figure 12A shows a cross-sectional view of a 20 μm
25 diameter nozzle 232 with a nozzle height of 50 μm . A fluid 256 flowing through the nozzle 232 and exiting the nozzle tip in the shape of a hemisphere has a potential voltage of 1000V. The substrate 200 has a potential voltage of zero volts. A simulated third electrode (not shown in the figure due to the scale of the drawing) is located 5 mm from the nozzle side of the substrate and has a potential voltage of zero
30 volts. This third electrode is generally an ion-sampling orifice of an atmospheric pressure ionization mass spectrometer. This simulates the electric field required for the formation of a Taylor cone rather than the electric field required to maintain an electrospray. Figure 12A shows the equipotential lines in 50 V increments. The

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closer the equipotential lines are spaced the higher the electric field. The simulated electric field at the fluid tip with these dimensions and potential voltages is 8.2×10^7 V/m. Figure 12B shows an expanded region around the nozzle of Figure 12A to show greater detail of the equipotential lines. Figure 12C shows the equipotential lines around this same nozzle with a fluid potential voltage of 1000V, substrate voltage of zero V and a third electrode voltage of 800 V. The electric field at the nozzle tip is 8.0×10^7 V/m indicating that the applied voltage of this third electrode has little effect on the electric field at the nozzle tip. Figure 12D shows the electric field lines around this same nozzle with a fluid potential voltage of 1000V, substrate voltage of 800 V and a third electrode voltage of 0 V. The electric field at the nozzle tip is reduced significantly to a value of 2.2×10^7 V/m. This indicates that very fine control of the electric field at the nozzle tip is achieved with this invention by independent control of the applied fluid and substrate voltages and is relatively insensitive to other electrodes placed up to 5 mm from the device. This level of control of the electric field at the nozzle tip is of significant importance for electrospray of fluids from a nozzle co-planar with the surface of a substrate.

This fine control of the electric field allows for precise control of the electrospray of fluids from these nozzles. When electrospraying fluids from this invention, this fine control of the electric field allows for a controlled formation of multiple Taylor cones and electrospray plumes from a single nozzle. By simply increasing the fluid voltage while maintaining the substrate voltage at zero V, the number of electrospray plumes emanating from one nozzle can be stepped from one to four as illustrated in Figures 6 and 7.

The high electric field at the nozzle tip applies a force to ions contained within the fluid exiting the nozzle. This force pushes positively-charged ions to the fluid surface when a positive voltage is applied to the fluid relative to the substrate potential voltage. Due to the repulsive force of likely-charged ions, the surface area of the Taylor cone generally defines and limits the total number of ions that can reside on the fluidic surface. It is generally believed that, for electrospray, a gas phase ion for an analyte can most easily be formed by that analyte when it resides on the surface of the fluid. The total surface area of the fluid increases as the number of Taylor cones at the nozzle tip increases resulting in the increase in solution phase ions at the surface of the fluid prior to electrospray formation. The ion intensity will

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increase as measured by the mass spectrometer when the number of electrospray plumes increase as shown in the example above.

Another important feature of the present invention is that since the electric field around each nozzle is preferably defined by the fluid and substrate voltage at the nozzle tip, multiple nozzles can be located in close proximity, on the order of tens of microns. This novel feature of the present invention allows for the formation of multiple electrospray plumes from multiple nozzles of a single fluid stream thus greatly increasing the electrospray sensitivity available for microchip-based electrospray devices. Multiple nozzles of an electrospray device in fluid communication with one another not only improve sensitivity but also increase the flow rate capabilities of the device. For example, the flow rate of a single fluid stream through one nozzle having the dimensions of a 10 micron inner diameter, 20 micron outer diameter, and a 50 micron length is about 1 $\mu\text{L}/\text{min.}$; and the flow rate through 200 of such nozzles is about 200 $\mu\text{L}/\text{min.}$ Accordingly, devices can be fabricated having the capacity for flow rates up to about 2 $\mu\text{L}/\text{min.}$, from about 2 $\mu\text{L}/\text{min.}$ to about 1 mL/min., from about 100 nL/min. to about 500 nL/min., and greater than about 2 $\mu\text{L}/\text{min.}$ possible.

Arrays of multiple electrospray devices having any nozzle number and format may be fabricated according to the present invention. The electrospray devices can be positioned to form from a low-density array to a high-density array of devices. Arrays can be provided having a spacing between adjacent devices of 9 mm, 4.5 mm, 2.25 mm, 1.12 mm, 0.56 mm, 0.28 mm, and smaller to a spacing as close as about 50 μm apart, respectively, which correspond to spacing used in commercial instrumentation for liquid handling or accepting samples from electrospray systems. Similarly, systems of electrospray devices can be fabricated in an array having a device density exceeding about 5 devices/ cm^2 , exceeding about 16 devices/ cm^2 , exceeding about 30 devices/ cm^2 , and exceeding about 81 devices/ cm^2 , preferably from about 30 devices/ cm^2 to about 100 devices/ cm^2 .

Dimensions of the electrospray device can be determined according to various factors such as the specific application, the layout design as well as the upstream and/or downstream device to which the electrospray device is interfaced or integrated. Further, the dimensions of the channel and nozzle may be optimized for

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the desired flow rate of the fluid sample. The use of reactive-ion etching techniques allows for the reproducible and cost effective production of small diameter nozzles, for example, a 2 μm inner diameter and 5 μm outer diameter. Such nozzles can be fabricated as close as 20 μm apart, providing a density of up to about 160,000
5 nozzles/ cm^2 . Nozzle densities up to about 10,000/ cm^2 , up to about 15,625/ cm^2 , up to about 27,566/ cm^2 , and up to about 40,000/ cm^2 , respectively, can be provided within an electrospray device. Similarly, nozzles can be provided wherein the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 500 μm , less than about 200 μm , less than about 100 μm , and less than
10 about 50 μm , respectively. For example, an electrospray device having one nozzle with an outer diameter of 20 μm would respectively have a surrounding sample well 30 μm wide. A densely packed array of such nozzles could be spaced as close as 50 μm apart as measured from the nozzle center.

In one currently preferred embodiment, the silicon substrate of the
15 electrospray device is approximately 250-500 μm in thickness and the cross-sectional area of the through-substrate channel is less than approximately 2,500 μm^2 . Where the channel has a circular cross-sectional shape, the channel and the nozzle have an inner diameter of up to 50 μm , more preferably up to 30 μm ; the nozzle has an outer diameter of up to 60 μm , more preferably up to 40 μm ; and nozzle has a height of
20 (and the annular region has a depth of) up to 100 μm . The recessed portion preferably extends up to 300 μm outwardly from the nozzle. The silicon dioxide layer has a thickness of approximately 1-4 μm , preferably 1-3 μm . The silicon nitride layer has a thickness of approximately less than 2 μm .

Furthermore, the electrospray device may be operated to produce
25 larger, minimally-charged droplets. This is accomplished by decreasing the electric field at the nozzle exit to a value less than that required to generate an electrospray of a given fluid. Adjusting the ratio of the potential voltage of the fluid and the potential voltage of the substrate controls the electric field. A fluid to substrate potential voltage ratio approximately less than 2 is preferred for droplet formation. The droplet
30 diameter in this mode of operation is controlled by the fluid surface tension, applied voltages and distance to a droplet receiving well or plate. This mode of operation is ideally suited for conveyance and/or apportionment of a multiplicity of discrete

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amounts of fluids, and may find use in such devices as ink jet printers and equipment and instruments requiring controlled distribution of fluids.

The electrospray device of the present invention includes a silicon substrate material defining a channel between an entrance orifice on a reservoir surface and a nozzle on a nozzle surface such that the electrospray generated by the device is generally perpendicular to the nozzle surface. The nozzle has an inner and an outer diameter and is defined by an annular portion recessed from the surface. The recessed annular region extends radially from the nozzle outer diameter. The tip of the nozzle is co-planar or level with and preferably does not extend beyond the substrate surface. In this manner the nozzle can be protected against accidental breakage. The nozzle, channel, reservoir and the recessed annular region are etched from the silicon substrate by reactive-ion etching and other standard semiconductor processing techniques.

All surfaces of the silicon substrate preferably have insulating layers to electrically isolate the liquid sample from the substrate such that different potential voltages may be individually applied to the substrate and the liquid sample. The insulating layers can constitute a silicon dioxide layer combined with a silicon nitride layer. The silicon nitride layer provides a moisture barrier against water and ions from penetrating through to the substrate causing electrical breakdown between a fluid moving in the channel and the substrate. The electrospray apparatus preferably includes at least one controlling electrode electrically contacting the substrate for the application of an electric potential to the substrate.

Preferably, the nozzle, channel and recess are etched from the silicon substrate by reactive-ion etching and other standard semiconductor processing techniques. The nozzle side features, through-substrate fluid channel, reservoir side features, and controlling electrodes are preferably formed monolithically from a monocrystalline silicon substrate -- i.e., they are formed during the course of and as a result of a fabrication sequence that requires no manipulation or assembly of separate components.

Because the electrospray device is manufactured using reactive-ion etching and other standard semiconductor processing techniques, the dimensions of such a device can be very small, for example, as small as 2 μm inner diameter and 5 μm outer diameter. Thus, a through-substrate fluid channel having, for example,

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5 μm inner diameter and a substrate thickness of 250 μm only has a volume of 4.9 pL. The micrometer-scale dimensions of the electrospray device minimize the dead volume and thereby increase efficiency and analysis sensitivity when combined with a separation device.

5 The electrospray device of the present invention provides for the efficient and effective formation of an electrospray. By providing an electrospray surface from which the fluid is ejected with dimensions on the order of micrometers, the electrospray device limits the voltage required to generate a Taylor cone as the voltage is dependent upon the nozzle diameter, the surface tension of the fluid, and
10 the distance of the nozzle from an extracting electrode. The nozzle of the electrospray device provides the physical asperity on the order of micrometers on which a large electric field is concentrated. Further, the electrospray device may provide additional electrode(s) on the ejecting surface to which electric potential(s) may be applied and controlled independent of the electric potentials of the fluid and the extracting
15 electrode in order to advantageously modify and optimize the electric field in order to focus the gas phase ions resulting from electrospray of fluids. The combination of the nozzle and the additional electrode(s) thus enhance the electric field between the nozzle, the substrate and the extracting electrode. The electrodes are preferable positioned within about 500 microns, and more preferably within about 200 microns
20 from the exit orifice.

 The microchip-based electrospray device of the present invention provides minimal extra-column dispersion as a result of a reduction in the extra-column volume and provides efficient, reproducible, reliable and rugged formation of an electrospray. This electrospray device is perfectly suited as a means of
25 electrospray of fluids from microchip-based separation devices. The design of this electrospray device is also robust such that the device can be readily mass-produced in a cost-effective, high-yielding process.

 In operation, a conductive or partly conductive liquid sample is introduced into the through-substrate channel entrance orifice on the injection surface.
30 The liquid is held at a potential voltage, either by means of a conductive fluid delivery device to the electrospray device or by means of an electrode formed on the injection surface isolated from the surrounding surface region and from the substrate. The electric field strength at the tip of the nozzle is enhanced by the application of a

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voltage to the substrate and/or the ejection surface, preferably zero volts up to approximately less than one-half of the voltage applied to the fluid. Thus, by the independent control of the fluid/nozzle and substrate/ejection surface voltages, the electrospray device of the present invention allows the optimization of the electric
5 field emanating from the nozzle. The electrospray device of the present invention may be placed 1-2 mm or up to 10 mm from the orifice of an atmospheric pressure ionization ("API") mass spectrometer to establish a stable nanoelectrospray at flow rates in the range of a few nanoliters per minute.

The electrospray device may be interfaced or integrated downstream to
10 a sampling device, depending on the particular application. For example, the analyte may be electrosprayed onto a surface to coat that surface or into another device for purposes of conveyance, analysis, and/or synthesis. As described above, highly charged droplets are formed at atmospheric pressure by the electrospray device from nanoliter-scale volumes of an analyte. The highly charged droplets produce gas-phase
15 ions upon sufficient evaporation of solvent molecules which may be sampled, for example, through an ion-sampling orifice of an atmospheric pressure ionization mass spectrometer ("API-MS") for analysis of the electrosprayed fluid.

One embodiment of the present invention is in the form of an array of multiple electrospray devices which allows for massive parallel processing. The
20 multiple electrospray devices or systems fabricated by massively parallel processing on a single wafer may then be cut or otherwise separated into multiple devices or systems.

The electrospray device may also serve to reproducibly distribute and deposit a sample from a mother plate to daughter plate(s) by nanoelectrospray
25 deposition or by the droplet method. A chip-based combinatorial chemistry system including a reaction well block may define an array of reservoirs for containing the reaction products from a combinatorially synthesized compound. The reaction well block further defines channels, nozzles and recessed portions such that the fluid in each reservoir may flow through a corresponding channel and exit through a
30 corresponding nozzle in the form of droplets. The reaction well block may define any number of reservoir(s) in any desirable configuration, each reservoir being of a suitable dimension and shape. The volume of a reservoir may range from a few picoliters up to several microliters.

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The reaction well block may serve as a mother plate to interface to a microchip-based chemical synthesis apparatus such that the droplet method of the electrospray device may be utilized to reproducibly distribute discrete quantities of the product solutions to a receiving or daughter plate. The daughter plate defines receiving wells that correspond to each of the reservoirs. The distributed product solutions in the daughter plate may then be utilized to screen the combinatorial chemical library against biological targets.

The electrospray device may also serve to reproducibly distribute and deposit an array of samples from a mother plate to daughter plates, for example, for proteomic screening of new drug candidates. This may be by either droplet formation or electrospray modes of operation. Electrospray device(s) may be etched into a microdevice capable of synthesizing combinatorial chemical libraries. At a desired time, a nozzle(s) may apportion a desired amount of a sample(s) or reagent(s) from a mother plate to a daughter plate(s). Control of the nozzle dimensions, applied voltages, and time provide a precise and reproducible method of sample apportionment or deposition from an array of nozzles, such as for the generation of sample plates for molecular weight determinations by matrix-assisted laser desorption/ionization time-of-flight mass spectrometry ("MALDI-TOFMS"). The capability of transferring analytes from a mother plate to daughter plates may also be utilized to make other daughter plates for other types of assays, such as proteomic screening. The fluid to substrate potential voltage ratio can be chosen for formation of an electrospray or droplet mode based on a particular application.

An array of multiple electrospray devices can be configured to disperse ink for use in an ink jet printer. The control and enhancement of the electric field at the exit of the nozzles on a substrate will allow for a variation of ink apportionment schemes including the formation of droplets approximately two times the nozzle diameters or of submicrometer, highly-charged droplets for blending of different colors of ink.

The electrospray device of the present invention can be integrated with miniaturized liquid sample handling devices for efficient electrospray of the liquid samples for detection using a mass spectrometer. The electrospray device may also be used to distribute and apportion fluid samples for use with high-throughput screen technology. The electrospray device may be chip-to-chip or wafer-to-wafer bonded to

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plastic, glass, or silicon microchip-based liquid separation devices capable of, for example, capillary electrophoresis, capillary electrochromatography, affinity chromatography, liquid chromatography ("LC"), or any other condensed-phase separation technique.

5 An array or matrix of multiple electrospray devices of the present invention may be manufactured on a single microchip as silicon fabrication using standard, well-controlled thin-film processes. This not only eliminates handling of such micro components but also allows for rapid parallel processing of functionally similar elements. The low cost of these electrospray devices allows for one-time use
10 such that cross-contamination from different liquid samples may be eliminated.

 Figures 13A – 13E illustrate the deposition of a discreet sample onto an electrospray device of the present invention. Figures 13A – 13C show a fluidic probe depositing or transferring a sample to a reservoir on the injection surface. The fluidic sample is delivered to the reservoir as a discreet volume generally less than
15 100 nL. The 'dots' represent analytes contained within a fluid. Figure 13D shows the fluidic sample volume evaporated leaving the analytes on the reservoir surface. This reservoir surface may be coated with a retentive phase, such as a hydrophobic C18-like phase commonly used for LC applications, for increasing the partition of analytes contained within the fluid to the reservoir surface. Figure 13E shows a
20 fluidic probe sealed against the injection surface to deliver a fluidic mobile phase to the microchip to reconstitute the transferred analytes for analysis by electrospray mass spectrometry. The probe can have a disposable tip, such as a capillary, micropipette, or microchip.

 A multi-system chip thus provides a rapid sequential chemical analysis
25 system fabricated using Micro-ElectroMechanical System ("MEMS") technology. For example, the multi-system chip enables automated, sequential separation and injection of a multiplicity of samples, resulting in significantly greater analysis throughput and utilization of the mass spectrometer instrument for, for example, high-throughput detection of compounds for drug discovery.

30 Another aspect of the present invention provides a silicon microchip-based electrospray device for producing electrospray of a liquid sample. The electrospray device may be interfaced downstream to an atmospheric pressure ionization mass spectrometer ("API-MS") for analysis of the electrosprayed fluid.

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Another aspect of the invention is an integrated miniaturized liquid phase separation device, which may have, for example, glass, plastic or silicon substrates integral with the electrospray device.

5 **Electrospray Device Fabrication Procedure**

 The electrospray device 250 is preferably fabricated as a monolithic silicon substrate utilizing well-established, controlled thin-film silicon processing techniques such as thermal oxidation, photolithography, reactive-ion etching (RIE), chemical vapor deposition, ion implantation, and metal deposition. Fabrication using
10 such silicon processing techniques facilitates massively parallel processing of similar devices, is time- and cost-efficient, allows for tighter control of critical dimensions, is easily reproducible, and results in a wholly integral device, thereby eliminating any assembly requirements. Further, the fabrication sequence may be easily extended to
15 create physical aspects or features on the injection surface and/or ejection surface of the electrospray device to facilitate interfacing and connection to a fluid delivery system or to facilitate integration with a fluid delivery sub-system to create a single integrated system.

Nozzle Surface Processing:

20 Figures 14A – 14E and Figures 15A – 15I illustrate the processing steps for the nozzle or ejection side of the substrate in fabricating the electrospray device of the present invention. Referring to the plan view of Figure 14A, a mask is used to pattern 202 that will form the nozzle shape in the completed electrospray device 250. The patterns in the form of circles 204 and 206 forms through-wafer
25 channels and a recessed annular space around the nozzles, respectively of a completed electrospray device. Figure 14B is the cross-sectional view taken along line 14B-14B of Figure 14A. A double-side polished silicon wafer 200 is subjected to an elevated temperature in an oxidizing environment to grow a layer or film of silicon dioxide 210 on the nozzle side and a layer or film of silicon dioxide 212 on the reservoir side of
30 the substrate 200. Each of the resulting silicon dioxide layers 210, 212 has a thickness of approximately 1-3 μm . The silicon dioxide layers 210, 212 serve as masks for subsequent selective etching of certain areas of the silicon substrate 200.

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A film of positive-working photoresist 208 is deposited on the silicon dioxide layer 210 on the nozzle side of the substrate 200. Referring to Figure 14C, an area of the photoresist 204 corresponding to the entrance to through-wafer channels and an area of photoresist corresponding to the recessed annular region 206 which
5 will be subsequently etched is selectively exposed through a mask (Figure 14A) by an optical lithographic exposure tool passing short-wavelength light, such as blue or near-ultraviolet at wavelengths of 365, 405, or 436 nanometers.

As shown in the cross-sectional view of Figure 14C, after development of the photoresist 208, the exposed area 204 of the photoresist is removed and open to
10 the underlying silicon dioxide layer 214 and the exposed area 206 of the photoresist is removed and open to the underlying silicon dioxide layer 216, while the unexposed areas remain protected by photoresist 208. Referring to Figure 14D, the exposed areas 214, 216 of the silicon dioxide layer 210 is then etched by a fluorine-based plasma with a high degree of anisotropy and selectivity to the protective photoresist
15 208 until the silicon substrate 218, 220 are reached. As shown in the cross-sectional view of Figure 14E, the remaining photoresist 208 is removed from the silicon substrate 200.

Referring to the plan view of Figure 15A, a mask is used to pattern 204 in the form of circles. Figure 15B is the cross-sectional view taken along line 15B-
20 15B of Figure 15A. A film of positive-working photoresist 208' is deposited on the silicon dioxide layer 210 on the nozzle side of the substrate 200. Referring to Figure 15C, an area of the photoresist 204 corresponding to the entrance to through-wafer channels is selectively exposed through a mask (Figure 15A) by an optical lithographic exposure tool passing short-wavelength light, such as blue or near-
25 ultraviolet at wavelengths of 365, 405, or 436 nanometers.

As shown in the cross-sectional view of Figure 15C, after development of the photoresist 208', the exposed area 204 of the photoresist is removed to the underlying silicon substrate 218. The remaining photoresist 208' is used as a mask during the subsequent fluorine based DRIE silicon etch to vertically etch the through-
30 wafer channels 224 shown in Figure 15D. After etching the through-wafer channels 224, the remaining photoresist 208' is removed from the silicon substrate 200.

As shown in the cross-sectional view of Figure 15E, the removal of the photoresist 208' exposes the mask pattern of Figure 14A formed in the silicon dioxide

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210 as shown in Figure 14E. Referring to Figure 15F, the silicon wafer of Figure 15E is subjected to an elevated temperature in an oxidizing environment to grow a layer or film of silicon dioxide 226, 228 on all exposed silicon surfaces of the wafer.

Referring to Figure 15G, the silicon dioxide 226 is then etched by a fluorine-based plasma with a high degree of anisotropy and selectivity until the silicon substrate 220 is reached. The silicon dioxide layer 228 is designed to serve as an etch stop during the DRIE etch of Figure 15H that is used to form the nozzle 232 and recessed annular region 230.

An advantage of the fabrication process described herein is that the process simplifies the alignment of the through-wafer channels and the recessed annular region. This allows the fabrication of smaller nozzles with greater ease without any complex alignment of masks. Dimensions of the through channel, such as the aspect ratio (i.e. depth to width), can be reliably and reproducibly limited and controlled.

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Reservoir Surface Processing:

Figures 16A – 16I illustrate the processing steps for the reservoir or injection side of the substrate 200 in fabricating the electrospray device 250 of the present invention. As shown in the cross-sectional view in Figure 16B (a cross-sectional view taken along line 16B-16B of Figure 16A), a film of positive-working photoresist 236 is deposited on the silicon dioxide layer 212. Patterns on the reservoir side are aligned to those previously formed on the nozzle side of the substrate using through-substrate alignments.

After alignment, an area of the photoresist 236 corresponding to the circular reservoir 234 is selectively exposed through a mask (Figure 16A) by an optical lithographic exposure tool passing short-wavelength light, such as blue or near- ultraviolet at wavelengths of 365, 405, or 436 nanometers. As shown in the cross-sectional view of Figure 16C, the photoresist 236 is then developed to remove the exposed areas of the photoresist 234 such that the reservoir region is open to the underlying silicon dioxide layer 238, while the unexposed areas remain protected by photoresist 236. The exposed area 238 of the silicon dioxide layer 212 is then etched by a fluorine-based plasma with a high degree of anisotropy and selectivity to the

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protective photoresist 236 until the silicon substrate 240 is reached as shown in Figure 16D.

As shown in Figure 16E, a fluorine-based etch creates a cylindrical region that defines a reservoir 242. The reservoir 242 is etched until the through-wafer channels 224 are reached. After the desired depth is achieved the remaining photoresist 236 is then removed in an oxygen plasma or in an actively oxidizing chemical bath like sulfuric acid (H_2SO_4) activated with hydrogen peroxide (H_2O_2), as shown in Figure 16F.

10 Preparation of the Substrate for Electrical Isolation

Referring to Figure 16G, the silicon wafer 200 is subjected to an elevated temperature in an oxidizing environment to grow a layer or film of silicon dioxide 244 on all silicon surfaces to a thickness of approximately 1-3 μm . The silicon dioxide layer serves as an electrical insulating layer. Silicon nitride 246 is further deposited using low pressure chemical vapor deposition (LPCVD) to provide a conformal coating of silicon nitride on all surfaces up to 2 μm in thickness, as shown in Figure 16H. LPCVD silicon nitride also provides further electrical insulation and a fluid barrier that prevents fluids and ions contained therein that are introduced to the electrospray device from causing an electrical connection between the fluid the silicon substrate 200. This allows for the independent application of a potential voltage to a fluid and the substrate with this electrospray device to generate the high electric field at the nozzle tip required for successful nanoelectrospray of fluids from microchip devices.

After fabrication of multiple electrospray devices on a single silicon wafer, the wafer can be diced or cut into individual devices. This exposes a portion of the silicon substrate 200 as shown in the cross-sectional view of Figure 16I on which a layer of conductive metal 248 is deposited.

All silicon surfaces are oxidized to form silicon dioxide with a thickness that is controllable through choice of temperature and time of oxidation. All silicon dioxide surfaces are LPCVD coated with silicon nitride. The final thickness of the silicon dioxide and silicon nitride can be selected to provide the desired degree of electrical isolation in the device. A thicker layer of silicon dioxide and silicon nitride provides a greater resistance to electrical breakdown. The silicon substrate is divided

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into the desired size or array of electrospray devices for purposes of metalization of the edge of the silicon substrate. As shown in Figure 16I, the edge of the silicon substrate 200 is coated with a conductive material 248 using well known thermal evaporation and metal deposition techniques.

5 The fabrication method confers superior mechanical stability to the fabricated electrospray device by etching the features of the electrospray device from a monocrystalline silicon substrate without any need for assembly. The alignment scheme allows for nozzle walls of less than 2 μm and nozzle outer diameters down to 5 μm to be fabricated reproducibly. Further, the lateral extent and shape of the
10 recessed annular region can be controlled independently of its depth. The depth of the recessed annular region also determines the nozzle height and is determined by the extent of etch on the nozzle side of the substrate.

 The above described fabrication sequence for the electrospray device can be easily adapted to and is applicable for the simultaneous fabrication of a single
15 monolithic system comprising multiple electrospray devices including multiple channels and/or multiple ejection nozzles embodied in a single monolithic substrate. Further, the processing steps may be modified to fabricate similar or different electrospray devices merely by, for example, modifying the layout design and/or by changing the polarity of the photomask and utilizing negative-working photoresist
20 rather than utilizing positive-working photoresist.

 In a further embodiment an alternate fabrication technique is set forth in Figures 17 – 20. This technique has several advantages over the prior technique, primarily due to the function of the etch stop deposited on the reservoir side of the substrate. This feature improves the production of through-wafer channels having a
25 consistent diameter throughout its length. An artifact of the etching process is the difficulty of maintaining consistent channel diameter when approaching an exposed surface of the substrate from within. Typically, the etching process forms a channel having a slightly smaller diameter at the end of the channel as it breaks through the opening. This is improved by the ability to slightly over-etch the channel when
30 contacting the etch stop. Further, another advantage of etching the reservoir and depositing an etch stop prior to the channel etch is that micro-protrusions resulting from the side passivation of the channels remaining at the channel opening are avoided. The etch stop also functions to isolate the plasma region from the cooling

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gas when providing through holes and avoiding possible contamination from etching by products.

Figures 17A – 17E and Figures 19A – 19G illustrate the processing steps for the nozzle or ejection side of the substrate in fabricating the electrospray device of the present invention. Figures 18A – 18G illustrate the processing steps for the reservoir or injection side of the substrate in fabricating the electrospray device of the present invention. Figures 20A – 20C illustrate the preparation of the substrate for electrical isolation.

Referring to the plan view of Figure 17A, a mask is used to pattern 302 that will form the nozzle shape in the completed electrospray device 250. The patterns in the form of circles 304 and 306 forms through-wafer channels and a recessed annular space around the nozzles, respectively of a completed electrospray device. Figure 17B is the cross-sectional view taken along line 17B-17B of Figure 17A. A double-side polished silicon wafer 300 is subjected to an elevated temperature in an oxidizing environment to grow a layer or film of silicon dioxide 310 on the nozzle side and a layer or film of silicon dioxide 312 on the reservoir side of the substrate 300. Each of the resulting silicon dioxide layers 310, 312 has a thickness of approximately 1-3 μm . The silicon dioxide layers 310, 312 serve as masks for subsequent selective etching of certain areas of the silicon substrate 300.

A film of positive-working photoresist 308 is deposited on the silicon dioxide layer 310 on the nozzle side of the substrate 300. Referring to Figure 17C, an area of the photoresist 304 corresponding to the entrance to through-wafer channels and an area of photoresist corresponding to the recessed annular region 306 which will be subsequently etched is selectively exposed through a mask (Figure 17A) by an optical lithographic exposure tool passing short-wavelength light, such as blue or near-ultraviolet at wavelengths of 365, 405, or 436 nanometers.

As shown in the cross-sectional view of Figure 17C, after development of the photoresist 308, the exposed area 304 of the photoresist is removed and open to the underlying silicon dioxide layer 314 and the exposed area 306 of the photoresist is removed and open to the underlying silicon dioxide layer 310, while the unexposed areas remain protected by photoresist 308. Referring to Figure 17D, the exposed areas 314, 316 of the silicon dioxide layer 310 is then etched by a fluorine-based plasma with a high degree of anisotropy and selectivity to the protective photoresist

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308 until the silicon substrate 318, 320 are reached. As shown in the cross-sectional view of Figure 17E, the remaining photoresist 308 is removed from the silicon substrate 300.

Referring to the plan view of Figure 18A, a mask is used to pattern 324 in the form of a circle. Figure 18B is the cross-sectional view taken along line 18B-18B of Figure 18A. As shown in the cross-sectional view in Figure 18B a film of positive-working photoresist 326 is deposited on the silicon dioxide layer 312. Patterns on the reservoir side are aligned to those previously formed on the nozzle side of the substrate using through-substrate alignments.

After alignment, an area of the photoresist 326 corresponding to the circular reservoir 324 is selectively exposed through the mask (Figure 18A) by an optical lithographic exposure tool passing short-wavelength light, such as blue or near-ultraviolet at wavelengths of 365, 405, or 436 nanometers. As shown in the cross-sectional view of Figure 18C, the photoresist 326 is then developed to remove the exposed areas of the photoresist 324 such that the reservoir region is open to the underlying silicon dioxide layer 328, while the unexposed areas remain protected by photoresist 326. The exposed area 328 of the silicon dioxide layer 312 is then etched by a fluorine-based plasma with a high degree of anisotropy and selectivity to the protective photoresist 326 until the silicon substrate 330 is reached as shown in Figure 18D.

As shown in Figure 18E, a fluorine-based etch creates a cylindrical region that defines a reservoir 332. The reservoir 332 is etched until the through-wafer channel depths are reached. After the desired depth is achieved the remaining photoresist 326 is then removed in an oxygen plasma or in an actively oxidizing chemical bath like sulfuric acid (H_2SO_4) activated with hydrogen peroxide (H_2O_2), as shown in Figure 18F.

Referring to Figure 18G, a plasma enhanced chemical vapor deposition ("PECVD") silicon dioxide layer 334 is deposited on the reservoir side of the substrate 300 to serve as an etch stop for the subsequent etch of the through substrate channel 336 shown in Figure 19D.

A film of positive-working photoresist 308' is deposited on the silicon dioxide layer 310 on the nozzle side of the substrate 300, as shown in Figure 19B. Referring to Figure 19C, an area of the photoresist 304 corresponding to the entrance

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to through-wafer channels is selectively exposed through a mask (Figure 19A) by an optical lithographic exposure tool passing short-wavelength light, such as blue or near-ultraviolet at wavelengths of 365, 405, or 436 nanometers.

As shown in the cross-sectional view of Figure 19C, after development
5 of the photoresist 308', the exposed area 304 of the photoresist is removed to the underlying silicon substrate 318. The remaining photoresist 308' is used as a mask during the subsequent fluorine based DRIE silicon etch to vertically etch the through-wafer channels 336 shown in Figure 19D. After etching the through-wafer channels 336, the remaining photoresist 308' is removed from the silicon substrate 300, as
10 shown in the cross-sectional view of Figure 19E.

The removal of the photoresist 308' exposes the mask pattern of Figure 17A formed in the silicon dioxide 310 as shown in Figure 19E. The fluorine based DRIE silicon etch is used to vertically etch the recessed annular region 338 shown in Figure 19F. Referring to Figure 19G, the silicon dioxide layers 310, 312 and 334 are
15 removed from the substrate by a hydrofluoric acid process.

An advantage of the fabrication process described herein is that the process simplifies the alignment of the through-wafer channels and the recessed annular region. This allows the fabrication of smaller nozzles with greater ease without any complex alignment of masks. Dimensions of the through channel, such
20 as the aspect ratio (i.e. depth to width), can be reliably and reproducibly limited and controlled.

Preparation of the Substrate for Electrical Isolation

Referring to Figure 20A, the silicon wafer 300 is subjected to an
25 elevated temperature in an oxidizing environment to grow a layer or film of silicon dioxide 342 on all silicon surfaces to a thickness of approximately 1-3 μm . The silicon dioxide layer serves as an electrical insulating layer. Silicon nitride 344 is further deposited using low pressure chemical vapor deposition (LPCVD) to provide a conformal coating of silicon nitride on all surfaces up to 2 μm in thickness, as shown
30 in Figure 20B. LPCVD silicon nitride also provides further electrical insulation and a fluid barrier that prevents fluids and ions contained therein that are introduced to the electrospray device from causing an electrical connection between the fluid the silicon substrate 300. This allows for the independent application of a potential voltage to a

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fluid and the substrate with this electrospray device to generate the high electric field at the nozzle tip required for successful nanoelectrospray of fluids from microchip devices.

After fabrication of multiple electrospray devices on a single silicon
5 wafer, the wafer can be diced or cut into individual devices. This exposes a portion of the silicon substrate 300 as shown in the cross-sectional view of Figure 20C on which a layer of conductive metal 346 is deposited, which serves as the substrate electrode. A layer of conductive metal 348 is deposited on the silicon nitride layer of the reservoir side, which serves as the fluid electrode.

10 All silicon surfaces are oxidized to form silicon dioxide with a thickness that is controllable through choice of temperature and time of oxidation. All silicon dioxide surfaces are LPCVD coated with silicon nitride. The final thickness of the silicon dioxide and silicon nitride can be selected to provide the desired degree of electrical isolation in the device. A thicker layer of silicon dioxide and silicon nitride
15 provides a greater resistance to electrical breakdown. The silicon substrate is divided into the desired size or array of electrospray devices for purposes of metalization of the edge of the silicon substrate. As shown in Figure 20C, the edge of the silicon substrate 300 is coated with a conductive material 248 using well known thermal evaporation and metal deposition techniques.

20 The fabrication methods confer superior mechanical stability to the fabricated electrospray device by etching the features of the electrospray device from a monocrystalline silicon substrate without any need for assembly. The alignment scheme allows for nozzle walls of less than 2 μm and nozzle outer diameters down to 5 μm to be fabricated reproducibly. Further, the lateral extent and shape of the
25 recessed annular region can be controlled independently of its depth. The depth of the recessed annular region also determines the nozzle height and is determined by the extent of etch on the nozzle side of the substrate.

Figures 21A and 21B show a perspective view of scanning electron
micrograph images of a multi-nozzle device fabricated in accordance with the present
30 invention. The nozzles have a 20 μm outer diameter and an 8 μm inner diameter. The pitch, which is the nozzle center to nozzle center spacing of the nozzles is 50 μm .

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The above described fabrication sequences for the electrospray device can be easily adapted to and are applicable for the simultaneous fabrication of a single monolithic system comprising multiple electrospray devices including multiple channels and/or multiple ejection nozzles embodied in a single monolithic substrate.

5 Further, the processing steps may be modified to fabricate similar or different electrospray devices merely by, for example, modifying the layout design and/or by changing the polarity of the photomask and utilizing negative-working photoresist rather than utilizing positive-working photoresist.

10 **Interface of a Multi-System Chip to a Mass Spectrometer**

Arrays of electrospray nozzles on a multi-system chip may be interfaced with a sampling orifice of a mass spectrometer by positioning the nozzles near the sampling orifice. The tight configuration of electrospray nozzles allows the positioning thereof in close proximity to the sampling orifice of a mass spectrometer.

15 A multi-system chip may be manipulated relative to the ion sampling orifice to position one or more of the nozzles for electrospray near the sampling orifice. Appropriate voltage(s) may then be applied to the one or more of the nozzles for electrospray.

Although the invention has been described in detail for the purpose of
20 illustration, it is understood that such detail is solely for that purpose, and variations can be made therein by those skilled in the art without departing from the spirit and scope of the invention which is defined by the following claims.

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WHAT IS CLAIMED IS:

1. An electrospray device for generating multiple sprays from a single fluid stream comprising:
 - a substrate having:
 - a) an injection surface;
 - b) an ejection surface opposing the injection surface, wherein the substrate is an integral monolith having either i) a plurality of spray units each capable of generating a single electrospray plume wherein the entrance orifice of each spray unit is in fluid communication with one another or ii) a plurality of spray units each capable of generating multiple electrospray plumes wherein the entrance orifice of each spray unit is in fluid communication with one another or iii) a single spray unit capable of generating multiple electrospray plumes, for spraying the fluid, each spray unit comprising:
 - an entrance orifice on the injection surface,
 - an exit orifice on the ejection surface,
 - a channel extending between the entrance orifice and the exit orifice, and
 - a recess surrounding the exit orifice positioned between the injection surface and the ejection surface; and
 - c) an electric field generating source positioned to define an electric field surrounding at least one exit orifice.
2. The electrospray device according to claim 1, wherein the substrate has a plurality of spray units each capable of generating a single electrospray plume wherein the entrance orifice of each spray unit is in fluid communication with one another.
3. The electrospray device according to claim 1, wherein the substrate has a plurality of spray units each capable of generating multiple electrospray plumes wherein the entrance orifice of each spray unit is in fluid communication with one another.

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4. The electrospray device according to claim 1, wherein the substrate has a single spray unit capable of generating multiple electrospray plumes.
5. The electrospray device according to claim 2, wherein the plurality of spray units are configured to generate a single combined electrospray plume of fluid.
6. The electrospray device according to claim 3, wherein at least one of the spray units is configured to generate multiple electrospray plumes of fluid which remain discrete.
7. The electrospray device according to claim 3, wherein the plurality of spray units are configured to generate a single combined electrospray plume of fluid.
8. The electrospray device according to claim 4, wherein the single spray unit is configured to generate multiple electrospray plumes of fluid which remain discrete.
9. The electrospray device of claim 2, wherein the exit orifices of the spray units are present on the ejection surface at a density of up to about 10,000 exit orifices/cm².
10. The electrospray device of claim 2, wherein the exit orifices of the spray units are present on the ejection surface at a density of up to about 15,625 exit orifices/cm².
11. The electrospray device of claim 2, wherein the exit orifices of the spray units are present on the ejection surface at a density of up to about 27,566 exit orifices/cm².
12. The electrospray device of claim 2, wherein the exit orifices of the spray units are present on the ejection surface at a density of up to about 40,000 exit orifices/cm².
13. The electrospray device of claim 2, wherein the exit orifices of the spray units are present on the ejection surface at a density of up to about 160,000 exit orifices/cm².

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14. The electrospray device of claim 3, wherein the exit orifices of the spray units are present on the ejection surface at a density of up to about 10,000 exit orifices/cm².

15. The electrospray device of claim 3, wherein the exit orifices of the spray units are present on the ejection surface at a density of up to about 15,625 exit orifices/cm².

16. The electrospray device of claim 3, wherein the exit orifices of the spray units are present on the ejection surface at a density of up to about 27,566 exit orifices/cm².

17. The electrospray device of claim 3, wherein the exit orifices of the spray units are present on the ejection surface at a density of up to about 40,000 exit orifices/cm².

18. The electrospray device of claim 3, wherein the exit orifices of the spray units are present on the ejection surface at a density of up to about 160,000 exit orifices/cm².

19. The electrospray device of claim 2, wherein the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 500 μm .

20. The electrospray device of claim 2, wherein the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 200 μm .

21. The electrospray device of claim 2, wherein the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 100 μm .

22. The electrospray device of claim 2, wherein the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 50 μm .

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23. The electrospray device of claim 3, wherein the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 500 μm .

24. The electrospray device of claim 3, wherein the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 200 μm .

25. The electrospray device of claim 3, wherein the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 100 μm .

26. The electrospray device of claim 3, wherein the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 50 μm .

27. The electrospray device according to claim 1, wherein said substrate comprises silicon.

28. The electrospray device according to claim 1, wherein said substrate is polymeric.

29. The electrospray device according to claim 1, wherein said substrate comprises glass.

30. The electrospray device according to claim 2, wherein said electric field generating source comprises:

a first electrode attached to said substrate to impart a first potential to said substrate; and

a second electrode to impart a second potential, wherein the first and the second electrodes are positioned to define an electric field surrounding at least one exit orifice.

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31. The electrospray device according to claim 30, wherein the first electrode is electrically insulated from the fluid and the second potential is applied to the fluid.

32. The electrospray device according to claim 30, wherein the first electrode is in electrical contact with the fluid and the second electrode is positioned on the ejection surface.

33. The electrospray device according to claim 30, wherein application of potentials to said first and second electrodes causes the fluid to discharge from at least one exit orifice in the form of an electrospray plume.

34. The electrospray device according to claim 3, wherein said electric field generating source comprises:

a first electrode attached to said substrate to impart a first potential to said substrate; and

a second electrode to impart a second potential, wherein the first and the second electrodes are positioned to define an electric field surrounding at least one exit orifice.

35. The electrospray device according to claim 34, wherein the first electrode is electrically insulated from the fluid and the second potential is applied to the fluid.

36. The electrospray device according to claim 34, wherein the first electrode is in electrical contact with the fluid and the second electrode is positioned on the ejection surface.

37. The electrospray device according to claim 34, wherein application of potentials to said first and second electrodes causes the fluid to discharge from at least one exit orifice in the form of multiple electrospray plumes.

38. The electrospray device according to claim 4, wherein said electric field generating source comprises:

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a first electrode attached to said substrate to impart a first potential to said substrate; and

a second electrode to impart a second potential, wherein the first and the second electrodes are positioned to define an electric field surrounding the exit orifice.

39. The electrospray device according to claim 38, wherein the first electrode is electrically insulated from the fluid and the second potential is applied to the fluid.

40. The electrospray device according to claim 38, wherein the first electrode is in electrical contact with the fluid and the second electrode is positioned on the ejection surface.

41. The electrospray device according to claim 38, wherein application of potentials to said first and second electrodes causes the fluid to discharge from the orifice in the form of multiple electrospray plumes.

42. The electrospray device according to claim 30, wherein said first electrode is positioned within 500 microns of the exit orifice.

43. The electrospray device according to claim 30, wherein said first electrode is positioned within 200 microns of the exit orifice.

44. The electrospray device according to claim 30, wherein said second electrode is positioned within 500 microns of the exit orifice.

45. The electrospray device according to claim 30, wherein said second electrode is positioned within 200 microns of the exit orifice.

46. The electrospray device according to claim 30, wherein the exit orifice has a distal end in conductive contact with the substrate.

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47. The electrospray device according to claim 34, wherein said first electrode is positioned within 500 microns of the exit orifice.

48. The electrospray device according to claim 34, wherein said first electrode is positioned within 200 microns of the exit orifice.

49. The electrospray device according to claim 34, wherein said second electrode is positioned within 500 microns of the exit orifice.

50. The electrospray device according to claim 34, wherein said second electrode is positioned within 200 microns of the exit orifice.

51. The electrospray device according to claim 34, wherein the exit orifice has a distal end in conductive contact with the substrate.

52. The electrospray device according to claim 38, wherein said first electrode is positioned within 500 microns of the exit orifice.

53. The electrospray device according to claim 38, wherein said first electrode is positioned within 200 microns of the exit orifice.

54. The electrospray device according to claim 38, wherein said second electrode is positioned within 500 microns of the exit orifice.

55. The electrospray device according to claim 38, wherein said second electrode is positioned within 200 microns of the exit orifice.

56. The electrospray device according to claim 38, wherein the exit orifice has a distal end in conductive contact with the substrate.

57. The electrospray device according to claim 4, wherein the device is configured to permit an electrospray of fluid at a flow rate of up to about 2 $\mu\text{L}/\text{minute}$.

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58. The electrospray device according to claim 4, wherein the device is configured to permit an electrospray of fluid at a flow rate of from 100 nL/minute to 500nL/minute.
59. The electrospray device according to claim 2, wherein the device is configured to permit an electrospray of fluid at a flow rate of up to about 2 μ L/minute.
60. The electrospray device according to claim 2, wherein the device is configured to permit an electrospray of fluid at a flow rate of greater than about 2 μ L/minute.
61. The electrospray device according to claim 60, wherein the flow rate is from 2 μ L/minute to 1 mL/minute.
62. The electrospray device according to claim 60, wherein the flow rate is from 100 nL/minute to 500 nL/minute.
63. The electrospray device according to claim 3, wherein the device is configured to permit an electrospray of fluid at a flow rate of up to about 2 μ L/minute.
64. The electrospray device according to claim 3, wherein the device is configured to permit an electrospray of fluid at a flow rate of greater than about 2 μ L/minute.
65. The electrospray device according to claim 64, wherein the flow rate is from 2 μ L/minute to mL/minute.
66. The electrospray device according to claim 64, wherein the flow rate is from 100 nL/minute to 500 nL/minute.
67. An electrospray system for spraying fluid comprising an array of a plurality of electrospray devices of claim 1.

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68. The electrospray system according to claim 67, wherein the electrospray device density in the array exceeds about 5 devices/cm².
69. The electrospray system according to claim 67, wherein the electrospray device density in the array exceeds about 16 devices/cm².
70. The electrospray system according to claim 67, wherein the electrospray device density in the array exceeds about 30 devices/cm².
71. The electrospray system according to claim 67, wherein the electrospray device density in the array exceeds about 81 devices/cm².
72. The electrospray system according to claim 67, wherein the electrospray device density in the array is from 30 devices/cm² to 100 devices/cm².
73. The electrospray system according to claim 67, wherein said array is an integral monolith of said devices.
74. The electrospray system according to claim 67, wherein at least two of the devices are in fluid communication with different fluid streams.
75. The electrospray system according to claim 67, wherein at least one spray unit is configured to generate multiple electrospray plumes of fluid.
76. The electrospray system according to claim 67, wherein at least one of the electrospray devices is configured to generate a single combined electrospray plume of fluid.
77. The electrospray system according to claim 67, wherein at least one spray unit of the plurality of spray units is configured to generate a single electrospray plume of fluid.

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78. The electrospray system according to claim 67, wherein at least one spray unit of the plurality of spray units is configured to generate multiple electrospray plumes of fluid which remain discrete.
79. The electrospray system according to claim 67, wherein said substrate comprises silicon.
80. The electrospray system according to claim 67, wherein said substrate is polymeric.
81. The electrospray system according to claim 67, wherein said substrate comprises glass.
82. The electrospray system according to claim 67, wherein at least one device comprises the substrate having the plurality of spray units each capable of generating the single electrospray plume wherein the entrance orifice of each spray unit is in fluid communication with one another.
83. The electrospray system according to claim 67, wherein at least one device comprises the substrate having the plurality of spray units each capable of generating multiple electrospray plumes wherein the entrance orifice of each spray unit is in fluid communication with one another.
84. The electrospray system according to claim 67, wherein at least one device comprises the substrate having the single spray unit capable of generating multiple electrospray plumes.
85. The electrospray system according to claim 82, wherein the plurality of spray units are configured to generate a single combined electrospray plume of fluid.
86. The electrospray system according to claim 83, wherein at least one of the spray units is configured to generate multiple electrospray plumes of fluid which remain discrete.

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87. The electrospray system according to claim 83, wherein the plurality of spray units are configured to generate a single combined electrospray plume of fluid.

88. The electrospray system according to claim 84, wherein the single spray unit is configured to generate multiple electrospray plumes of fluid which remain discrete.

89. The electrospray system of claim 82, wherein in at least one device the exit orifices of the spray units are present on the ejection surface at a density of up to about 10,000 exit orifices/cm².

90. The electrospray system of claim 82, wherein in at least one device the exit orifices of the spray units are present on the ejection surface at a density of up to about 15,625 exit orifices/cm².

91. The electrospray system of claim 82, wherein in at least one device the exit orifices of the spray units are present on the ejection surface at a density of up to about 27,566 exit orifices/cm².

92. The electrospray system of claim 82, wherein in at least one device the exit orifices of the spray units are present on the ejection surface at a density of up to about 40,000 exit orifices/cm².

93. The electrospray system of claim 82, wherein in at least one device the exit orifices of the spray units are present on the ejection surface at a density of up to about 160,000 exit orifices/cm².

94. The electrospray system of claim 83, wherein in at least one device the exit orifices of the spray units are present on the ejection surface at a density of up to about 10,000 exit orifices/cm².

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95. The electrospray system of claim 83, wherein in at least one device the exit orifices of the spray units are present on the ejection surface at a density of up to about 15,625 exit orifices/cm².

96. The electrospray system of claim 83, wherein in at least one device the exit orifices of the spray units are present on the ejection surface at a density of up to about 27,566 exit orifices/cm².

97. The electrospray system of claim 83, wherein in at least one device the exit orifices of the spray units are present on the ejection surface at a density of up to about 40,000 exit orifices/cm².

98. The electrospray system of claim 83, wherein in at least one device the exit orifices of the spray units are present on the ejection surface at a density of up to about 160,000 exit orifices/cm².

99. The electrospray system of claim 82, wherein in at least one device the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 500 μm.

100. The electrospray system of claim 83, wherein in at least one device the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 200 μm.

101. The electrospray system of claim 83, wherein in at least one device the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 100 μm.

102. The electrospray system of claim 82, wherein in at least one device the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 50 μm.

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103. The electrospray system of claim 83, wherein in at least one device the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 500 μm .

104. The electrospray system of claim 83, wherein in at least one device the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 200 μm .

105. The electrospray system of claim 83, wherein in at least one device the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 100 μm .

106. The electrospray system of claim 83, wherein in at least one device the spacing on the ejection surface between the centers of adjacent exit orifices of the spray units is less than about 50 μm .

107. The electrospray system according to claim 82, wherein said electric field generating source comprises:

a first electrode attached to said substrate to impart a first potential to said substrate; and

a second electrode to impart a second potential, wherein the first and the second electrodes are positioned to define an electric field surrounding at least one exit orifice.

108. The electrospray system according to claim 107, wherein the first electrode is electrically insulated from the fluid and the second potential is applied to the fluid.

109. The electrospray system according to claim 107, wherein the first electrode is in electrical contact with the fluid and the second electrode is positioned on the ejection surface.

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110. The electrospray system according to claim 107, wherein application of potentials to said first and second electrodes causes the fluid to discharge from at least one exit orifice in the form of an electrospray plume.

111. The electrospray system according to claim 83, wherein said electric field generating source comprises:

a first electrode attached to said substrate to impart a first potential to said substrate; and

a second electrode to impart a second potential, wherein the first and the second electrodes are positioned to define an electric field surrounding at least one exit orifice.

112. The electrospray system according to claim 111, wherein the first electrode is electrically insulated from the fluid and the second potential is applied to the fluid.

113. The electrospray system according to claim 111, wherein the first electrode is in electrical contact with the fluid and the second electrode is positioned on the ejection surface.

114. The electrospray system according to claim 111, wherein application of potentials to said first and second electrodes causes the fluid to discharge from at least one exit orifice in the form of multiple electrospray plumes.

115. The electrospray system according to claim 84, wherein said electric field generating source comprises:

a first electrode attached to said substrate to impart a first potential to said substrate; and

a second electrode to impart a second potential, wherein the first and the second electrodes are positioned to define an electric field surrounding the exit orifice.

116. The electrospray system according to claim 115, wherein the first electrode is electrically insulated from the fluid and the second potential is applied to the fluid.

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117. The electrospray system according to claim 115, wherein the first electrode is in electrical contact with the fluid and the second electrode is positioned on the ejection surface.

118. The electrospray system according to claim 115, wherein application of potentials to said first and second electrodes causes the fluid to discharge from the orifice in the form of multiple electrospray plumes.

119. The electrospray system according to claim 107, wherein said first electrode is positioned within 200 microns of the exit orifice.

120. The electrospray system according to claim 107, wherein said second electrode is positioned within 200 microns of the exit orifice.

121. The electrospray system according to claim 107, wherein the exit orifice has a distal end in conductive contact with the substrate.

122. The electrospray system according to claim 111, wherein said first electrode is positioned within 200 microns of the exit orifice.

123. The electrospray system according to claim 111, wherein said second electrode is positioned within 200 microns of the exit orifice.

124. The electrospray system according to claim 111, wherein the exit orifice has a distal end in conductive contact with the substrate.

125. The electrospray system according to claim 115, wherein said first electrode is positioned within 200 microns of the exit orifice.

126. The electrospray system according to claim 115, wherein said second electrode is positioned within 200 microns of the exit orifice.

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127. The electrospray system according to claim 115, wherein the exit orifice has a distal end in conductive contact with the substrate.
128. The electrospray system according to claim 84, wherein at least one device is configured to permit an electrospray of fluid at a flow rate of up to about 2 $\mu\text{L}/\text{minute}$.
129. The electrospray system according to claim 84, wherein at least one device is configured to permit an electrospray of fluid at a flow rate of from 100 nL/minute to 500 nL/minute.
130. The electrospray system according to claim 82, wherein the device is configured to permit an electrospray of fluid at a flow rate of up to about 2 $\mu\text{L}/\text{minute}$.
131. The electrospray system according to claim 82, wherein the device is configured to permit an electrospray of fluid at a flow rate of greater than about 2 $\mu\text{L}/\text{minute}$.
132. The electrospray system according to claim 131, wherein the flow rate is from 2 $\mu\text{L}/\text{minute}$ to 1 mL/minute.
133. The electrospray system according to claim 131, wherein the flow rate is from 100 nL/minute to 500 nL/minute.
134. The electrospray system according to claim 83, wherein at least one device is configured to permit an electrospray of fluid at a flow rate of up to about 2 $\mu\text{L}/\text{minute}$.
135. The electrospray system according to claim 83, wherein at least one device is configured to permit an electrospray of fluid at a flow rate of greater than about 2 $\mu\text{L}/\text{minute}$.
136. The electrospray system according to claim 135, wherein the flow rate is from 2 $\mu\text{L}/\text{minute}$ to 1 mL/minute.

137. The electrospray system according to claim 135, wherein the flow rate is from 100 nL/minute to 500 nL/minute.
138. The electrospray system according to claim 67, wherein the spacing on the ejection surface between adjacent devices is about 9 mm or less.
139. The electrospray system according to claim 67, wherein the spacing on the ejection surface between adjacent devices is about 4.5 mm or less.
140. The electrospray system according to claim 67, wherein the spacing on the ejection surface between adjacent devices is about 2.2 mm or less.
141. The electrospray system according to claim 67, wherein the spacing on the ejection surface between adjacent devices is about 1.1 mm or less.
142. The electrospray system according to claim 67, wherein the spacing on the ejection surface between adjacent devices is about 0.56 mm or less.
143. The electrospray system according to claim 67, wherein the spacing on the ejection surface between adjacent devices is about 0.28 mm or less.
144. The electrospray system according to claim 82, wherein the spacing on the ejection surface between adjacent devices is about 9 mm or less.
145. The electrospray system according to claim 82, wherein the spacing on the ejection surface between adjacent devices is about 4.5 mm or less.
146. The electrospray system according to claim 82, wherein the spacing on the ejection surface between adjacent devices is about 2.2 mm or less.
147. The electrospray system according to claim 82, wherein the spacing on the ejection surface between adjacent devices is about 1.1 mm or less.

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148. The electrospray system according to claim 82, wherein the spacing on the ejection surface between adjacent devices is about 0.56 mm or less.

149. The electrospray system according to claim 82, wherein the spacing on the ejection surface between adjacent devices is about 0.28 mm or less.

150. The electrospray system according to claim 83, wherein the spacing on the ejection surface between adjacent devices is about 9 mm or less.

151. The electrospray system according to claim 83, wherein the spacing on the ejection surface between adjacent devices is about 4.5 mm or less.

152. The electrospray system according to claim 83, wherein the spacing on the ejection surface between adjacent devices is about 2.2 mm or less.

153. The electrospray system according to claim 83, wherein the spacing on the ejection surface between adjacent devices is about 1.1 mm or less.

154. The electrospray system according to claim 83, wherein the spacing on the ejection surface between adjacent devices is about 0.56 mm or less.

155. The electrospray system according to claim 83, wherein the spacing on the ejection surface between adjacent devices is about 0.28 mm or less.

156. The electrospray system according to claim 84, wherein the spacing on the ejection surface between adjacent devices is about 9 mm or less.

157. The electrospray system according to claim 84, wherein the spacing on the ejection surface between adjacent devices is about 4.5 mm or less.

158. The electrospray system according to claim 84, wherein the spacing on the ejection surface between adjacent devices is about 2.2 mm or less.

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159. The electrospray system according to claim 84, wherein the spacing on the ejection surface between adjacent devices is about 1.1 mm or less.

160. The electrospray system according to claim 84, wherein the spacing on the ejection surface between adjacent devices is about 0.56 mm or less.

161. The electrospray system according to claim 84, wherein the spacing on the ejection surface between adjacent devices is about 0.28 mm or less.

162. A system for processing multiple sprays of fluid comprising: an electrospray device according to claim 1 and a device to receive multiple sprays of fluid from said electrospray device.

163. The system according to claim 162, wherein the device to receive multiple sprays of fluid receives electrospray plumes of the fluid emanating from the plurality of the spray units of said electrospray device.

164. The system according to claim 163, wherein multiple electrospray plumes of the fluid emanate from at least one of the plurality of spray units of said electrospray device.

165. The system according to claim 162, wherein the device to receive multiple sprays of fluid receives multiple electrospray plumes of the fluid emanating from the single spray unit of said electrospray device.

166. The system according to claim 162, wherein the device to receive multiple sprays of fluid receives droplets of the fluid emanating from the plurality of spray units of said electrospray device.

167. The system according to claim 162, wherein said device to receive multiple sprays of fluid comprises a surface for receiving said fluid.

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168. The system according to claim 167, wherein said surface comprises a daughter plate or MALDI sample plate, having a plurality of fluid receiving wells each positioned to receive fluid ejected from said electrospray device.

169. The system according to claim 162, wherein said device to receive multiple sprays of fluid is a mass spectrometry device.

170. A system for processing multiple sprays of fluid comprising: an electrospray system according to claim 67 and a device to receive multiple sprays of fluid from said electrospray system.

171. The system according to claim 170, wherein the device to receive multiple sprays of fluid receives electrospray plumes of the fluid emanating from a plurality of the spray units of said electrospray system.

172. The system according to claim 171, wherein multiple electrospray plumes of the fluid emanate from at least one of the spray units of said electrospray system.

173. The system according to claim 170, wherein the device to receive multiple sprays of fluid receives droplets of the fluid emanating from the plurality of spray units of said electrospray system.

174. The system according to claim 170, wherein said device to receive multiple sprays of fluid comprises a surface for receiving said fluid.

175. The system according to claim 174, wherein said surface comprises:
a daughter plate or MALDI sample plate, having a plurality of fluid receiving wells each positioned to receive fluid ejected from said electrospray system.

176. The system according to claim 170, wherein said device to receive multiple sprays of fluid is a mass spectrometry device.

177. A system for processing multiple sprays of fluid comprising:

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an electrospray device according to claim 1 and
a device to provide at least one sample in solution or fluid or combination thereof to at least one entrance orifice of said electrospray device.

178. The system according to claim 177, wherein at least one of:

a) the entrance orifices of the plurality of spray units of said electrospray device are in fluid communication with one another by a first reservoir, and

b) the entrance orifice of the single spray unit is in fluid communication with a second reservoir; and wherein said device to provide at least one sample in solution or fluid or combination thereof to at least one entrance orifice comprises:

at least one conduit to provide delivery of at least one sample in solution or fluid or combination thereof to at least one reservoir of said device.

179. The system according to claim 178, wherein said at least one conduit comprises a capillary, micropipette, or microchip.

180. The system according to claim 178, wherein the at least one conduit and reservoir provide a fluid tight seal therebetween.

181. The system according to claim 178, wherein said at least one conduit is compatible with multiple entrance orifices and is repositionable from one entrance orifice to another entrance orifice.

182. The system according to claim 181, wherein said at least one conduit is capable of being receded from one entrance orifice and repositioned in line with another entrance orifice and placed in sealing engagement with the another entrance orifice to provide fluid thereto.

183. The system according to claim 177, wherein said device to provide at least one sample in solution or fluid or combination thereof to at least one entrance orifice of said electrospray device carries out liquid separation analysis on the fluid.

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184. The system according to claim 183, wherein the liquid separation analysis is capillary electrophoresis, capillary dielectrophoresis, capillary electrochromatography, or liquid chromatography.

185. A system for processing multiple sprays of fluid comprising:
a system according to claim 177 and
a device to receive multiple sprays of fluid from said electrospray device.

186. The system according to claim 185, wherein the device to receive multiple sprays of fluid receives plumes of the fluid emanating from the plurality of the spray units of said electrospray device.

187. The system according to claim 185, wherein the device to receive multiple sprays of fluid receives multiple electrospray plumes of the fluid emanating from at least one spray unit of said electrospray device

188. The system according to claim 185, wherein said device to receive multiple sprays of fluid comprises a surface for receiving said fluid.

189. The system according to claim 188, wherein said surface comprises:
a daughter plate or MALDI sample plate, having a plurality of fluid receiving wells each positioned to receive fluid ejected from said electrospray system.

190. The system according to claim 185, wherein said device to receive multiple sprays of fluid is a mass spectrometry device.

191. A system for processing multiple sprays of fluid comprising:
an electrospray system according to claim 67 and
a device to provide at least one sample in solution or fluid or combination thereof to at least one entrance orifice of said electrospray system.

192. The system according to claim 191, wherein at least one of:

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a) the entrance orifices of the plurality of spray units of said electrospray device are in fluid communication with one another by a first reservoir, and

b) the entrance orifice of the single spray unit is in fluid communication with a second reservoir; and wherein said device to provide at least one sample in solution or fluid or combination thereof to at least one entrance orifice comprises:

at least one conduit to provide delivery of at least one sample in solution or fluid or combination thereof to at least one reservoir of said device.

193. The system according to claim 192, wherein said at least one conduit comprises a capillary, micropipette, or microchip.

194. The system according to claim 192, wherein the at least one conduit and reservoir provide a fluid tight seal therebetween, said at least one conduit optionally comprising a disposable tip.

195. The system according to claim 192, wherein said at least one conduit is compatible with multiple entrance orifices and is repositionable from one entrance orifice to another entrance orifice.

196. The system according to claim 195, wherein said at least one conduit is capable of being receded from one entrance orifice and repositioned in line with another entrance orifice and placed in sealing engagement with the another entrance orifice to provide fluid thereto.

197. The system according to claim 191, wherein said device to provide at least one sample in solution or fluid or combination thereof to at least one entrance orifice of said electrospray device carries out liquid separation analysis on the fluid.

198. The system according to claim 197, wherein the liquid separation analysis is capillary electrophoresis, capillary dielectrophoresis, capillary electrochromatography, or liquid chromatography.

199. A system for processing multiple sprays of fluid comprising:

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a system according to claim 191 and
a device to receive multiple sprays of fluid from said electrospray system.

200. The system according to claim 199, wherein the device to receive multiple sprays of fluid receives plumes of the fluid emanating from the plurality of the spray units of said electrospray system.

201. The system according to claim 199, wherein the device to receive multiple sprays of fluid receives multiple electrospray plumes of the fluid emanating from at least one spray unit of said electrospray system.

202. The system according to claim 199, wherein said device to receive multiple sprays of fluid comprises a surface for receiving said fluid.

203. The system according to claim 202, wherein said surface comprises:
a daughter plate or MALDI sample plate, having a plurality of fluid receiving wells each positioned to receive fluid ejected from said electrospray system.

204. The system according to claim 199, wherein said device to receive multiple sprays of fluid is a mass spectrometry device.

205. A method for processing multiple sprays of fluid comprising:
providing an electrospray device according to claim 1;
providing a device to provide at least one fluid sample to at least one entrance orifice of said electrospray device;
providing a device to receive multiple sprays of fluid or droplets from said electrospray device;
passing a fluid from said fluid providing device to said electrospray device;
generating an electric field surrounding the exit orifice of said spray unit such that fluid discharged therefrom forms an electrospray or droplets; and
passing said electrospray or droplets from said electrospray device to said receiving device.

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206. The method of claim 205, further comprising using said receiving device for performing mass spectrometry analysis, liquid chromatography analysis, or protein, DNA, or RNA combinatorial chemistry analysis.

207. A method for processing multiple sprays of fluid comprising:
providing an electrospray system according to claim 67;
providing a device to provide at least one fluid sample to at least one entrance orifice of at least one electrospray device of said electrospray system;
providing a device to receive multiple sprays of fluid or droplets from said at least one electrospray device;
passing a fluid from said fluid providing device to said at least one electrospray device;
generating an electric field surrounding an exit orifice of at least one spray unit within said at least one electrospray device such that fluid discharged therefrom forms an electrospray or droplets; and
passing said electrospray or droplets from said at least one electrospray device to said receiving device.

208. The method of claim 207, further comprising using said receiving device for performing mass spectrometry analysis, liquid chromatography analysis, or protein, DNA, or RNA combinatorial chemistry analysis.

209. A method of generating an electrospray comprising:
providing an electrospray device according to claim 1;
passing a fluid into the entrance orifice, through the channel, and through the exit orifice of at least one spray unit;
generating an electric field surrounding the exit orifice of said at least one spray unit such that fluid discharged therefrom forms an electrospray.

210. The method according to claim 209, further comprising:
detecting components of the electrospray by spectroscopic detection.

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211. The method according to claim 210, wherein the spectroscopic detection is selected from the group consisting of UV absorbance, laser induced fluorescence, and evaporative light scattering.
212. The method according to claim 209, wherein the fluid is discharged at a flow rate of up to about 2 $\mu\text{L}/\text{minute}$.
213. The method according to claim 209, wherein the fluid is discharged at a flow rate of greater than about 2 $\mu\text{L}/\text{minute}$.
214. The method according to claim 209, wherein the fluid is discharged at a flow rate of from 2 $\mu\text{L}/\text{minute}$ to 1 mL/minute.
215. The method according to claim 209, wherein the fluid is discharged at a flow rate of from 100 nL/minute to 500 nL/minute.
216. A method of mass spectrometric analysis comprising:
providing the system according to claim 162, wherein the device to receive multiple sprays of fluid from said electrospray device is a mass spectrometer;
passing a fluid into the entrance orifice, through the channel, and through the exit orifice of at least one spray unit under conditions effective to produce an electrospray; and
passing the electrospray into the mass spectrometer, whereby the fluid is subjected to a mass spectrometry analysis.
217. The method according to claim 216, wherein the mass spectrometry analysis is selected from the group consisting of atmospheric pressure ionization and laser desorption ionization.
218. A method of liquid chromatographic analysis comprising:

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providing the system according to claim 177, wherein the device to provide at least one sample in solution or fluid or combination thereof to at least one entrance orifice of said electrospray device is a liquid chromatography device;

passing a fluid through the liquid chromatography device so that the fluid is subjected to liquid chromatographic separation; and

passing a fluid into the entrance orifice, through the channel, and through the exit orifice of at least one spray unit under conditions effective to produce an electrospray.

219. A method of mass spectrometric analysis comprising:

providing the system of claim 181, wherein a mass spectrometer receives multiple sprays of fluid from said electrospray device and the device to provide at least one sample in solution or fluid or combination thereof to at least one entrance orifice of said electrospray device is a liquid chromatography device;

passing a fluid through the liquid chromatography device so that the fluid is subjected to liquid chromatographic separation;

passing a fluid into the entrance orifice, through the channel, and through the exit orifice of at least one spray unit under conditions effective to produce an electrospray; and

passing the electrospray into the mass spectrometer, whereby the fluid is subjected to a mass spectrometry analysis.

220. A method of generating an electrospray comprising:

providing an electrospray system according to claim 67;

passing a fluid into the entrance orifice, through the channel, and through the exit orifice of at least one spray unit;

generating an electric field surrounding the exit orifice such that fluid discharged from the exit orifice of said at least one spray unit forms an electrospray.

221. The method according to claim 220, further comprising:

detecting components of the electrospray by spectroscopic detection.

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222. The method according to claim 221, wherein the spectroscopic detection is selected from the group consisting of UV absorbance, laser induced fluorescence, and evaporative light scattering.
223. The method according to claim 220, wherein the fluid is discharged at a flow rate of up to about 2 $\mu\text{L}/\text{minute}$.
224. The method according to claim 220, wherein the fluid is discharged at a flow rate of greater than about 2 $\mu\text{L}/\text{minute}$.
225. The method according to claim 220, wherein the fluid is discharged at a flow rate of from 2 $\mu\text{L}/\text{minute}$ to 1 mL/minute.
226. The method according to claim 220, wherein the fluid is discharged at a flow rate of from 100 nL/minute to 500 nL/minute.
227. A method of mass spectrometric analysis comprising:
providing the system according to claim 170, wherein the device to receive multiple sprays of fluid from said electrospray device is a mass spectrometer;
passing a fluid into the entrance orifice, through the channel, and through the exit orifice of at least one spray unit under conditions effective to produce an electrospray; and
passing the electrospray into the mass spectrometer, whereby the fluid is subjected to a mass spectrometry analysis.
228. The method according to claim 227, wherein the mass spectrometry analysis is selected from the group consisting of atmospheric pressure ionization and laser desorption ionization.
229. A method of liquid chromatographic analysis comprising:

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providing the system according to claim 191, wherein the device to provide at least one sample in solution or fluid or combination thereof to at least one entrance orifice of said electrospray system is a liquid chromatography device;

passing a fluid through the liquid chromatography device so that the fluid is subjected to liquid chromatographic separation; and

passing a fluid into the entrance orifice, through the channel, and through the exit orifice of at least one spray unit under conditions effective to produce an electrospray.

230. A method of mass spectrometric analysis comprising:

providing the system of claim 195, wherein a mass spectrometer receives multiple sprays of fluid from said electrospray system and the device to provide at least one sample in solution or fluid or combination thereof to at least one entrance orifice of said electrospray system is a liquid chromatography device;

passing a fluid through the liquid chromatography device so that the fluid is subjected to liquid chromatographic separation;

passing a fluid into the entrance orifice, through the channel, and through the exit orifice of at least one spray unit under conditions effective to produce an electrospray; and

passing the electrospray into the mass spectrometer, whereby the fluid is subjected to a mass spectrometry analysis.

231. A method of generating multiple sprays from a single fluid stream of an electrospray device comprising:

providing an electrospray device for spraying a fluid comprising:

a substrate having a) an injection surface; b) an ejection surface opposing the injection surface, wherein the substrate is an integral monolith having a plurality of spray units wherein entrance orifices of each spray unit are in fluid communication with one another,

each spray unit comprising:

an entrance orifice on the injection surface,

an exit orifice on the ejection surface,

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a channel extending between the entrance orifice and the exit orifice, and
a recess surrounding the exit orifice positioned between the injection surface and the ejection surface; and
c) an electric field generating source positioned to define an electric field surrounding each exit orifice, wherein each spray unit generates at least one plume of the fluid capable of overlapping with that emanating from other spray units of said electrospray device;
depositing on the injection surface analyte from a fluid sample;
eluting the analyte deposited on the injection surface with an eluting fluid;
passing the eluting fluid containing analyte into the entrance orifice, through the channel, and through the exit orifice of each spray unit;
generating an electric field surrounding the exit orifice such that fluid discharged from the exit orifice of each of the spray units forms an electrospray.

232. The method according to claim 231, wherein said depositing on the injection surface comprises:

contacting the fluid sample with the injection surface and
evaporating the fluid sample under conditions effective to deposit the analyte on the injection surface.

233. The method according to claim 231, wherein the substrate for said electrospray device has a plurality of spray units for spraying the fluid.

234. The method according to claim 231, wherein the fluid is discharged at a flow rate of up to about 2 $\mu\text{L}/\text{minute}$.

235. The method according to claim 231, wherein the fluid is discharged at a flow rate of greater than about 2 $\mu\text{L}/\text{minute}$.

236. The method according to claim 231, wherein the fluid is discharged at a flow rate of from 2 $\mu\text{L}/\text{minute}$ to 1 mL/minute.

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237. The method according to claim 231, wherein the fluid is discharged at a flow rate of from 100 nL/minute to 500 nL/minute.

238. A method of mass spectrometric analysis comprising:

providing a mass spectrometer and

passing the electrospray produced by the method according to claim 231 into the mass spectrometer, whereby the fluid is subjected to a mass spectrometry analysis.

239. The method according to claim 238, wherein the mass spectrometry analysis is selected from the group consisting of atmospheric pressure ionization and laser desorption ionization.

240. A method of producing an electrospray device comprising:

providing a substrate having opposed first and second surfaces, the first surface coated with a photoresist over an etch-resistant material;

exposing the photoresist on the first surface to an image to form a pattern in the form of at least one ring on the first surface;

removing the exposed photoresist on the first surface which is outside and inside the at least one ring leaving the unexposed photoresist;

removing the etch-resistant material from the first surface of the substrate where the exposed photoresist was removed to form holes in the etch-resistant material;

optionally, removing all photoresist remaining on the first surface;

coating the first surface with a second coating of photoresist;

exposing the second coating of photoresist within the at least one ring to an image;

removing the exposed second coating of photoresist from within the at least one ring to form at least one hole;

removing material from the substrate coincident with the at least one hole in the second coating of photoresist on the first surface to form at least one passage

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extending through the second coating of photoresist on the first surface and into substrate;

optionally removing all photoresist from the first surface;

applying an etch-resistant layer to all exposed surfaces on the first surface of the substrate;

removing the etch-resistant layer from the first surface that is around the at least one ring;

removing material from the substrate exposed by the removed etch-resistant layer around the at least one ring to define at least one nozzle on the first surface;

providing a photoresist over an etch-resistant material on the second surface;

exposing the photoresist on the second surface to an image to form a pattern circumscribing extensions of the at least one hole formed in the etch-resistant material of the first surface;

removing the exposed photoresist on the second surface;

removing the etch-resistant material on the second surface coincident with where the photoresist was removed;

removing material from the substrate coincident with where the etch-resistant material on the second surface was removed to form a reservoir extending into the substrate to the extent needed to join the reservoir and the at least one passage; and

applying an etch-resistant material to all surfaces of the substrate to form the electrospray device.

241. The method according to claim 240, wherein the substrate is made from silicon and the etch-resistant material is silicon dioxide.

242. The method according to claim 240 further comprising:

applying a silicon nitride layer over all surfaces after said applying an etch-resistant material to all exposed surfaces of the substrate.

243. The method according to claim 242 further comprising:

applying a conductive material to a desired area of the substrate.

244. A method of producing an electrospray device comprising:

- providing a substrate having opposed first and second surfaces, the first surface coated with a photoresist over an etch-resistant material;

- exposing the photoresist on the first surface to an image to form a pattern in the form of at least one ring on the first surface;

- removing the exposed photoresist on the first surface which is outside and inside the at least one ring leaving the unexposed photoresist;

- removing the etch-resistant material from the first surface of the substrate where the exposed photoresist was removed to form holes in the etch-resistant material;

- providing a photoresist over an etch-resistant material on the second surface;

- exposing the photoresist on the second surface to an image to form a pattern circumscribing extensions of the at least one ring formed in the etch-resistant material of the first surface;

- removing the exposed photoresist on the second surface;

- removing the etch-resistant material on the second surface coincident with where the photoresist was removed;

- removing material from the substrate coincident with where the etch-resistant material on the second surface was removed to form a reservoir extending into the substrate; and

- coating the second surface with an etch-resistant material;

- coating the first surface with a second coating of photoresist;

- exposing the second coating of photoresist within the at least one ring to an image;

- removing the exposed second coating of photoresist from within the at least one ring to form at least one hole;

- removing material from the substrate coincident with the at least one hole in the second layer of photoresist on the first surface to form at least one passage

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extending through the second layer of photoresist on the first surface and into substrate to the extent needed to reach the etch-resistant material coating the reservoir;

removing at least the photoresist around the at least one ring from the first surface;

removing material from the substrate exposed by the removed etch-resistant material around the at least one ring to define at least one nozzle on the first surface;

removing from the substrate at least the etch-resistant material coating the reservoir; and

applying an etch resistant material to coat all exposed surfaces of the substrate to form the electrospray device.

245. The method according to claim 244, wherein the substrate is made from silicon and the etch-resistant material is silicon dioxide.

246. The method according to claim 244 further comprising:

applying a silicon nitride layer over all surfaces after said applying an etch-resistant material to all exposed surfaces of the substrate.

247. The method according to claim 246 further comprising:

applying a conductive material to a desired area of the substrate.

248. A method for producing larger, minimally-charged droplets from a device, comprising:

providing the electrospray device of claim 2;

passing a fluid into at least one entrance orifice, through the channel, and through the exit orifice of at least one spray unit of said electrospray device; and

generating an electric field surrounding the exit orifice to a value less than that required to generate an electrospray of said fluid.

249. The method according to claim 248, wherein the fluid to substrate potential voltage ratio is less than about 2.

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250. A method for producing larger, minimally-charged droplets from a device, comprising:

providing the electrospray system of claim 67;

passing a fluid into at least one entrance orifice, through the channel, and through the exit orifice of at least one spray unit of at least one electrospray device; and

generating an electric field surrounding the exit orifice to a value less than that required to generate an electrospray of said fluid.

251. The method according to claim 250, wherein the fluid to substrate potential voltage ratio is less than about 2.

252. The system according to claim 180, wherein said at least one conduit comprises a disposable tip.

253. The method according to any one of claims 244 to 247, further comprising removing all photoresist remaining on the first surface prior to said providing a photoresist over an etch-resistant material on the second surface.

254. The method according to any one of claims 244 to 247, further comprising removing the remaining photoresist on the second surface prior to said coating the second surface with an etch-resistant material.

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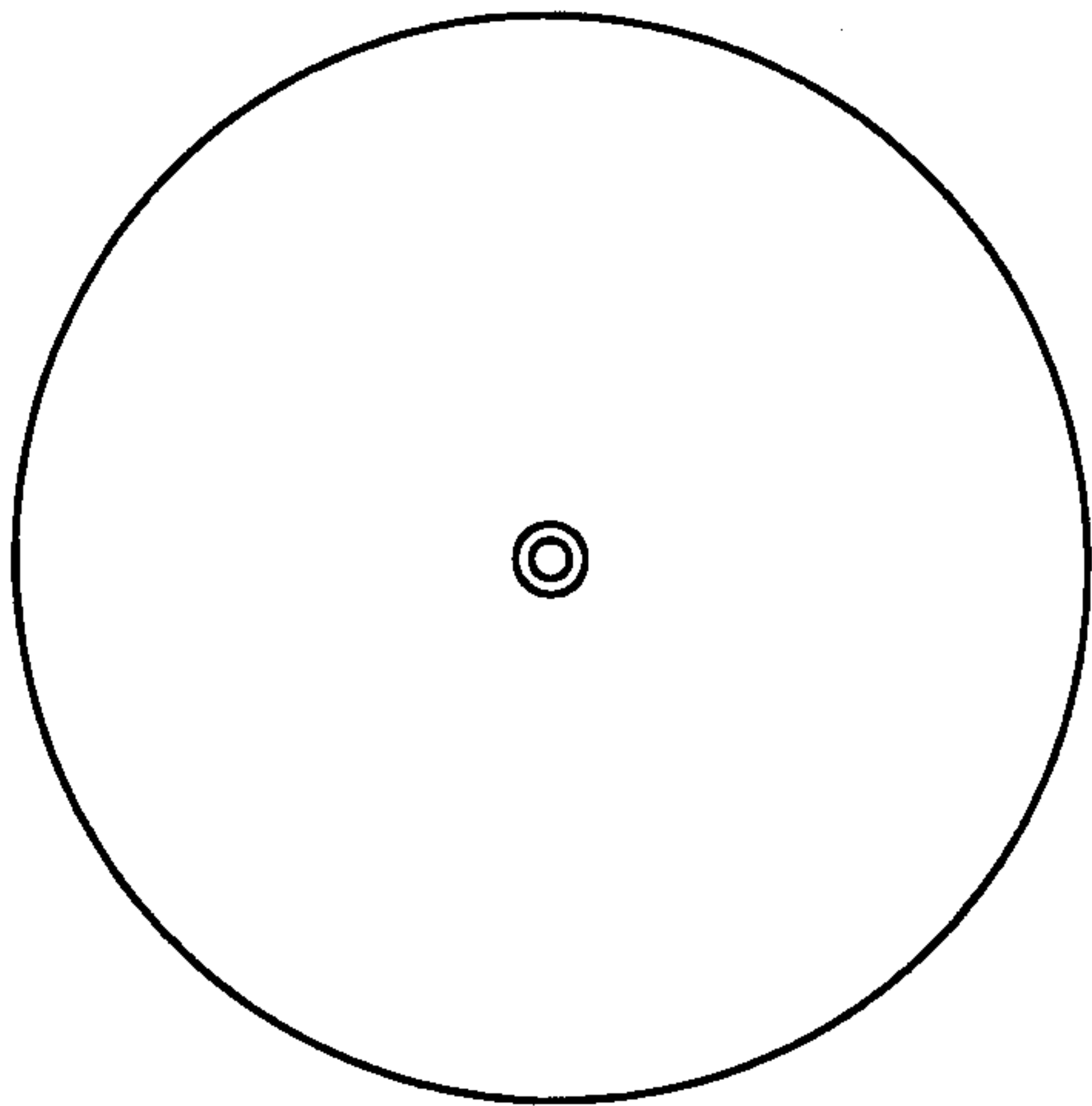


FIG. 1A

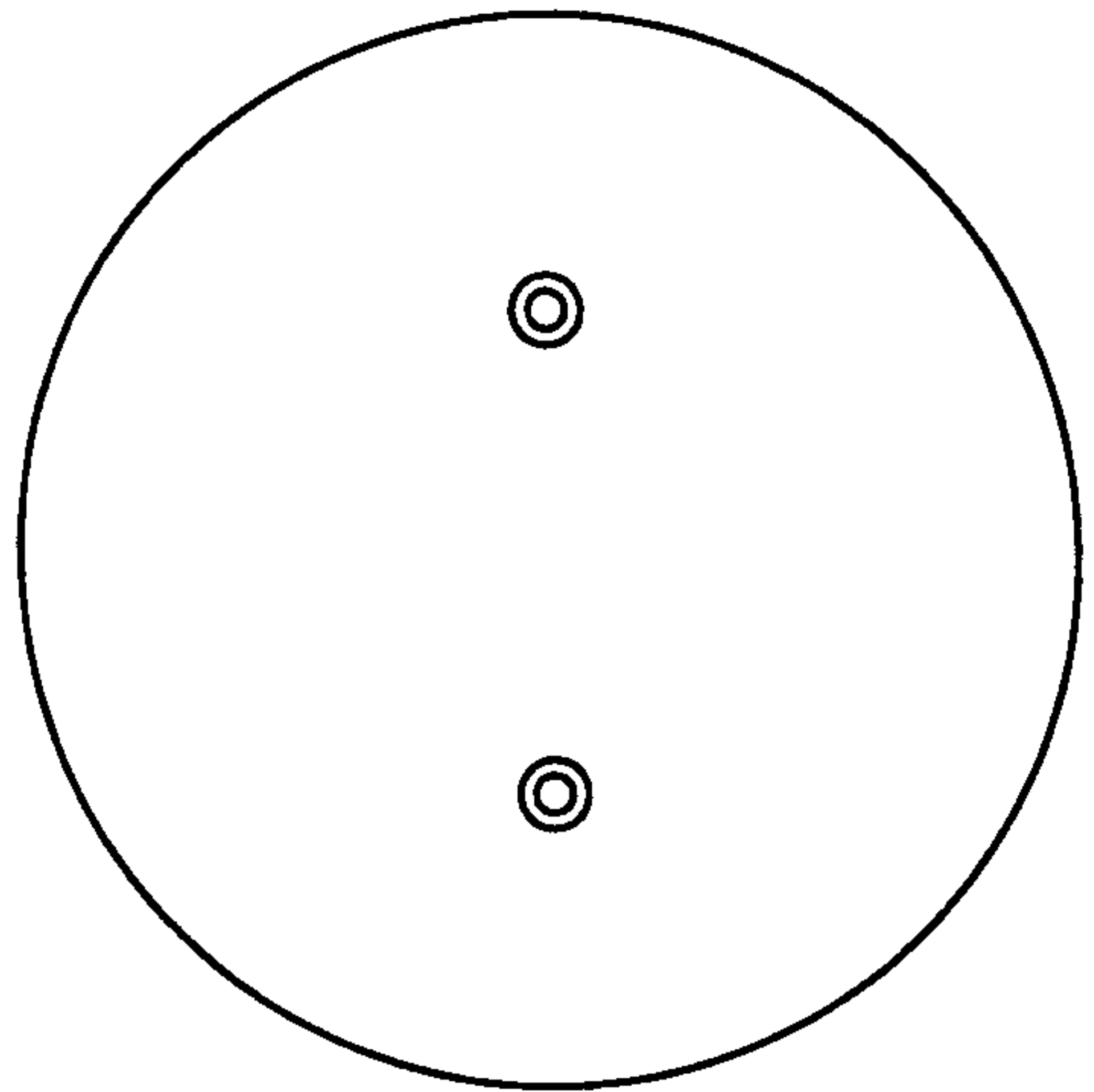


FIG. 1B

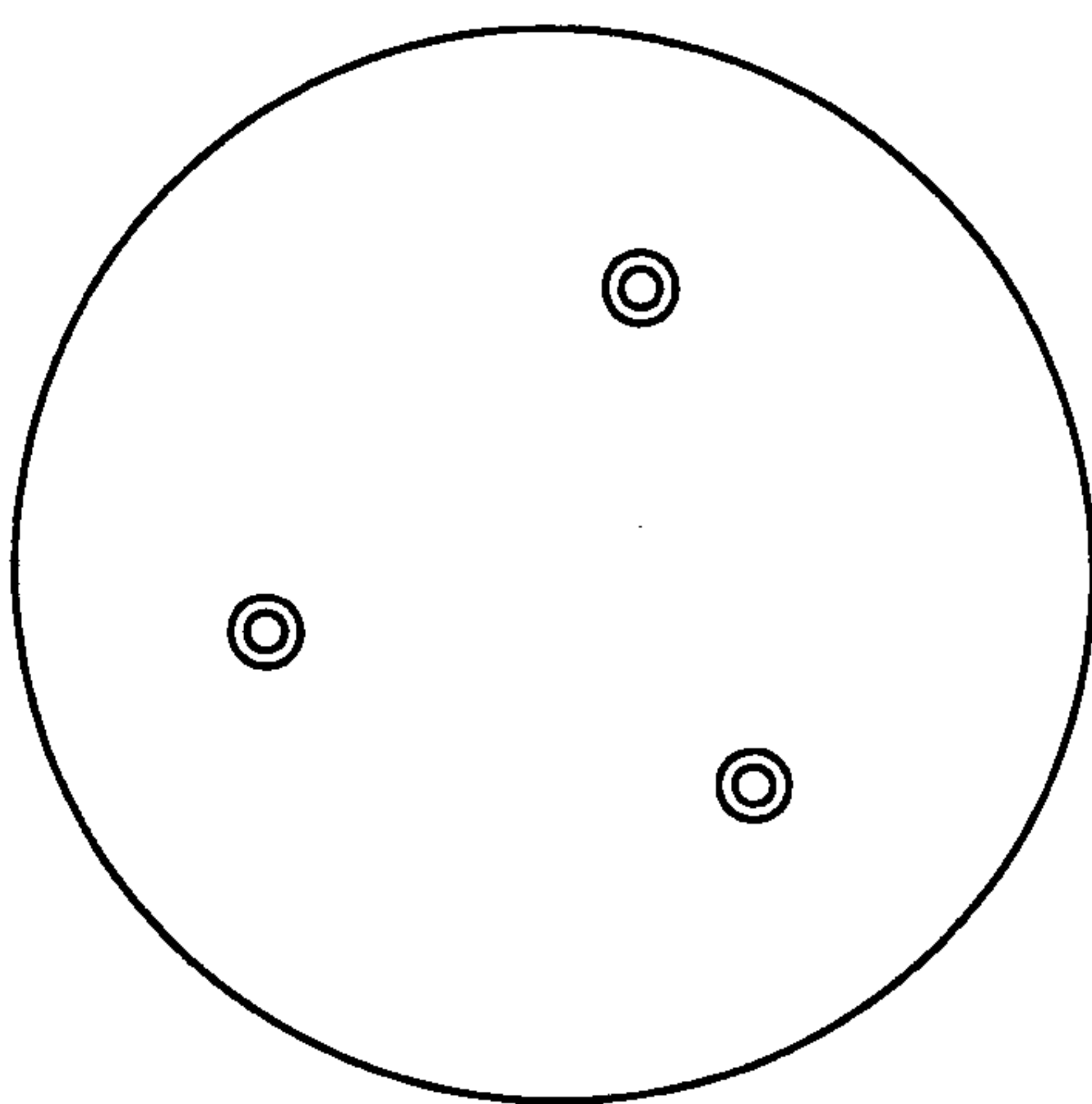


FIG. 1C

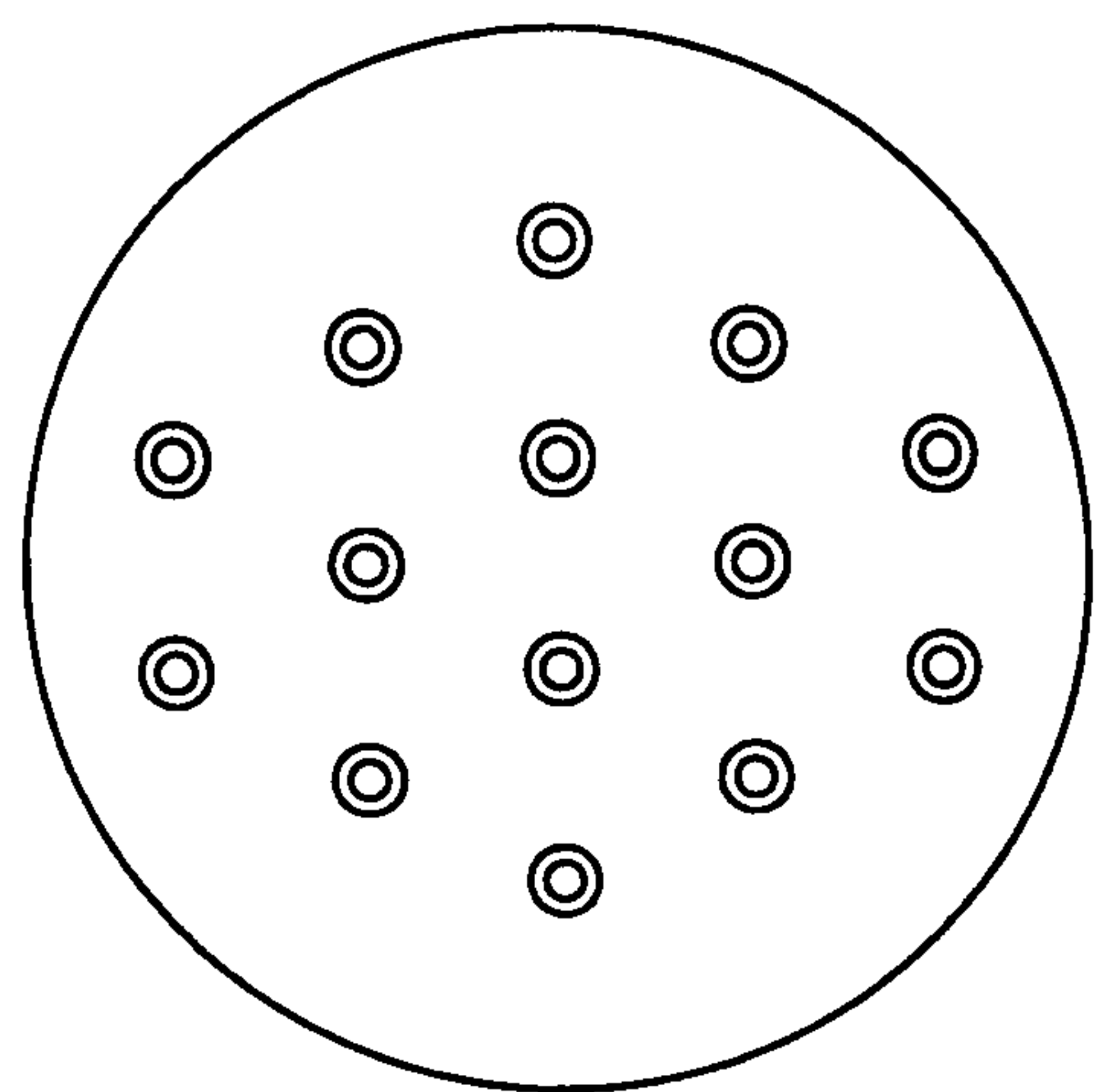
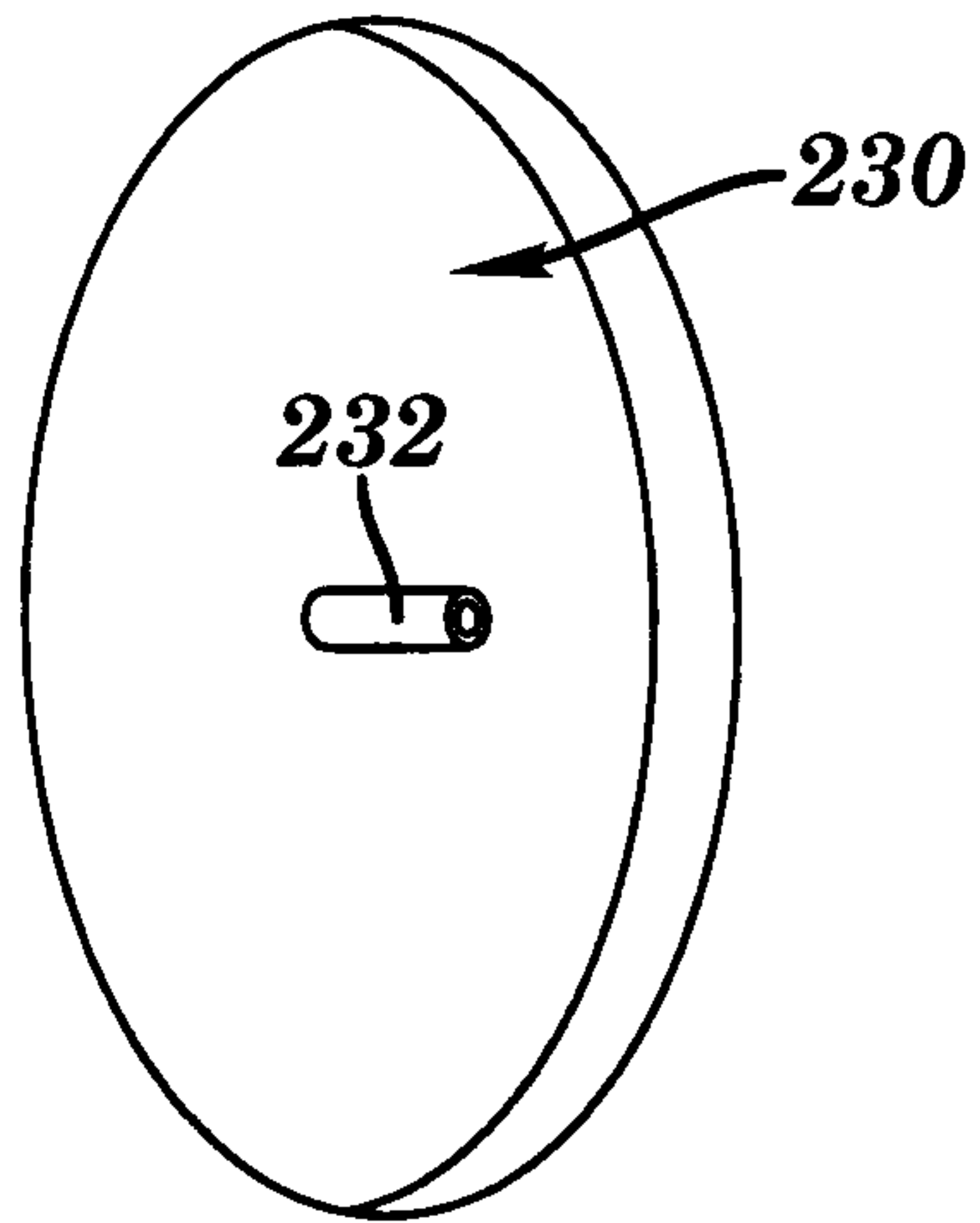
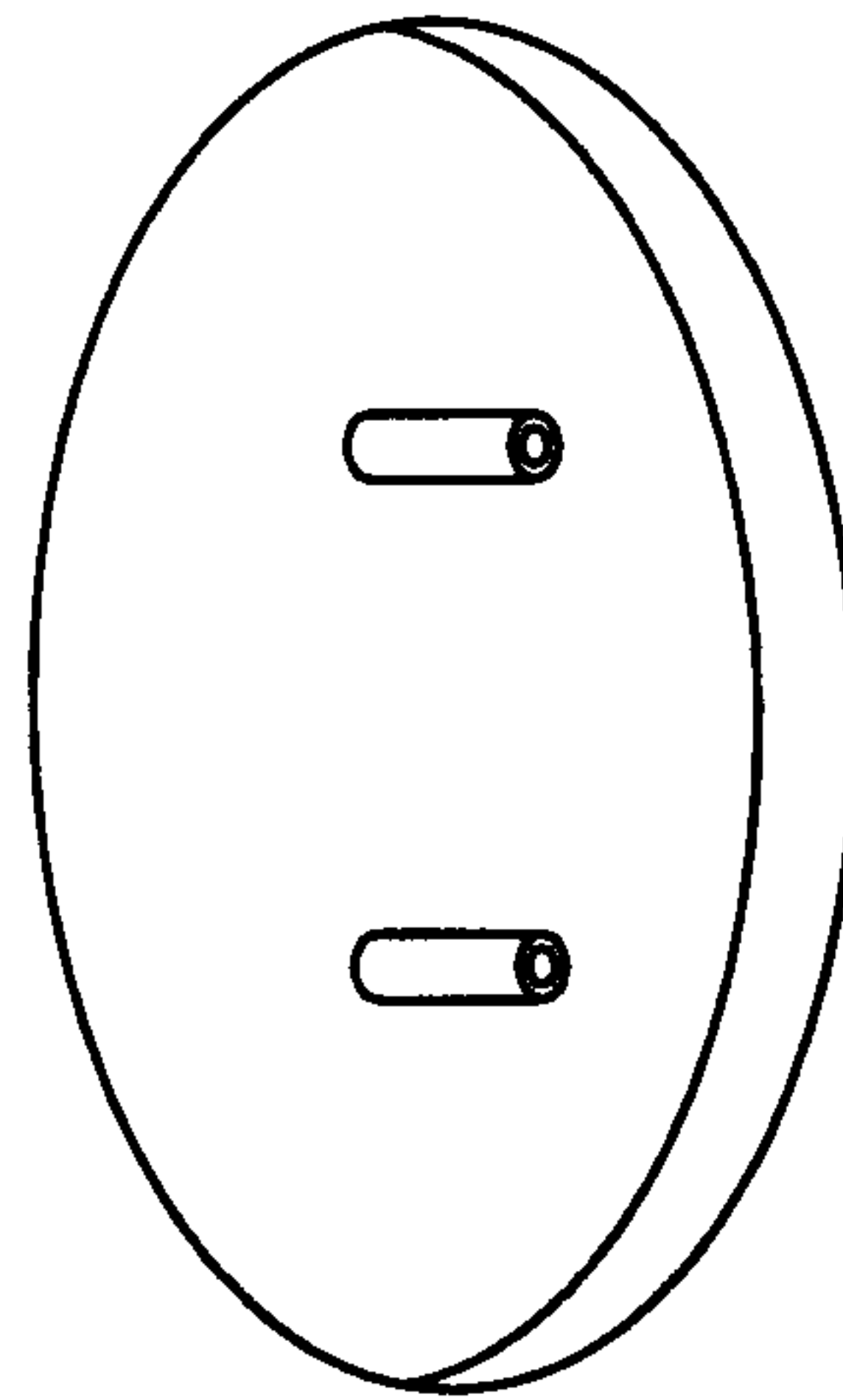
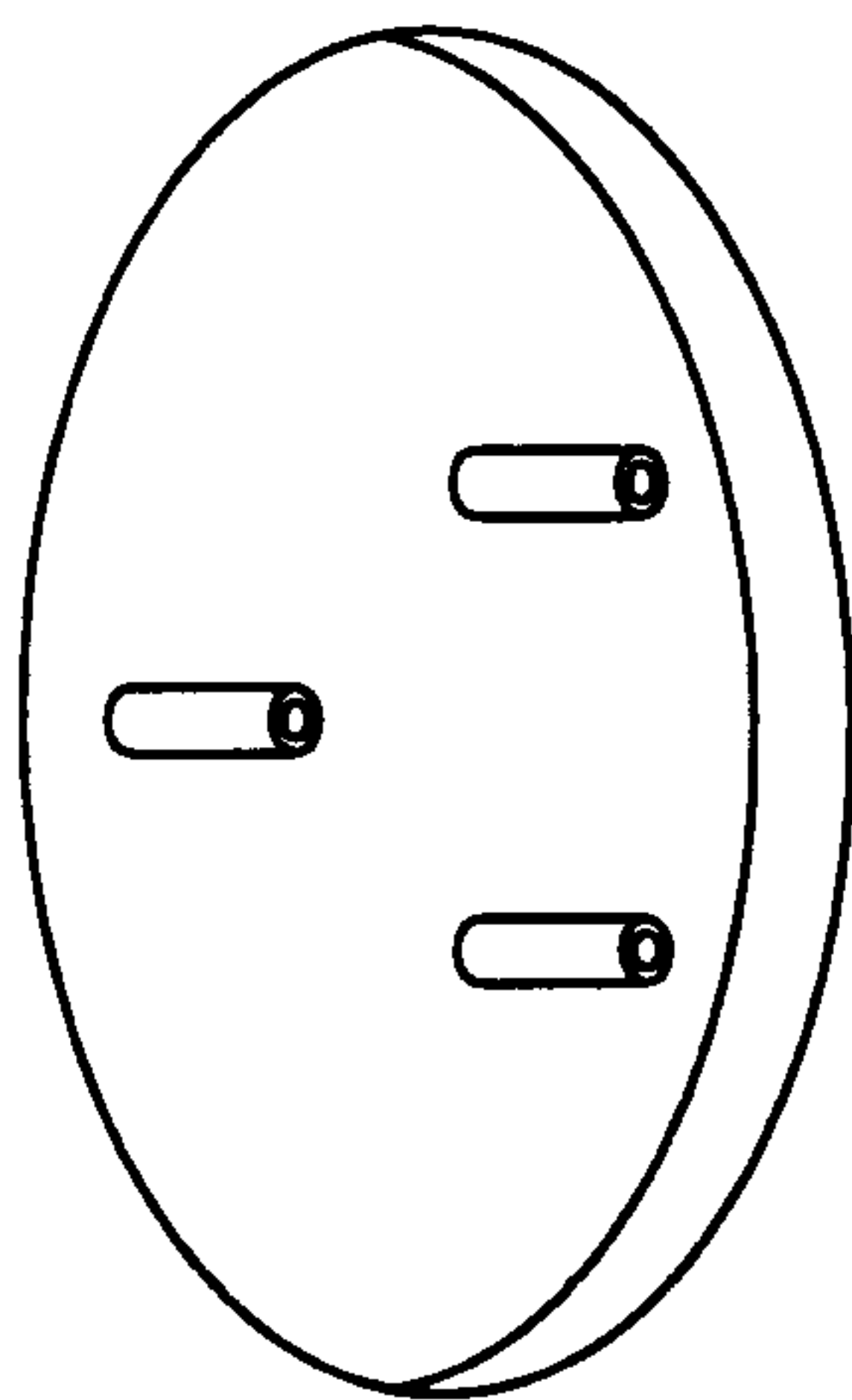
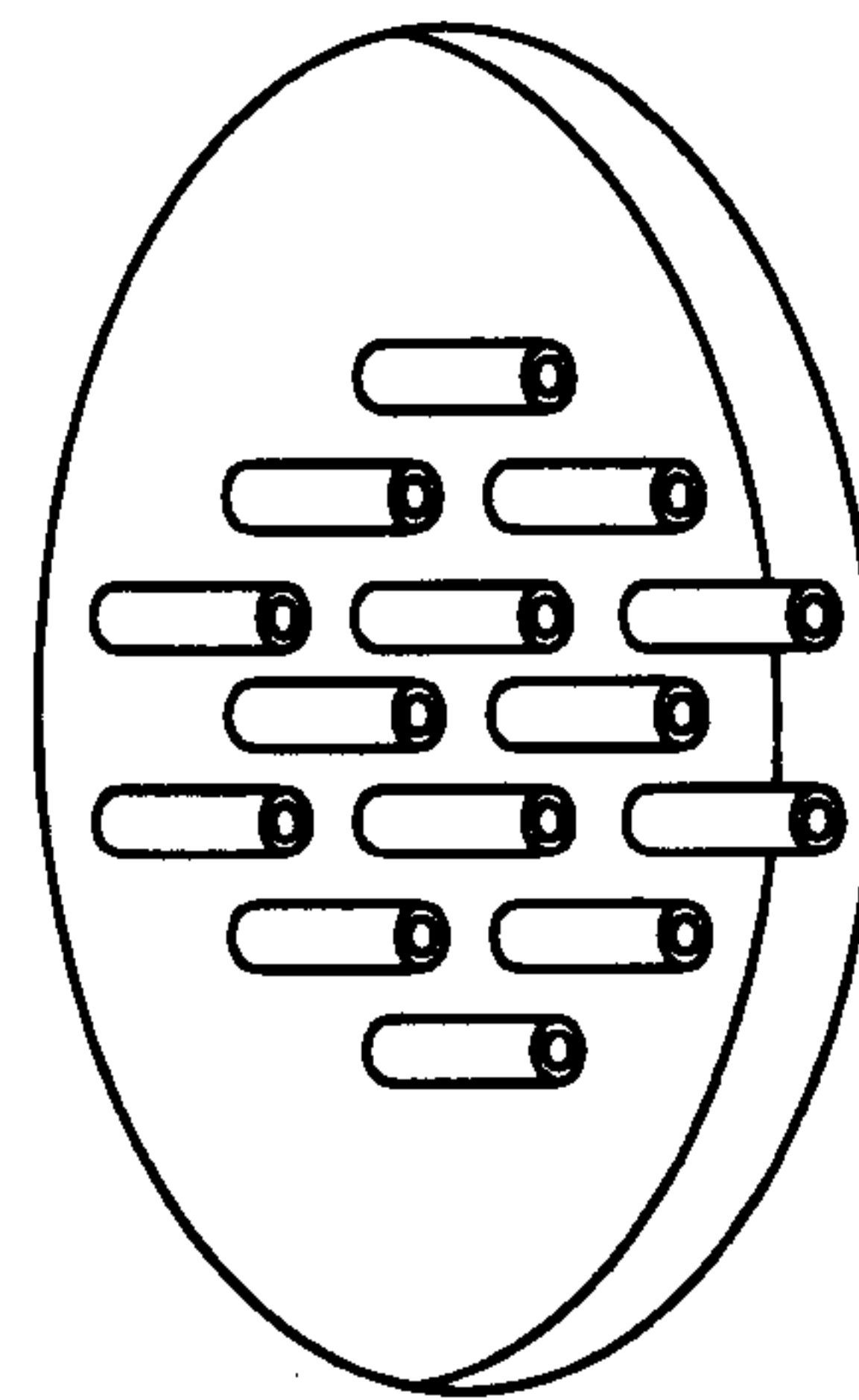
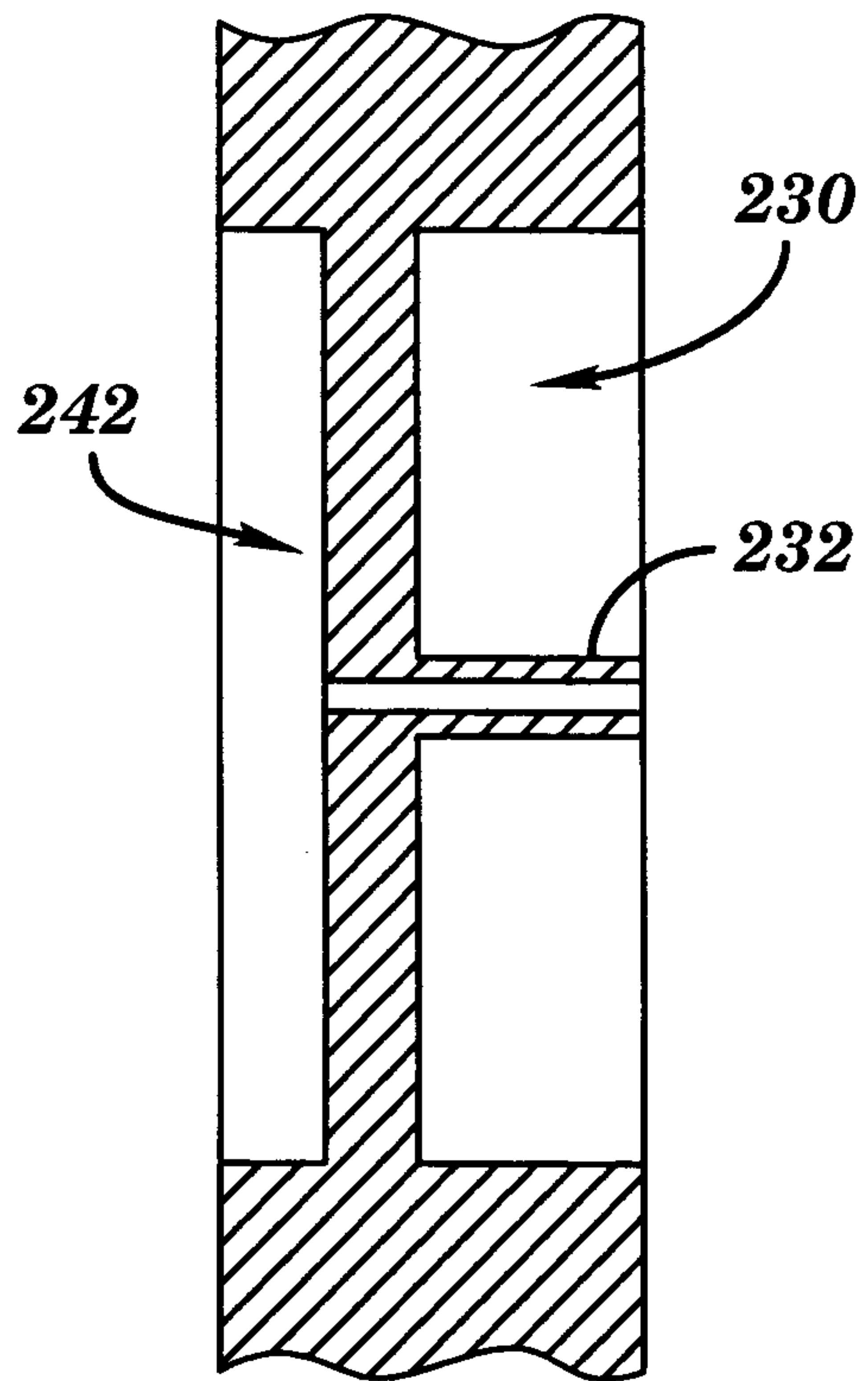
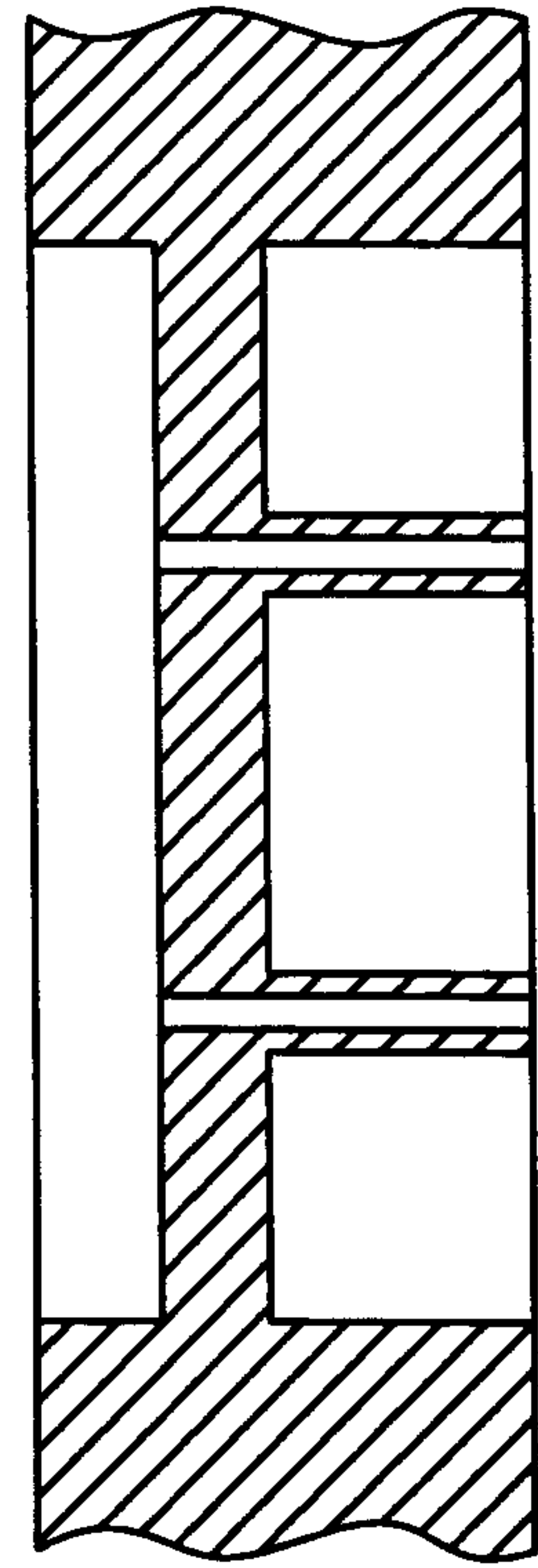
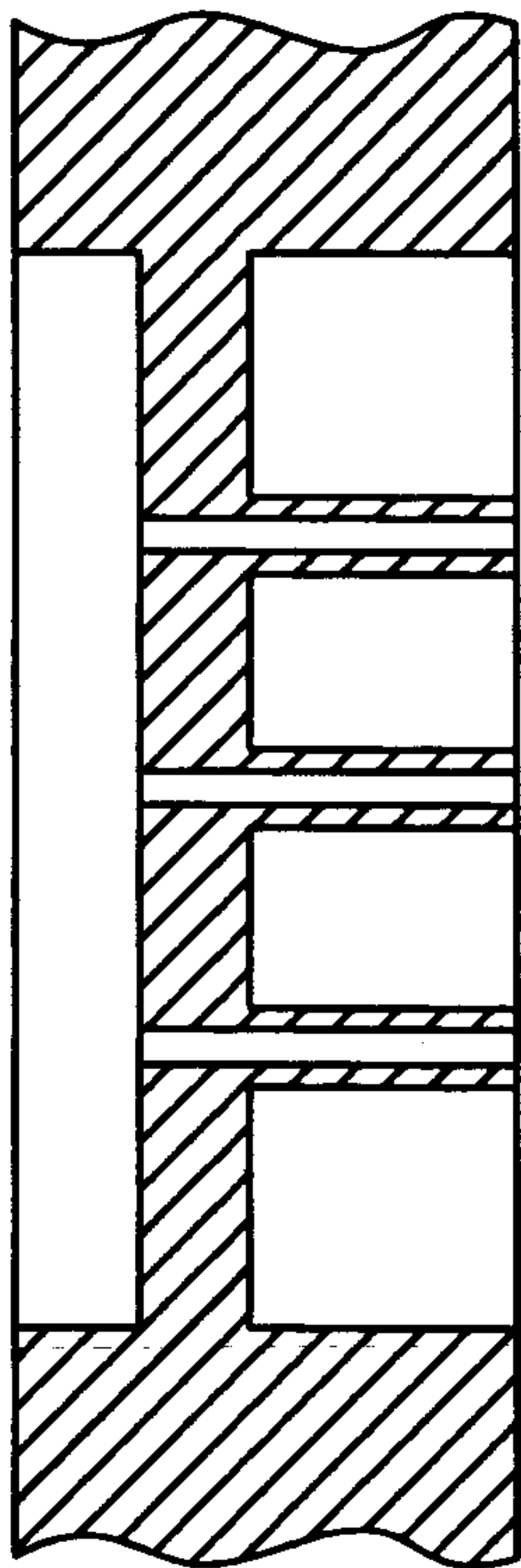
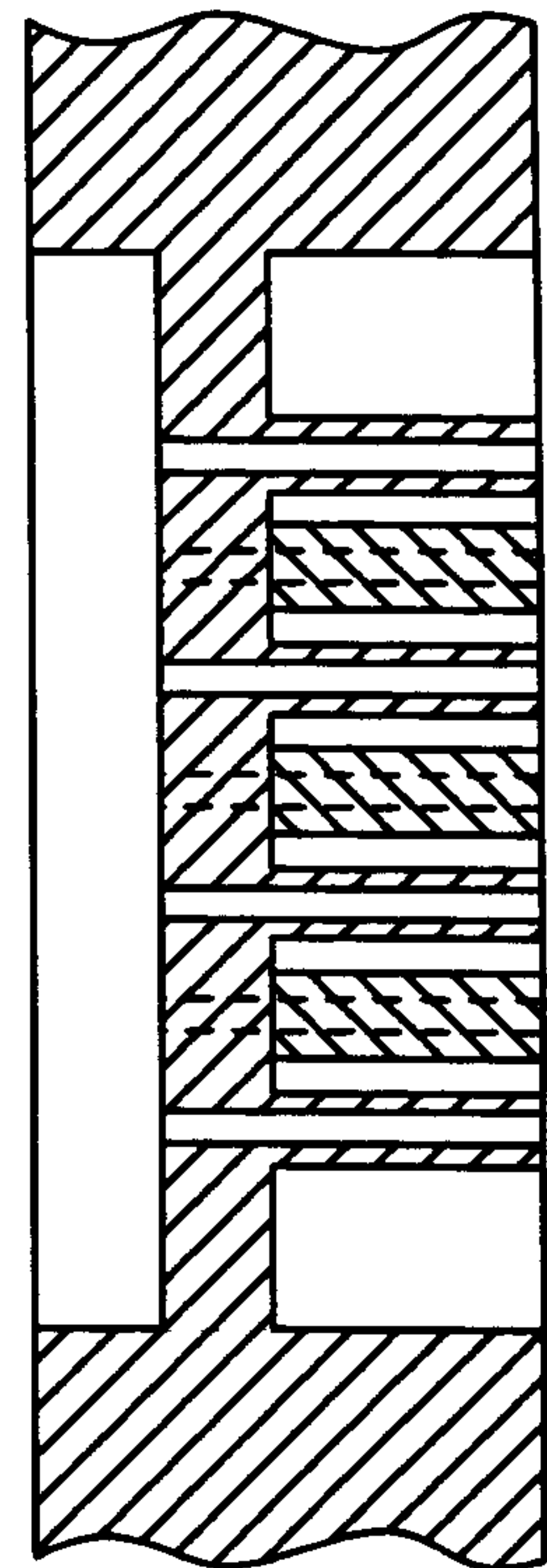


FIG. 1D

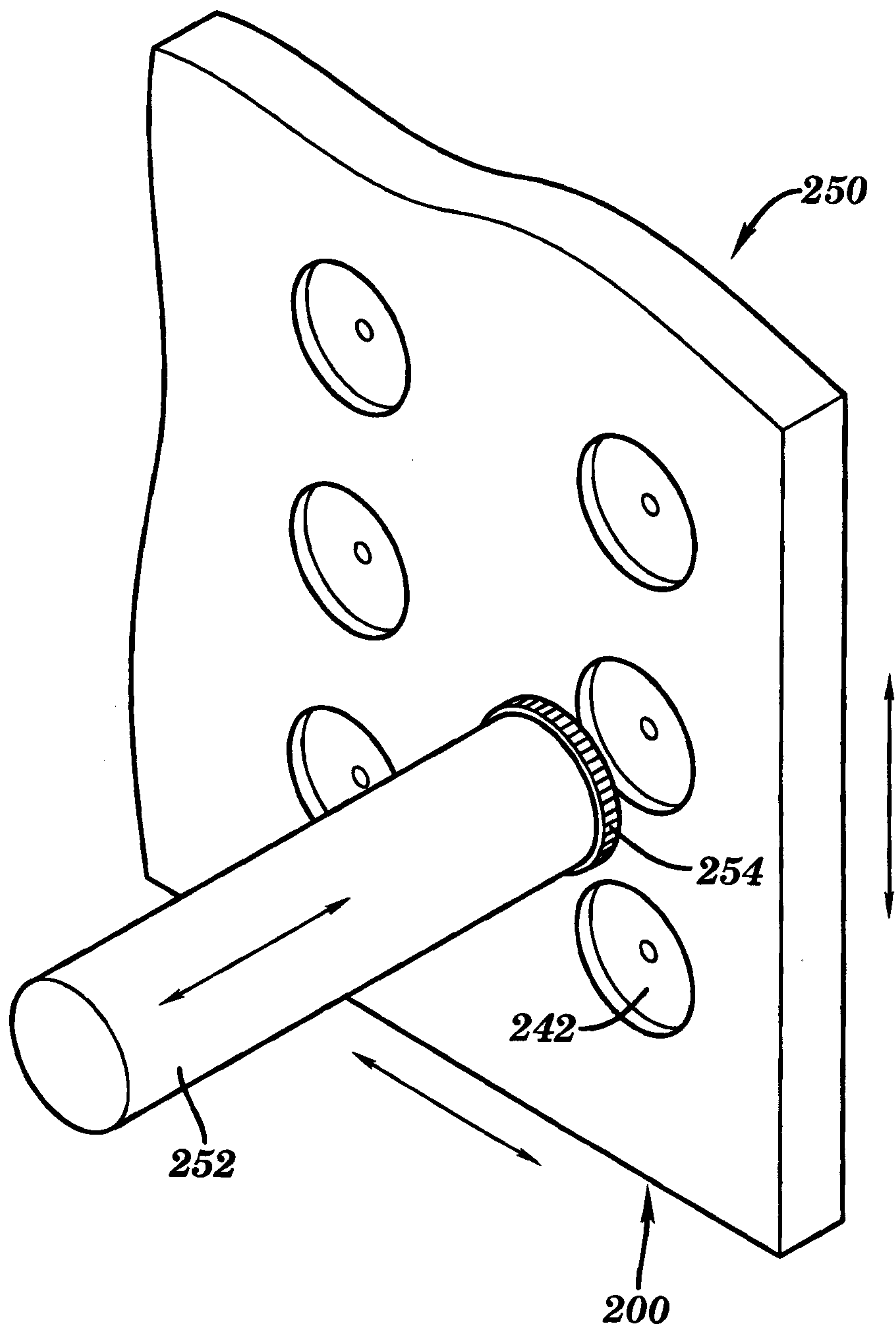
2/66

**FIG. 2A****FIG. 2B****FIG. 2C****FIG. 2D**

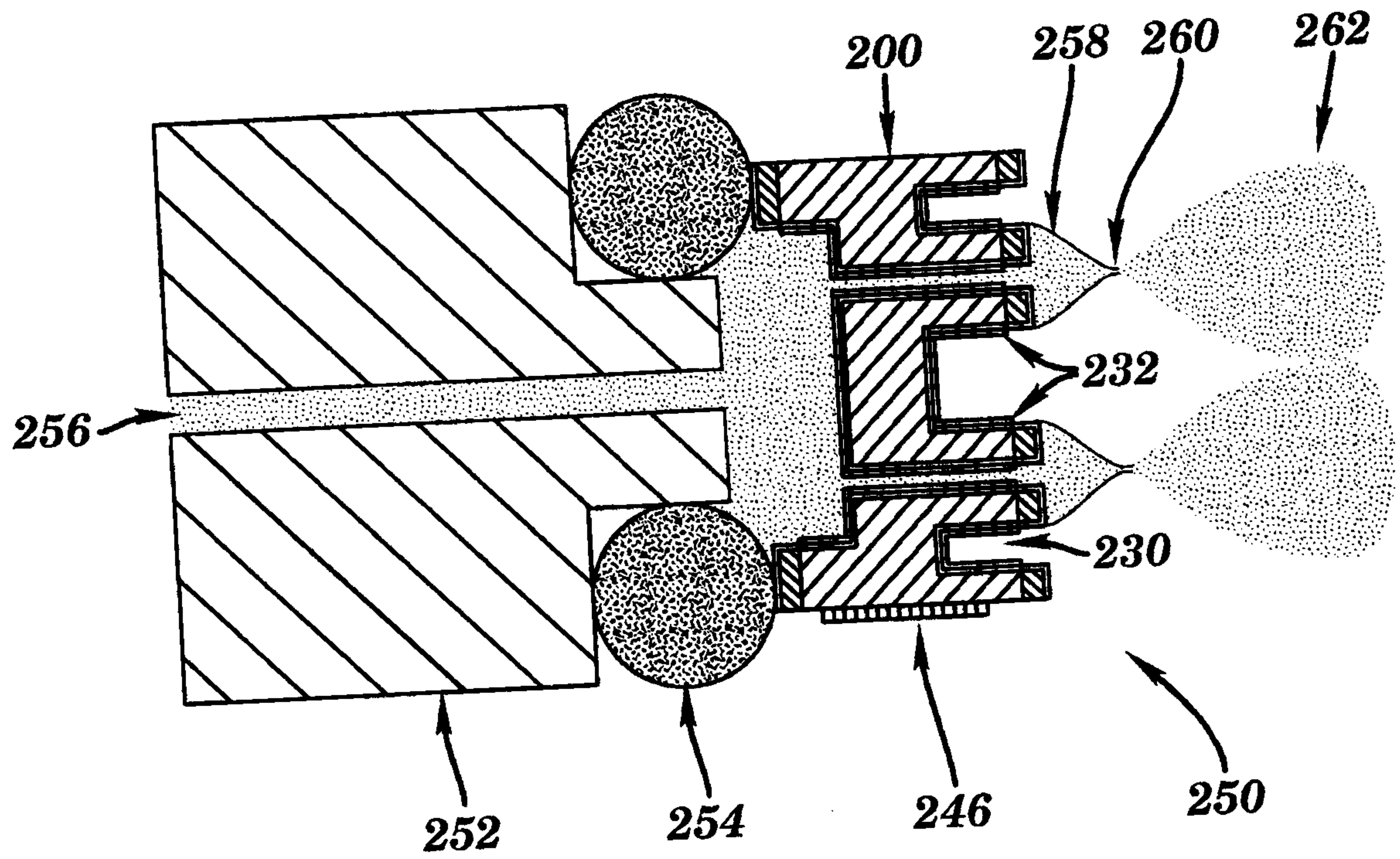
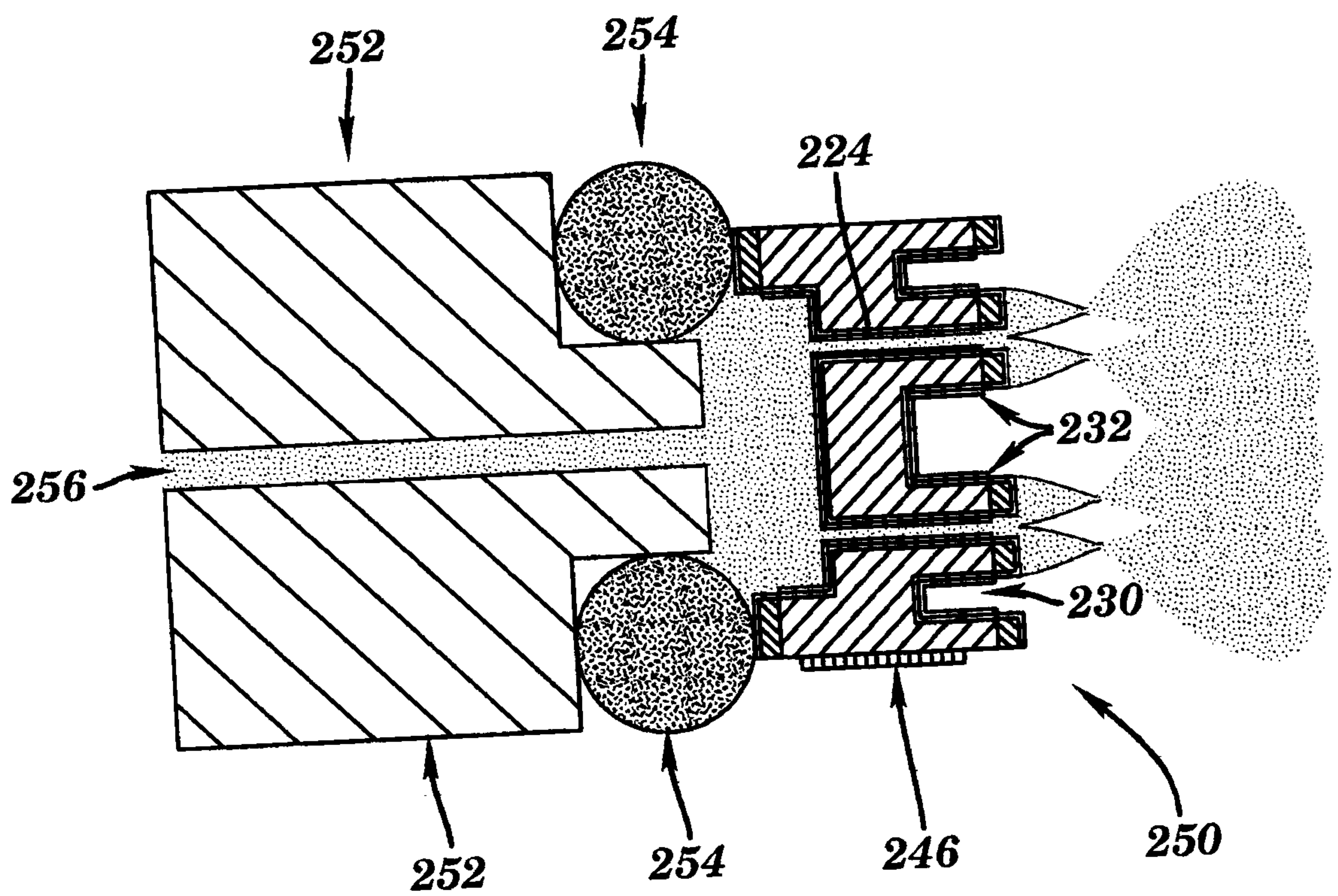
3/66

**FIG. 3A****FIG. 3B****FIG. 3C****FIG. 3D**

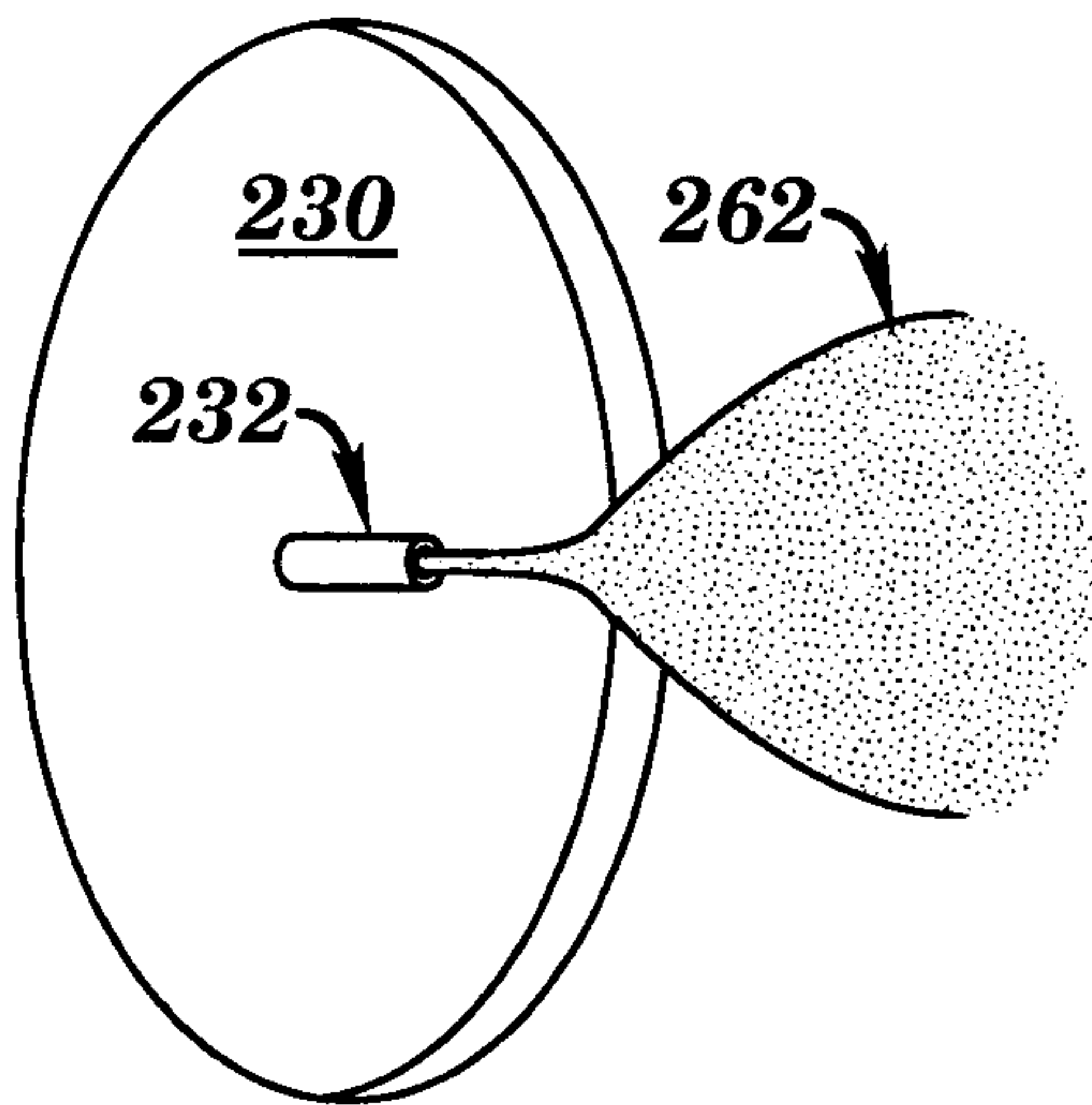
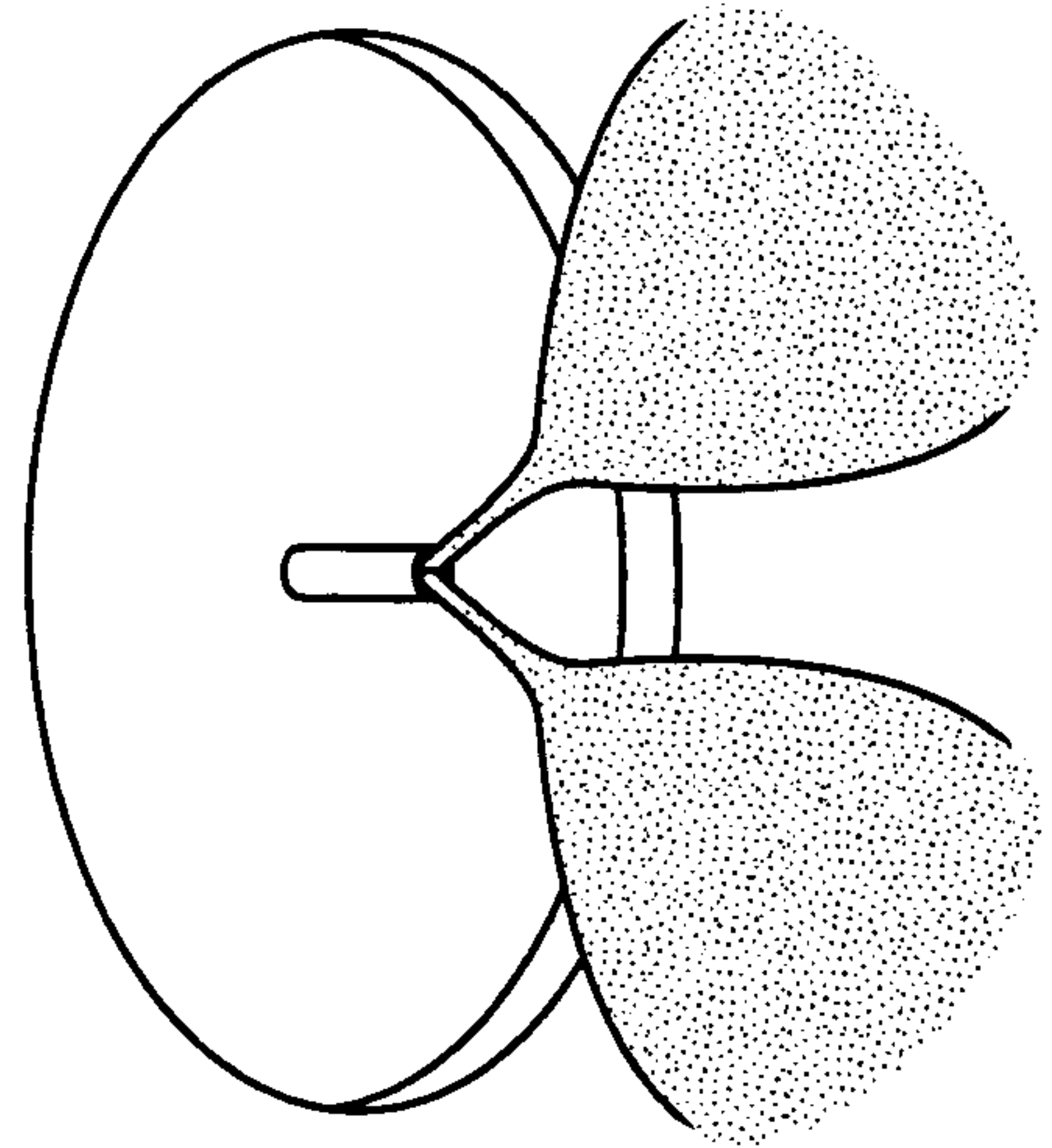
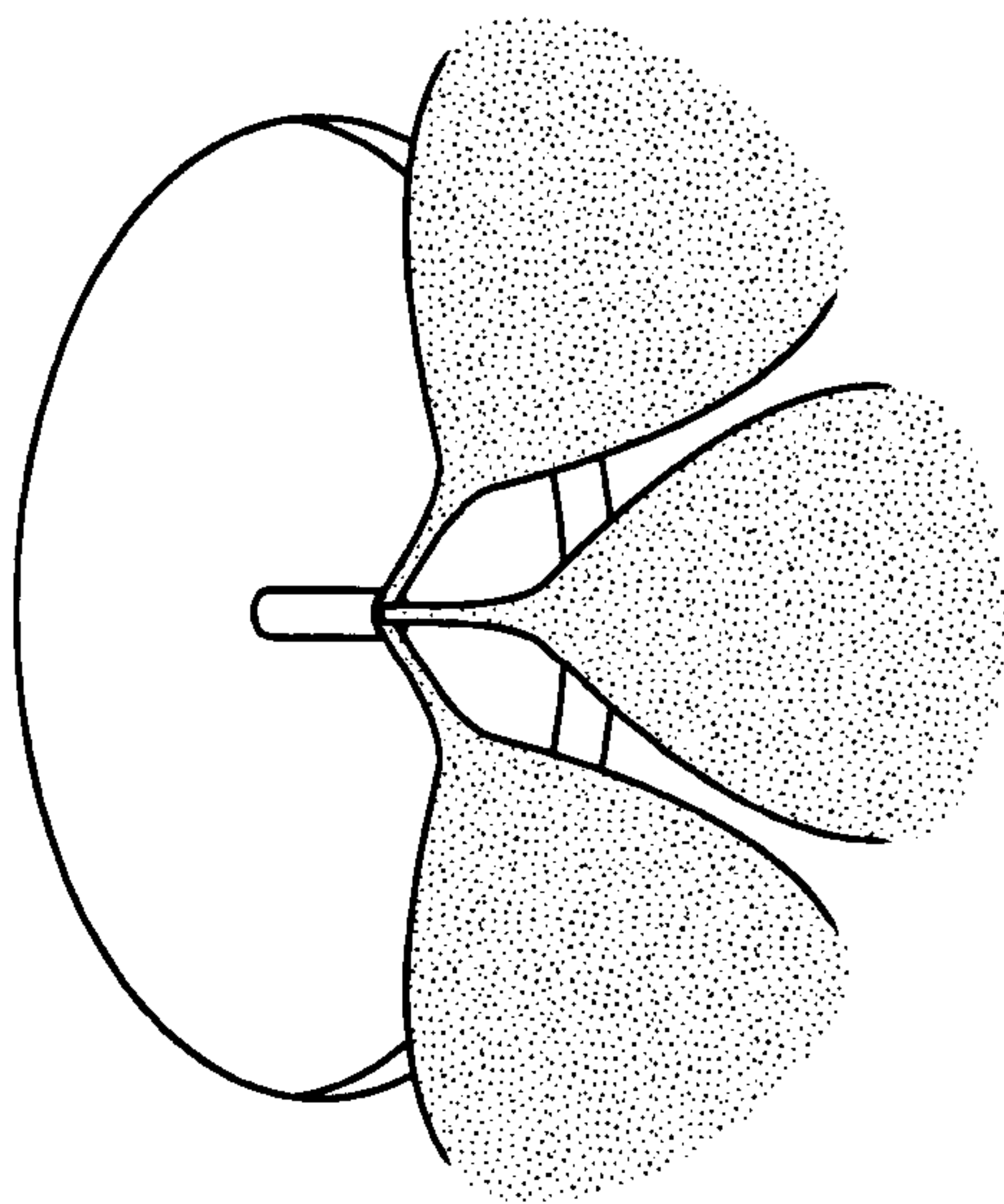
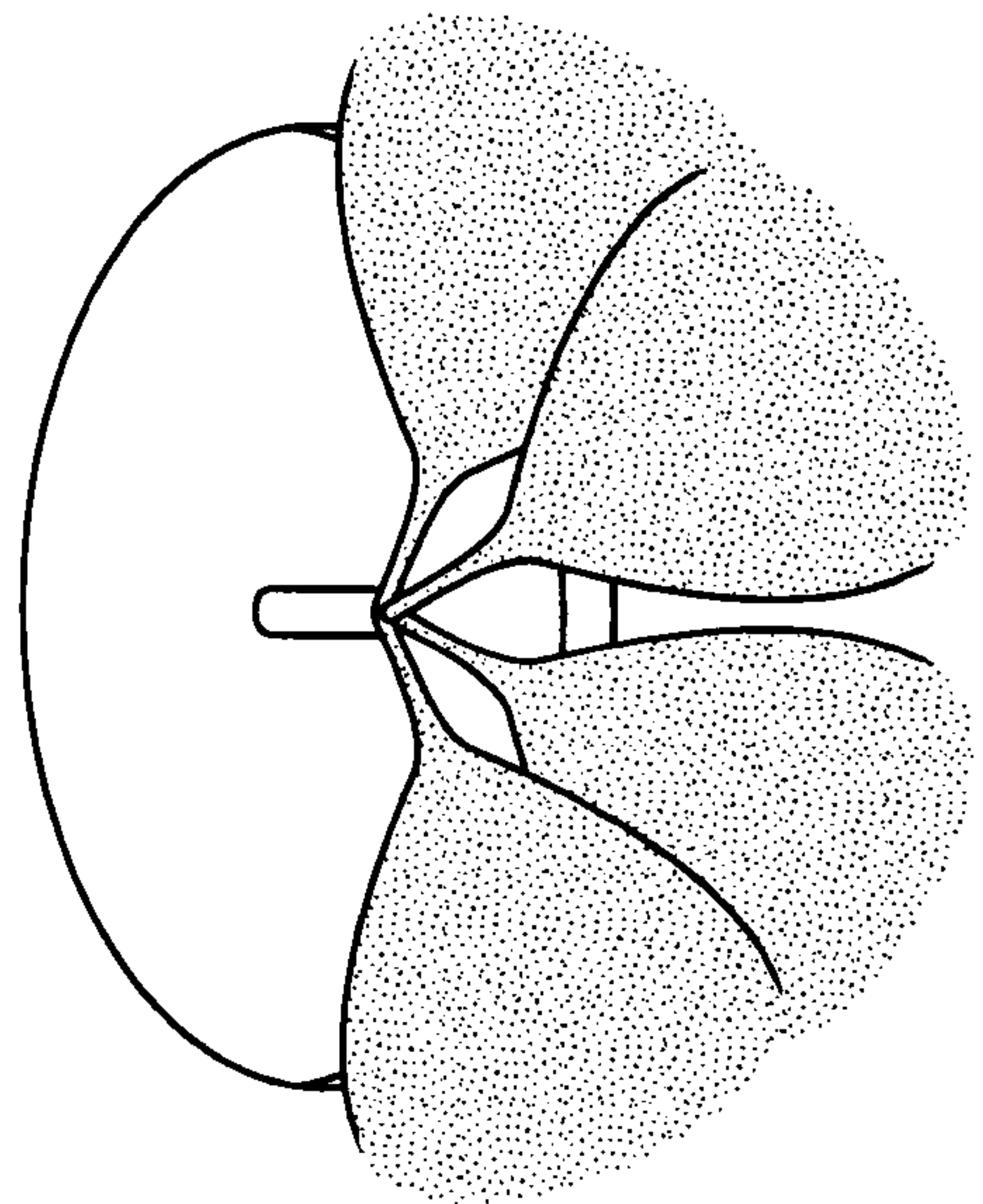
4/66

**FIG. 4**

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**FIG. 5A****FIG. 5B**

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**FIG. 6A****FIG. 6B****FIG. 6C****FIG. 6D**

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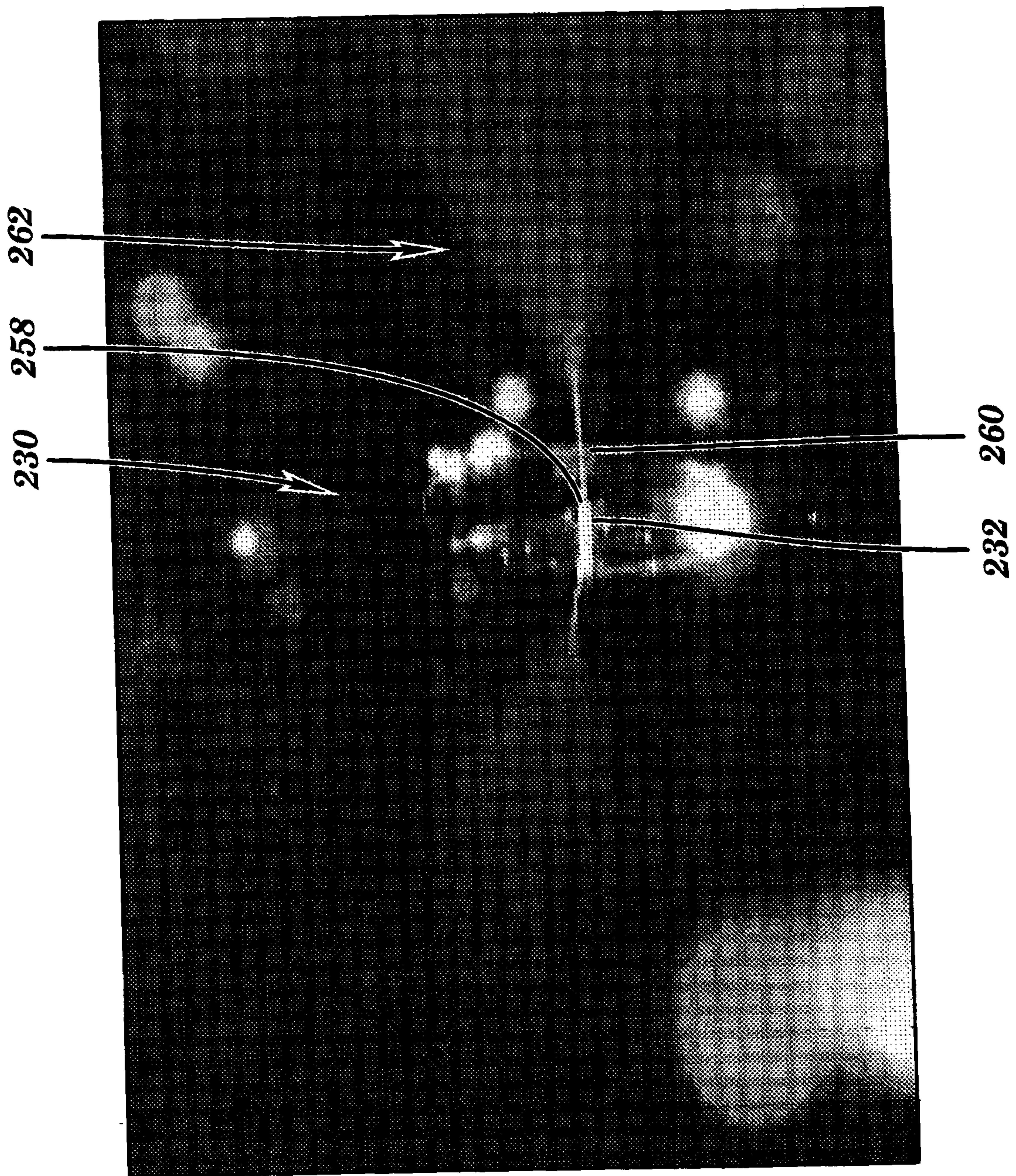


FIG. 7A

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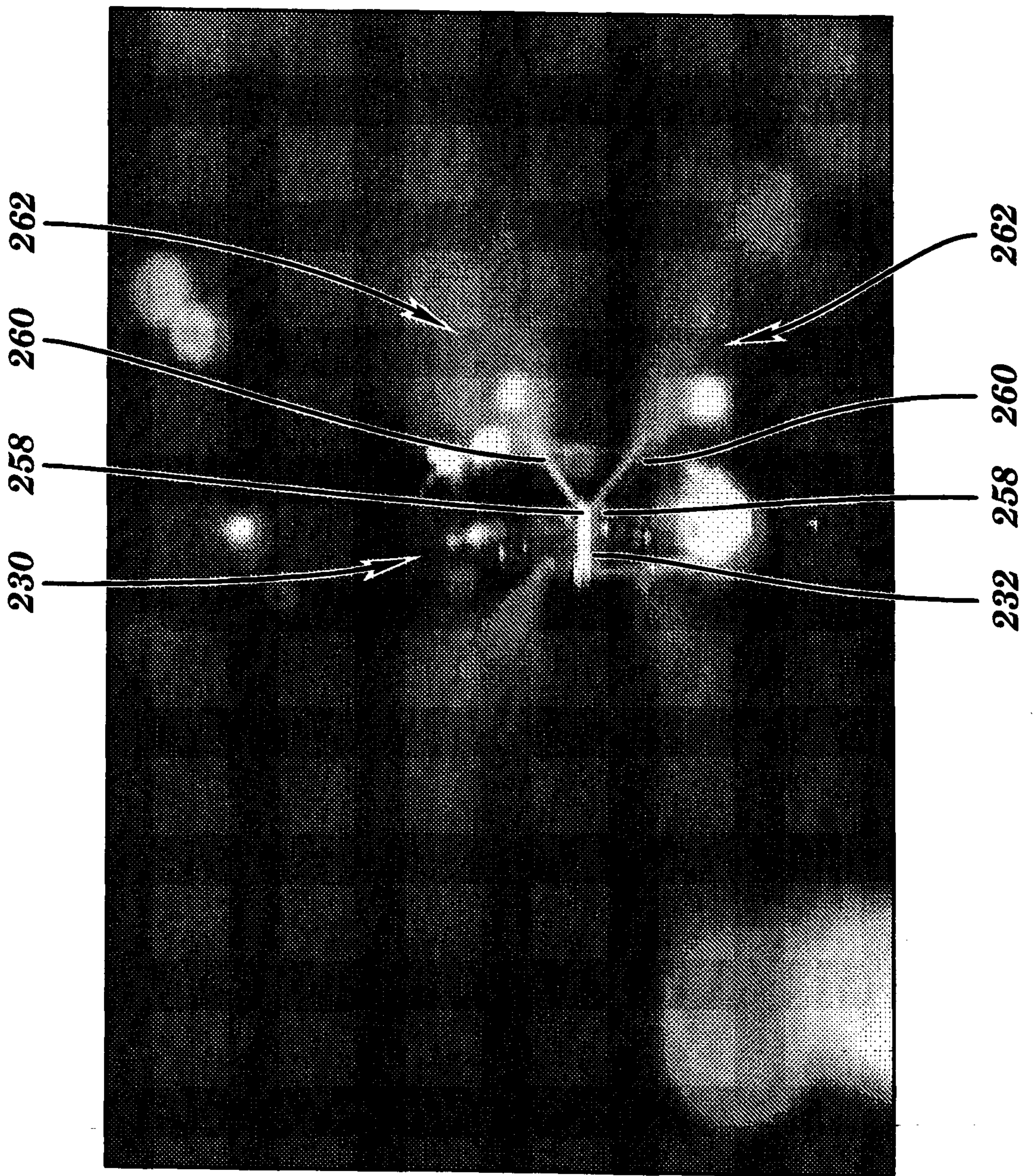
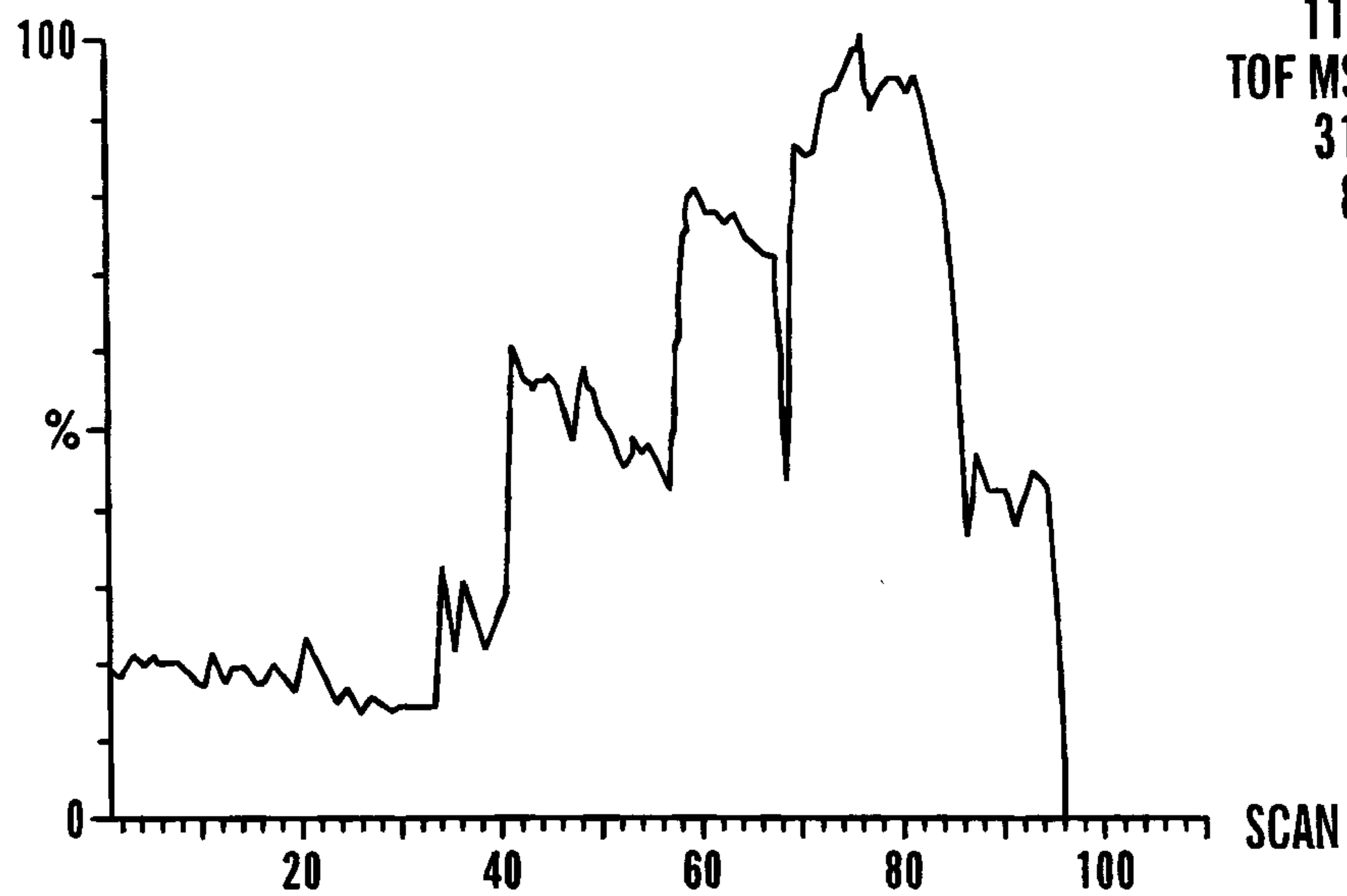


FIG. 7B

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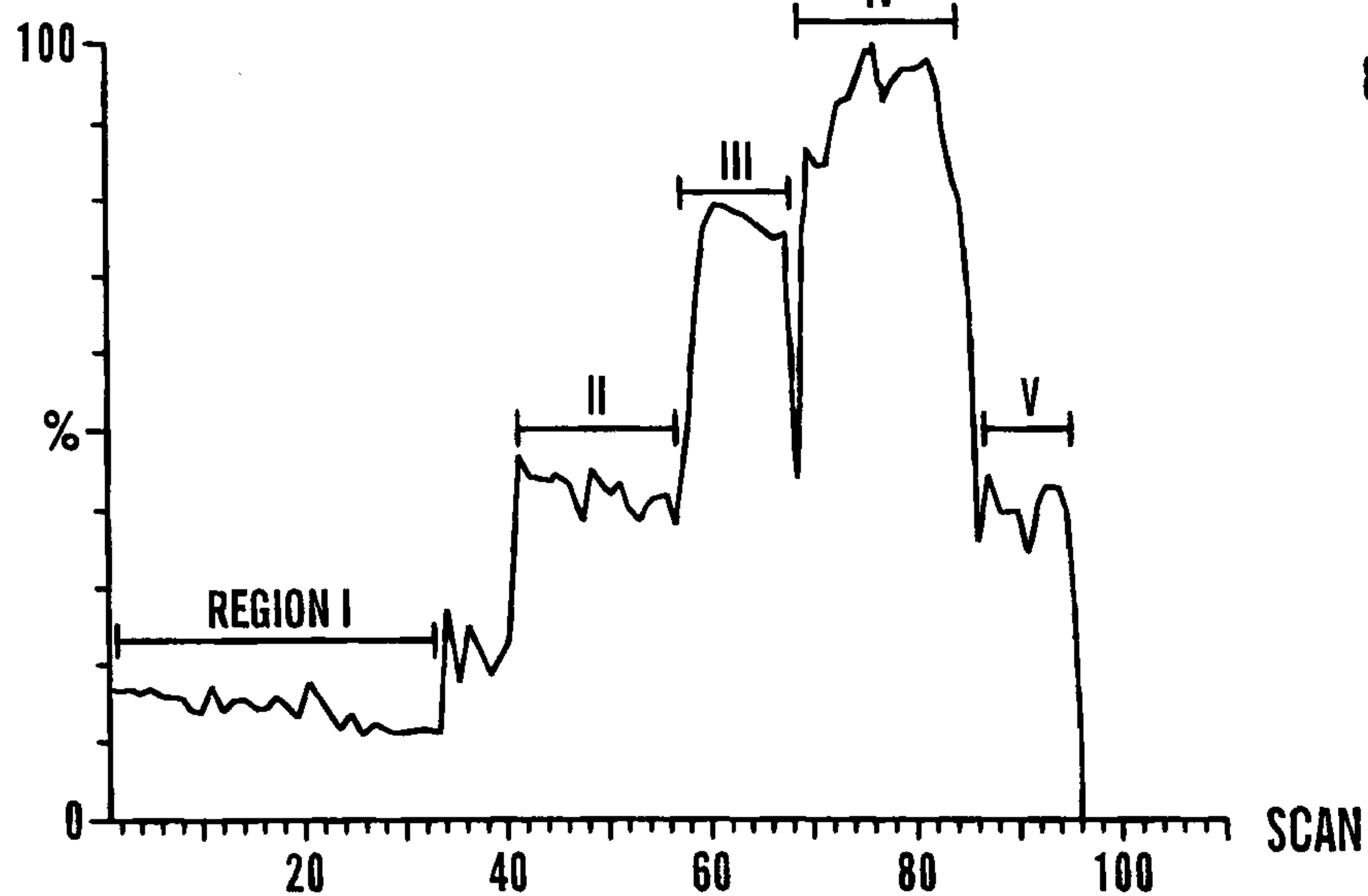
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FIG. 8B

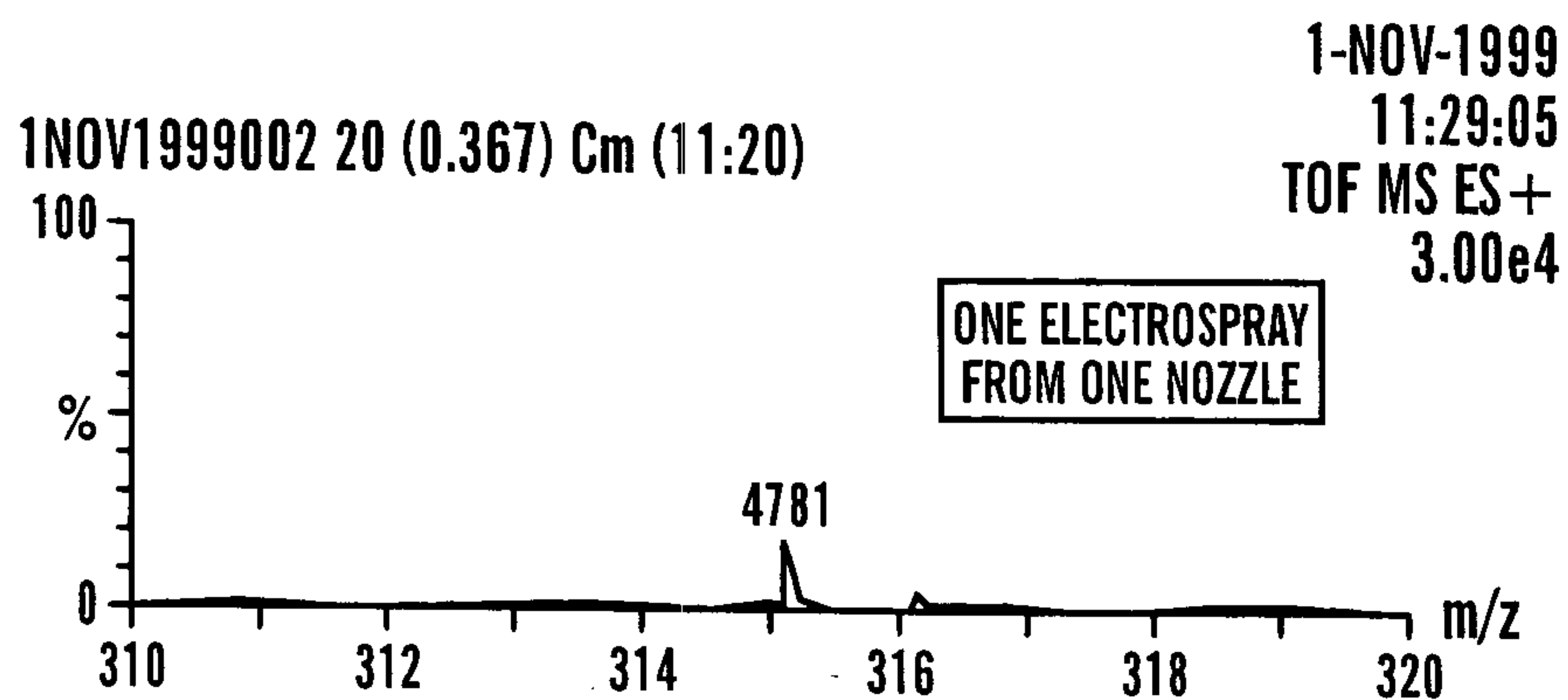
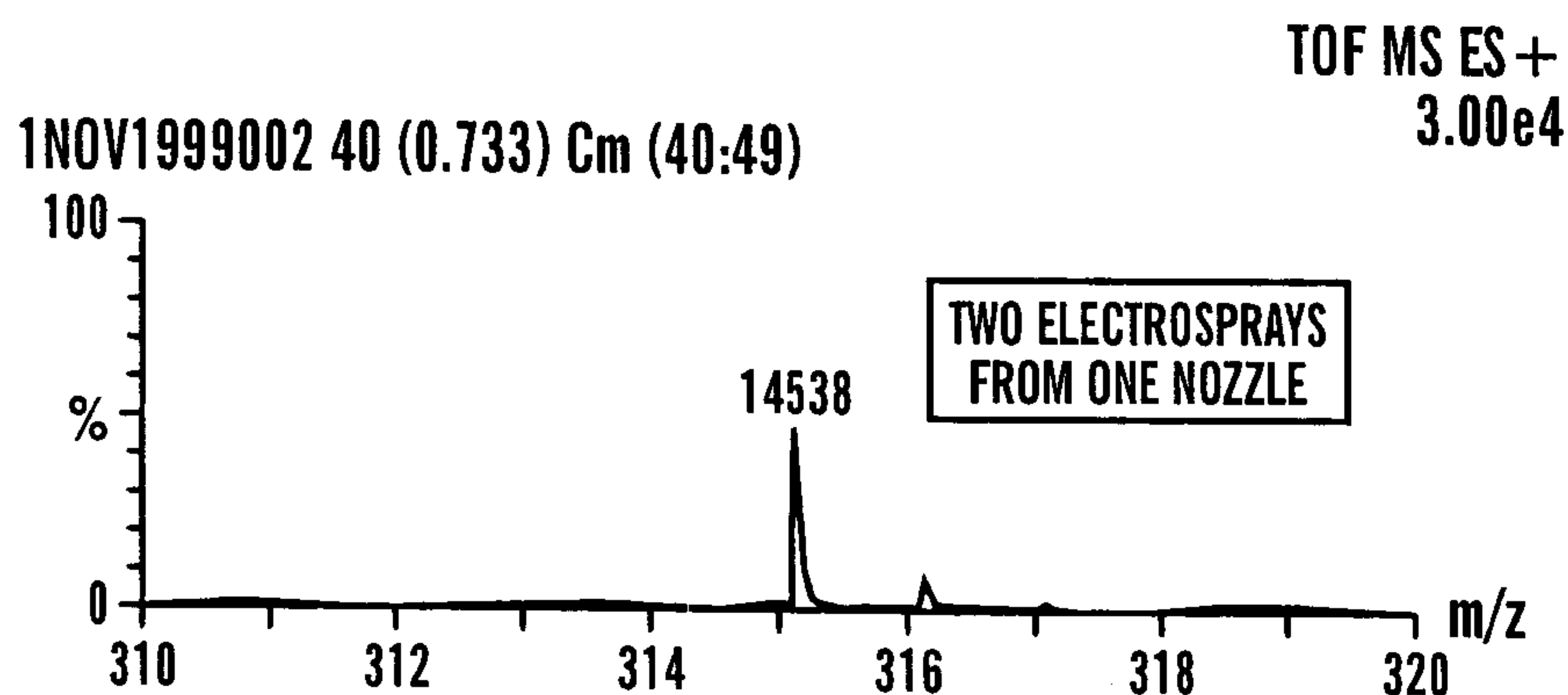
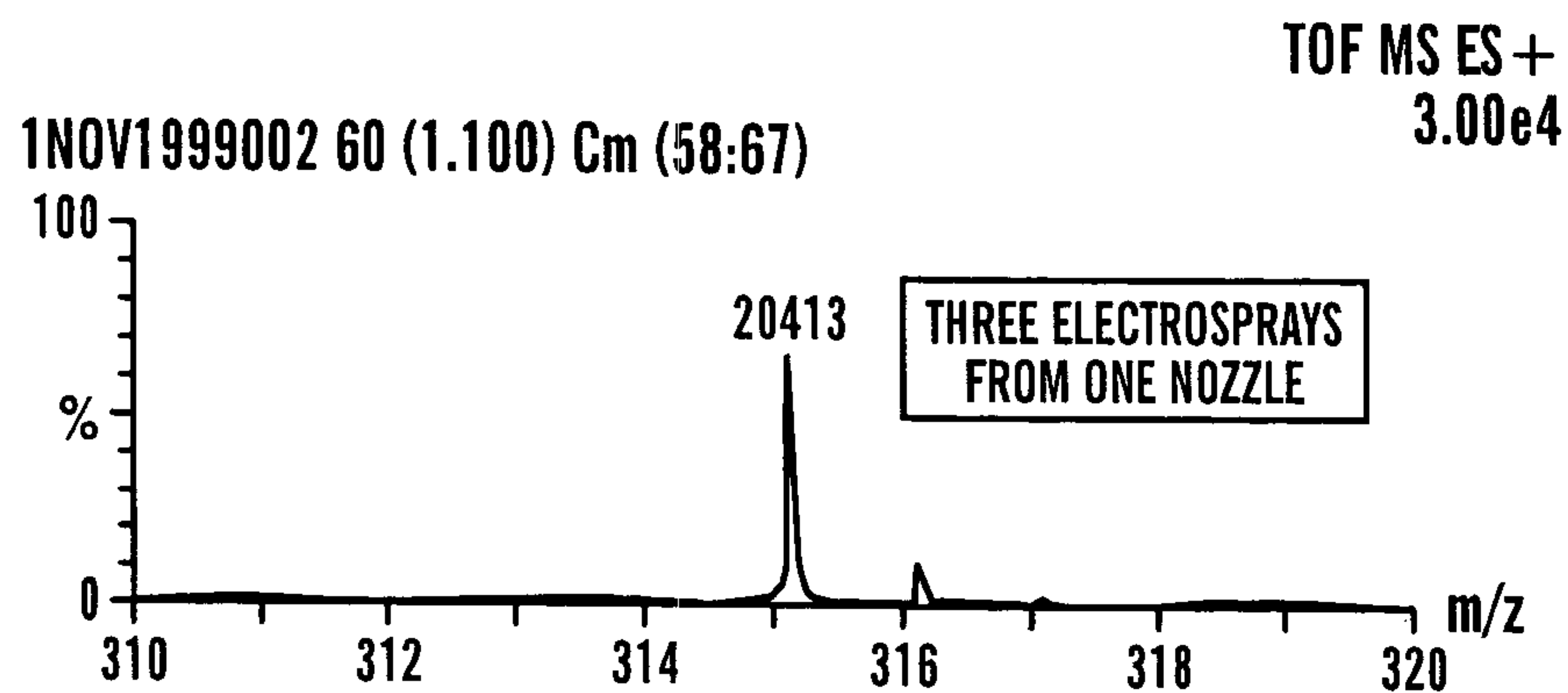
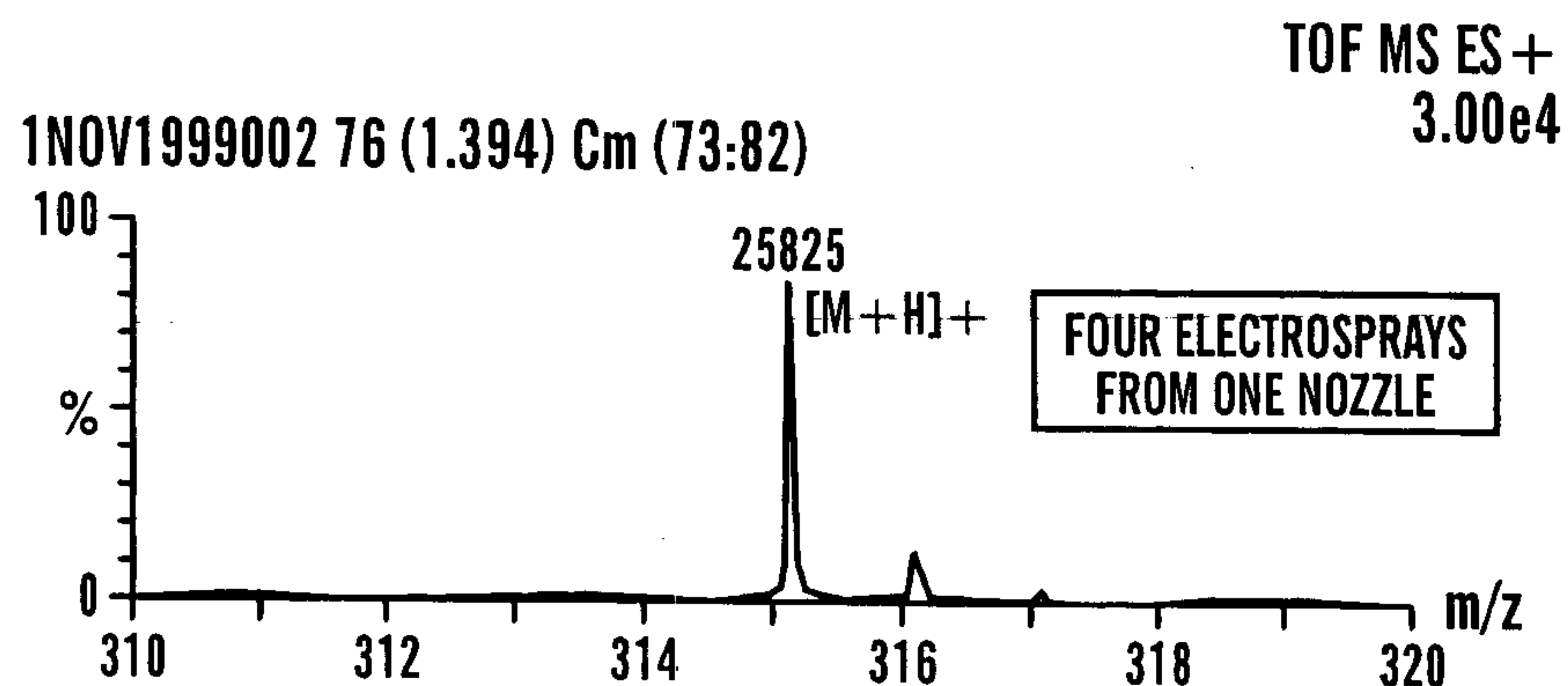
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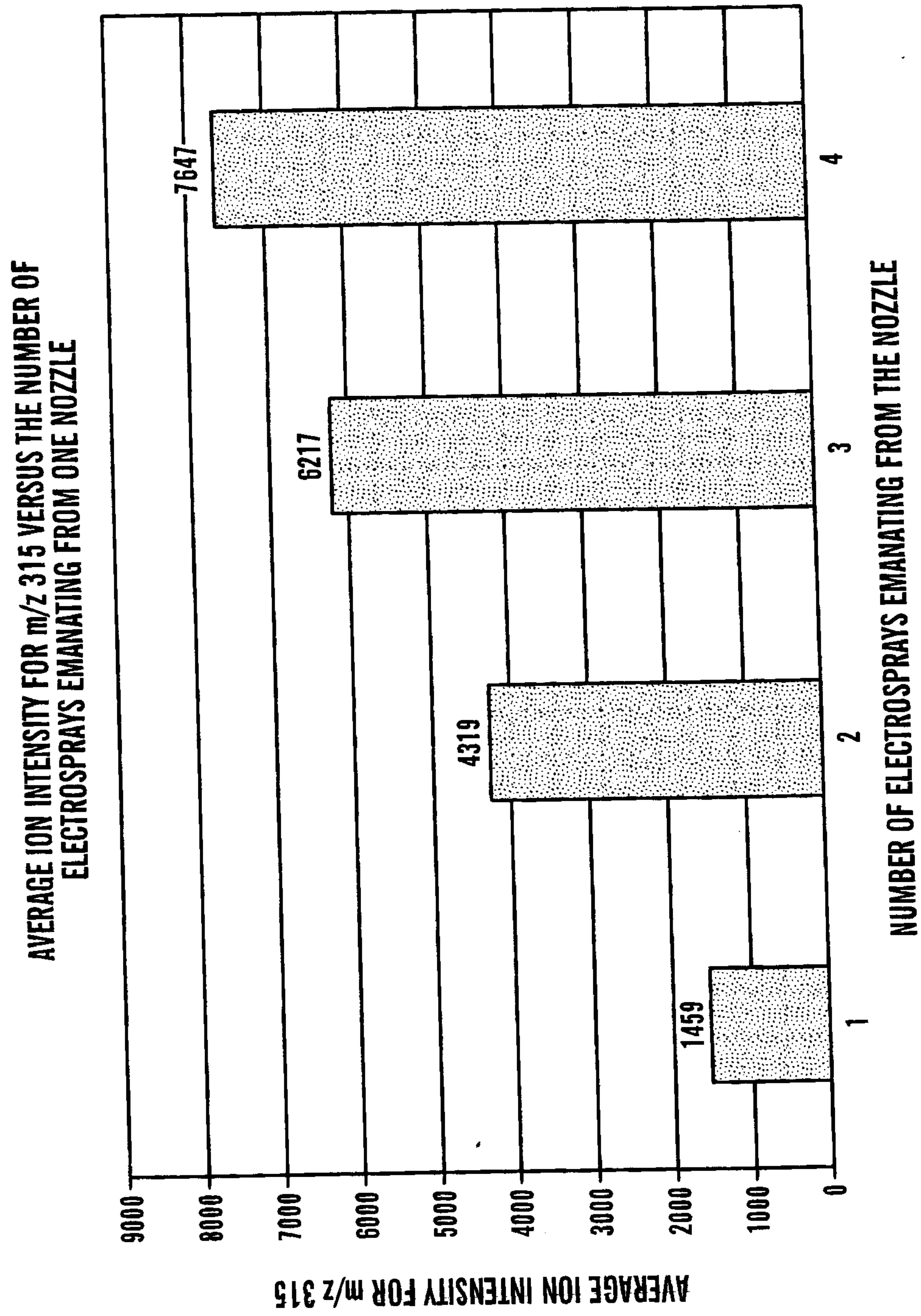
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FIG. 8A

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FIG. 9A**FIG. 9B****FIG. 9C****FIG. 9D**

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**FIG. 10**

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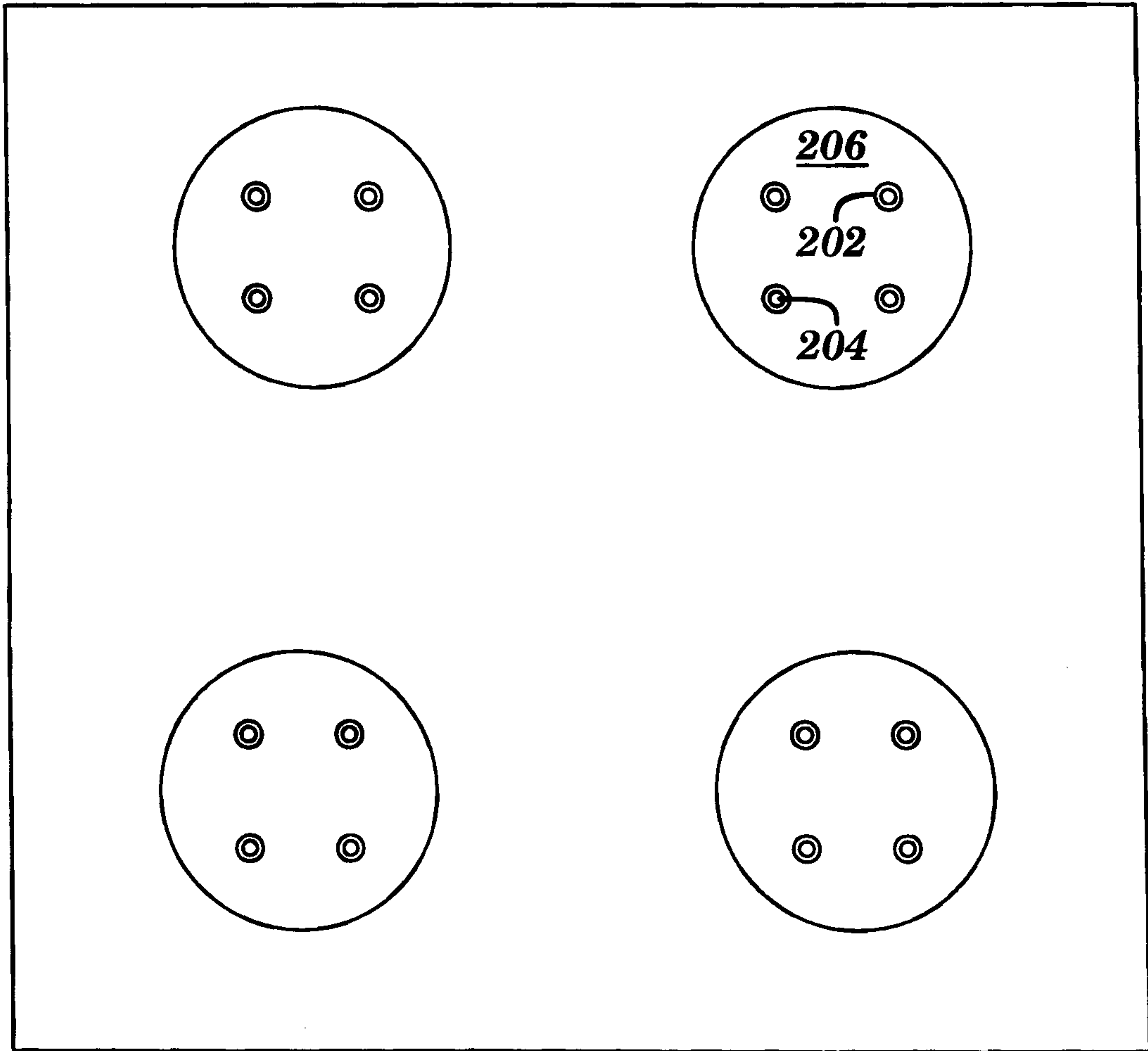


FIG. 11A

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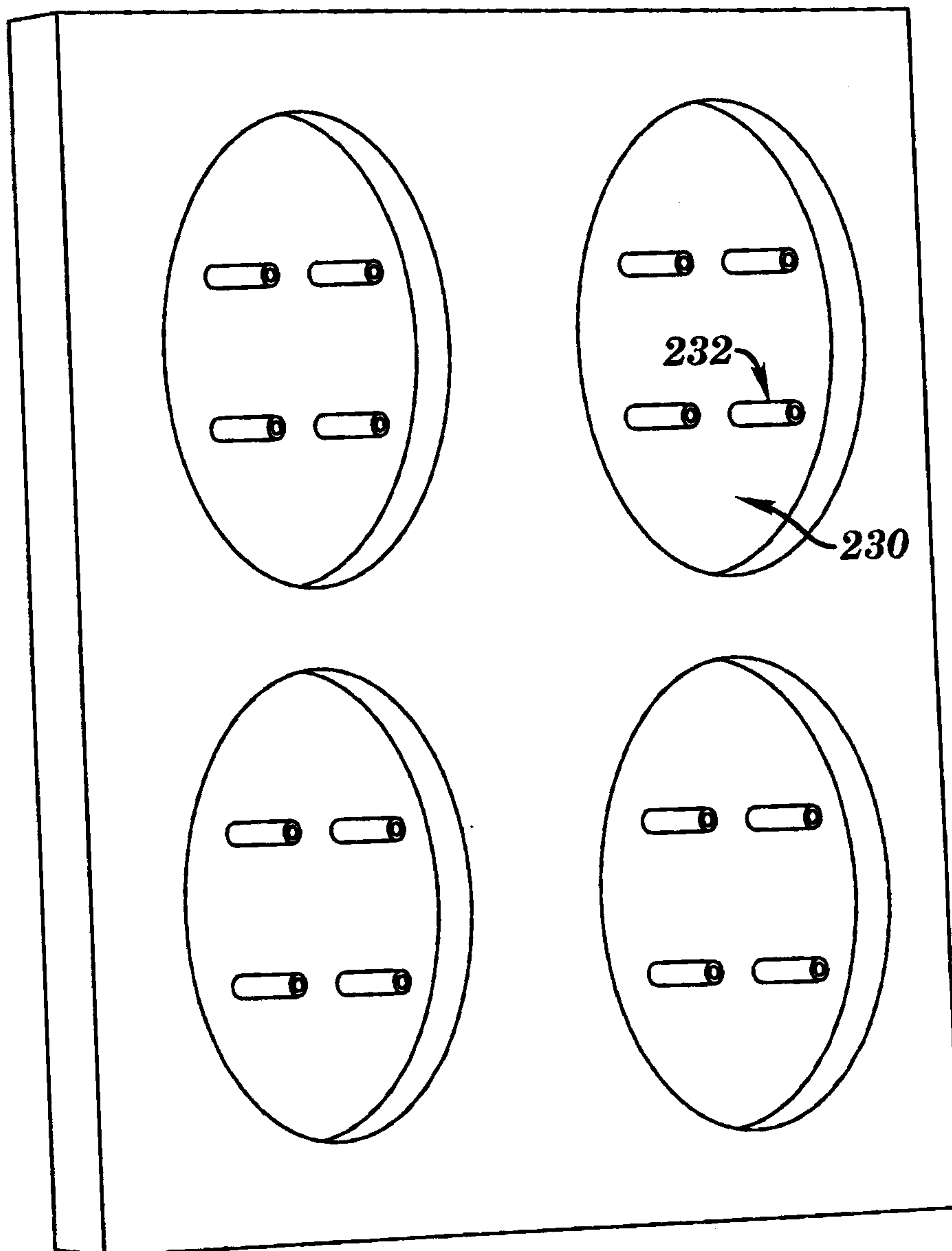
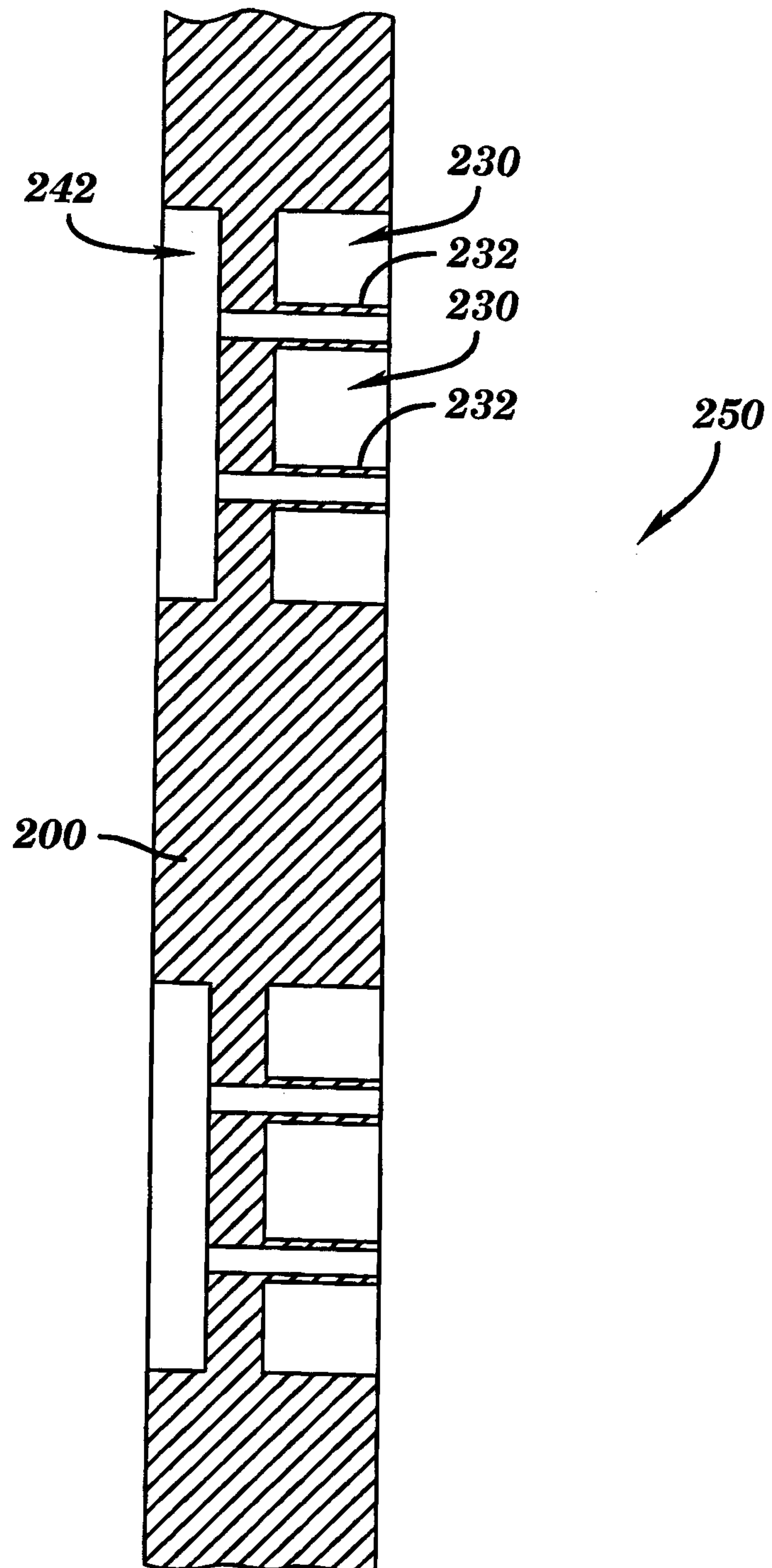


FIG. 11B

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**FIG. 11C**

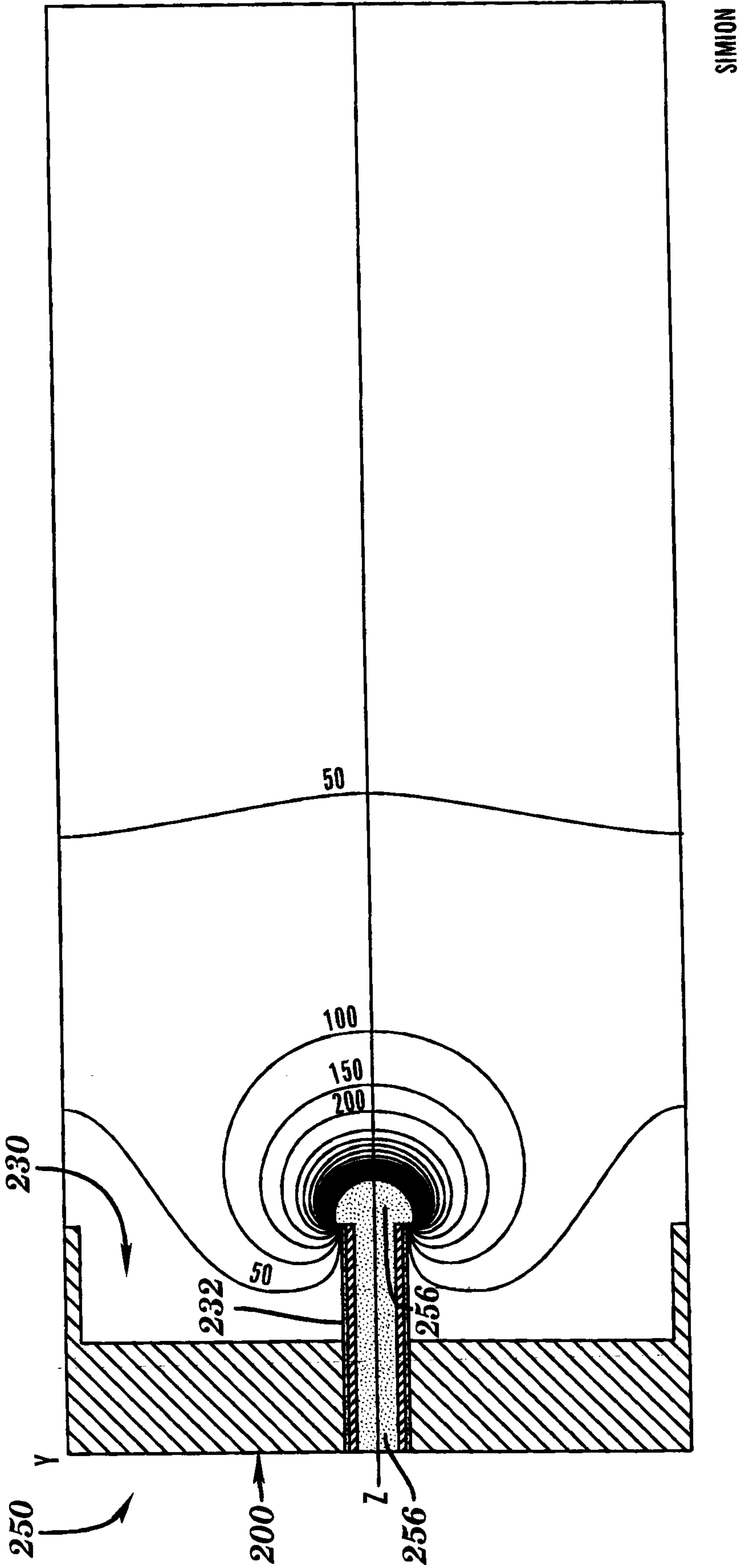


FIG. 12A

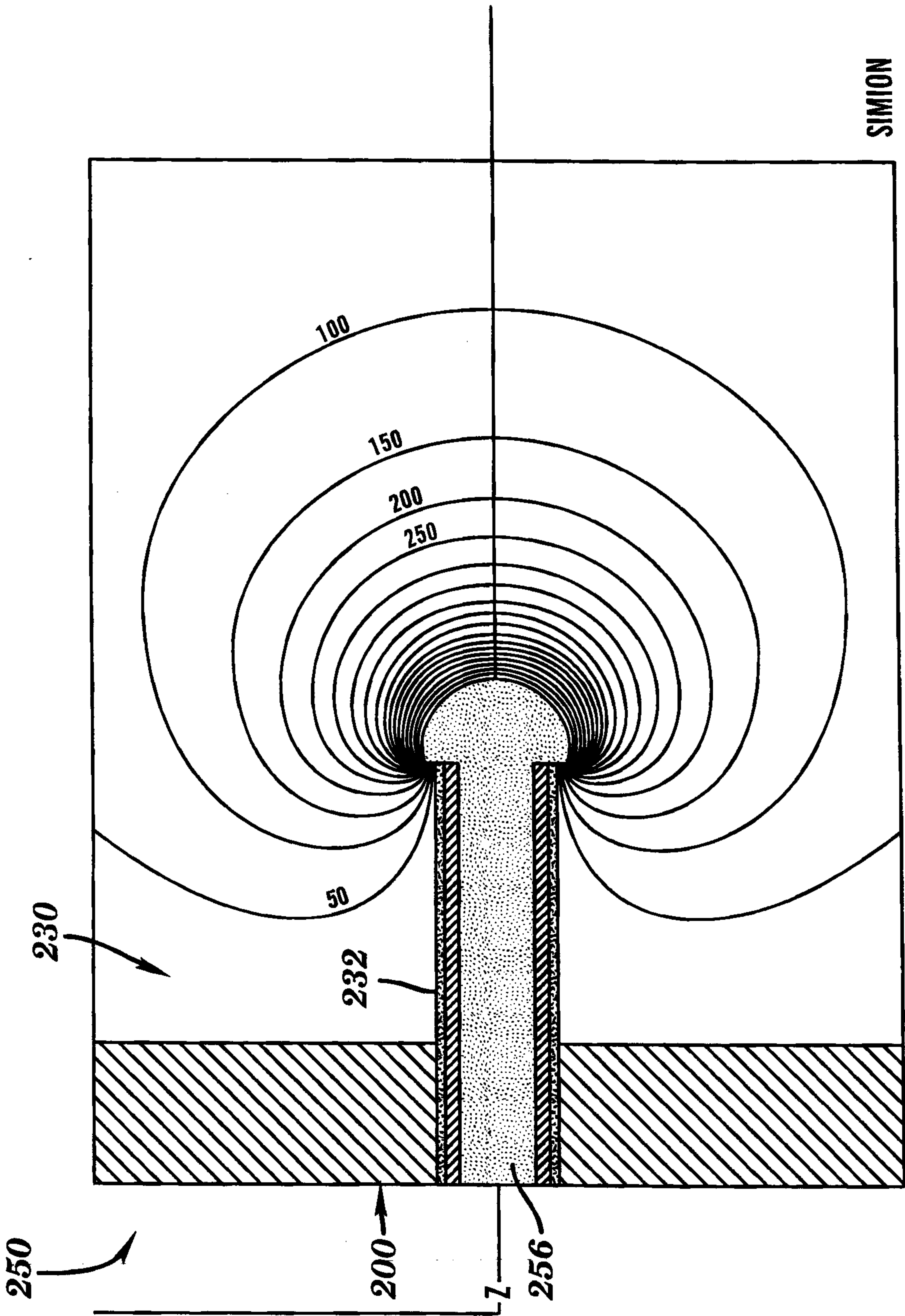


FIG. 12B

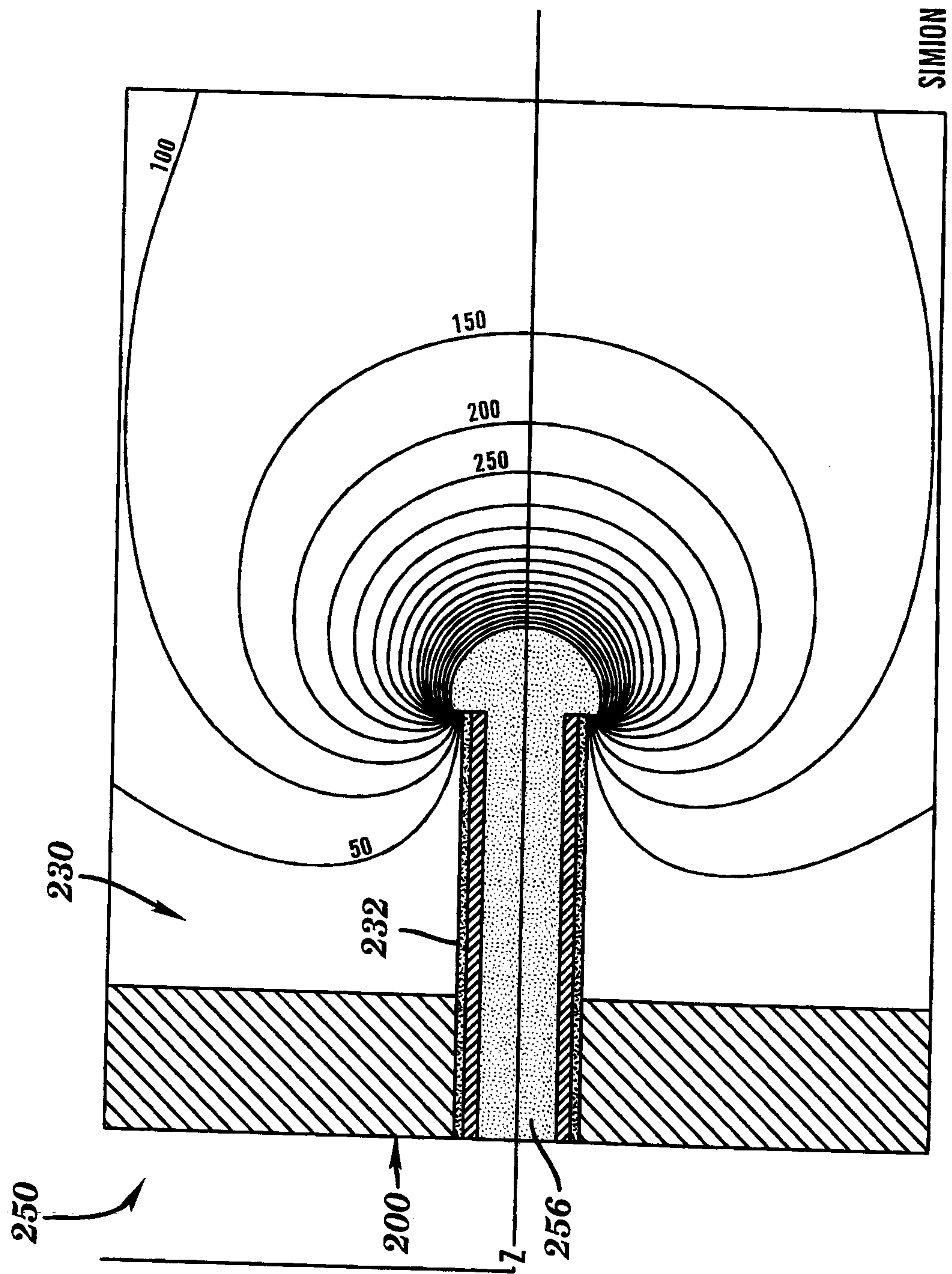


FIG. 12C

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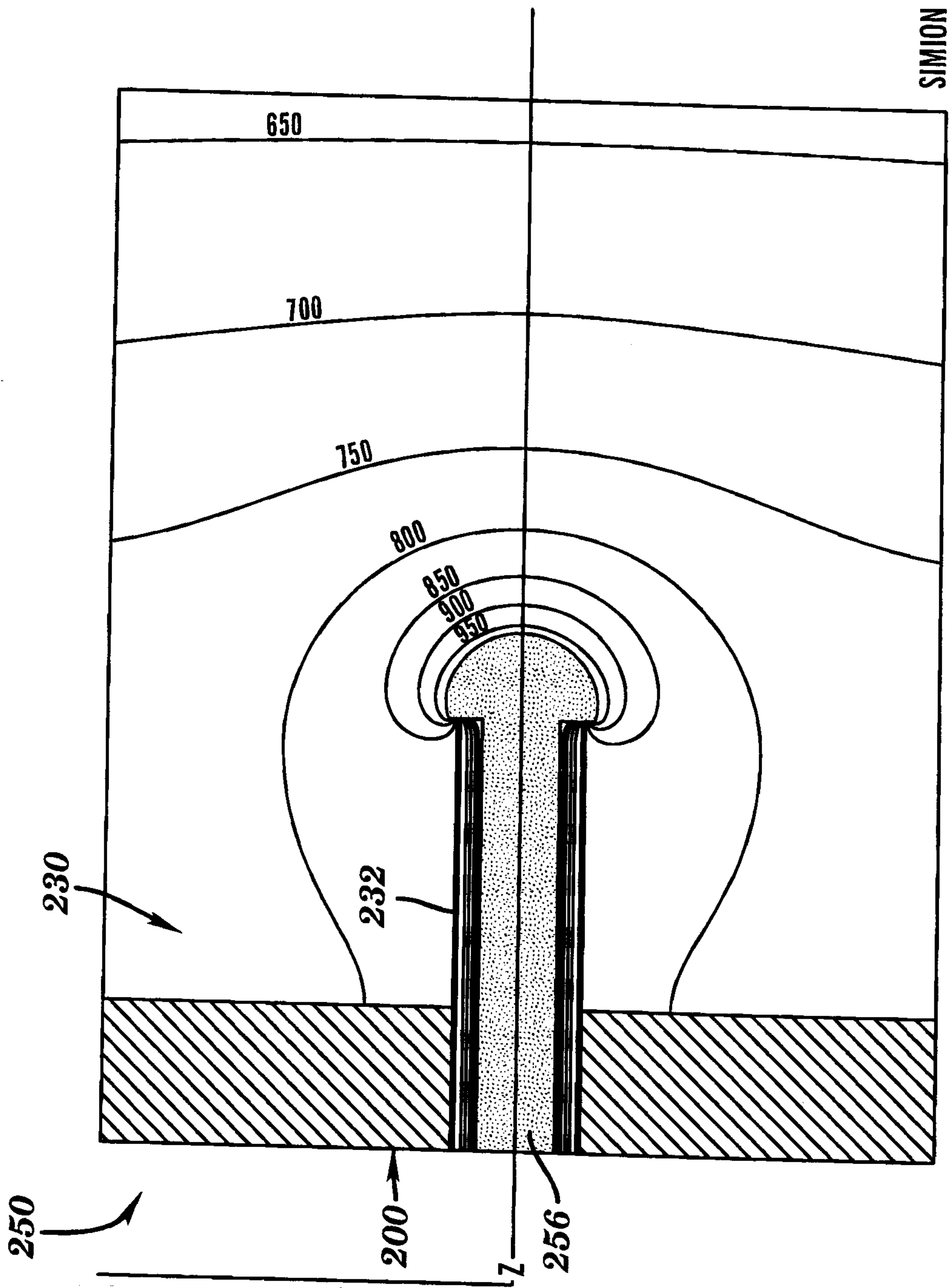


FIG. 12D

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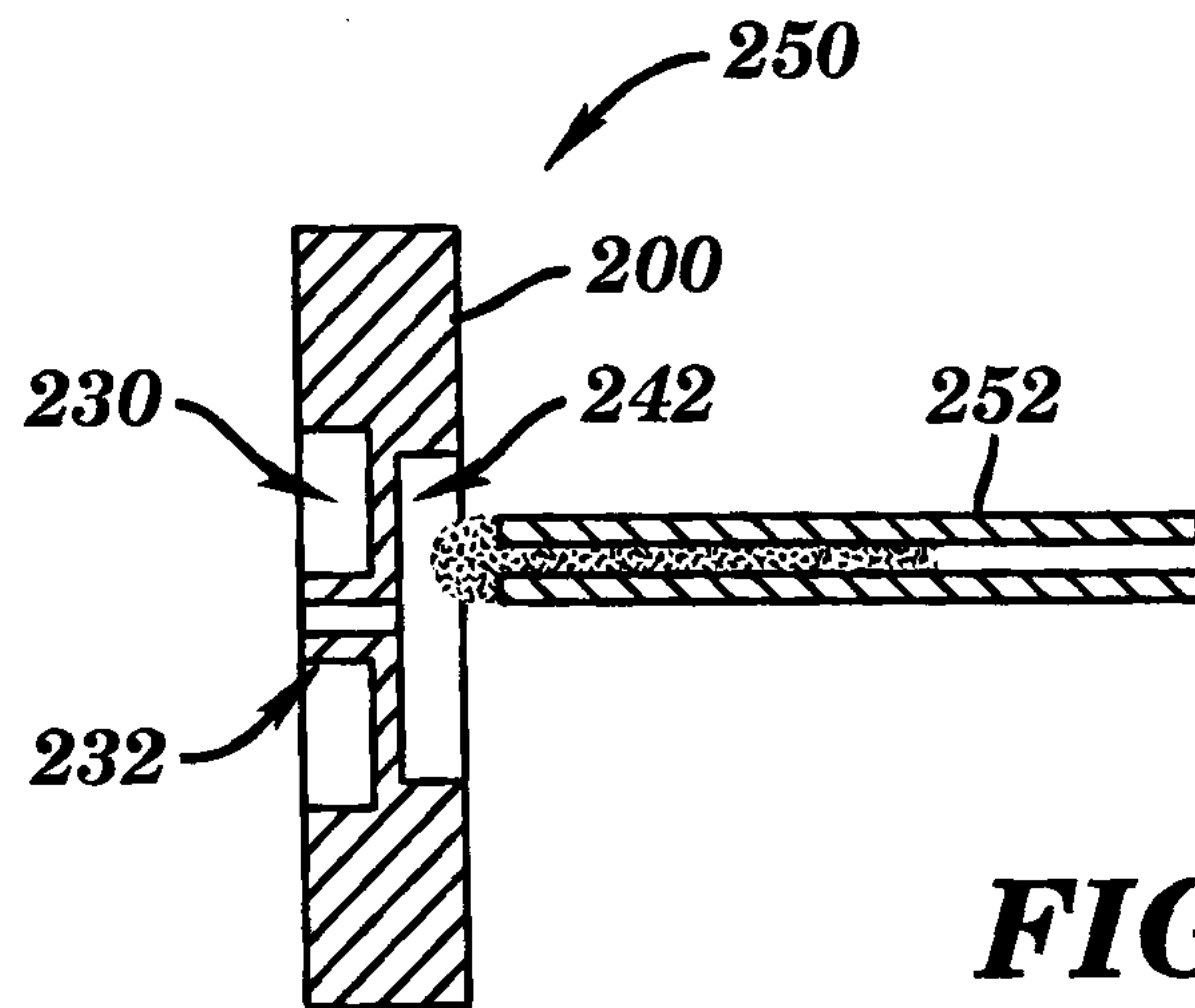


FIG. 13A

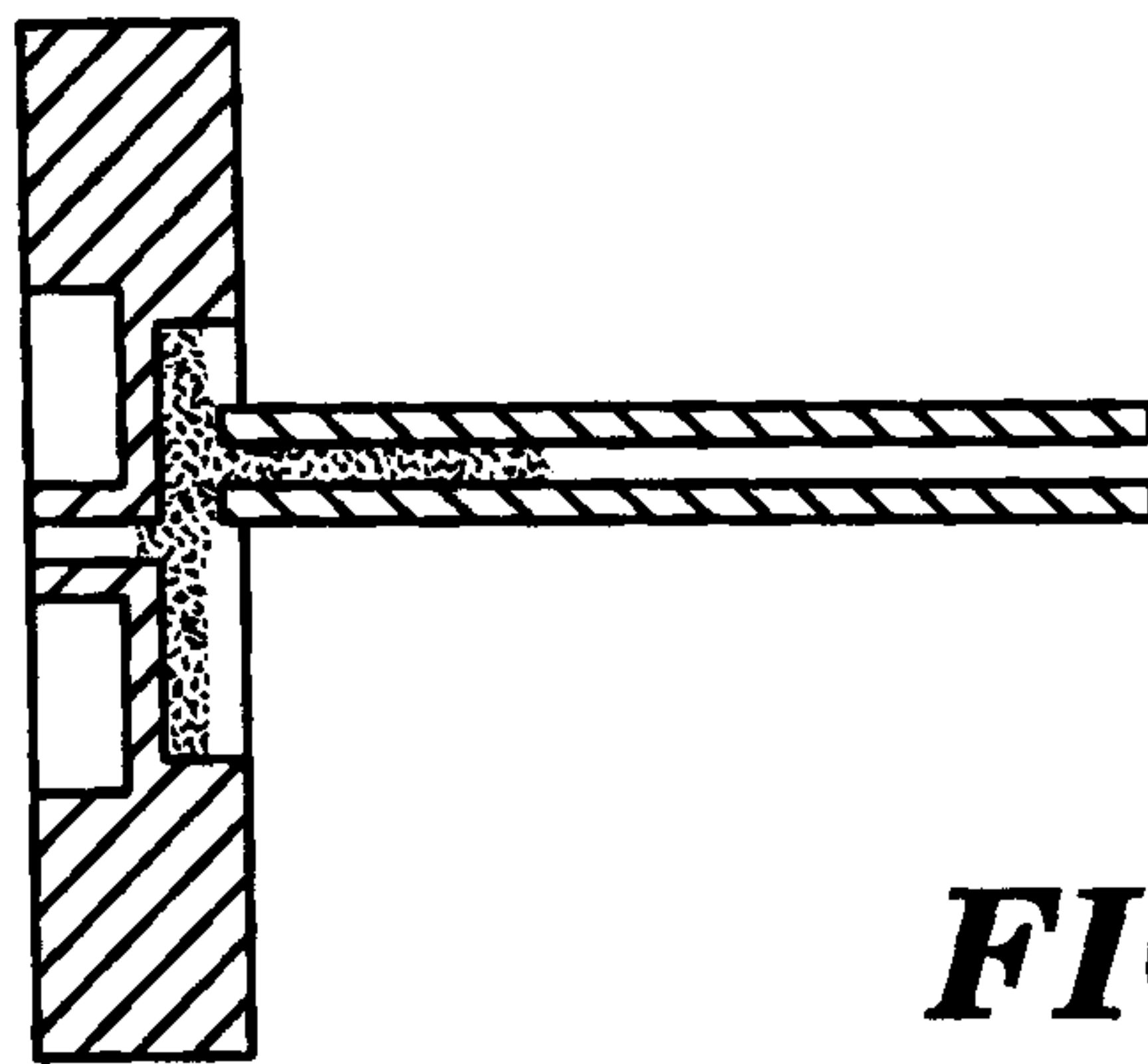


FIG. 13B

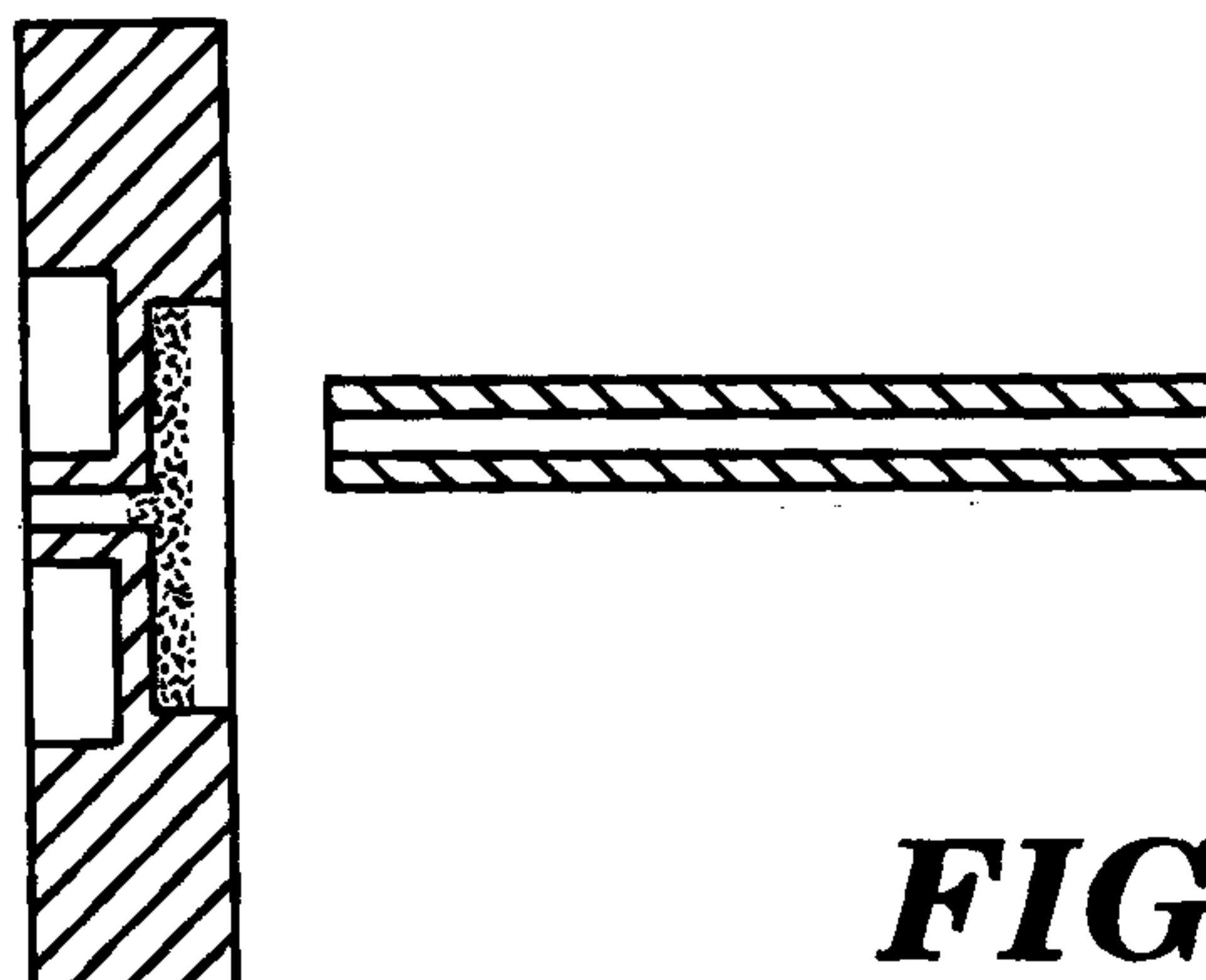
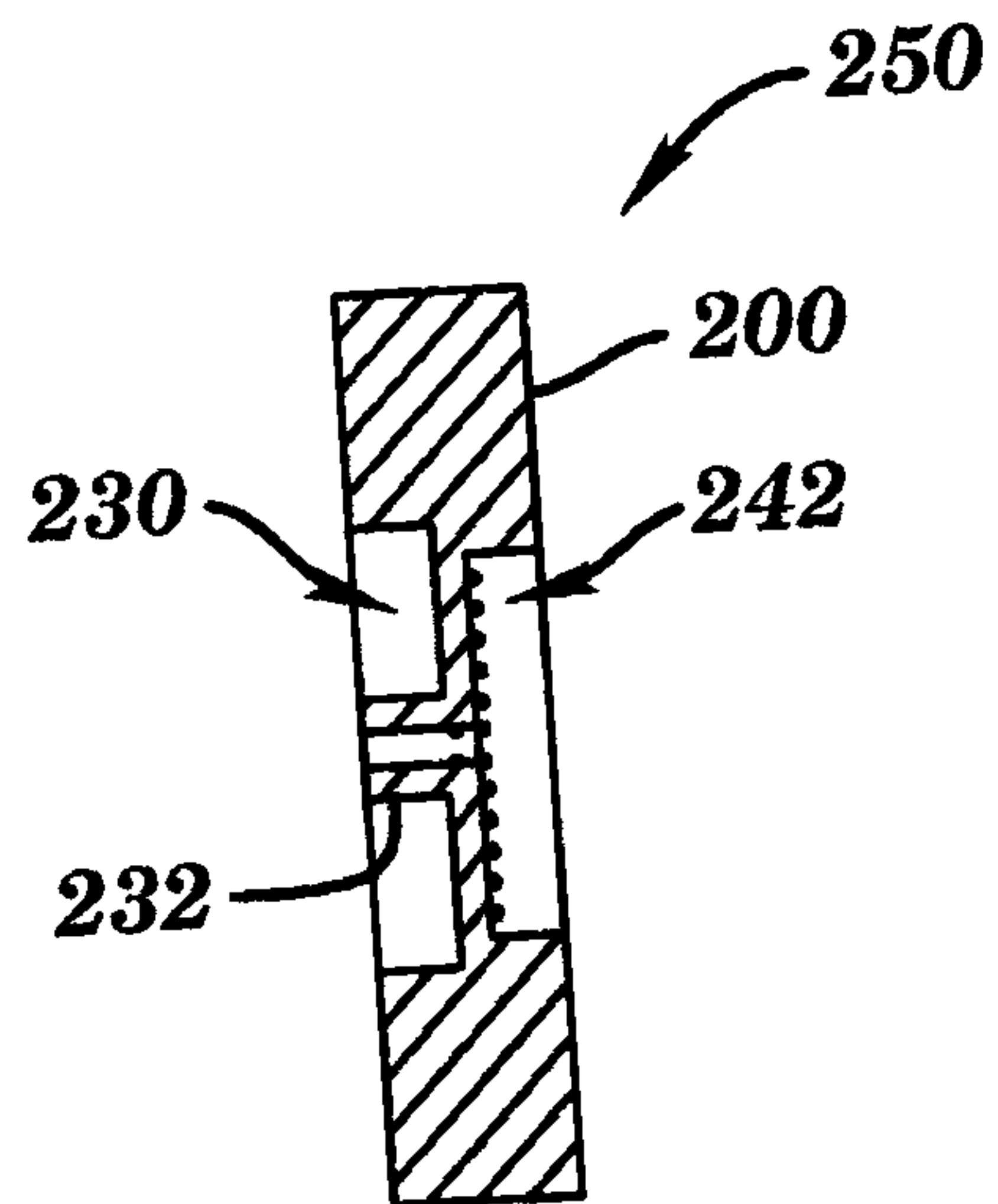
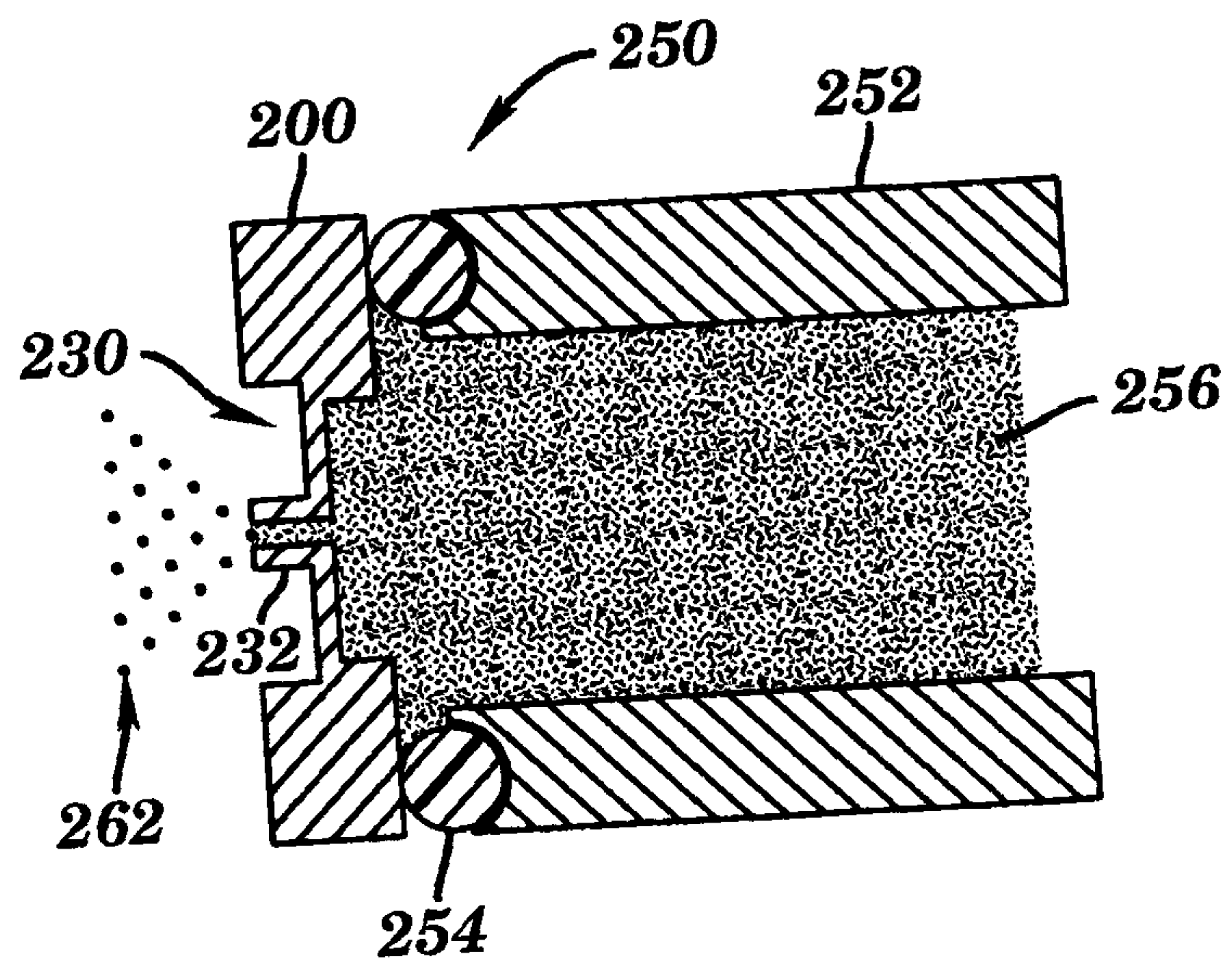


FIG. 13C

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**FIG. 13D****FIG. 13E**

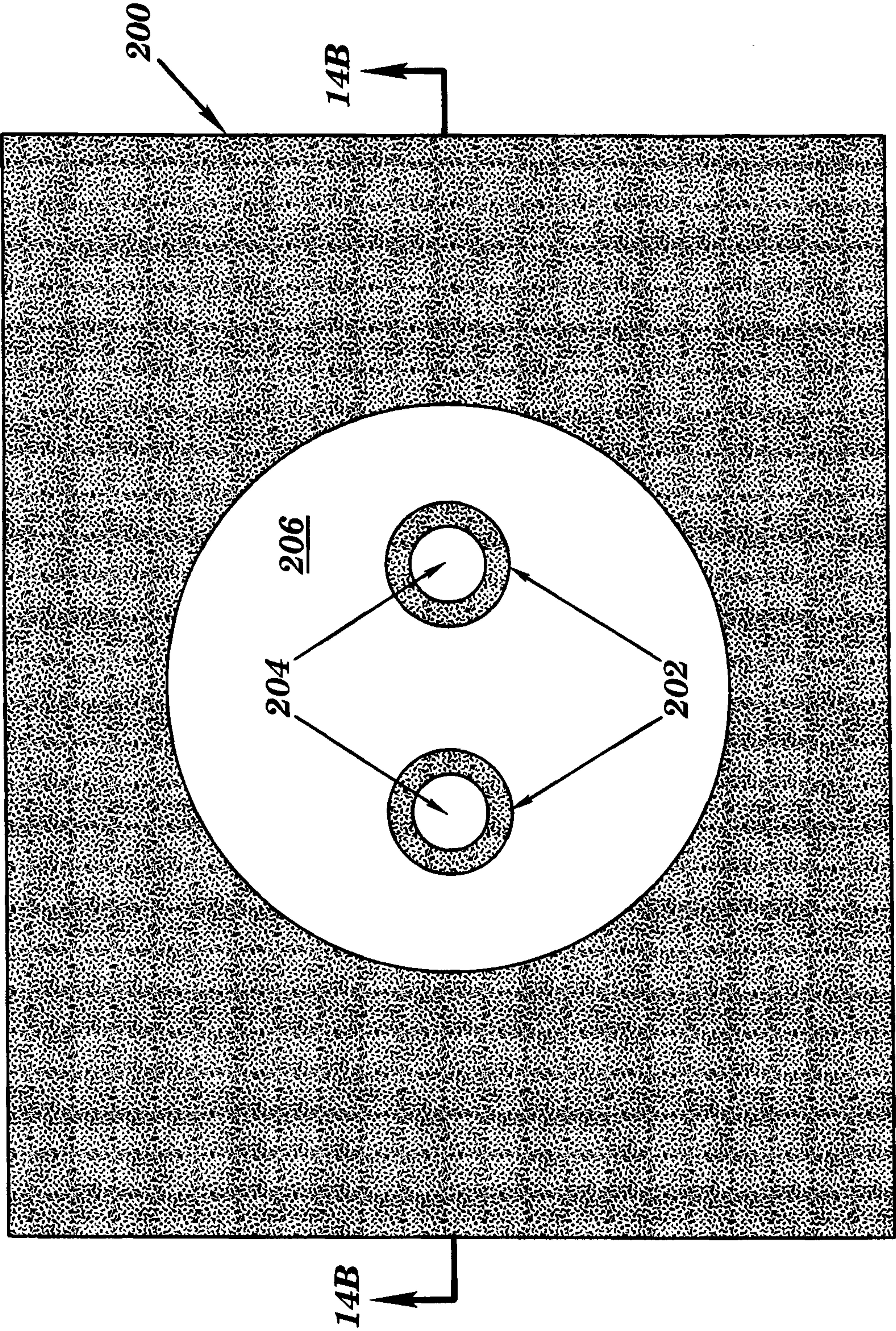


FIG. 14A

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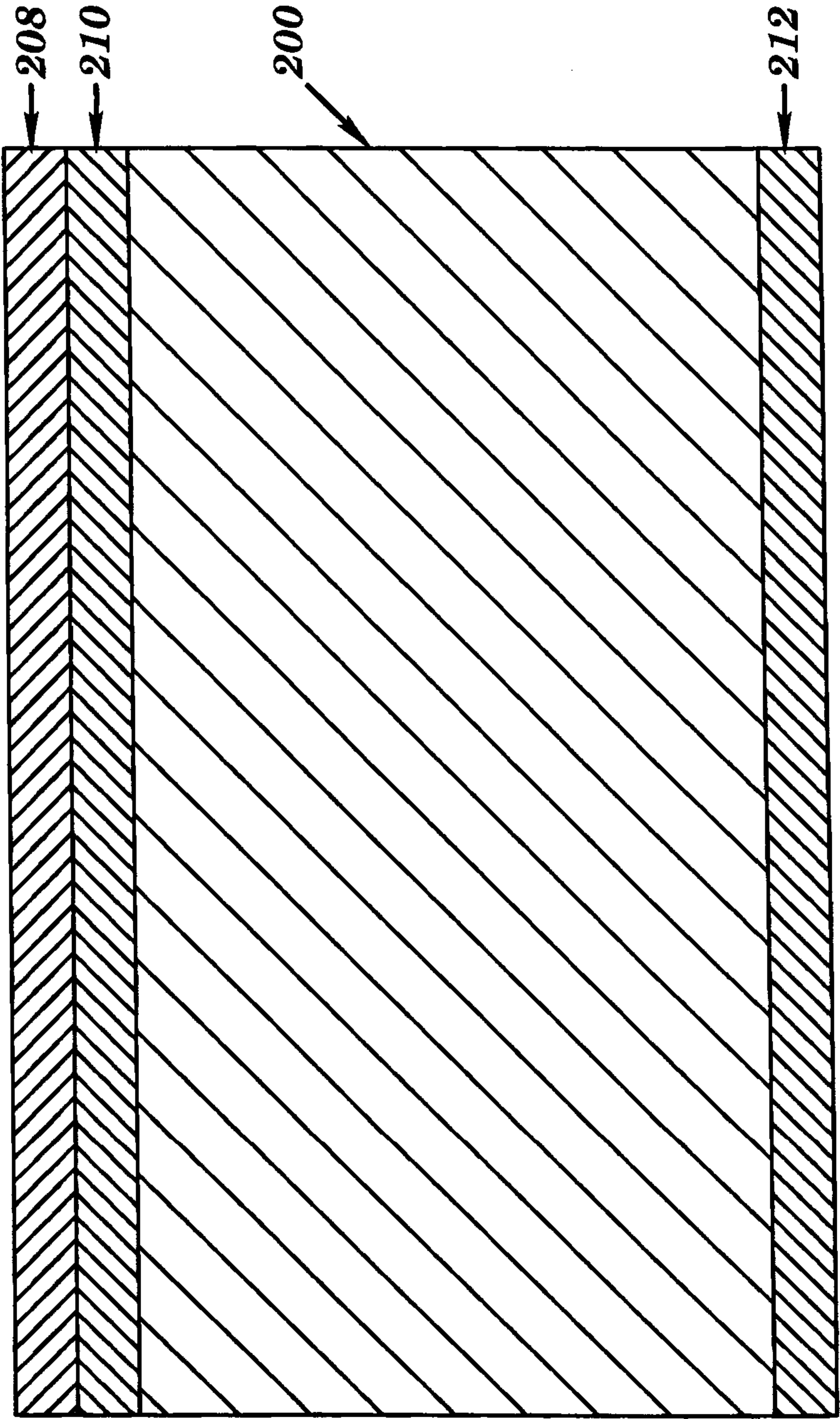


FIG. 14B

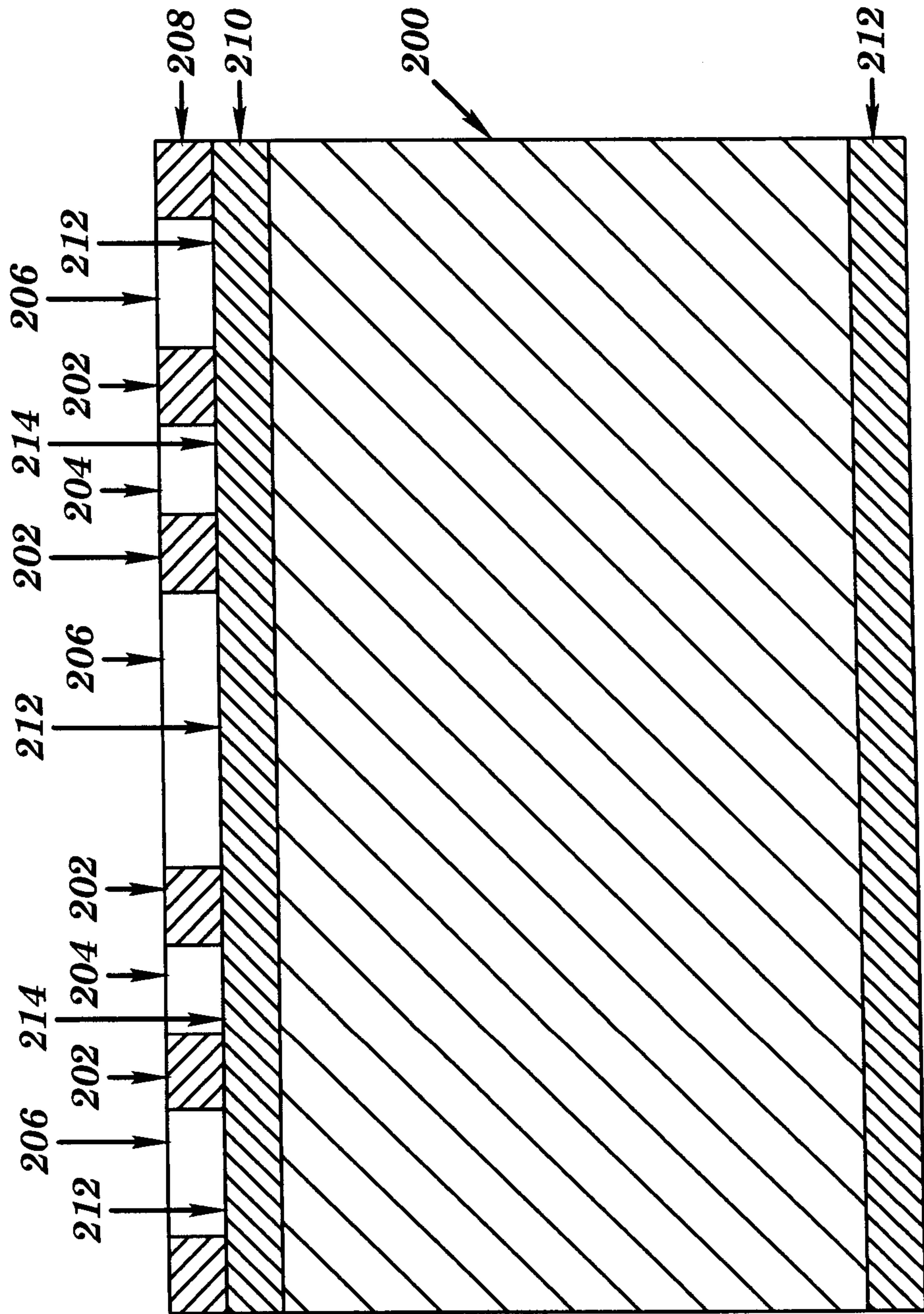


FIG. 14C

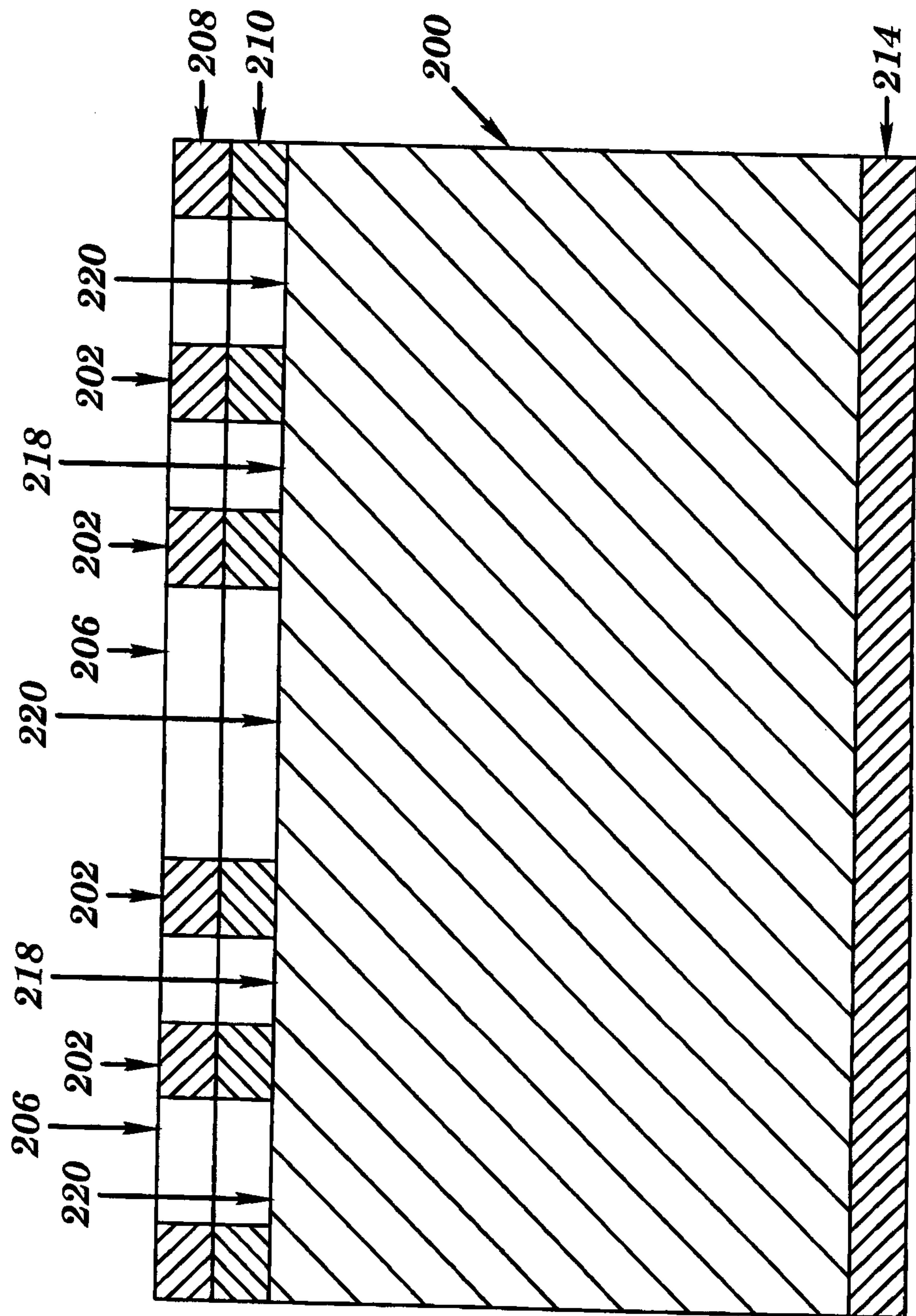


FIG. 14D

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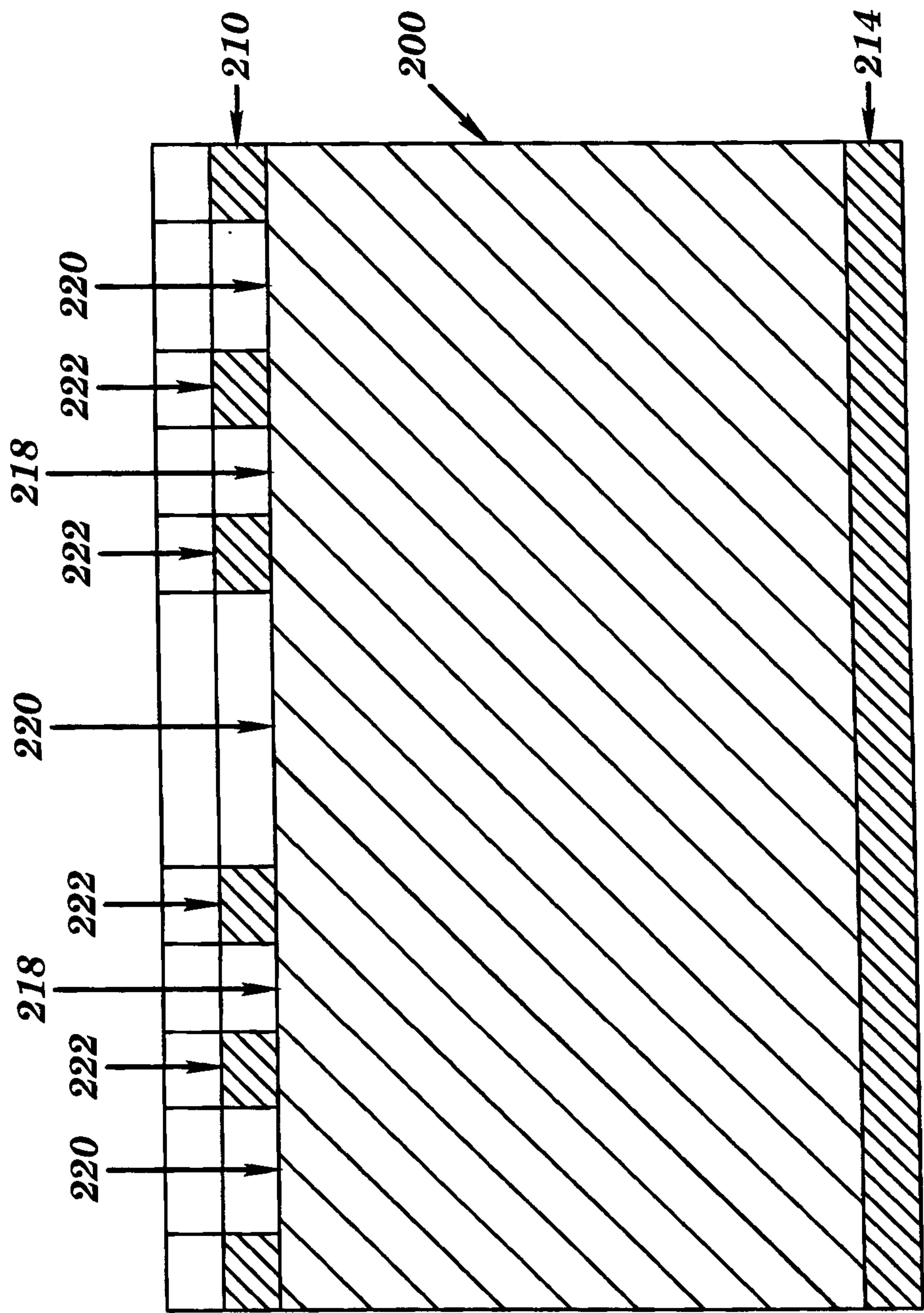


FIG. 14E

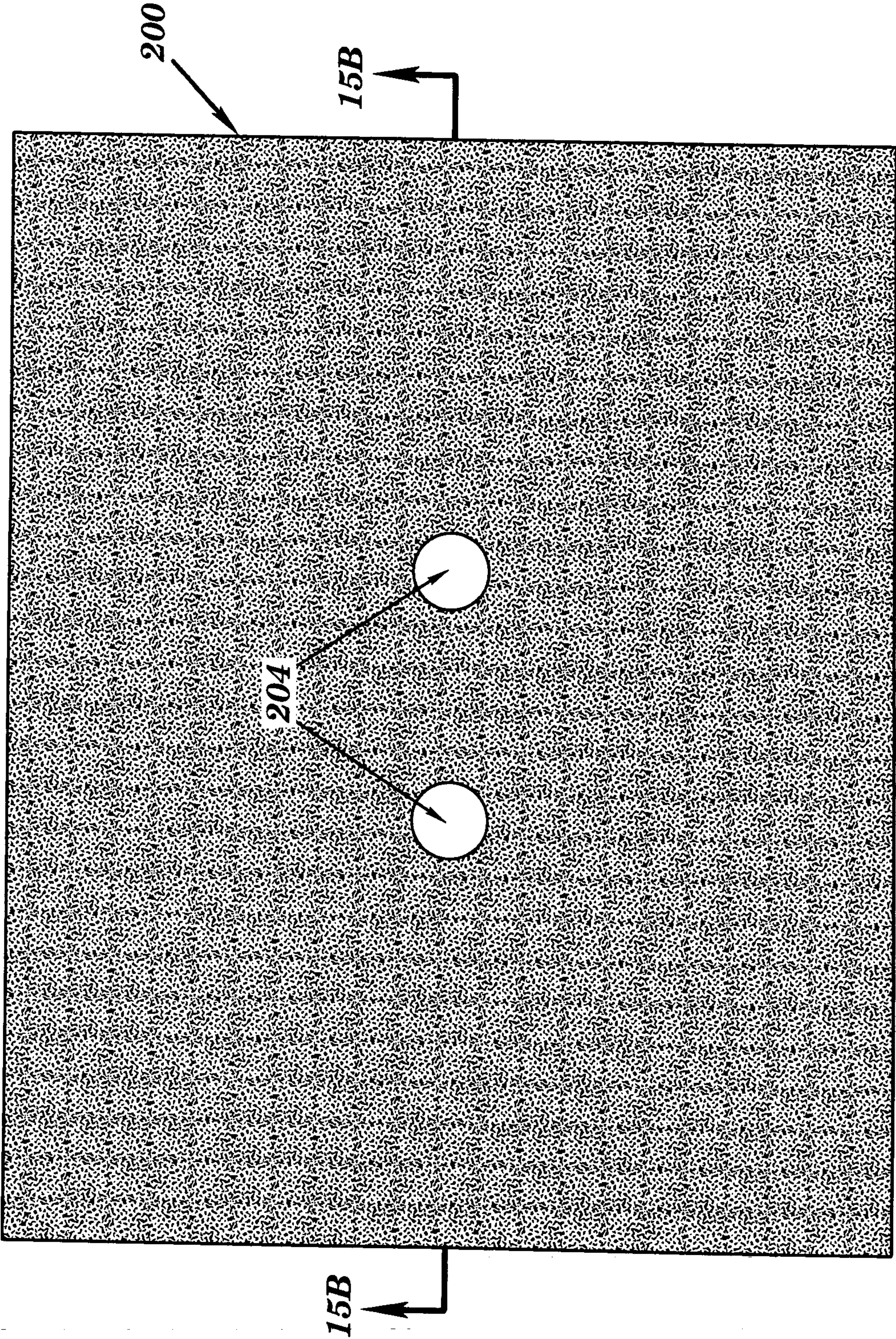


FIG. 15A

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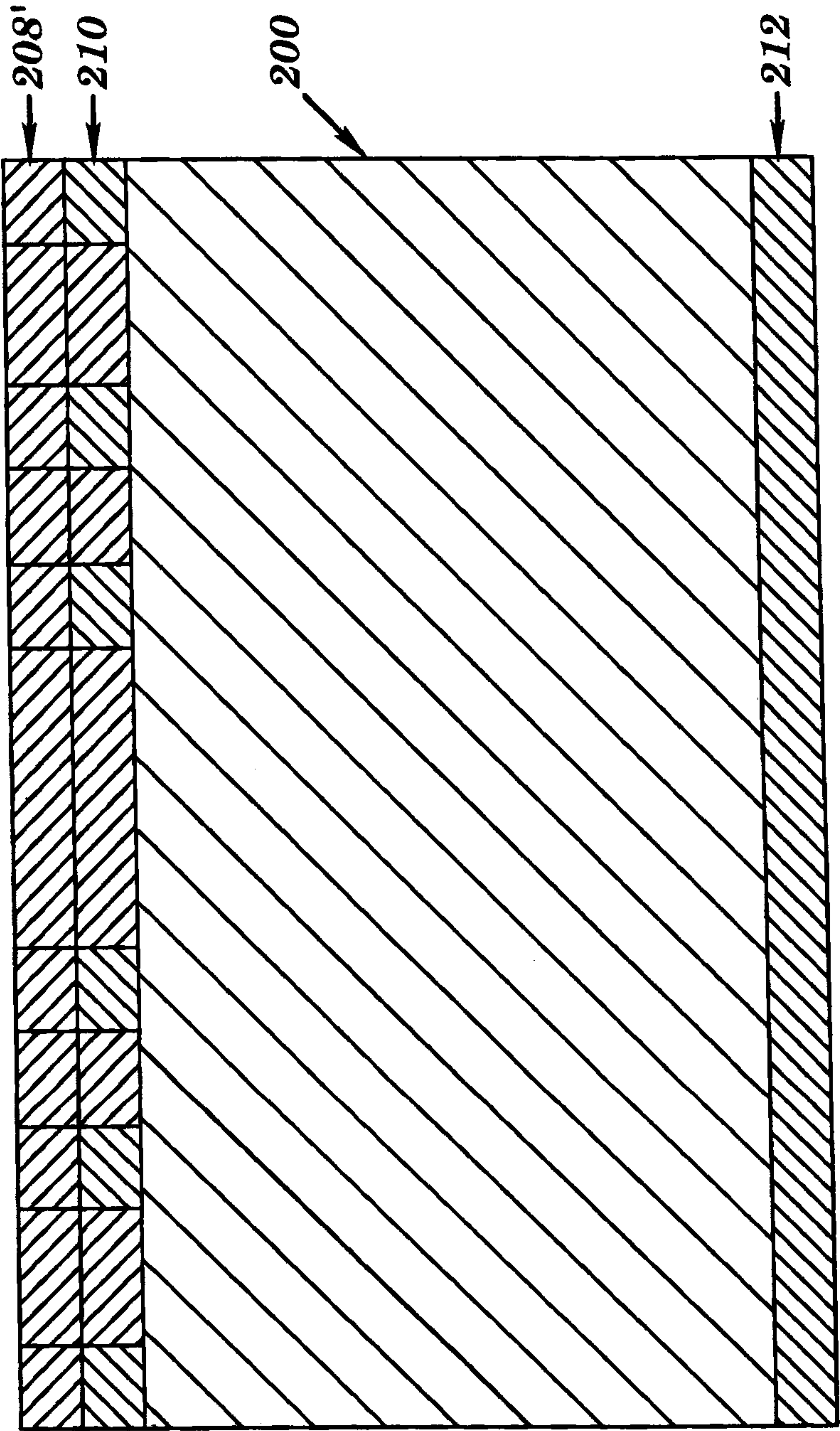


FIG. 15B

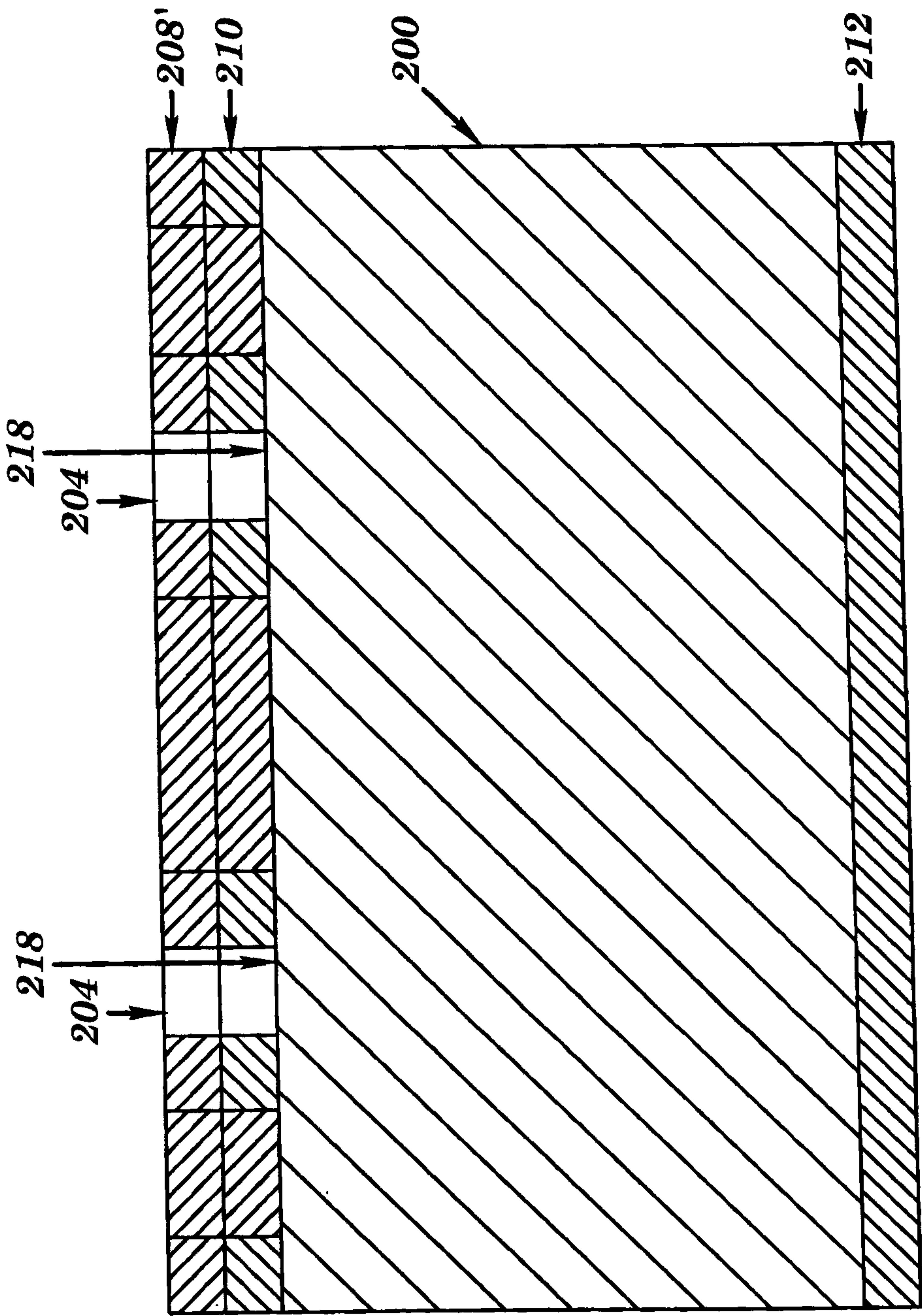


FIG. 15C

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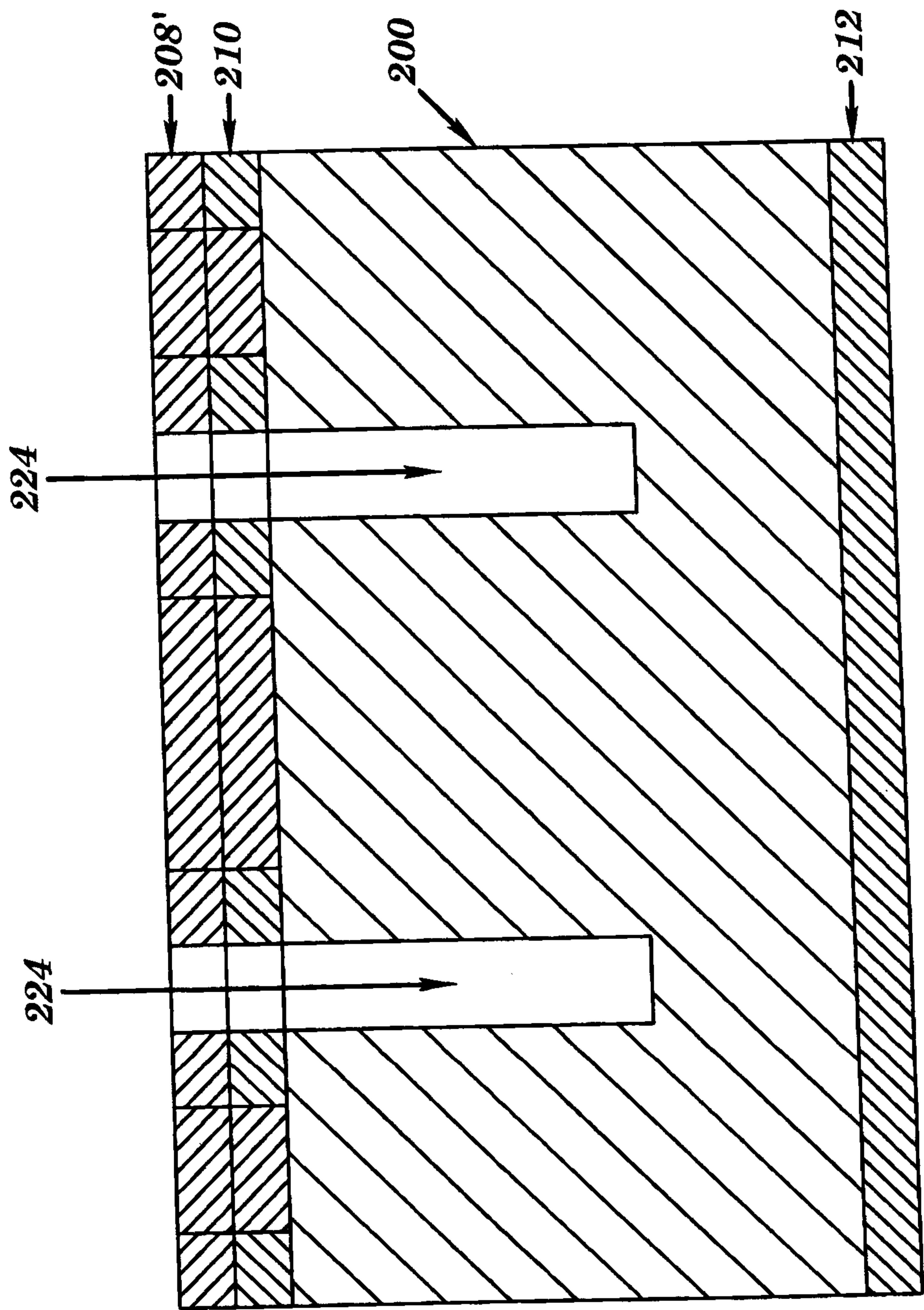


FIG. 15D

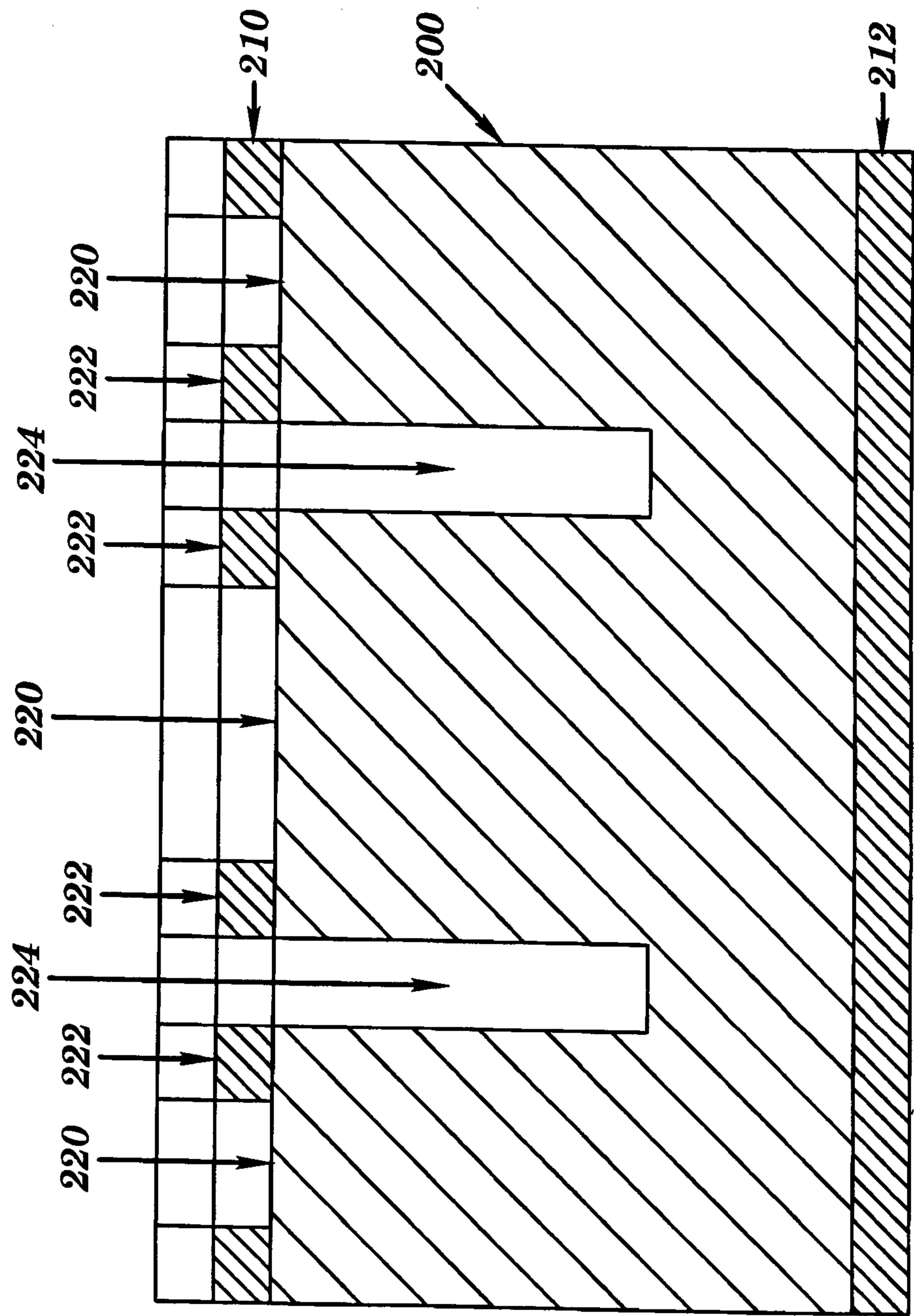


FIG. 15E

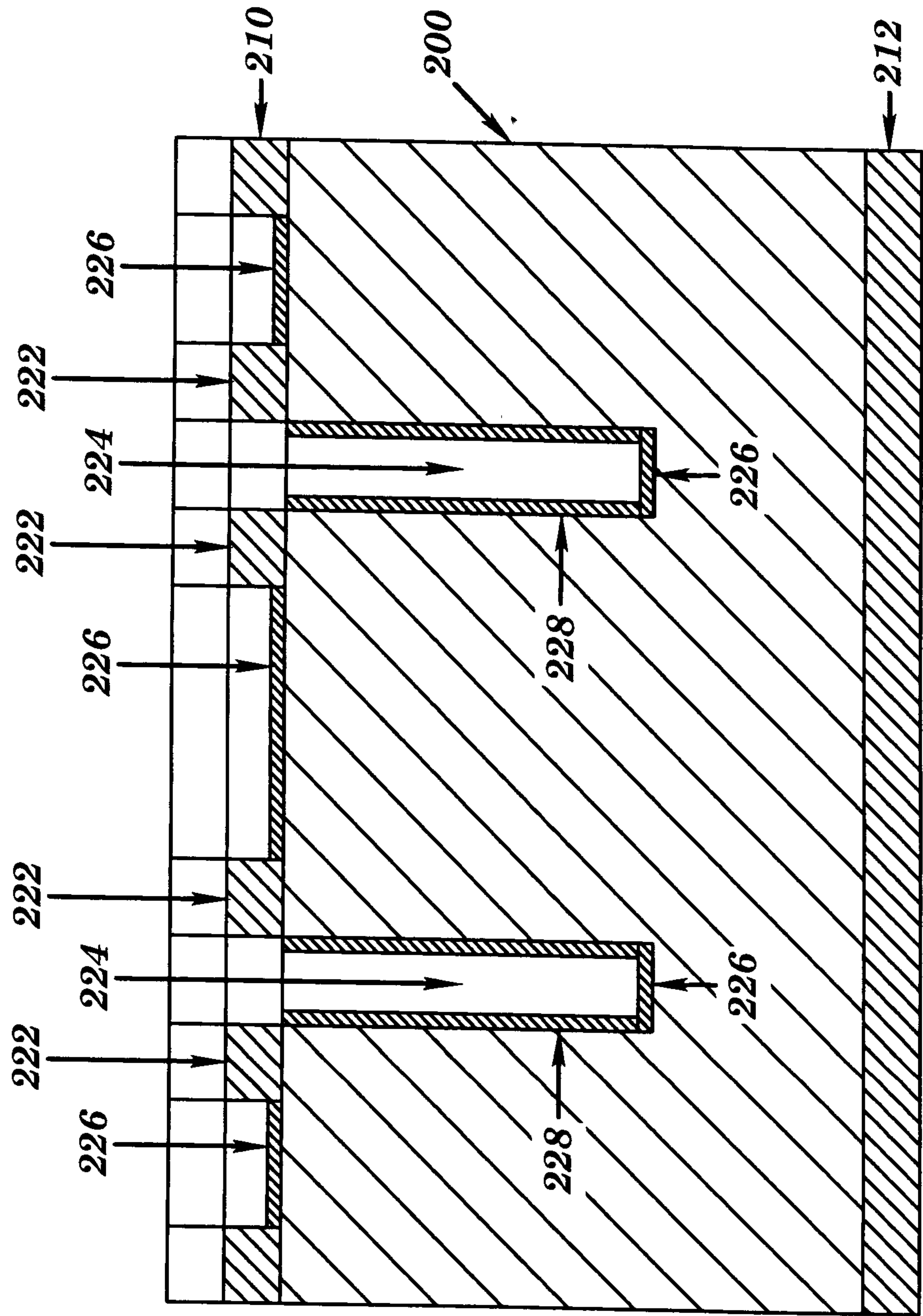


FIG. 15F

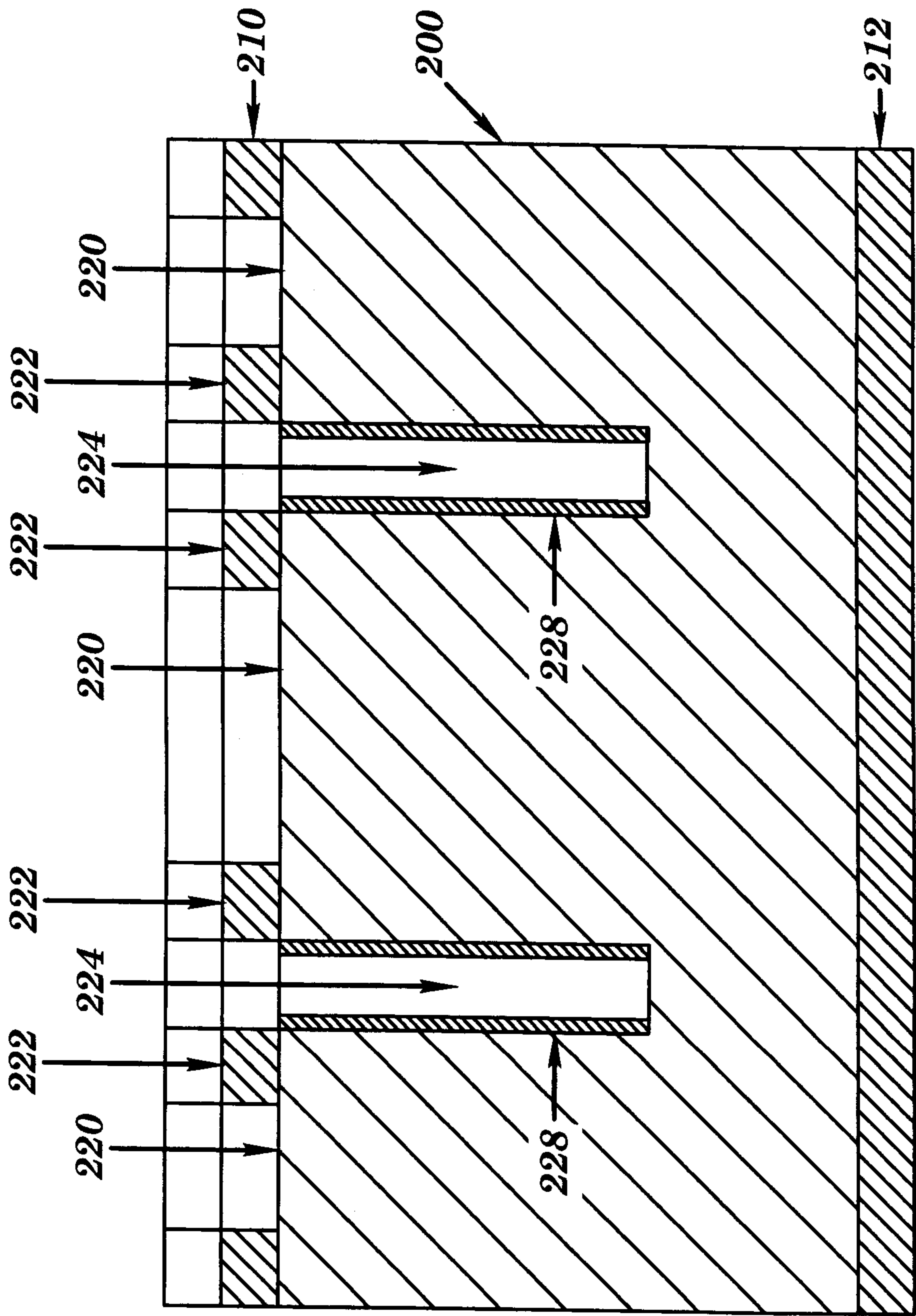


FIG. 15G

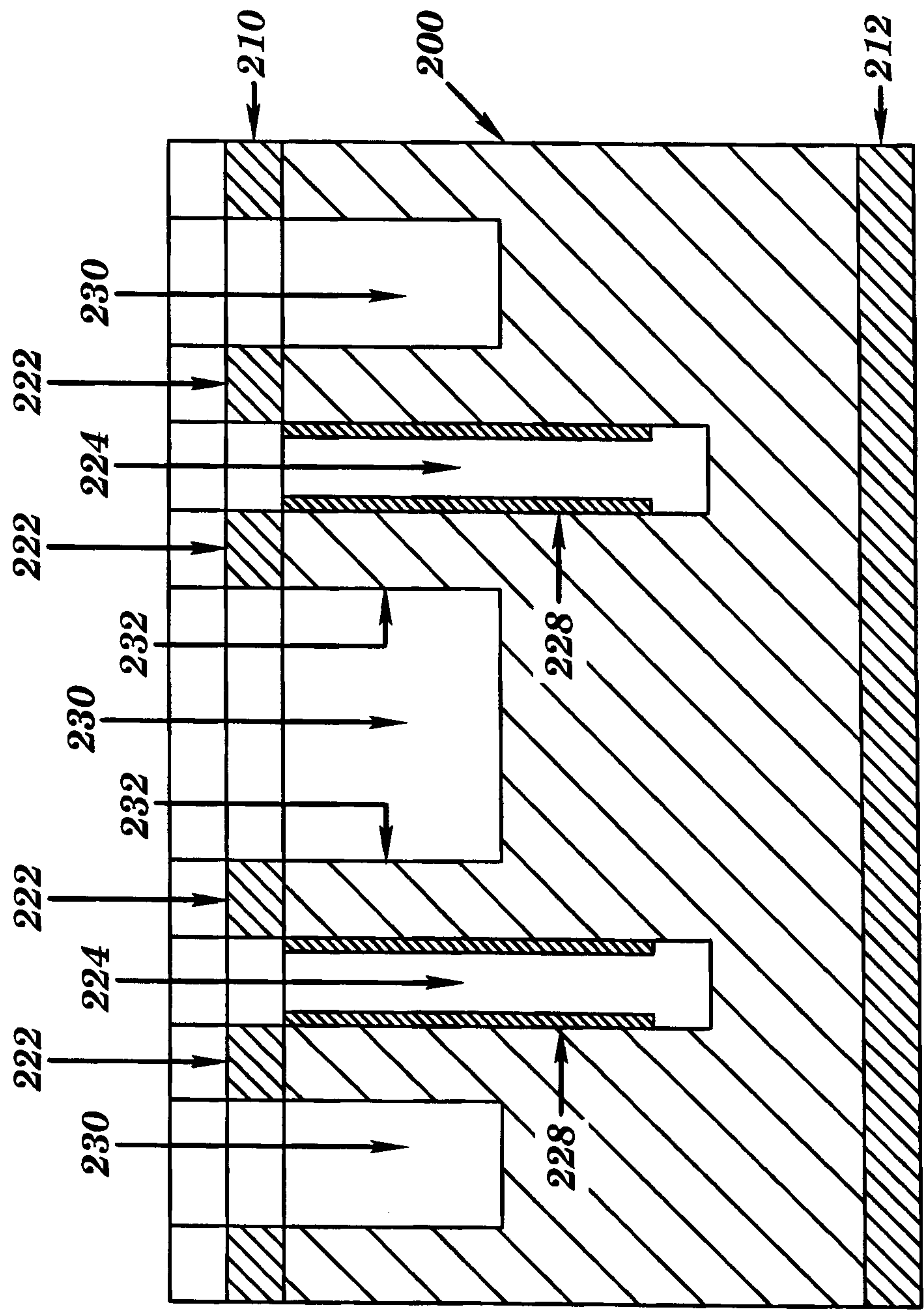


FIG. 15H

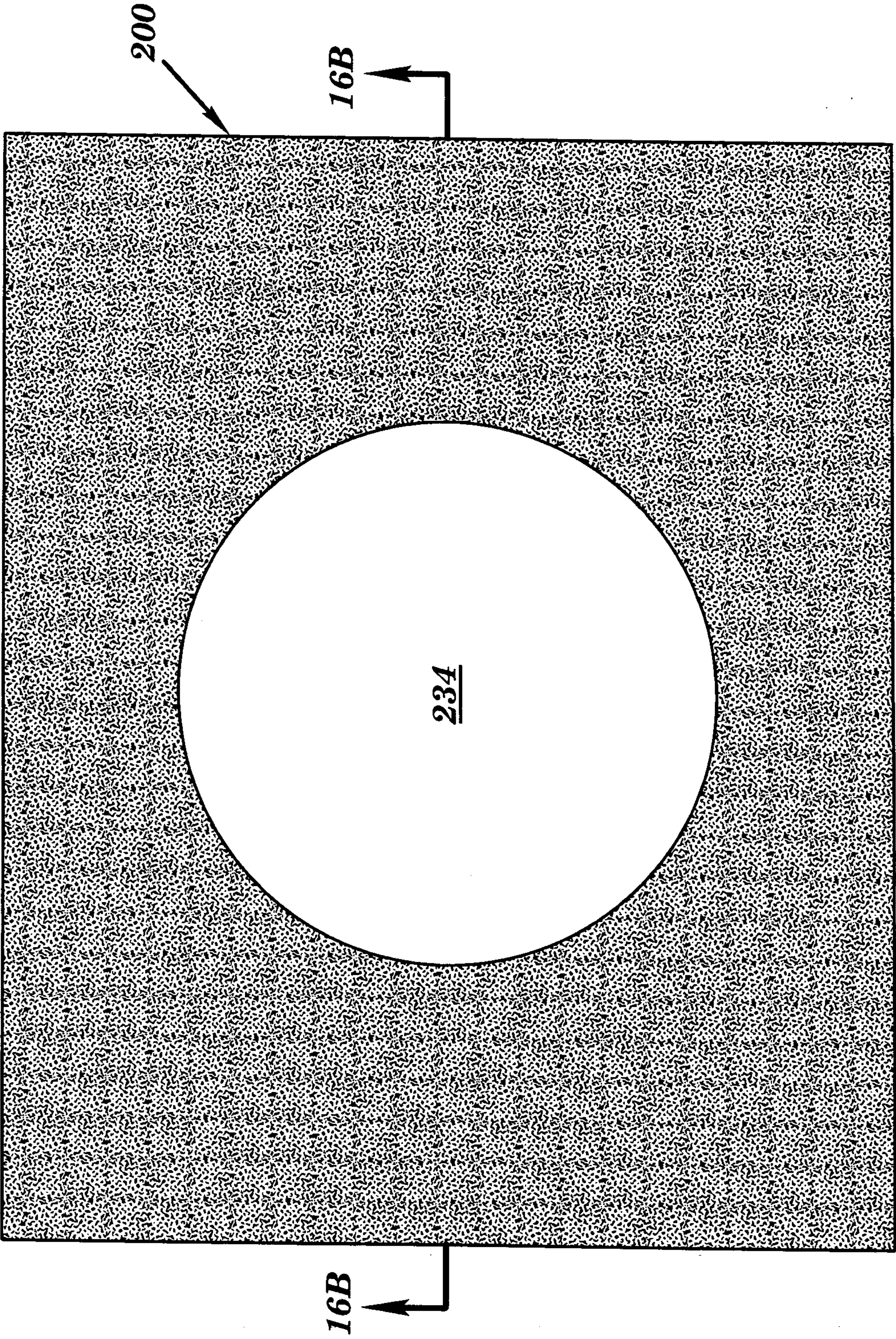


FIG. 16A

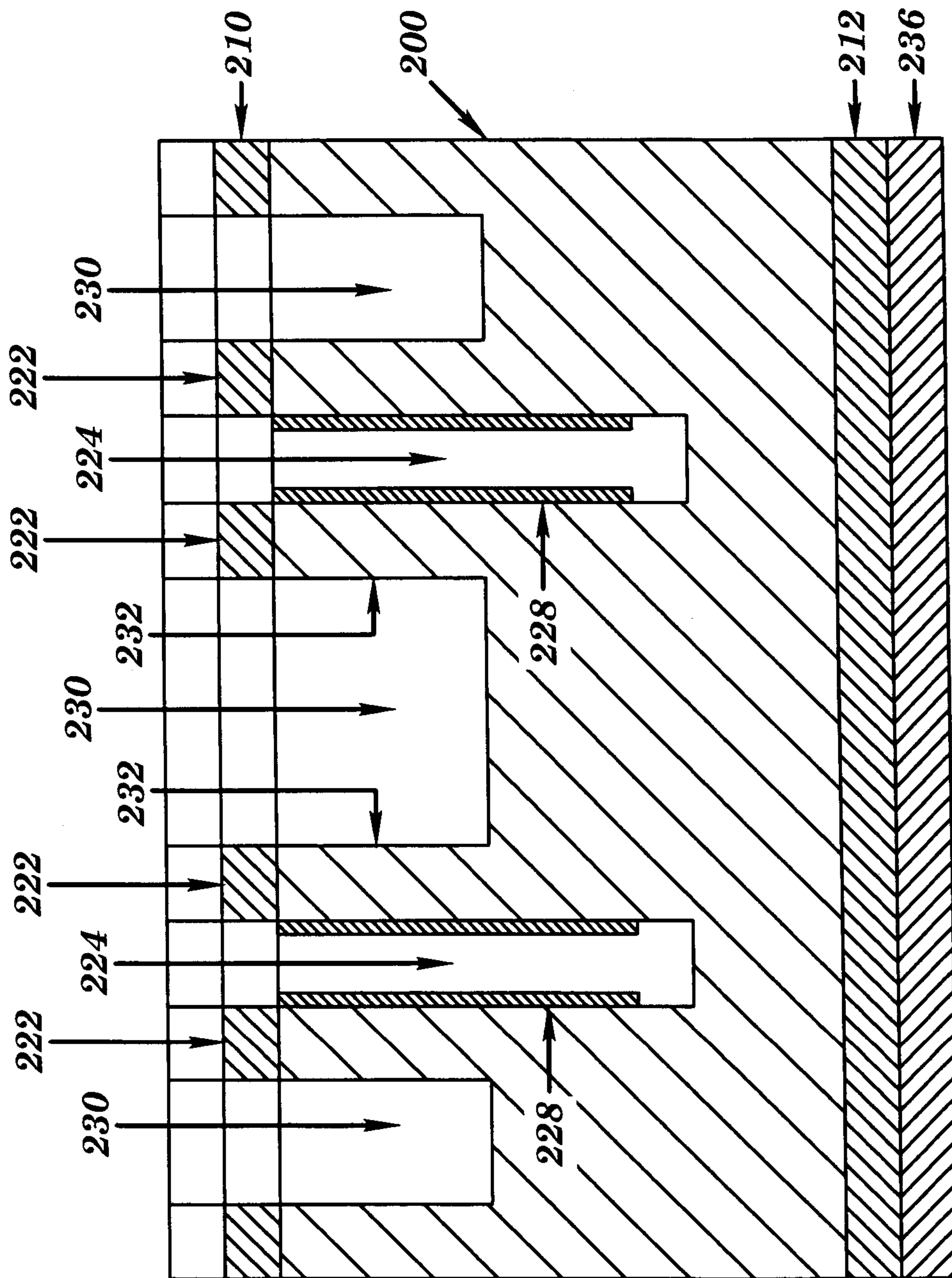


FIG. 16B

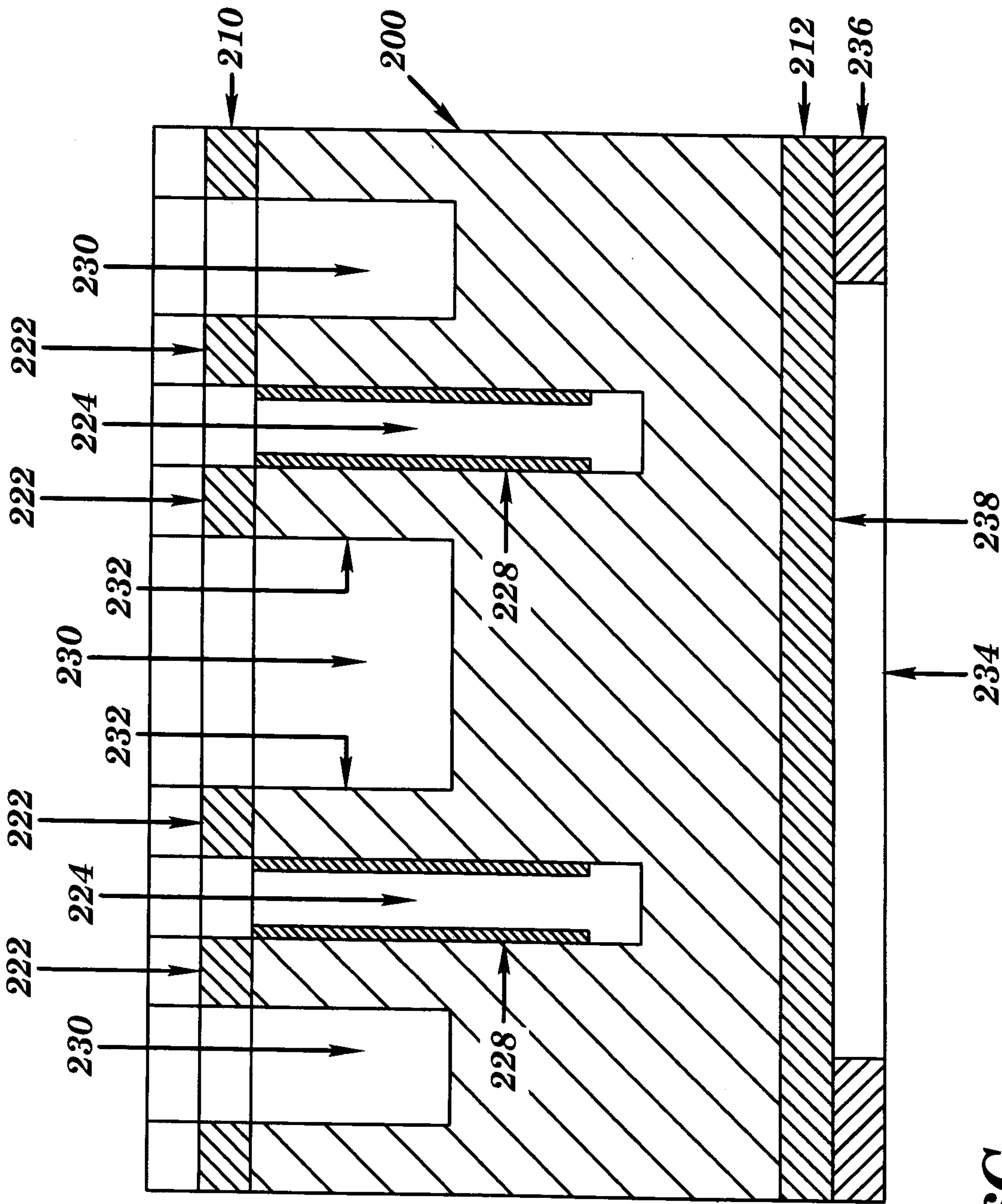


FIG. 16C

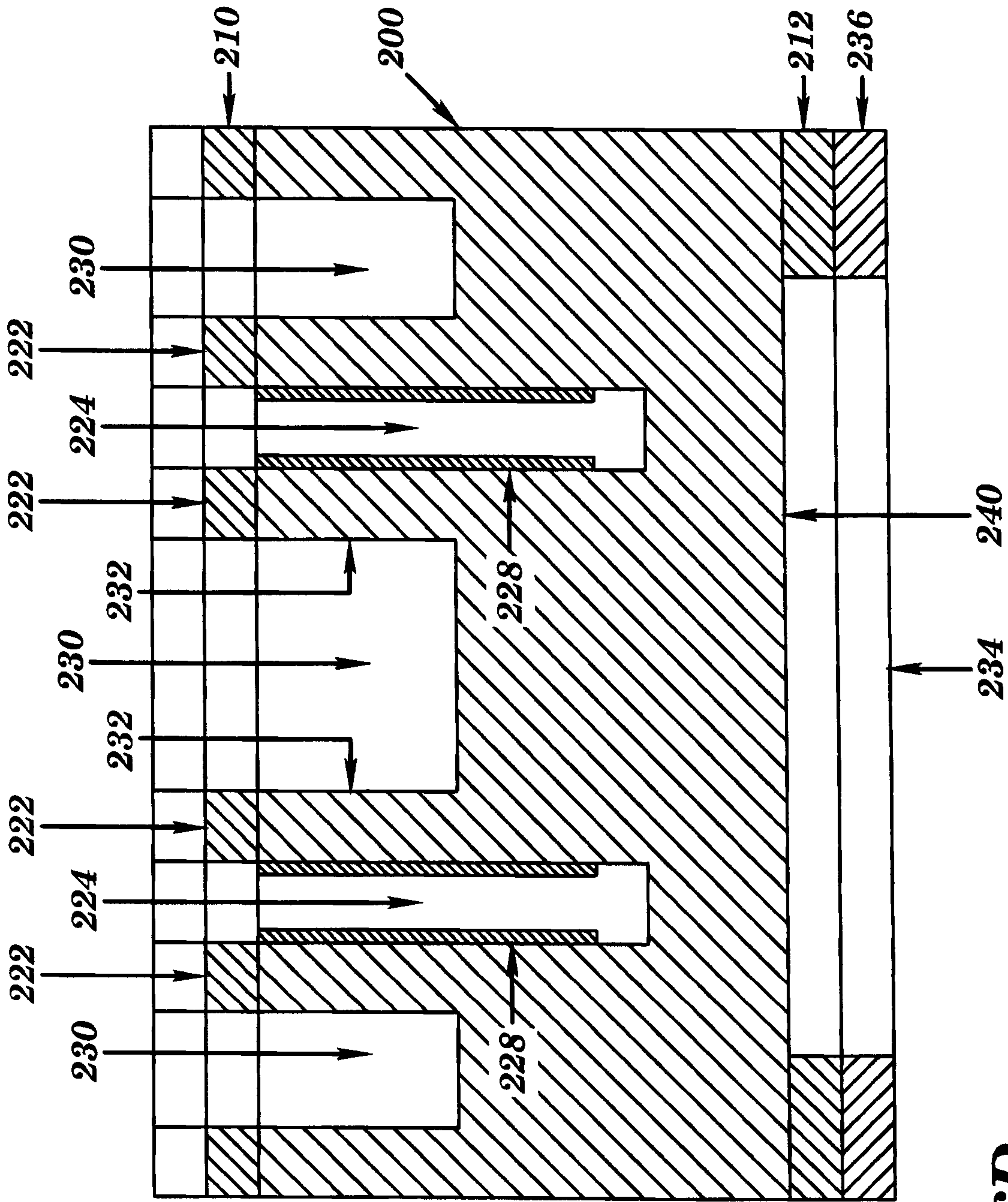


FIG. 16D

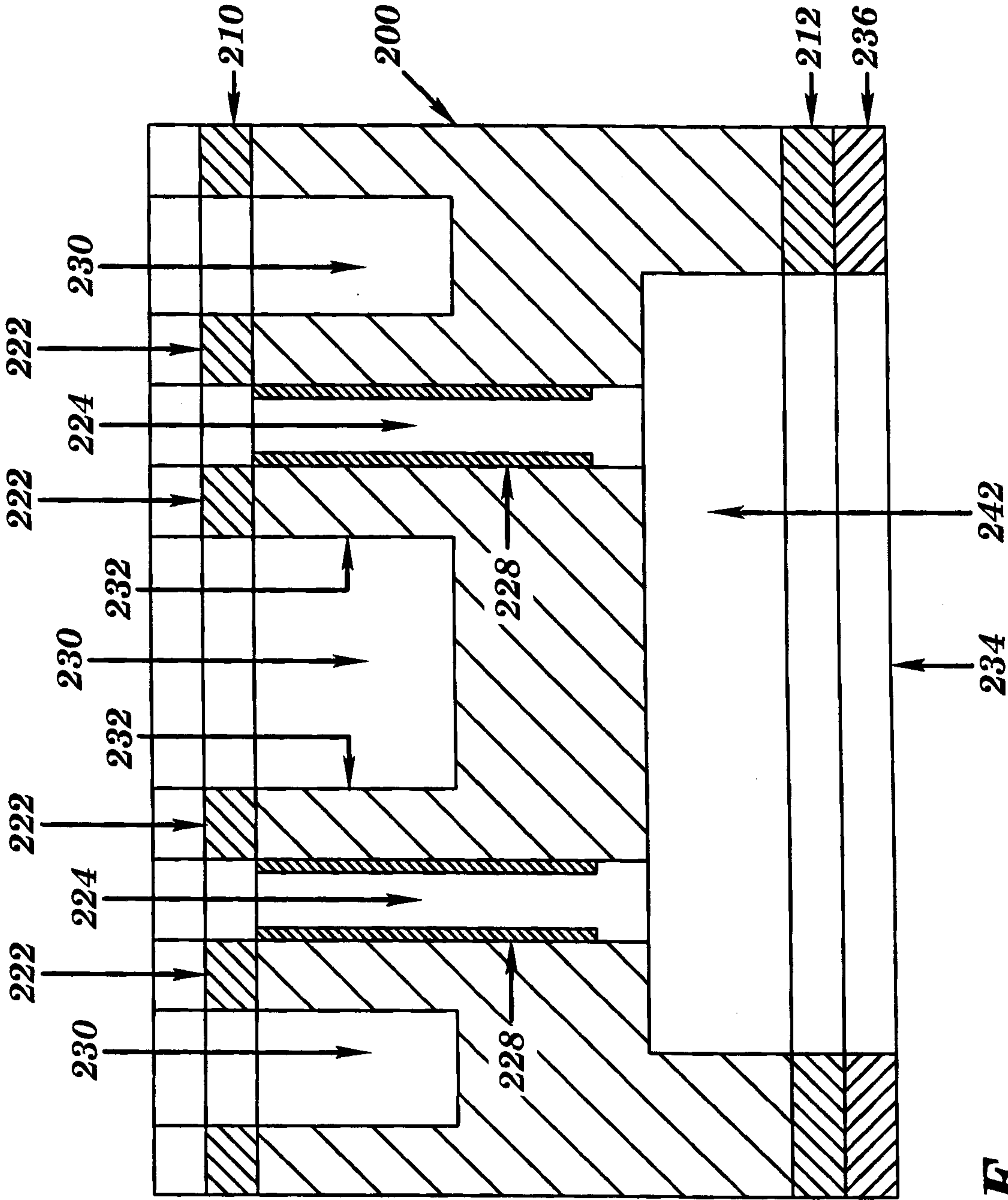


FIG. 16E

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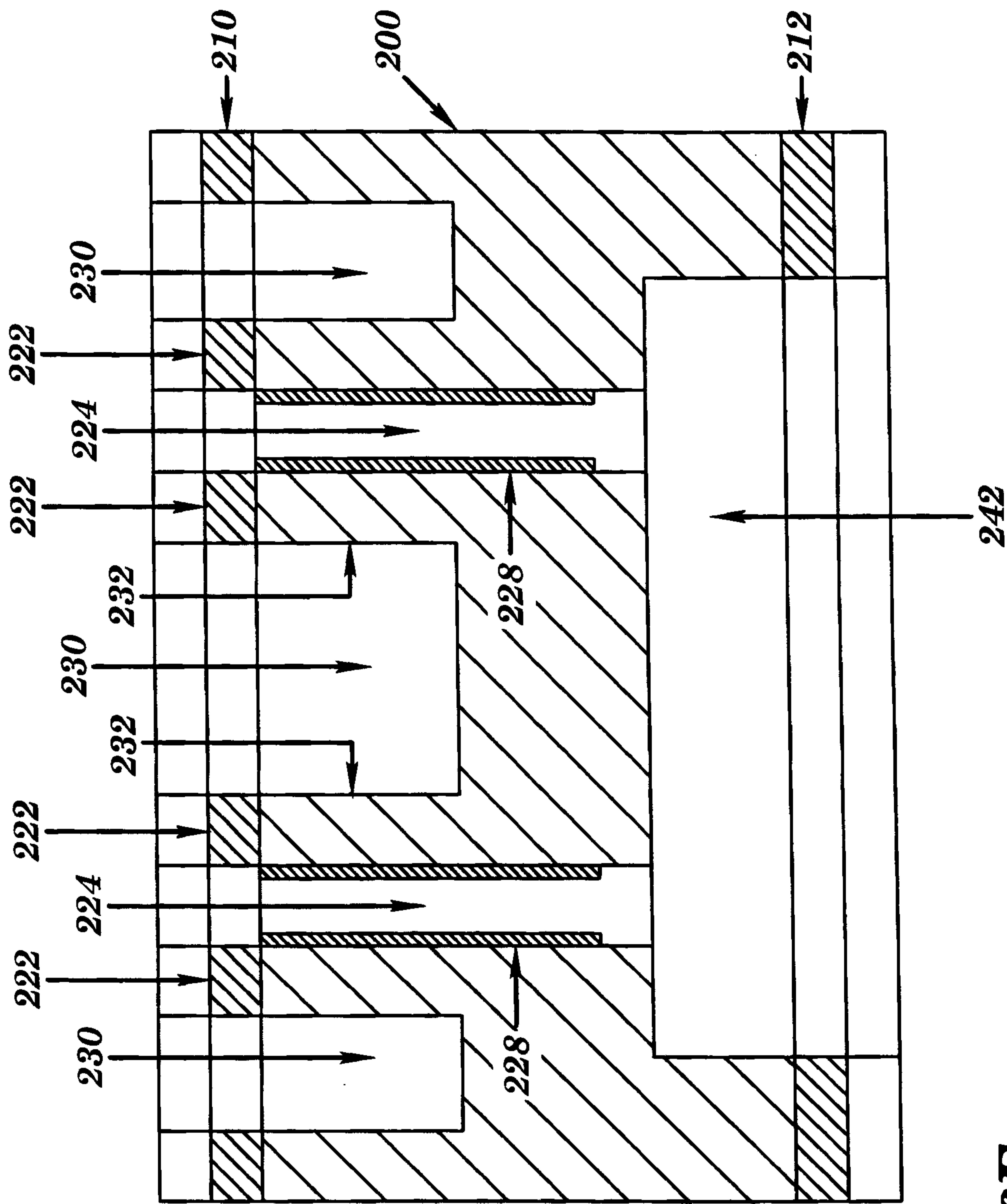


FIG. 16F

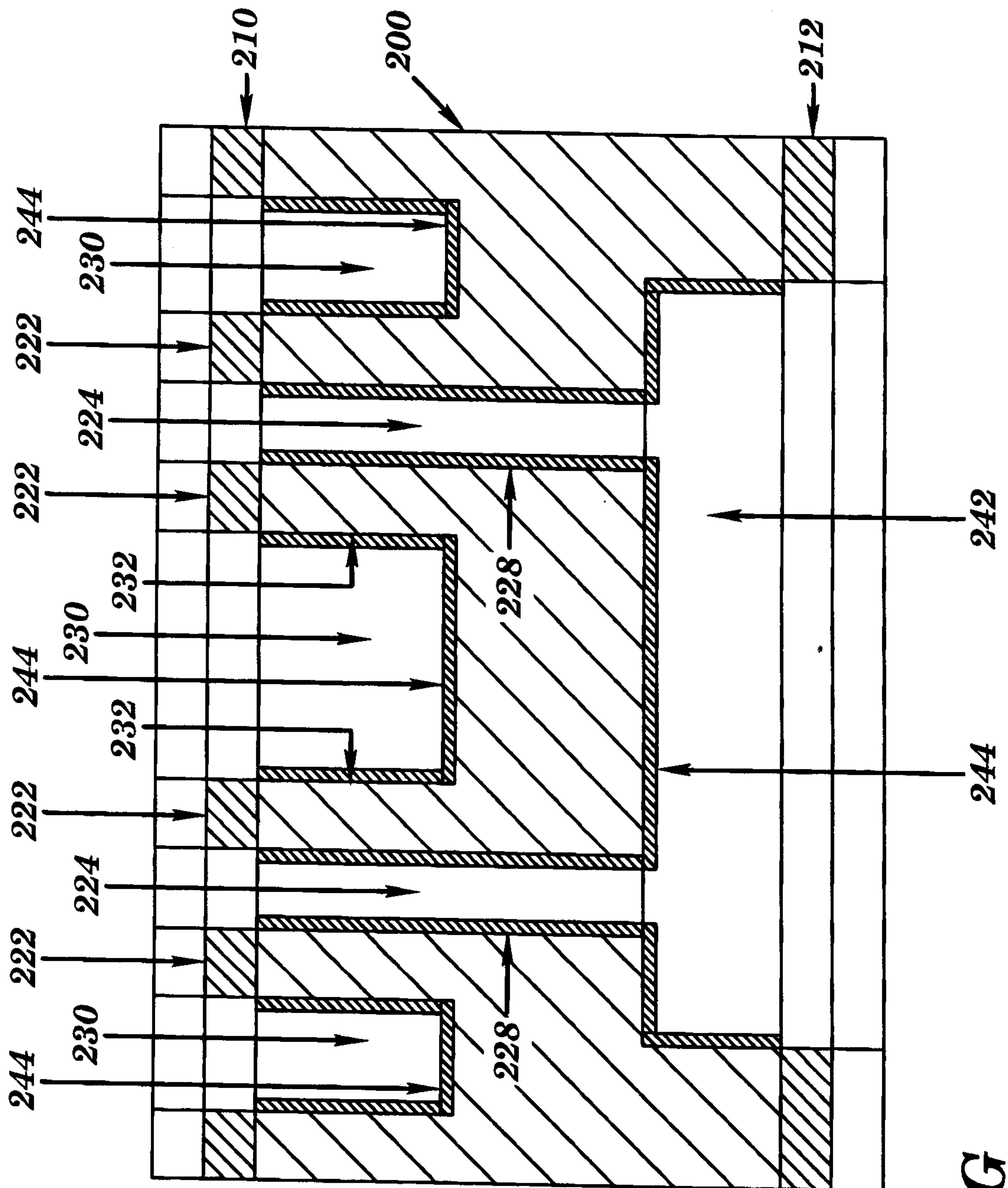


FIG. 16G.

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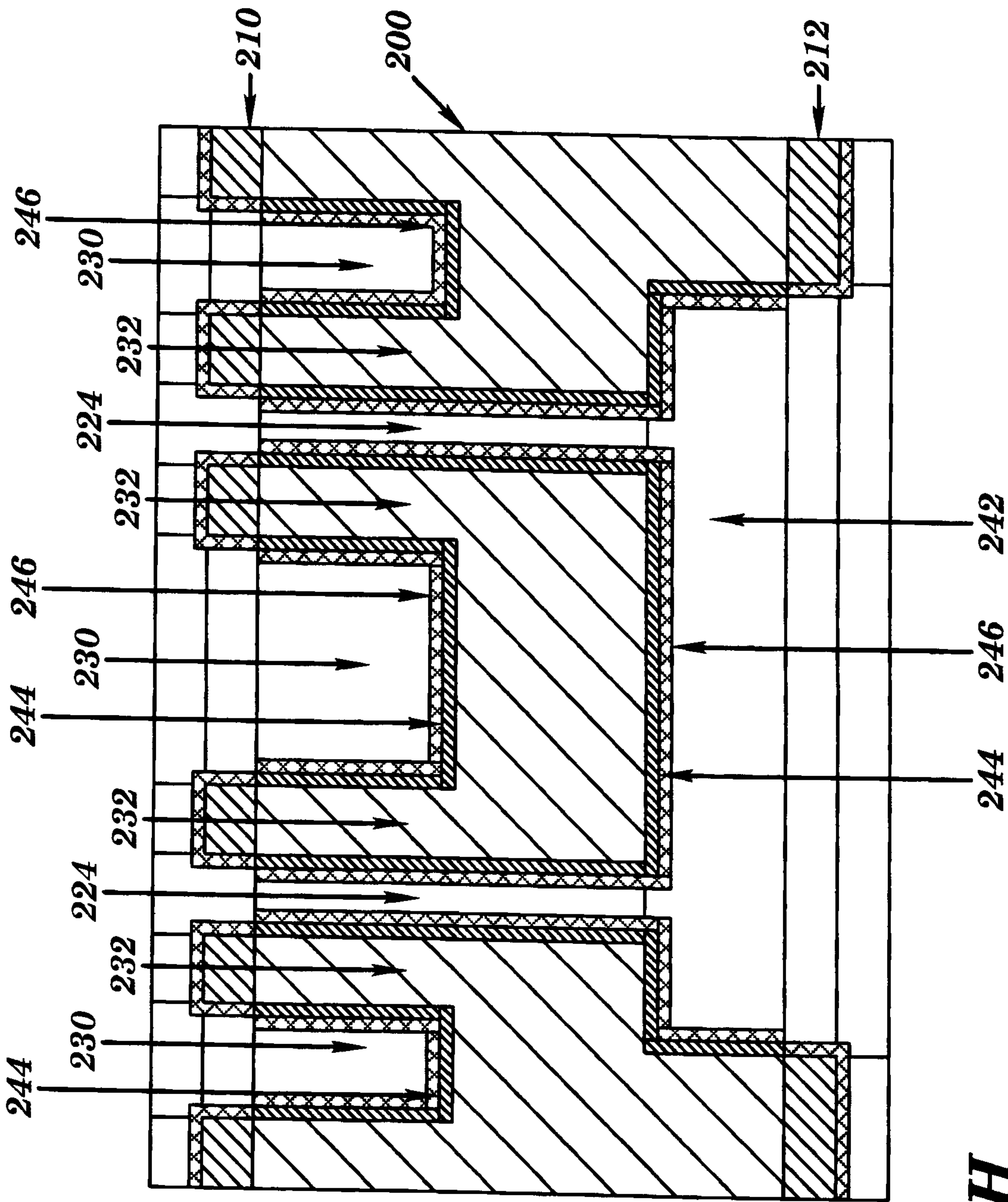
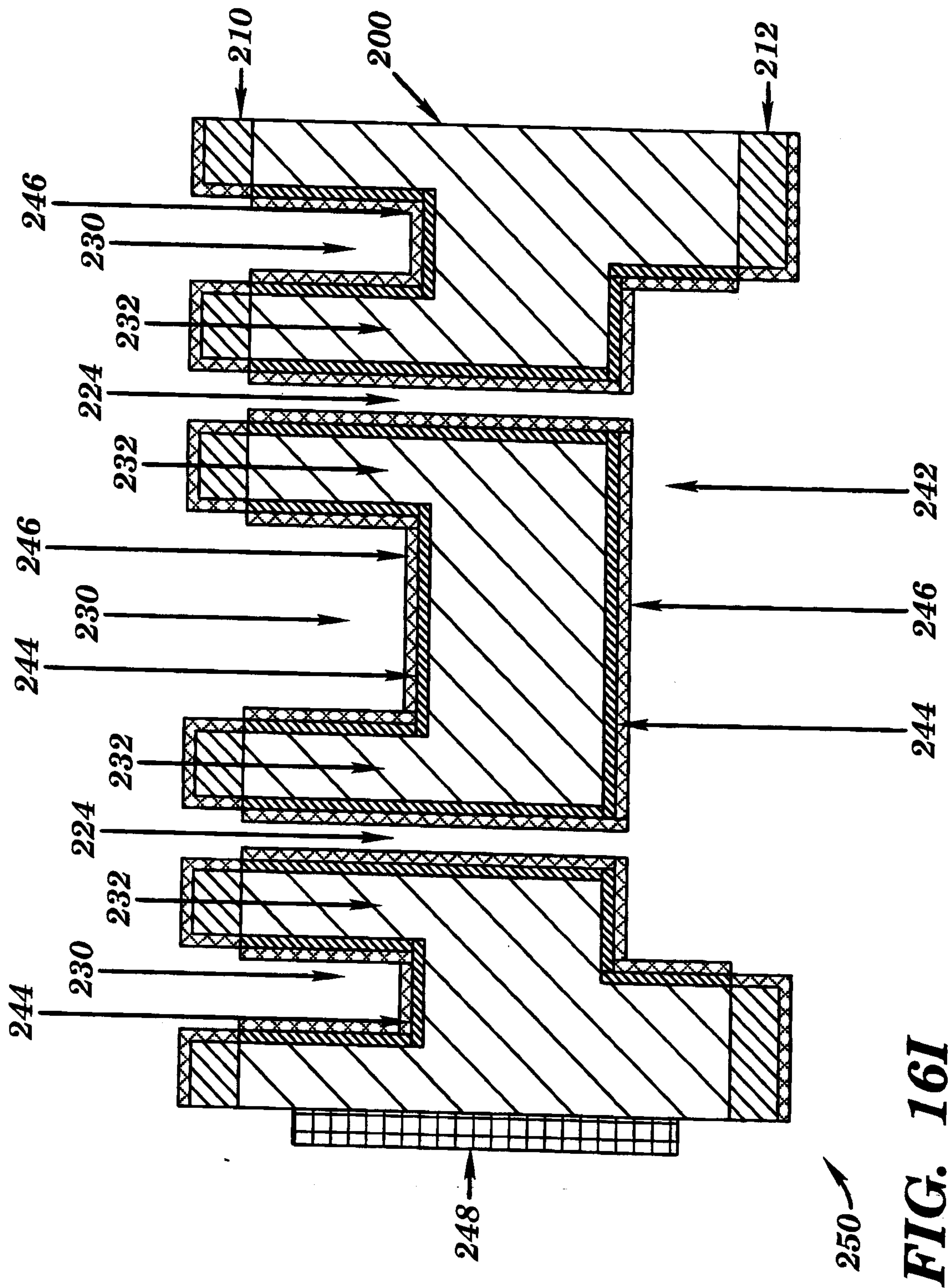


FIG. 16H



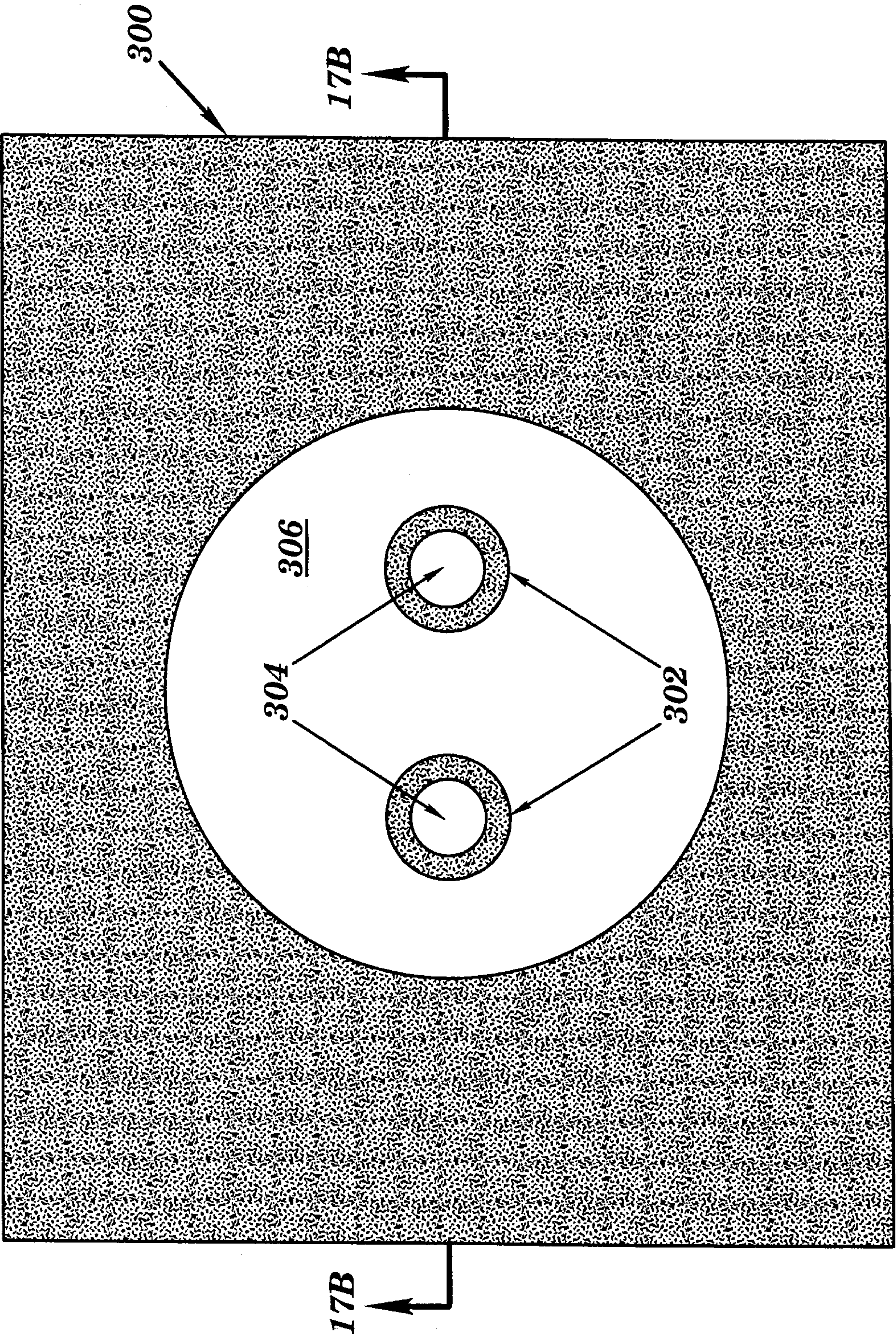


FIG. 17A

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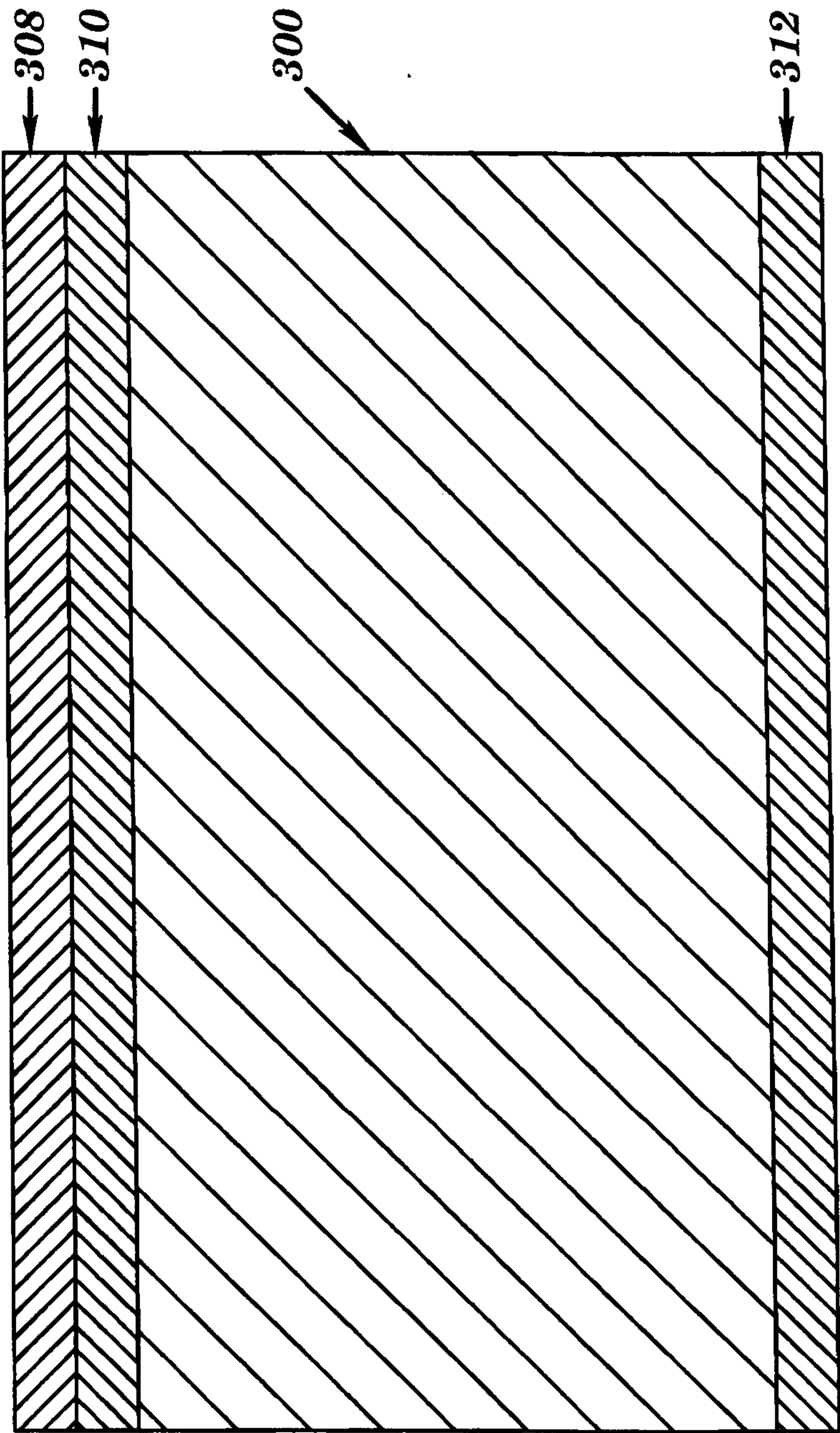


FIG. 17B

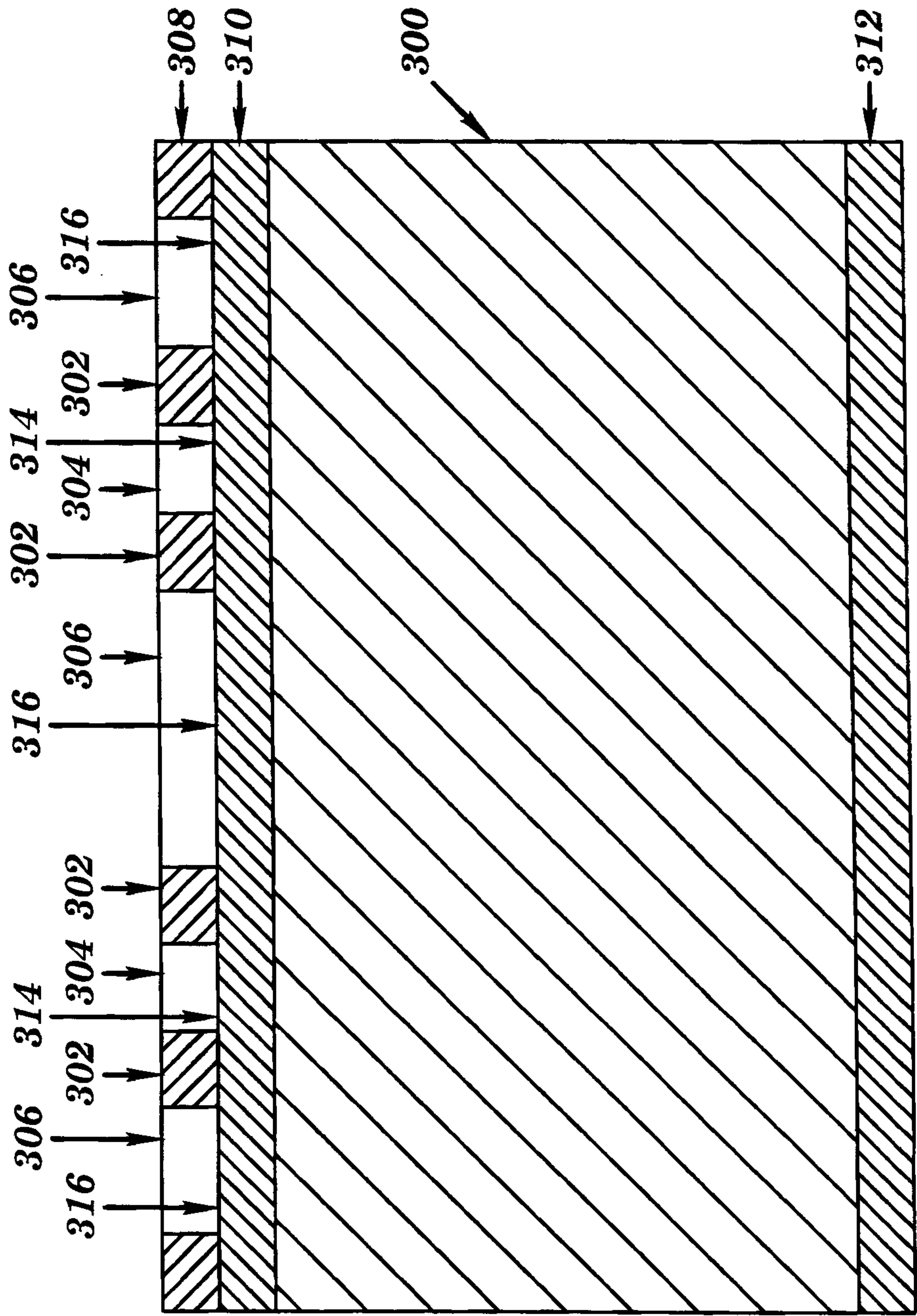


FIG. 17C

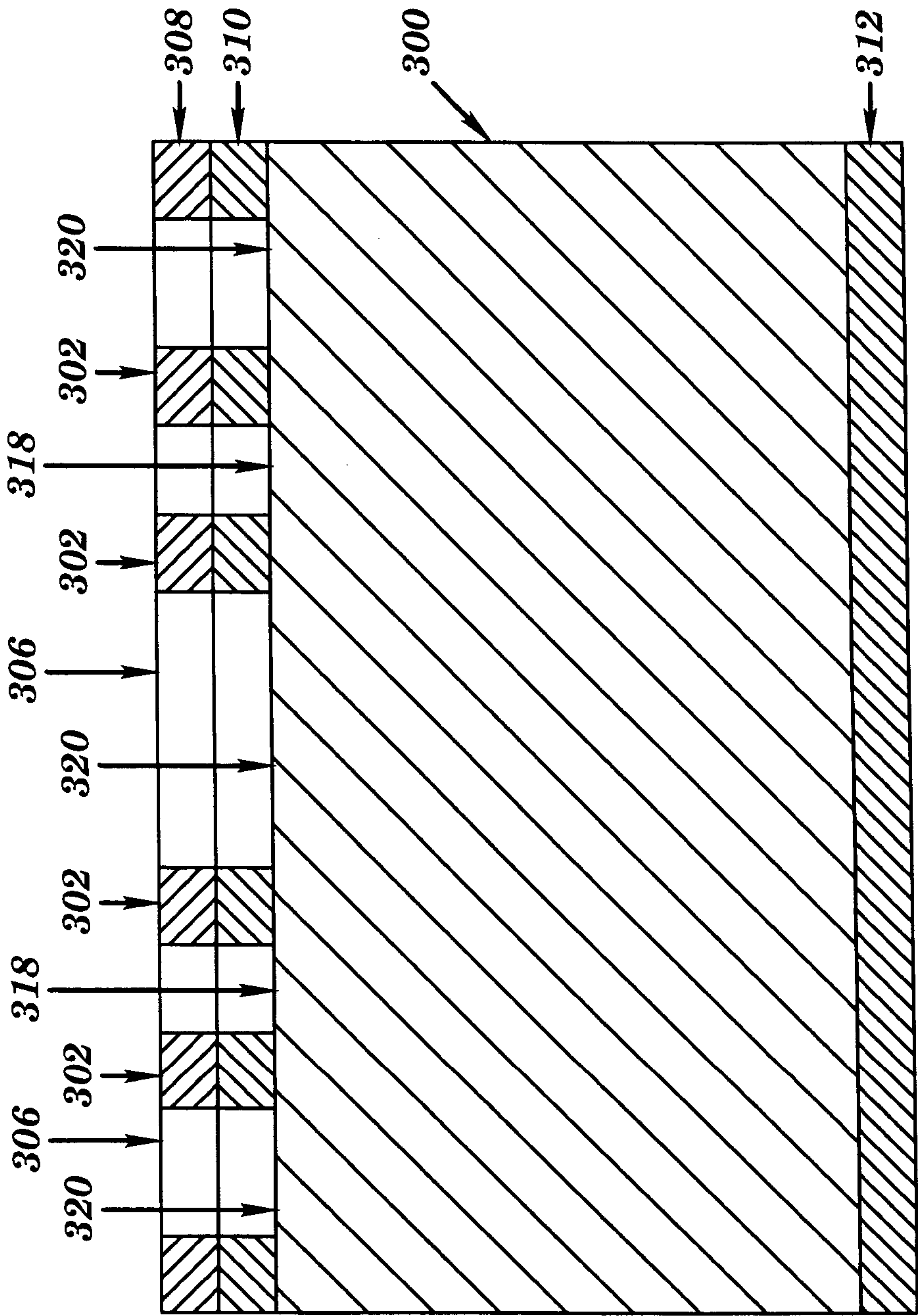


FIG. 17D

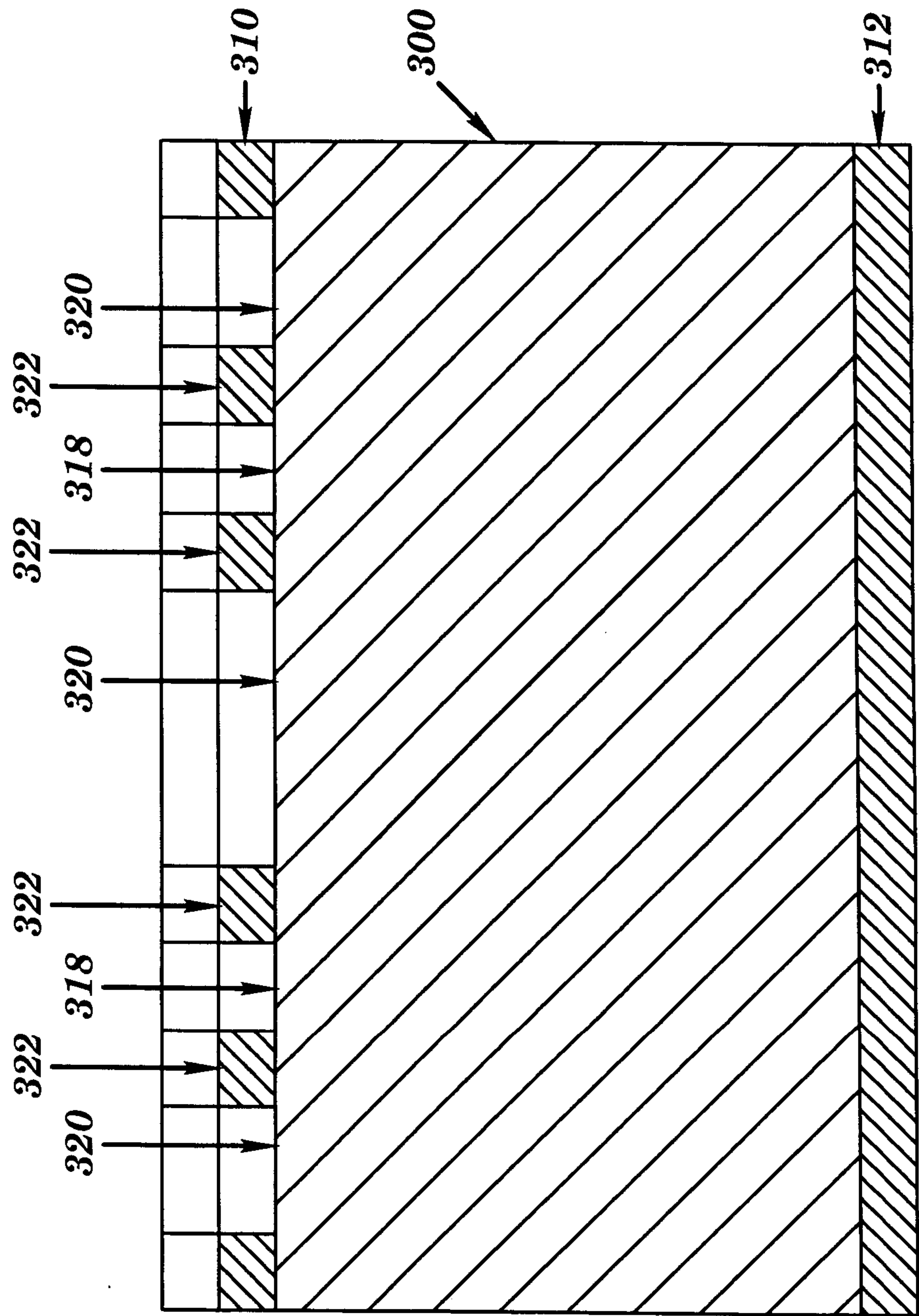


FIG. 17E

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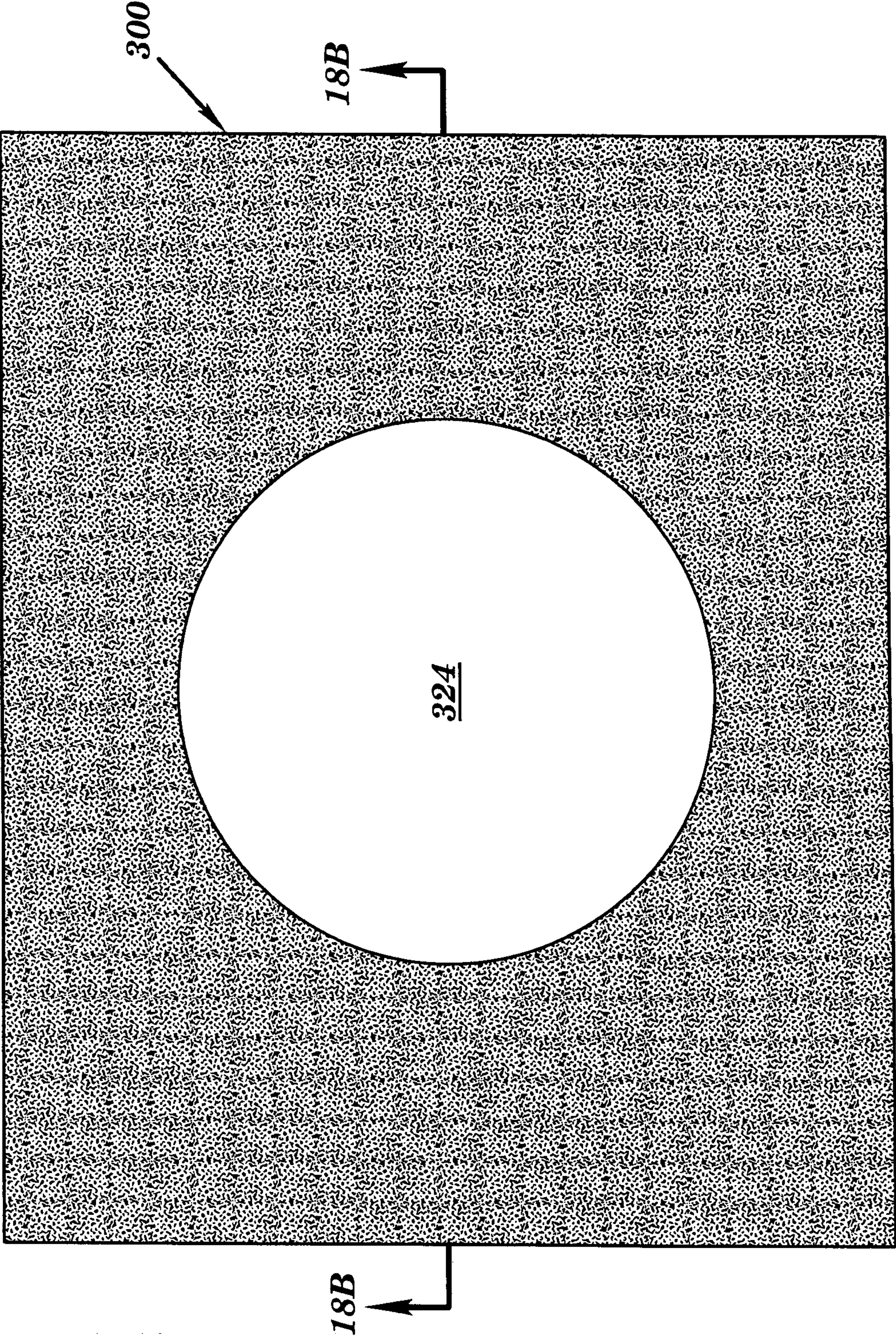


FIG. 18A

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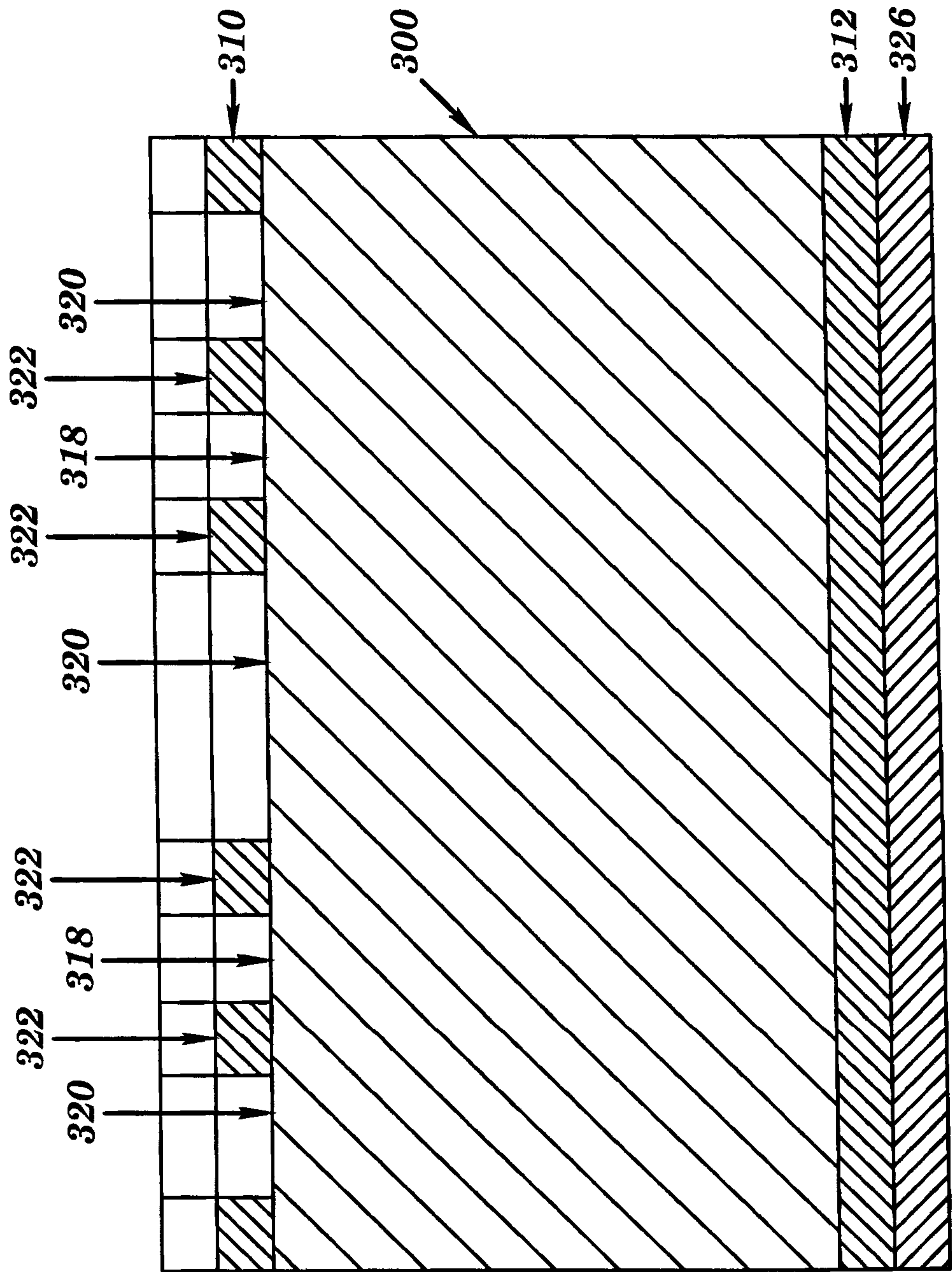


FIG. 18B

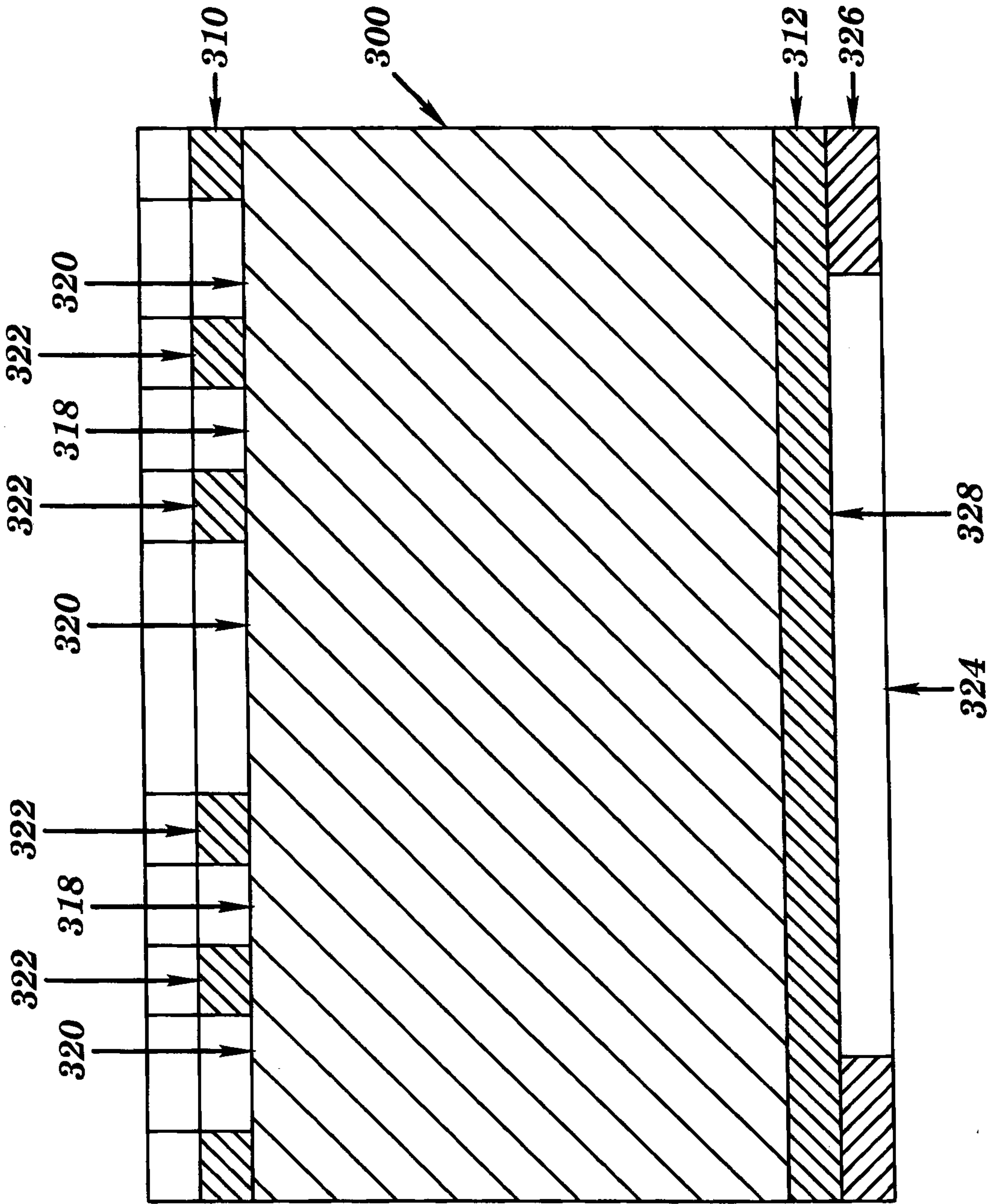


FIG. 18C

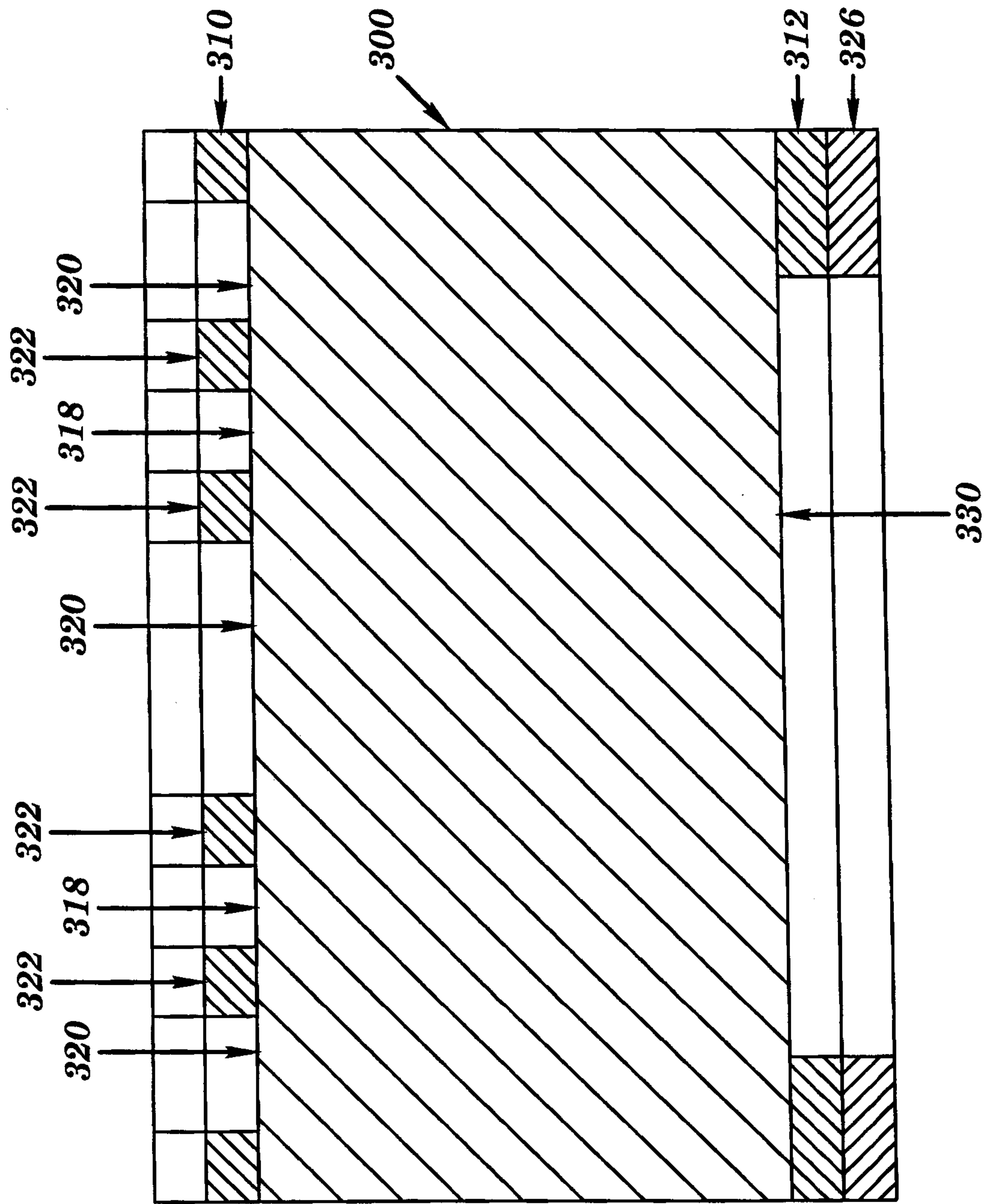


FIG. 18D

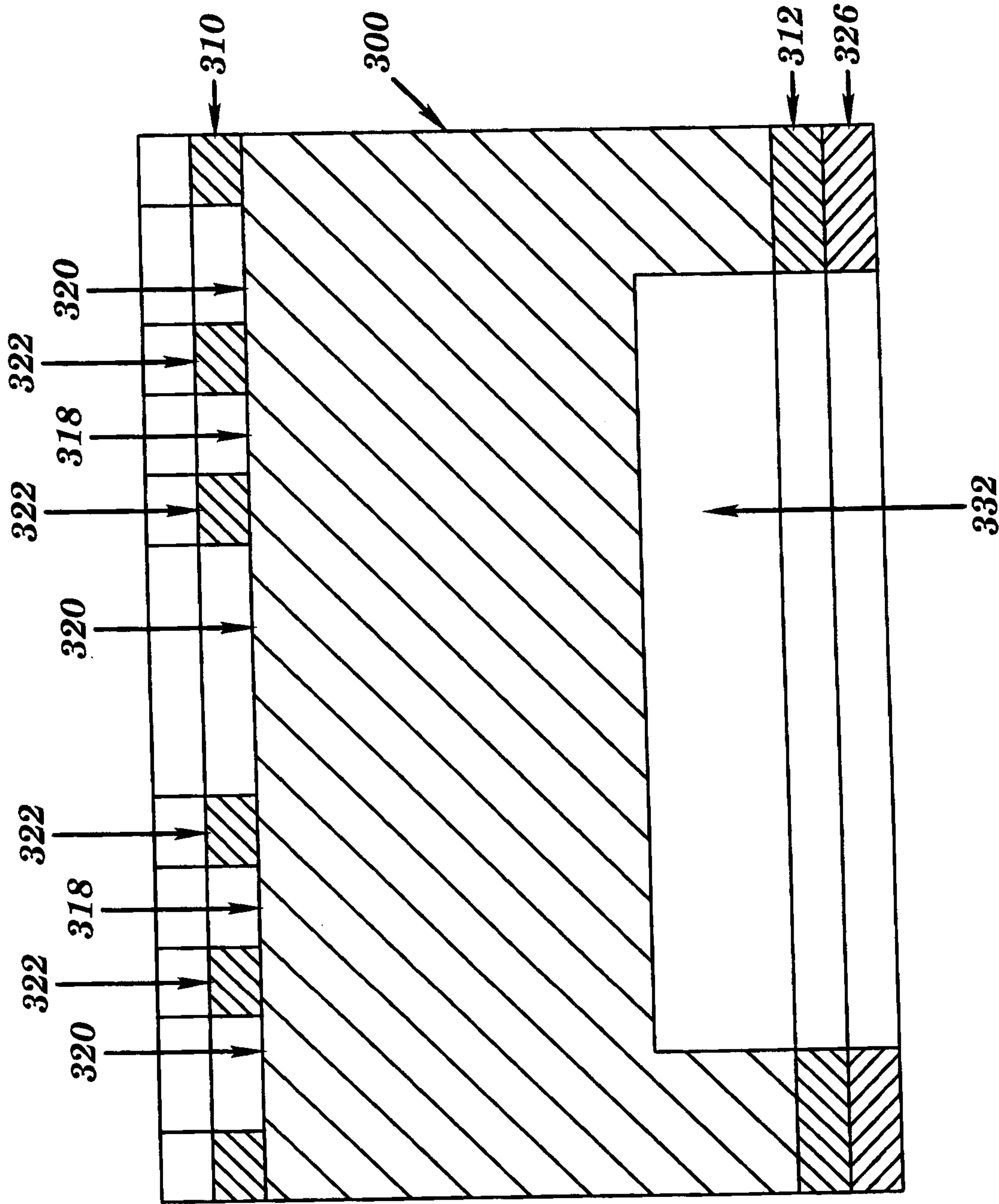


FIG. 18E

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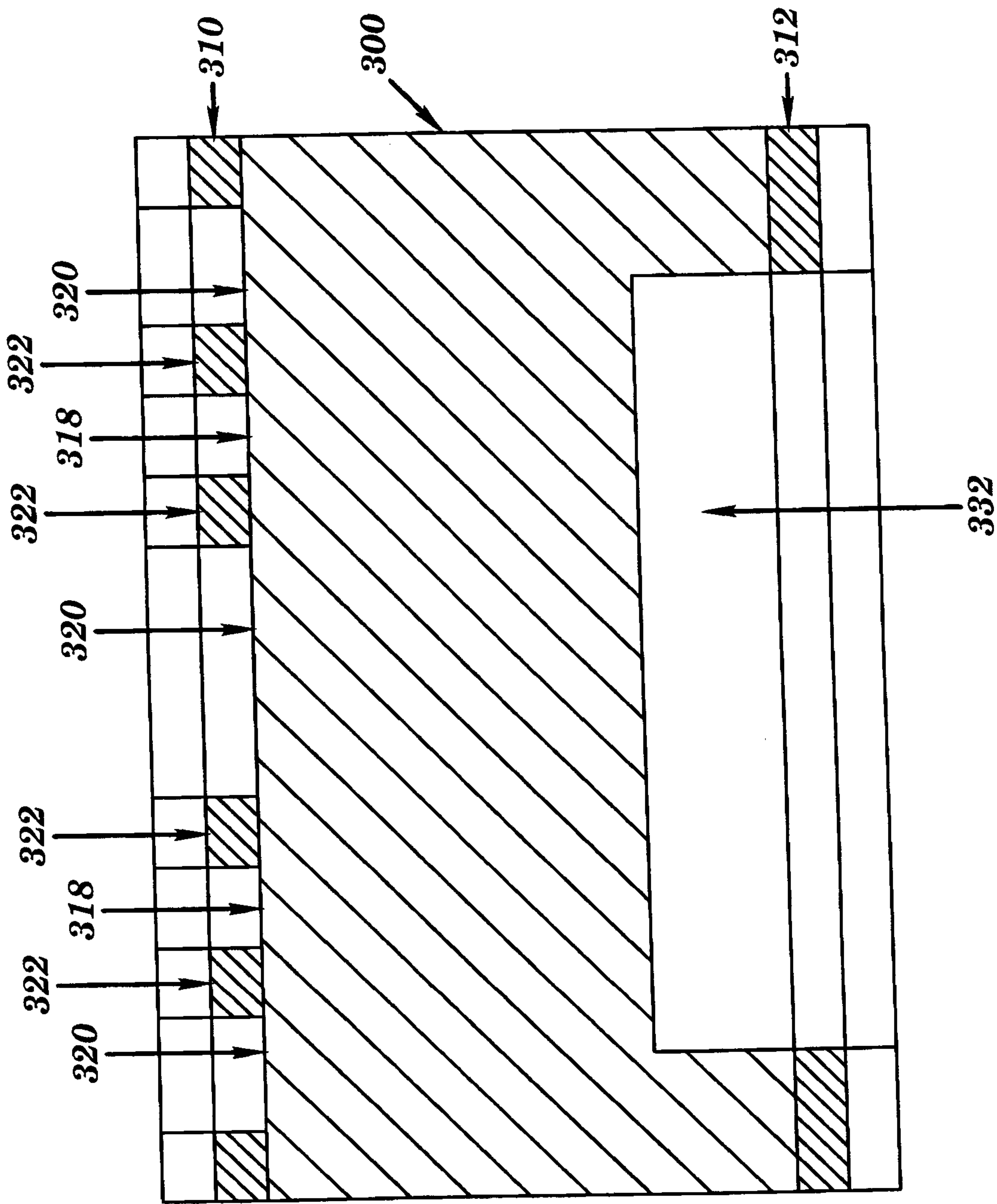


FIG. 18F

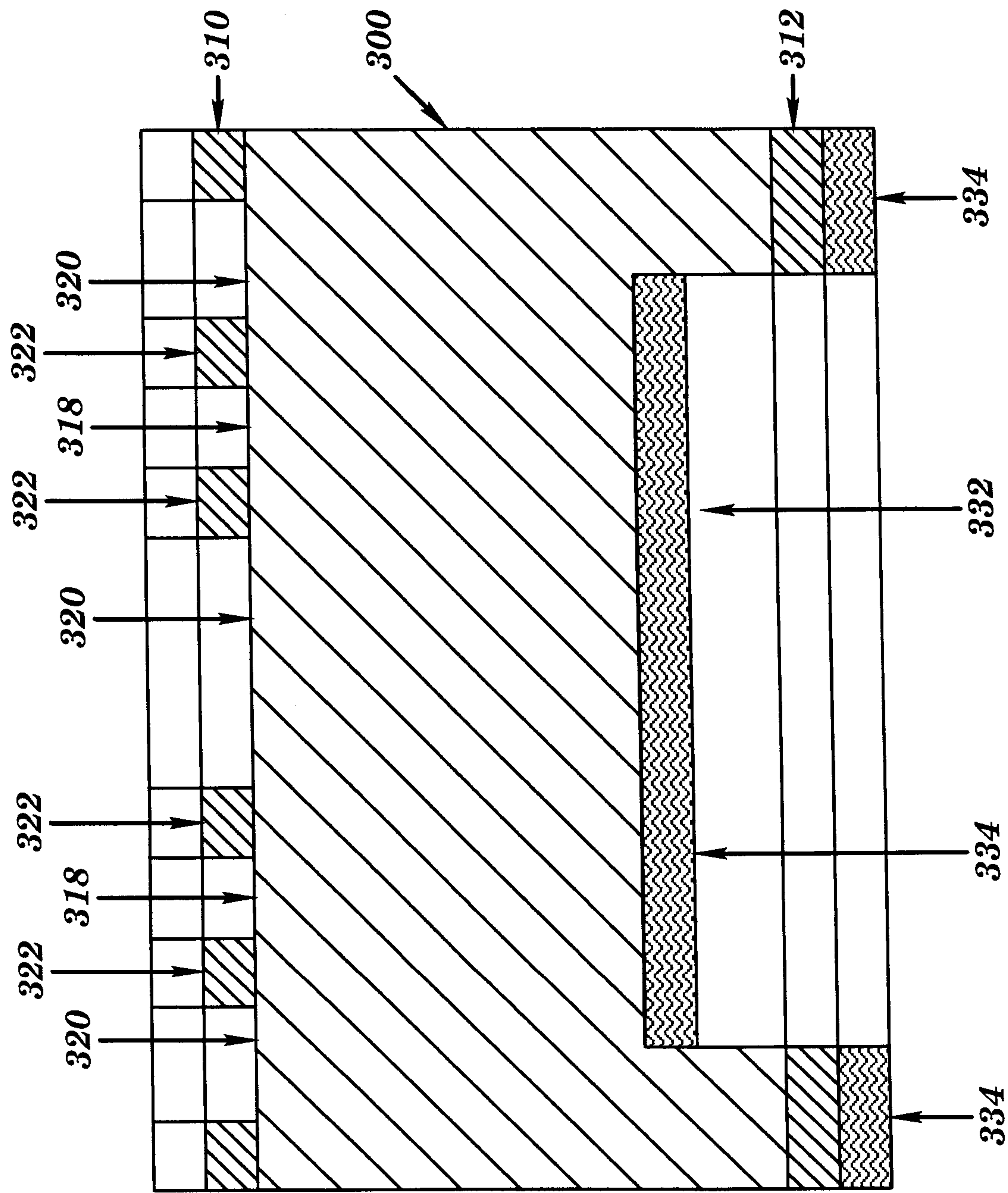


FIG. 18G

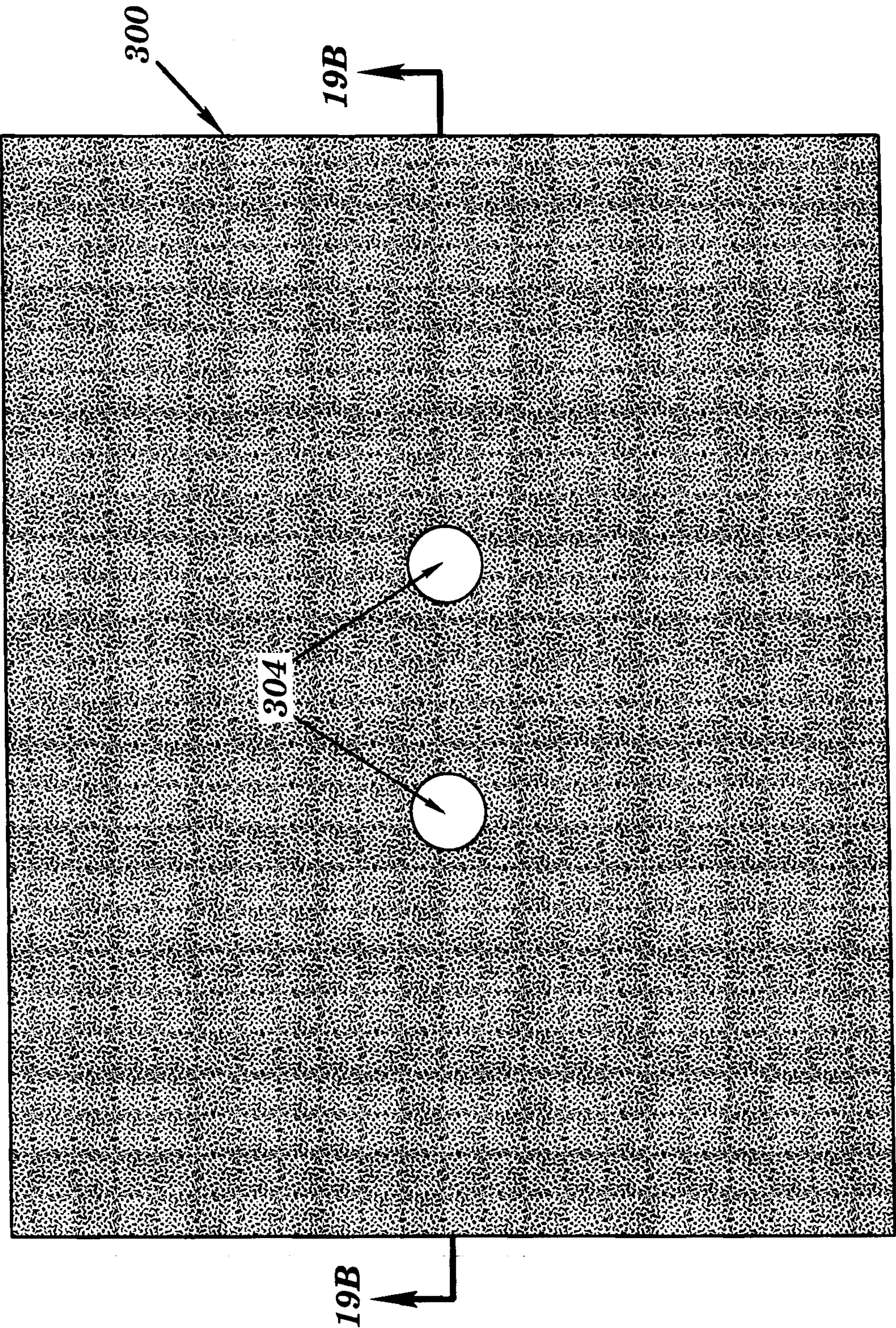


FIG. 19A

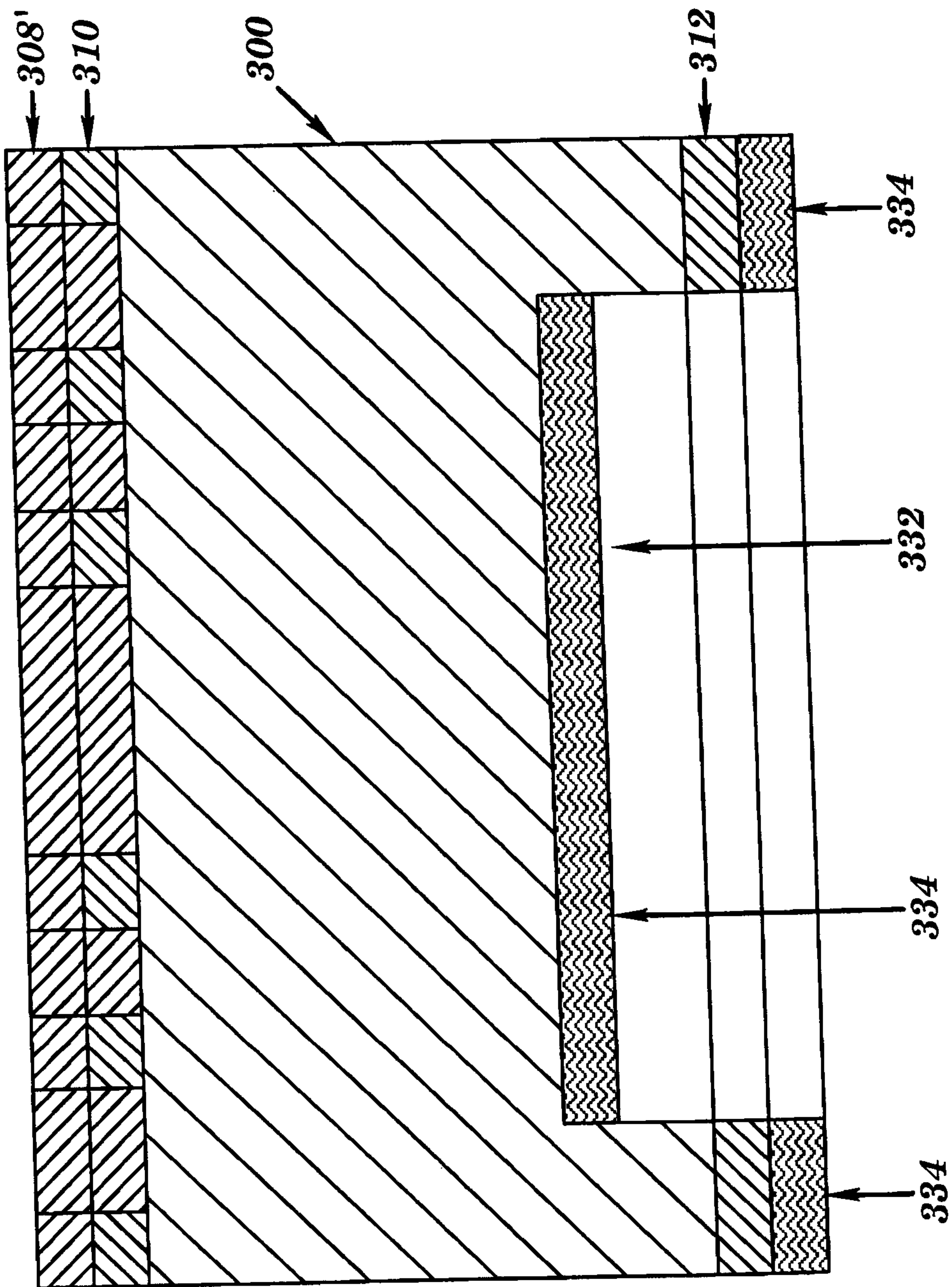


FIG. 19B

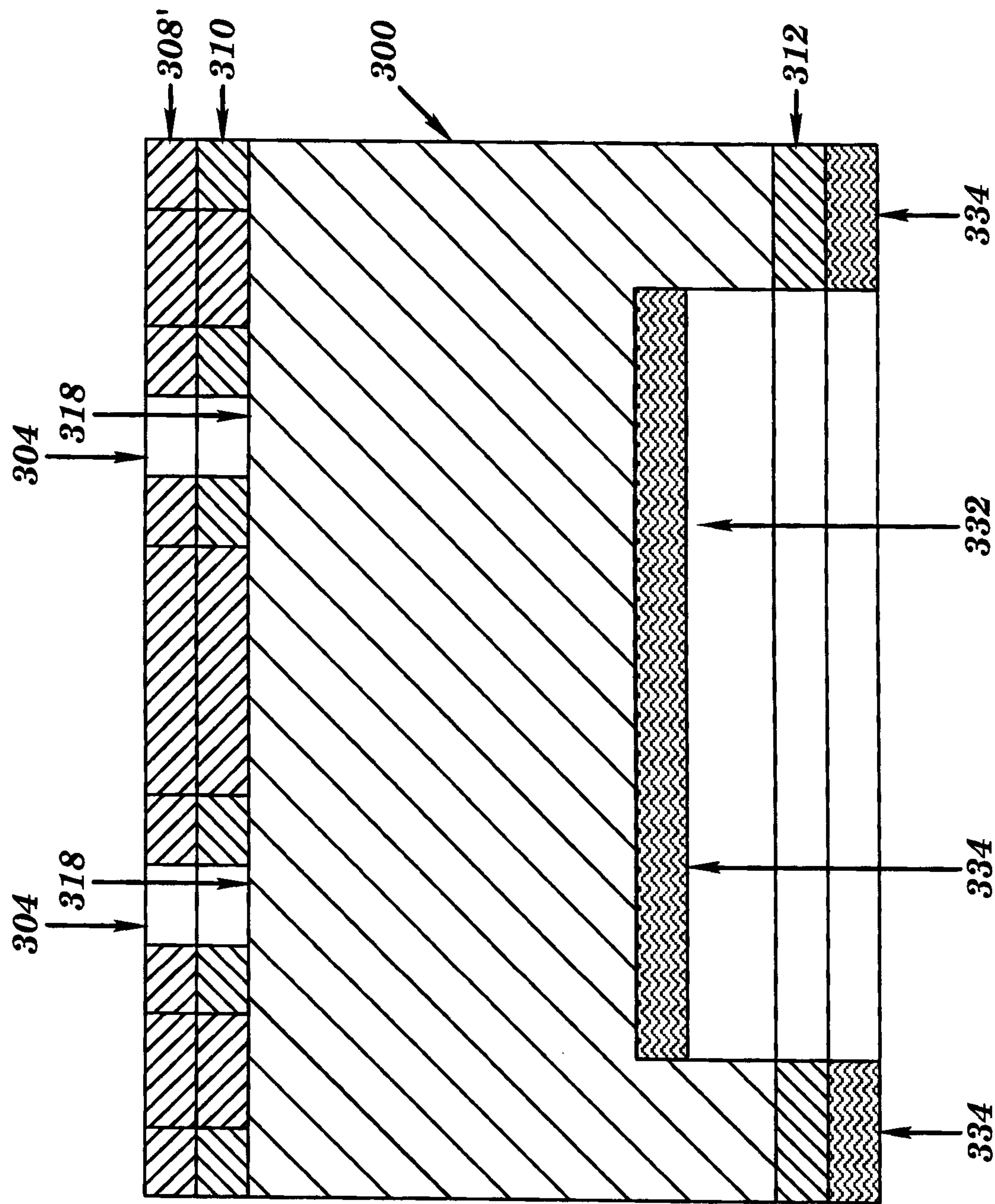


FIG. 19C

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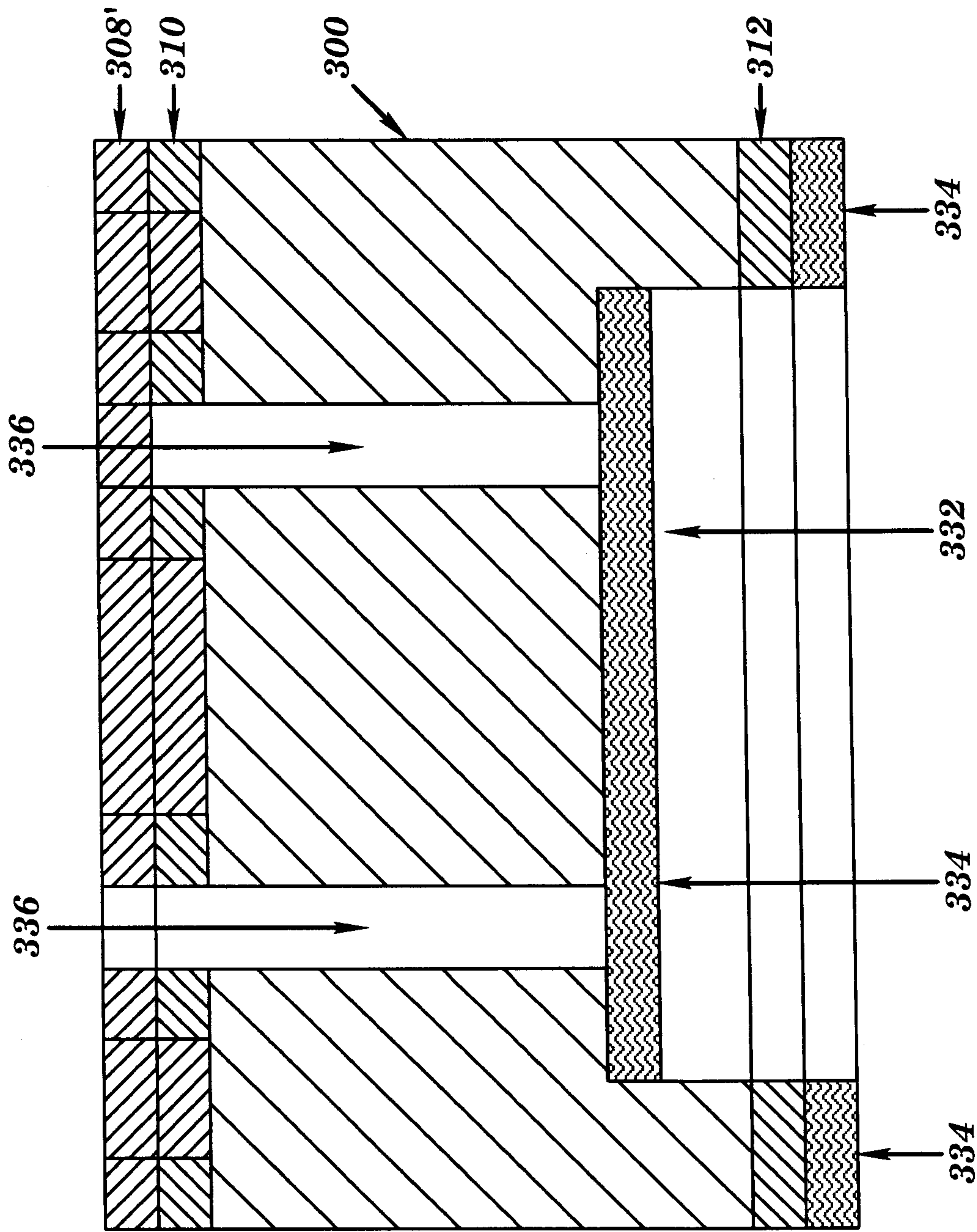


FIG. 19D

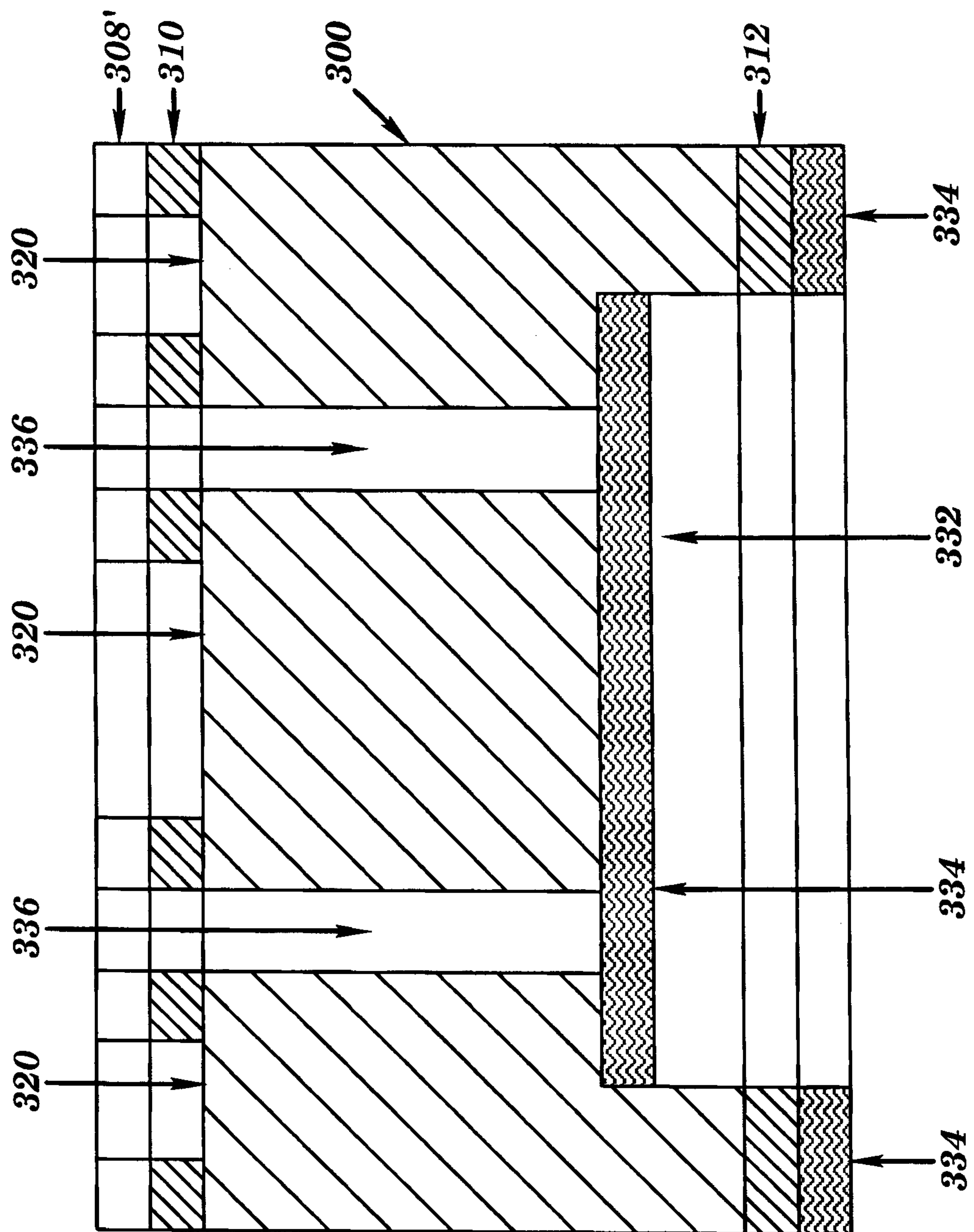


FIG. 19E

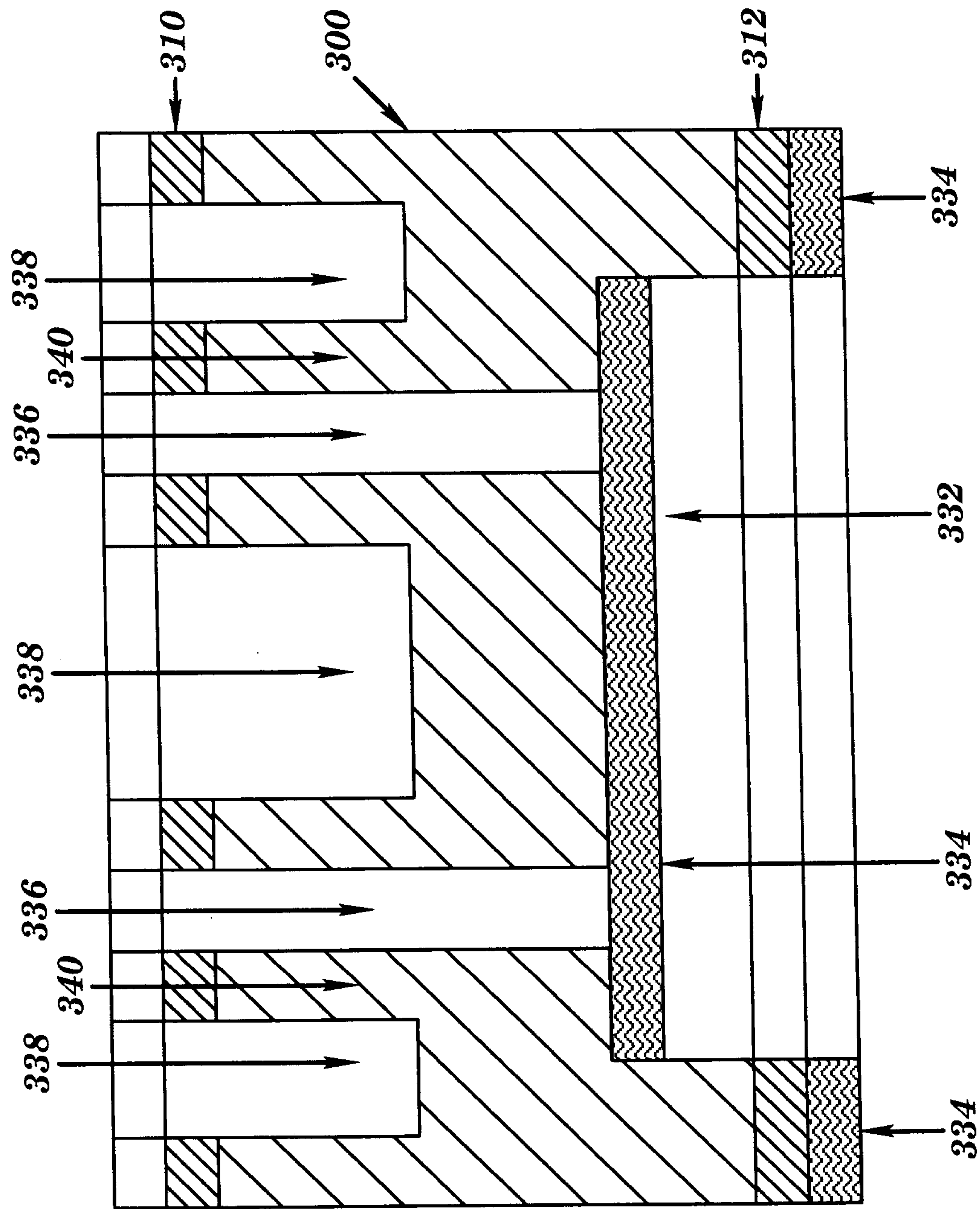


FIG. 19F

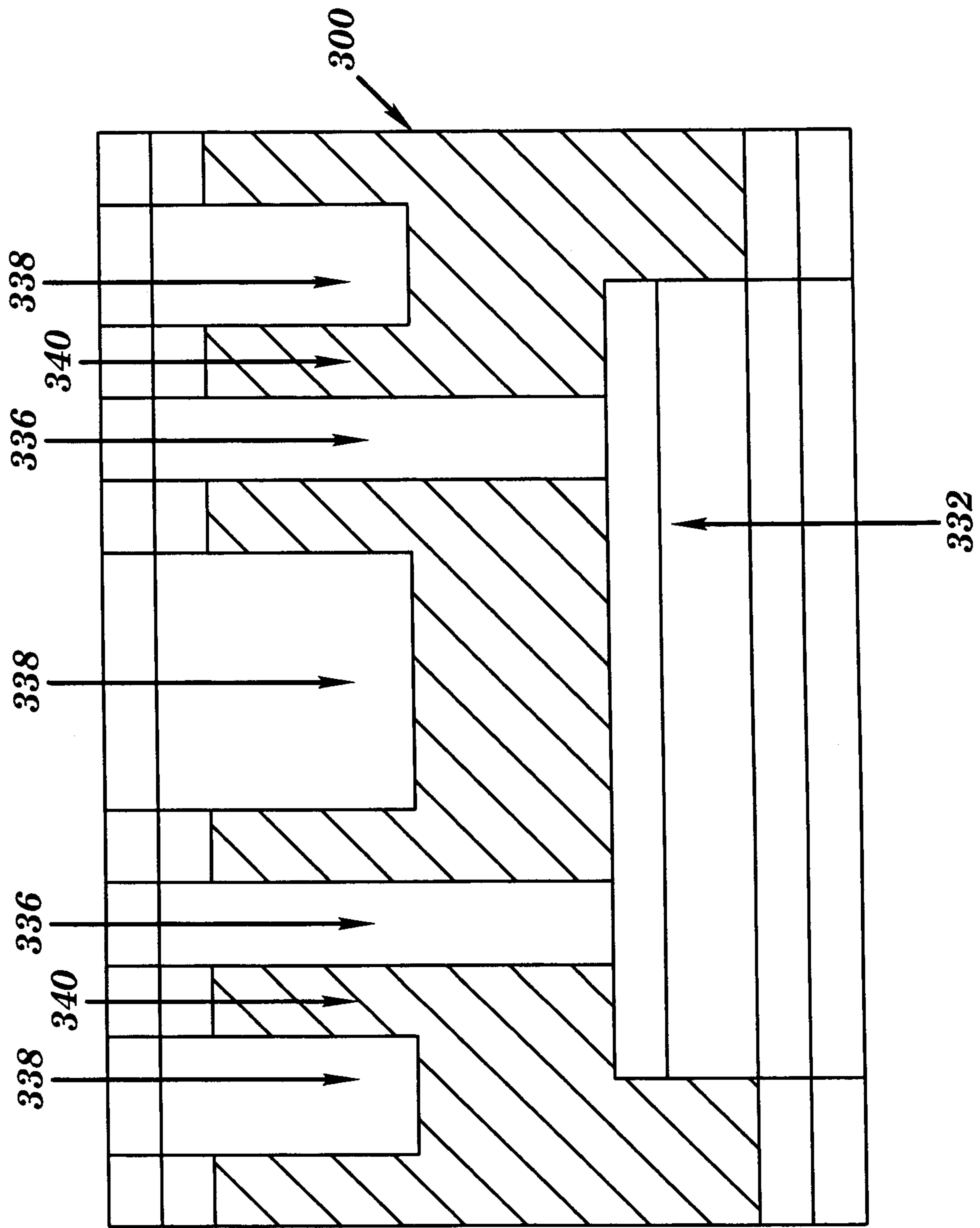


FIG. 19G

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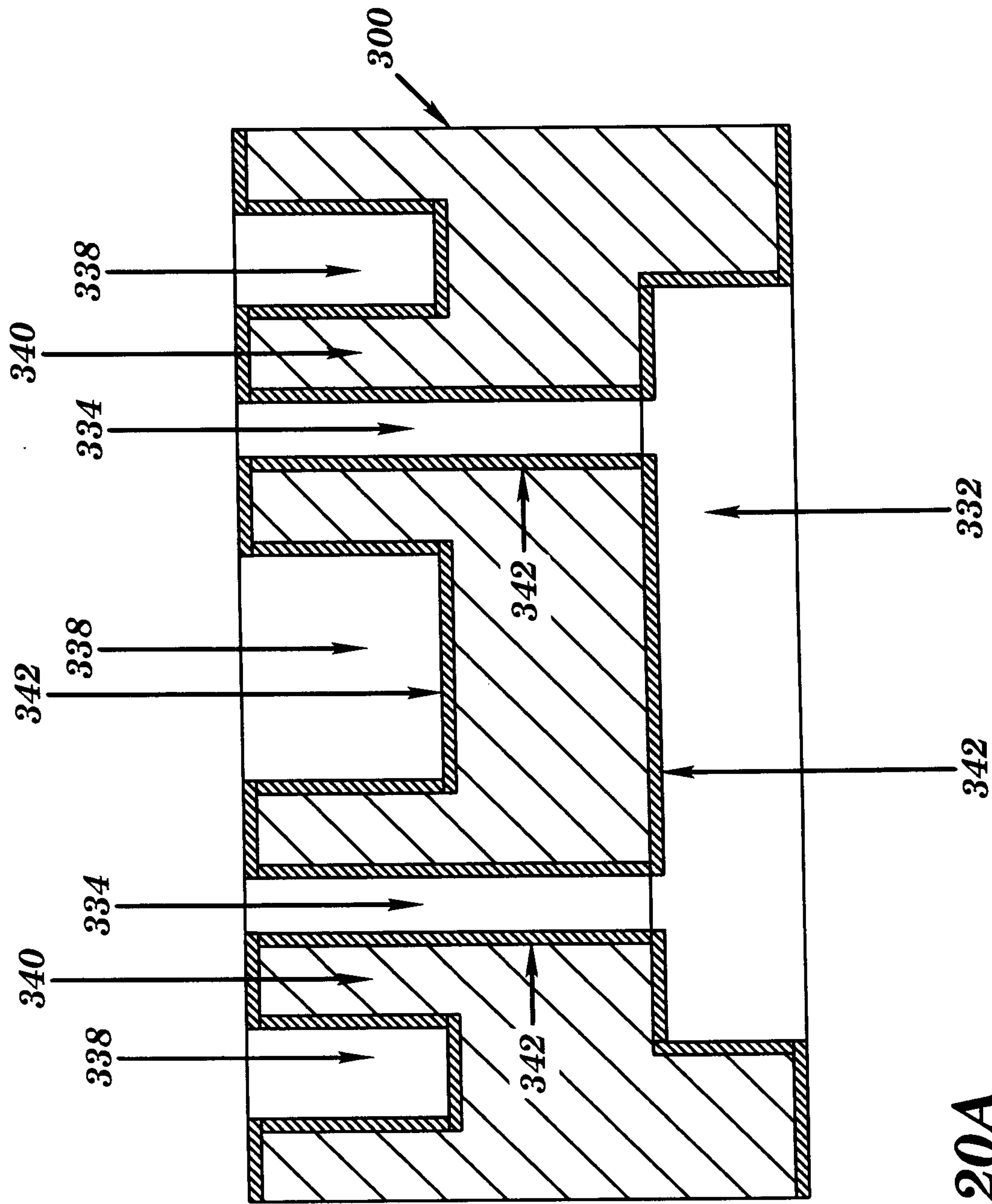


FIG. 20A

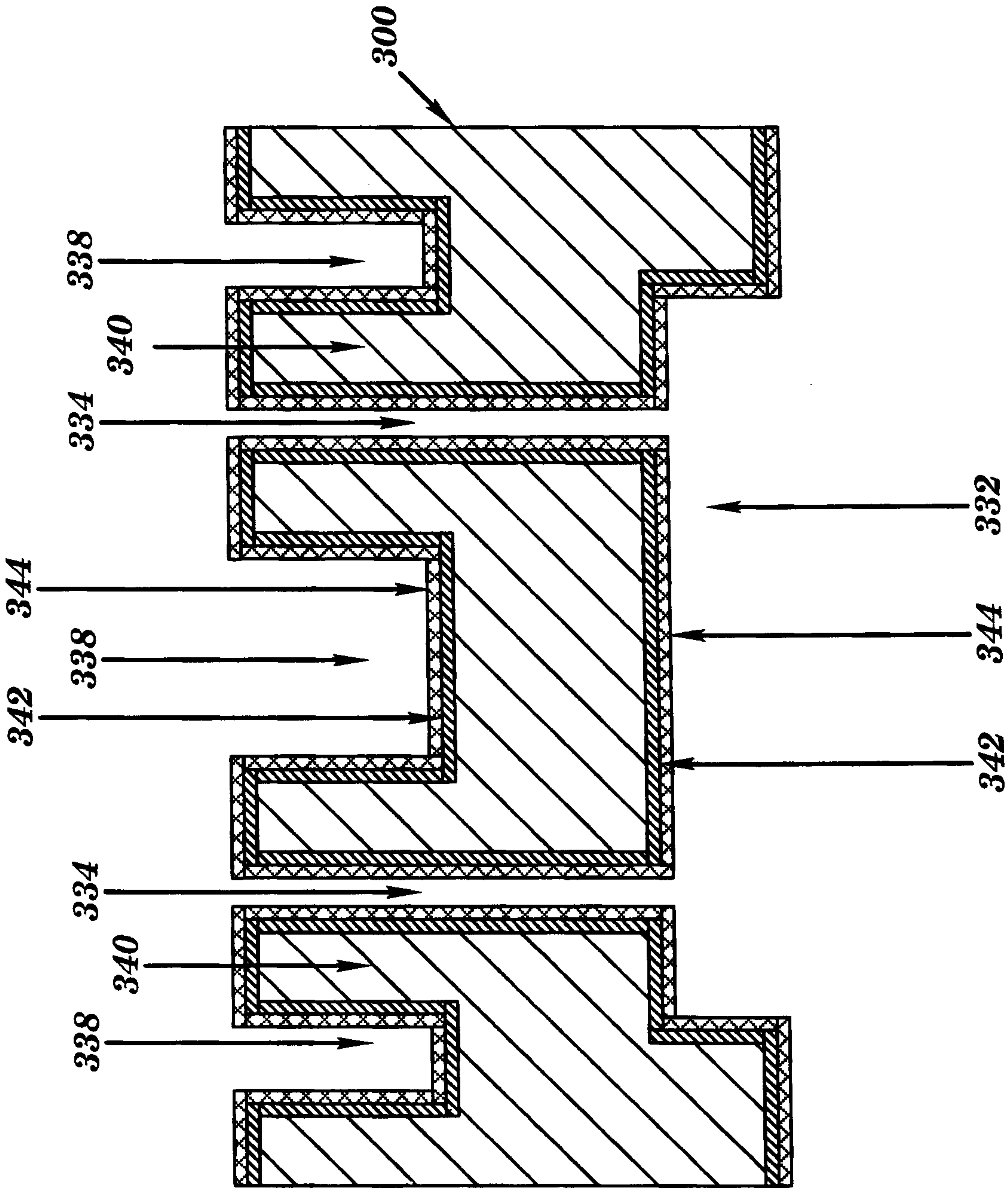


FIG. 20B

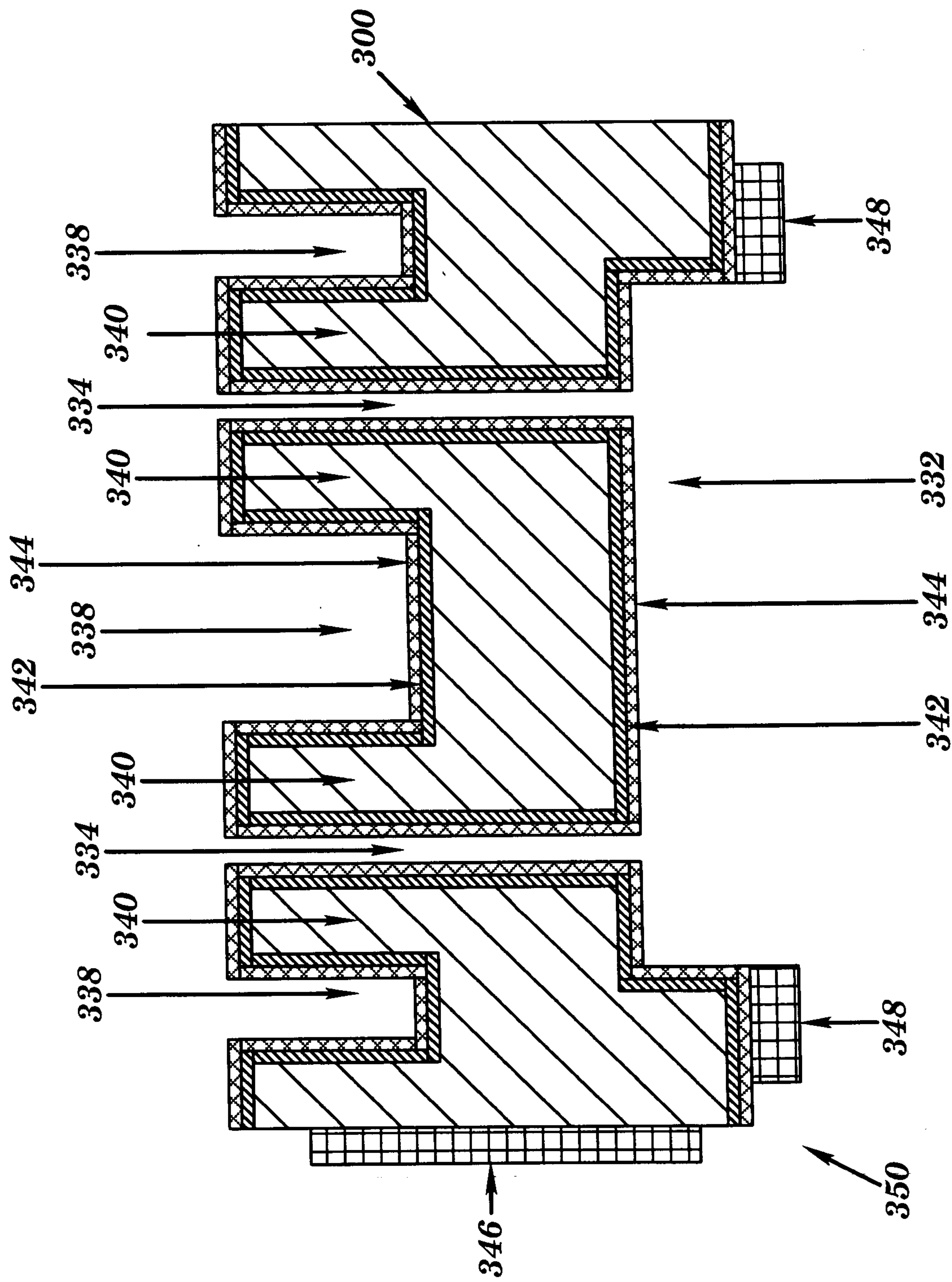


FIG. 20C

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Unscannable items
received with this application
(Request original documents in File Prep. Section on the 10th floor)

Documents reçu avec cette demande ne pouvant être balayés
(Commander les documents originaux dans la section de préparation des dossiers au
10^{ème} étage)

